THE DATASHEET OF

S25FL127SABMFV001

www.win-source.net 0086-755-83957316

128 Mb (16 MB) FL-S Flash

SPI Multi-I/O, 3.0 V

Features

- CMOS 3.0 V core
- Density
  - 128 Mb (16 MB)
- SPI with multi-I/O
  - SPI clock polarity and phase modes 0 and 3
  - Extended addressing: 24- or 32-bit address options
  - Serial command set and footprint compatible with S25FL-A, S25FL-K, and S25FL-P SPI families
  - Multi I/O command set and footprint compatible with S25FL-P SPI family
- READ commands
  - Normal, Fast, Dual, Quad
  - AutoBoot - power up or reset and execute a Normal or Quad read command automatically at a preselected address
  - Common flash interface (CFI) data for configuration information.
- Programming (0.8 MBps)
  - 256- or 512-byte page programming buffer options
  - Quad-input page programming (QPP) for slow clock systems
  - Automatic ECC -internal hardware error correction code generation with single bit error correction
- Erase (0.5 MBps)
  - Hybrid sector size option - physical set of sixteen 4-KB sectors at top or bottom of address space with all remaining sectors of 64 KB
  - Uniform sector option - always erase 256-KB blocks for software compatibility with higher density and future devices.
- Cycling endurance
  - 100,000 program-erase cycles per sector, minimum
- Data retention
  - 20 year data retention, minimum
- Security features
  - One-time programmable (OTP) array of 1024 bytes
  - Block protection:
    - Status Register bits to control protection against program or erase of a contiguous range of sectors.
    - Hardware and software control options
  - Advance sector protection (ASP)
    - Individual sector protection controlled by boot code or password
- 65-nm MIRRORBIT™ technology with Eclipse architecture
- Supply voltage: 2.7 V to 3.6 V
- Temperature range:
  - Industrial (–40°C to +85°C)
  - Industrial Plus (–40°C to +105°C)
  - Automotive AEC-Q100 grade 3 (–40°C to +85°C)
  - Automotive AEC-Q100 grade 2 (–40°C to +105°C)

- Packages (all Pb-free)
  - 8-lead SOIC (208 mil)
  - 16-lead SOIC (300 mil)
  - 8-contact WSON 6 x 5 mm
  - BGA-24 6 x 8 mm
    - 5 x 5 ball (FAB024) and 4 x 6 ball (FAC024) footprint options
  - Known good die (KGD) and known tested die

Performance summary

Maximum read rates

Command	Clock rate (MHz)	MBps
Read	50	6.25
Fast Read	108	13.5
Dual Read	108	27
Quad Read	108	54

Typical program and erase rates

Operation	KBps
Page programming (256-byte page buffer)	650
Page programming (512-byte page buffer)	800
4-KB physical sector erase (hybrid sector option)	30
64-KB physical sector erase (hybrid sector option)	500
256-KB logical sector erase (uniform sector option)	500
256-KB logical sector erase (uniform sector option)	500

Current consumption

Operation	Current (mA)
Serial read 50 MHz	16 (max)
Serial read 108 MHz	24 (max)
Quad read 108 MHz	47 (max)
Program	50 (max)
Erase	50 (max)
Standby	0.07 (typ)

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1 Overview

1.1 General description

The S25FL127S device is a flash non-volatile memory product using:

- MIRRORBIT™ technology - that stores two data bits in each memory array transistor
- Eclipse architecture - that dramatically improves program and erase performance
- 65-nm process lithography

This device connects to a host system via an SPI. Traditional SPI single bit serial input and output (Single I/O or SIO) is supported as well as optional two bit (Dual I/O or DIO) and four bit (Quad I/O or QIO) serial commands. This multiple width interface is called SPI multi-I/O or MIO.

The Eclipse architecture features a page programming buffer that allows up to 128 words (256 bytes) or 256 words (512 bytes) to be programmed in one operation, resulting in faster effective programming and erase than prior generation SPI program or erase algorithms.

Executing code directly from flash memory is often called eXecute-in-Place (XIP). By using FL-S devices at the higher clock rates supported, with QIO command, the instruction read transfer rate can match or exceed traditional parallel interface, asynchronous, NOR flash memories while reducing signal count dramatically.

The S25FL127S product offers a high density coupled with the flexibility and fast performance required by a variety of embedded applications. It is ideal for code shadowing, XIP, and data storage.

1.2 Migration notes

1.2.1 Features comparison

The S25FL127S device is command set and footprint compatible with prior generation FL-K, FL-P, and FL-S family devices.

Table 1 FL generations comparison

Parameter	FL-K	FL-P	FL-S	FL127S
Technology Node	90-nm	90-nm	65-nm	65-nm
Architecture	Floating Gate	MIRRORBIT™	MIRRORBIT™ Eclipse	MIRRORBIT™ Eclipse
Density	4 Mb–128 Mb	32 Mb–256 Mb	128 Mb, 256 Mb, 512 Mb, 1 Gb	128 Mb
Bus Width	x1, x2, x4	x1, x2, x4	x1, x2, x4	x1, x2, x4
Supply Voltage	2.7V - 3.6V	2.7V - 3.6V	2.7V - 3.6V / 1.65V - 3.6V V_{IO}	2.7V - 3.6V
Normal Read Speed (SDR)	6 MBps (50 MHz)	5 MBps (40 MHz)	6 MBps (50 MHz)	6 MBps (50 MHz)
Fast Read Speed (SDR)	13 MBps (104 MHz)	13 MBps (104 MHz)	17 MBps (133 MHz)	13.5 MBps (108 MHz)
Dual Read Speed (SDR)	26 MBps (104 MHz)	20 MBps (80 MHz)	26 MBps (104 MHz)	27 MBps (108 MHz)

Notes
1. 256B program page option only for 128 Mb and 256-Mb density FL-S devices.
2. FL-P column indicates FL129P MIO SPI device (for 128-Mb density). FL128P does not support MIO, OTP or 4-KB sectors.
3. 64-KB sector erase option only for 128-Mb/256-Mb density FL-P and FL-S devices.
4. FL-K family devices can erase 4-KB sectors in groups of 32 KB or 64 KB.
5. Refer to individual datasheets for further details.

Table 1 FL generations comparison (Continued)

Parameter	FL-K	FL-P	FL-S	FL127S
Quad Read Speed (SDR)	52 MBps (104 MHz)	40 MBps (80 MHz)	52 MBps (104 MHz)	54 MBps (108 MHz)
Fast Read Speed (DDR)	–	–	16 MBps (66 MHz)	–
Dual Read Speed (DDR)	–	–	33 MBps (66 MHz)	–
Quad Read Speed (DDR)	–	–	66 MBps (66 MHz)	–
Program Buffer Size	256B	256B	256B / 512B	256B / 512B
Uniform Sector Size	4 KB	64 KB / 256 KB	64 KB / 256 KB	64 KB / 256 KB
Parameter Sector Size	N/A	4 KB	4 KB (option)	4 KB (option)
Number of Parameter Sector	0	32	32 (option)	16 (option)
Sector Erase Rate (typ.)	135 KBps (4 KB), 435 KBps (64 KB)	130 KBps (64 KB)	30 KBps (4 KB), 500 KBps (64 KB / 256 KB)	30 KBps (4 KB), 500 KBps (64 KB / 256 KB)
Page Programming Rate (typ.)	365 KBps (256B)	170 KBps (256B)	1000 KBps (256B), 1500 KBps (512B)	650 KBps (256B), 800 KBps (512B)
OTP	768B (3 x 256B)	506B	1024B	1024B
Advanced Sector Protection	No	No	Yes	Yes
Auto Boot Mode	No	No	Yes	Yes
Erase Suspend/Resume	Yes	No	Yes	Yes
Program Suspend/ Resume	Yes	No	Yes	Yes
Operating Temperature	–40 °C to +85 °C	–40 °C to +85 °C / +105 °C	–40 °C to +85 °C / +105 °C	–40 °C to +85 °C / +105 °C

Notes
1. 256B program page option only for 128 Mb and 256-Mb density FL-S devices.
2. FL-P column indicates FL129P MIO SPI device (for 128-Mb density). FL128P does not support MIO, OTP or 4-KB sectors.
3. 64-KB sector erase option only for 128-Mb/256-Mb density FL-P and FL-S devices.
4. FL-K family devices can erase 4-KB sectors in groups of 32 KB or 64 KB.
5. Refer to individual datasheets for further details.

1.2.2 Known differences from prior generations

1.2.2.1 Error reporting

Prior generation FL memories either do not have error status bits or do not set them if program or erase is attempted on a protected sector. The FL-S family does have error reporting status bits for program and erase operations. These can be set when there is an internal failure to program or erase or when there is an attempt to program or erase a protected sector. In either case the program or erase operation did not complete as requested by the command.

1.2.2.2 Secure silicon region (OTP)

The size and format (address map) of the one time program area is different from prior generations. The method for protecting each portion of the OTP area is different. For additional details see **"Secure silicon region (OTP)"** on page 69.

1.2.2.3 Configuration Register Freeze Bit

The Configuration Register Freeze Bit CR1[0], locks the state of the Block Protection bits as in prior generations. In the FL-S family it also locks the state of the configuration register TBPARM bit CR1[2], TBPROT bit CR1[5], and the secure silicon region (OTP) area.

1.2.2.4 Sector architecture

The FL127S has sixteen 4-KB sectors that may be located at the top or bottom of address space. Other members of the FL-S family and FL-P family have thirty two 4-KB sectors that may be located at the top or bottom of address space.

These smaller parameter sectors may also be removed, leaving all sectors uniform in size, depending on the selected configuration (SR2[7]).

1.2.2.5 Sector Erase commands

The command for erasing an 8-KB area (two 4-KB sectors) is not supported.

The command for erasing a 4-KB sector is supported only for use on the 4-KB parameter sectors at the top or bottom of the device address space. The 4-KB erase command will only erase the parameter sectors.

The erase command for 64-KB sectors is supported when the configuration option for 4-KB parameter sectors with 64-KB uniform sectors is used. The 64-KB erase command may be applied to erase a group of sixteen 4-KB sectors.

The erase command for a 256-KB sector replaces the 64-KB erase command when the configuration option for 256-KB uniform sectors is used.

1.2.2.6 Deep power down

The Deep power down (DPD) function is not supported in FL-S family devices.

The legacy DPD (B9h) command code is instead used to enable legacy SPI memory controllers, that can issue the former DPD command, to access a new bank address register. The bank address register allows SPI memory controllers that do not support more than 24 bits of address, the ability to provide higher order address bits for commands, as needed to access the larger address space of the 256-Mb and 512-Mb density FL-S devices. For additional information see **"Extended address"** on page 53.

1.2.2.7 Hardware reset

A separate hardware reset input is provided in packages with greater than 8 connections. In 8-connection packages, a new option is provided to replace the HOLD# / IO3 input with an IO3 / RESET# input to allow for hardware reset in small packages.

1.2.2.8 New features

The FL-S family introduces several new features to SPI category memories:

- Extended address for access to higher memory density.
- AutoBoot for simpler access to boot code following power up.
- Enhanced high performance read commands using mode bits to eliminate the overhead of SIO instructions when repeating the same type of read command.
- Multiple options for initial read latency (number of dummy cycles) for faster initial access time or higher clock rate read commands.
- Automatic ECC for enhanced data integrity.
- Advanced sector protection for individually controlling the protection of each sector. This is very similar to the advanced sector protection feature found in several other parallel interface NOR memory families.

2 SPI with multiple input / output (SPI-MIO)

Many memory devices connect to their host system with separate parallel control, address, and data signals that require a large number of signal connections and larger package size. The large number of connections increase power consumption due to so many signals switching and the larger package increases cost.

The S25FL-S family of devices reduces the number of signals for connection to the host system by serially transferring all control, address, and data information over 4 to 6 signals. This reduces the cost of the memory package, reduces signal switching power, and either reduces the host connection count or frees host connectors for use in providing other features.

The S25FL-S family of devices uses the industry standard single bit serial peripheral interface (SPI) and also supports optional extension commands for two bit (Dual) and four bit (Quad) wide serial transfers. This multiple width interface is called SPI multi-I/O or SPI-MIO.

3 Signal descriptions

3.1 Input/output summary

Table 2 Signal list

Signal name	Type	Description
RESET#	Input	**Hardware Reset.** The signal has an internal pull-up resistor and should be left unconnected in the host system if not used.
SCK	Input	**Serial Clock.**
CS#	Input	**Chip Select.**
SI / IO0	I/O	**Serial Input** for single bit data commands or IO0 for Dual or Quad commands.
SO / IO1	I/O	**Serial Output** for single bit data commands. IO1 for Dual or Quad commands.
WP# / IO2	I/O	**Write Protect** when not in Quad mode. IO2 in Quad mode. The signal has an internal pull-up resistor and may be left unconnected in the host system if not used for Quad commands.
HOLD# / IO3 or IO3 / RESET#	I/O	**Hold** (pause) serial transfer in single bit or Dual data commands. IO3 in Quad-I/O mode. RESET# when enabled by SR2[5] = 1 and not in Quad I/O mode, CR1[1] = 0. or when CS# is HIGH. The signal has an internal pull-up resistor and may be left unconnected in the host system if not used for Quad commands.
V_{CC}	Supply	**Power Supply.**
V_{SS}	Supply	**Ground.**
NC	Unused	**Not Connected.** No device internal signal is connected to the package connector nor is there any future plan to use the connector for a signal. The connection may safely be used for routing space for a signal on a printed circuit board (PCB). However, any signal connected to an NC must not have voltage levels higher than V_{CC}.
RFU	Reserved	**Reserved for Future Use.** No device internal signal is currently connected to the package connector but there is potential future use of the connector for a signal. It is recommended to not use RFU connectors for PCB routing channels so that the PCB may take advantage of future enhanced features in compatible footprint devices.
DNU	Reserved	**Do Not Use.** A device internal signal may be connected to the package connector. The connection may be used by Infineon for test or other purposes and is not intended for connection to any host system signal. Any DNU signal related function will be inactive when the signal is at V_{IL}. The signal has an internal pull-down resistor and may be left unconnected in the host system or may be tied to V_{SS}. Do not use these connections for PCB signal routing channels. Do not connect any host system signal to this connection.

3.2 Address and data configuration

Traditional SPI single bit wide commands (single or SIO) send information from the host to the memory only on the SI signal. Data may be sent back to the host serially on the Serial Output (SO) signal.

Dual or Quad Output commands send information from the host to the memory only on the SI signal. Data will be returned to the host as a sequence of bit pairs on IO0 and IO1 or four bit (nibble) groups on IO0, IO1, IO2, and IO3.

Dual or Quad Input/Output (I/O) commands send information from the host to the memory as bit pairs on IO0 and IO1 or four bit (nibble) groups on IO0, IO1, IO2, and IO3. Data is returned to the host similarly as bit pairs on IO0 and IO1 or four bit (nibble) groups on IO0, IO1, IO2, and IO3.

3.3 Hardware Reset (RESET#)

The RESET# input provides a hardware method of resetting the device to standby state, ready for receiving a command. When RESET# is driven to logic LOW (V_{IL}) for at least a period of t_{RP}, the device:

- terminates any operation in progress,
- tristates all outputs,
- resets the volatile bits in the Configuration Register,
- resets the volatile bits in the Status Registers,
- resets the Bank Address Register to 0,
- loads the Program Buffer with all 1s,
- reloads all internal configuration information necessary to bring the device to standby mode,
- and resets the internal Control Unit to standby state.

RESET# causes the same initialization process as is performed when power comes up and requires t_{PU} time.

RESET# may be asserted LOW at any time. To ensure data integrity any operation that was interrupted by a hardware reset should be reinitiated once the device is ready to accept a command sequence.

When RESET# is first asserted LOW, the device draws I_{CC1} (50 MHz value) during t_{PU}. If RESET# continues to be held at V_{SS} the device draws CMOS standby current (I_{SB}).

RESET# has an internal pull-up resistor and should be left unconnected in the host system if not used.

The RESET# input is not available on all packages options. When not available the RESET# input of the device is tied to the inactive state, inside the package.

3.4 Serial Clock (SCK)

This input signal provides the synchronization reference for the SPI interface. Instructions, addresses, or data input are latched on the rising edge of the SCK signal. Data output changes after the falling edge of SCK.

3.5 Chip Select (CS#)

The chip select signal indicates when a command for the device is in process and the other signals are relevant for the memory device. When the CS# signal is at the logic HIGH state, the device is not selected and all input signals are ignored and all output signals are high impedance. Unless an internal program, erase or write registers (WRR) embedded operation is in progress, the device will be in the Standby Power mode. Driving the CS# input to logic LOW state enables the device, placing it in the Active Power mode. After power-up, a falling edge on CS# is required prior to the start of any command.

CS# toggle with no CLK and data is considered as non-valid. The flash should not be selected (CS# LOW with no CLK and data) when it's not being addressed. This is considered as a spec violation and can eventually cause the device to remain in busy state (SR1 = 0x03) after an embedded operation (program/erase/and so on).

3.6 Serial Input (SI) / IO0

This input signal is used to transfer data serially into the device. It receives instructions, addresses, and data to be programmed. Values are latched on the rising edge of serial SCK clock signal.

SI becomes IO0 - an input and output during Dual and Quad commands for receiving instructions, addresses, and data to be programmed (values latched on rising edge of serial SCK clock signal) as well as shifting out data (on the falling edge of SCK).

3.7 Serial Output (SO) / IO1

This output signal is used to transfer data serially out of the device. Data is shifted out on the falling edge of the serial SCK clock signal.

SO becomes IO1 - an input and output during Dual and Quad commands for receiving addresses, and data to be programmed (values latched on rising edge of serial SCK clock signal) as well as shifting out data (on the falling edge of SCK.

3.8 Write Protect (WP#) / IO2

When WP# is driven LOW (V_{IL}), during a WRR command and while the Status Register Write Disable (SRWD) bit of the Status Register is set to a 1, it is not possible to write to the Status and Configuration Registers. This prevents any alteration of the Block Protect (BP2, BP1, BP0) and TBPROT bits of the Status Register. As a consequence, all the data bytes in the memory area that are protected by the Block Protect and TBPROT bits, are also hardware protected against data modification if WP# is LOW during a WRR command.

The WP# function is not available when the Quad mode is enabled (CR[1] = 1). The WP# function is replaced by IO2 for input and output during Quad mode for receiving addresses, and data to be programmed (values are latched on rising edge of the SCK signal) as well as shifting out data (on the falling edge of SCK).

WP# has an internal pull-up resistor; when unconnected, WP# is at V_{IH} and may be left unconnected in the host system if not used for Quad mode.

3.9 Hold (HOLD#) / IO3 / RESET#

The Hold (HOLD#) signal is used to pause any serial communications with the device without deselecting the device or stopping the serial clock. The HOLD# input and function is available when enabled by a configuration bit SR2[5] = 0.

To enter the Hold condition, the device must be selected by driving the CS# input to the logic LOW state. It is recommended that the user keep the CS# input LOW state during the entire duration of the Hold condition. This is to ensure that the state of the interface logic remains unchanged from the moment of entering the Hold condition. If the CS# input is driven to the logic HIGH state while the device is in the Hold condition, the interface logic of the device will be reset. To restart communication with the device, it is necessary to drive HOLD# to the logic HIGH state while driving the CS# signal into the logic LOW state. This prevents the device from going back into the Hold condition.

The Hold condition starts on the falling edge of the Hold (HOLD#) signal, provided that this coincides with SCK being at the logic LOW state. If the falling edge does not coincide with the SCK signal being at the logic LOW state, the Hold condition starts whenever the SCK signal reaches the logic LOW state. Taking the HOLD# signal to the logic LOW state does not terminate any write, program or erase operation that is currently in progress.

During the Hold condition, SO is in high impedance and both the SI and SCK input are Don’t Care.

The Hold condition ends on the rising edge of the Hold (HOLD#) signal, provided that this coincides with the SCK signal being at the logic LOW state. If the rising edge does not coincide with the SCK signal being at the logic LOW state, the Hold condition ends whenever the SCK signal reaches the logic LOW state.

The HOLD# function is not available when the Quad mode is enabled (CR1[1] = 1). The Hold function is replaced by IO3 for input and output during Quad mode for receiving addresses, and data to be programmed (values are latched on rising edge of the SCK signal) as well as shifting out data (on the falling edge of SCK.

A configuration bit SR2[5] may be set to 1 to replace the HOLD# / IO3 functions with the IO3 / RESET# functions. Then the IO3 / RESET# may be used to initiate the hardware reset function. The IO3 / RESET# input is only treated as RESET# when the device is not in Quad-I/O mode, CR1[1] = 0, or when CS# is HIGH.

When Quad I/O mode is in use, CR1[1] = 1, and the device is selected with CS# LOW, the IO3 / RESET# is used only as IO3 for information transfer. When CS# is HIGH, the IO3 / RESET# is not in use for information transfer and is used as the RESET# input. By conditioning the reset operation on CS# HIGH during Quad mode, the reset function remains available during Quad mode.

When the system enters a reset condition, the CS# signal must be driven HIGH as part of the reset process and the IO3 / RESET# signal is driven LOW. When CS# goes HIGH, the IO3 / RESET# input transitions from being IO3 to being the RESET# input. The reset condition is then detected when CS# remains HIGH and the IO3 / RESET# signal remains LOW for t_{RP}.

The HOLD#/IO3 or IO3/RESET# signals have an internal pull-up resistor and may be left unconnected in the host system if not used for Quad mode or the reset function.

When Quad mode is enabled, IO3 / RESET# is ignored for t_{CS} following CS# going HIGH. This allows some time for the memory or host system to actively drive IO3 / RESET# to a valid level following the end of a transfer. Following the end of a Quad I/O read, the memory will actively drive IO3 HIGH before disabling the output during t_{DIS}. Following a transfer in which IO3 was used to transfer data to the memory, e.g. the QPP command, the host system is responsible for driving IO3 HIGH before disabling the host IO3 output. This will ensure that IO3 / Reset is not left floating or being pulled slowly to HIGH by the internal or an external passive pull-up. Thus, an unintended reset is not triggered by the IO3 / RESET# not being recognized as HIGH before the end of t_{RP}. Once IO3 / RESET# is HIGH, the memory or host system can stop driving the signal. The integrated pull-up on IO3 will then hold IO3 HIGH unless the host system actively drives IO3 / RESET# to initiate a reset.

Note that IO3 / Reset# cannot be shared by more than one SPI-MIO memory if any of them are operating in Quad I/O mode as IO3 being driven to or from one selected memory may look like a reset signal to a second not selected memory sharing the same IO3 / RESET# signal (see **“IO3 / RESET# input initiated hardware (warm) reset”** on page 37 for the IO3 / RESET timing).

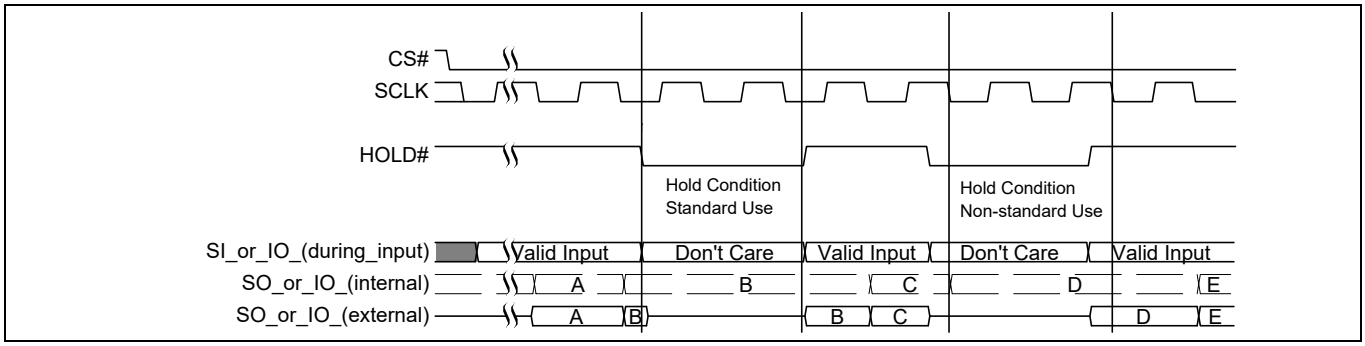


Figure 1 HOLD mode operation

3.10 Voltage Supply (V_{CC})

V_{CC} is the voltage source for all device internal logic. It is the single voltage used for all device internal functions including read, program, and erase. The voltage may vary from 2.7 V to 3.6 V.

3.11 Supply and Signal Ground (V_{SS})

V_{SS} is the common voltage drain and ground reference for the device core, input signal receivers, and output drivers.

3.12 Not Connected (NC)

No device internal signal is connected to the package connector nor is there any future plan to use the connector for a signal. The connection may safely be used for routing space for a signal on a Printed Circuit Board (PCB). However, any signal connected to an NC must not have voltage levels higher than V_{CC}.

3.13 Reserved for Future Use (RFU)

No device internal signal is currently connected to the package connector but is there potential future use of the connector. It is recommended to not use RFU connectors for PCB routing channels so that the PCB may take advantage of future enhanced features in compatible footprint devices.

3.14 Do Not Use (DNU)

A device internal signal may be connected to the package connector. The connection may be used by Cypress for test or other purposes and is not intended for connection to any host system signal. Any DNU signal related function will be inactive when the signal is at V_{IL}. The signal has an internal pull-down resistor and may be left unconnected in the host system or may be tied to V_{SS}. Do not use these connections for PCB signal routing channels. Do not connect any host system signal to these connections.

3.15 Block diagrams

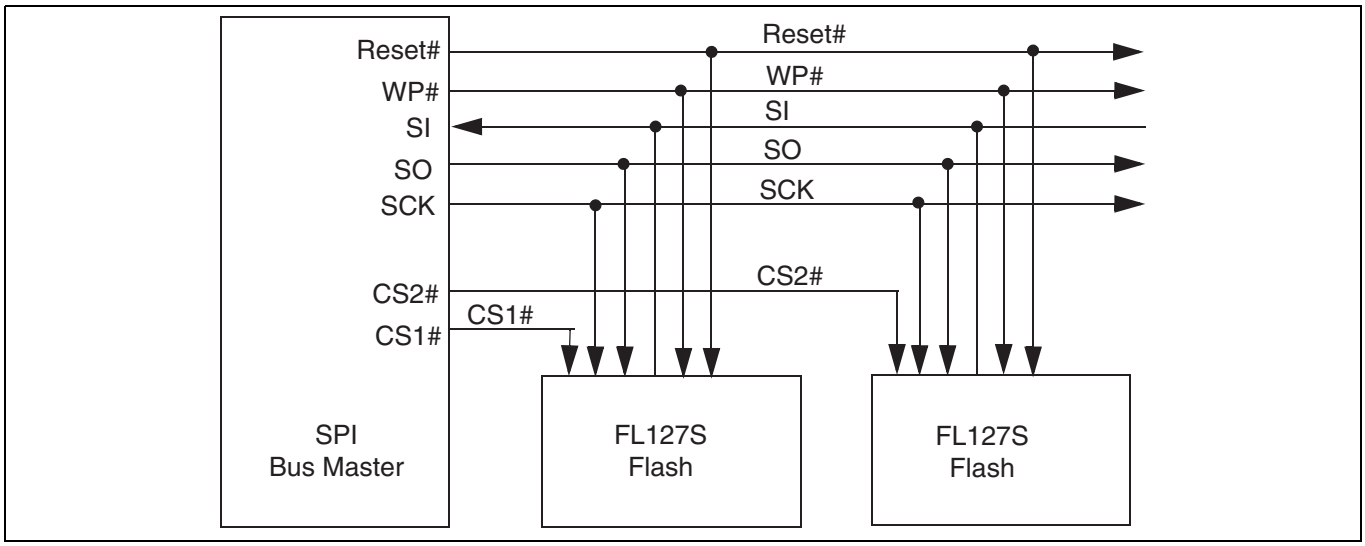


Figure 2 Bus master and memory devices on the SPI bus - single bit data path

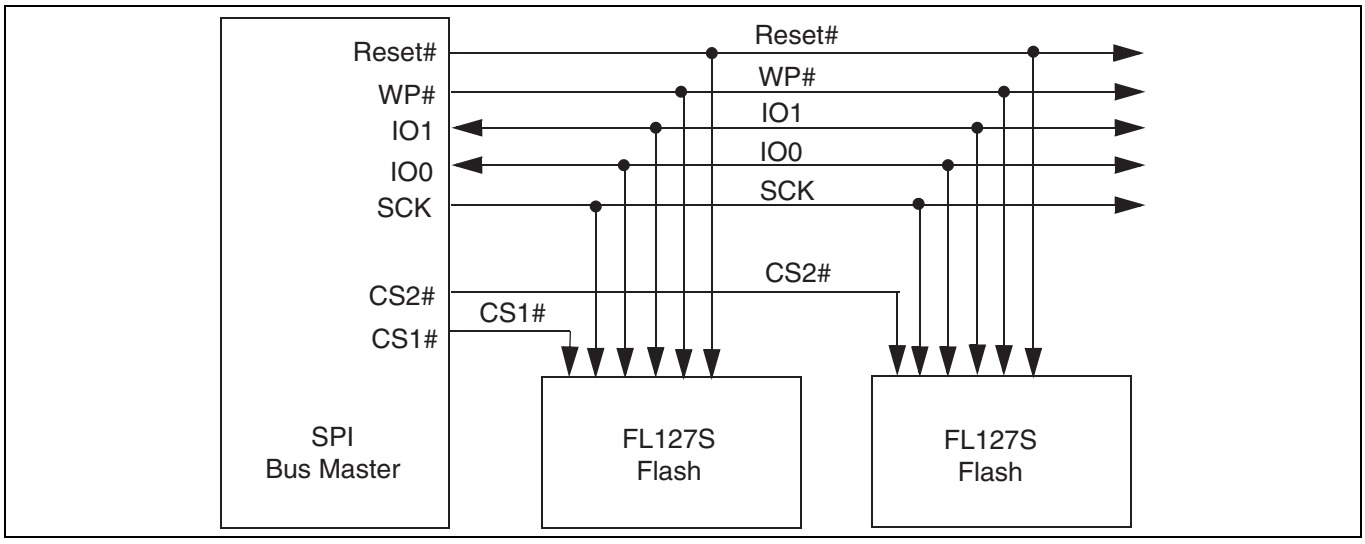


Figure 3 Bus master and memory devices on the SPI bus - dual bit data path

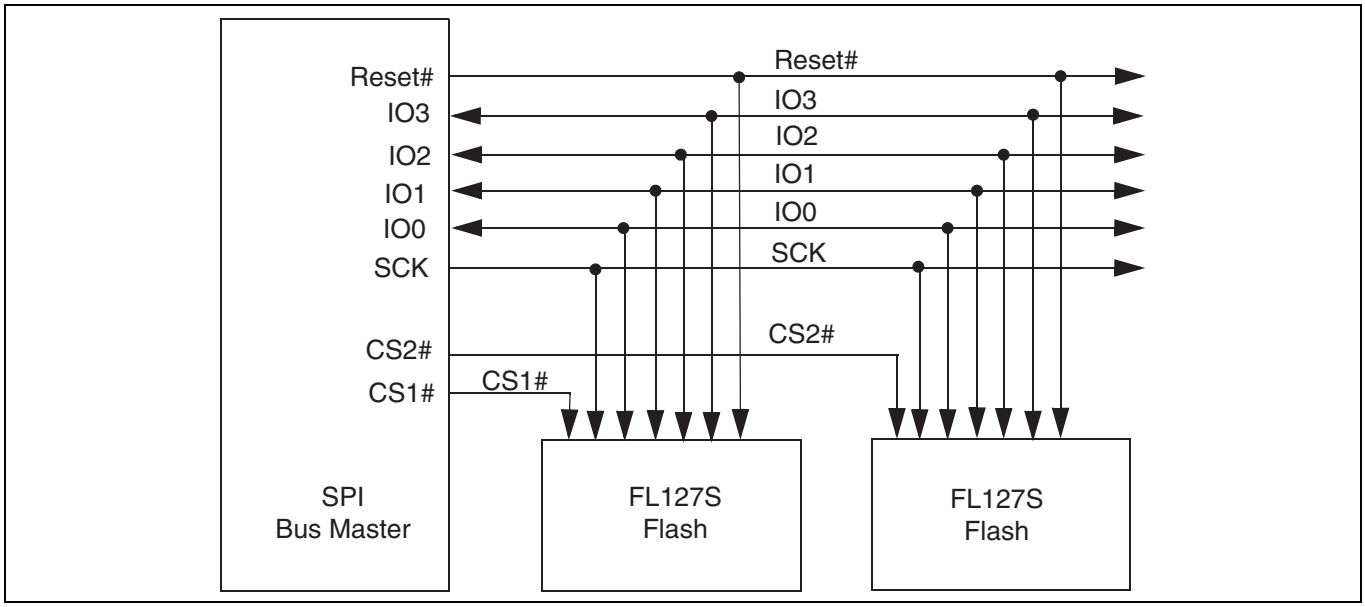


Figure 4 Bus master and memory devices on the SPI bus - quad bit data path

4 Signal protocols

4.1 SPI clock modes

4.1.1 Single data rate (SDR)

The S25FL-S family of devices can be driven by an embedded microcontroller (bus master) in either of the two following clocking modes.

- **Mode 0** with Clock Polarity (CPOL) = 0 and, Clock Phase (CPHA) = 0
- **Mode 3** with CPOL = 1 and, CPHA = 1

For these two modes, input data into the device is always latched in on the rising edge of the SCK signal and the output data is always available from the falling edge of the SCK clock signal.

The difference between the two modes is the clock polarity when the bus master is in standby mode and not transferring any data.

- SCK will stay at logic LOW state with CPOL = 0, CPHA = 0
- SCK will stay at logic HIGH state with CPOL = 1, CPHA = 1

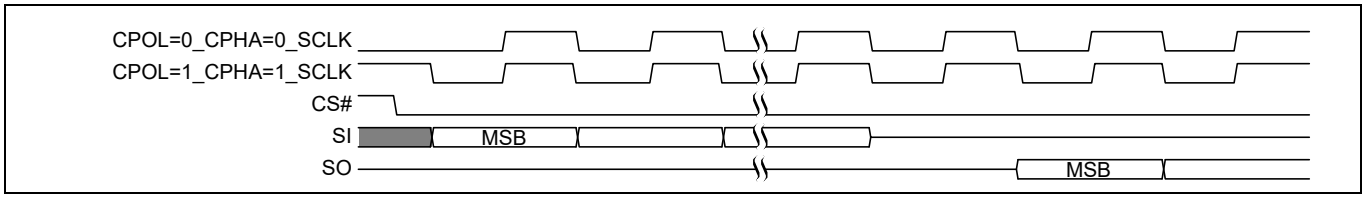


Figure 5 SPI Modes Supported

Timing diagrams throughout the remainder of the document are generally shown as both Mode 0 and 3 by showing SCK as both HIGH and LOW at the fall of CS#. In some cases a timing diagram may show only Mode 0 with SCK LOW at the fall of CS#. In this case, Mode 3 timing simply means clock is HIGH at the fall of CS# so no SCK rising edge set up or hold time to the falling edge of CS# is needed for Mode 3.

SCK cycles are measured (counted) from one falling edge of SCK to the next falling edge of SCK. In Mode 0, the beginning of the first SCK cycle in a command is measured from the falling edge of CS# to the first falling edge of SCK because SCK is already LOW at the beginning of a command.

4.2 Command protocol

All communication between the host system and S25FL-S family of memory devices is in the form of units called commands.

All commands begin with an instruction that selects the type of information transfer or device operation to be performed. Commands may also have an address, instruction modifier, latency period, data transfer to the memory, or data transfer from the memory. All instruction, address, and data information is transferred serially between the host system and memory device.

All instructions are transferred from host to memory as a single bit serial sequence on the SI signal.

Single bit wide commands may provide an address or data sent only on the SI signal. Data may be sent back to the host serially on the SO signal.

Dual or Quad Output commands provide an address sent to the memory only on the SI signal. Data will be returned to the host as a sequence of bit pairs on IO0 and IO1 or four bit (nibble) groups on IO0, IO1, IO2, and IO3.

Dual or Quad Input/Output (I/O) commands provide an address sent from the host as bit pairs on IO0 and IO1 or, four bit (nibble) groups on IO0, IO1, IO2, and IO3. Data is returned to the host similarly as bit pairs on IO0 and IO1 or, four bit (nibble) groups on IO0, IO1, IO2, and IO3.

Commands are structured as follows:

- Each command begins with CS# going LOW and ends with CS# returning HIGH. The memory device is selected by the host driving the Chip Select (CS#) signal LOW throughout a command.
- The serial clock (SCK) marks the transfer of each bit or group of bits between the host and memory.
- Each command begins with an eight bit (byte) instruction. The instruction is always presented only as a single bit serial sequence on the Serial Input (SI) signal with one bit transferred to the memory device on each SCK rising edge. The instruction selects the type of information transfer or device operation to be performed.
- The instruction may be standalone or may be followed by address bits to select a byte location within one of several address spaces in the device. The instruction determines the address space used. The address may be either a 24-bit or a 32-bit address. The address transfers occur on SCK rising edge.
- The width of all transfers following the instruction are determined by the instruction sent. Following transfers may continue to be single bit serial on only the SI or Serial Output (SO) signals, they may be done in two bit groups per (dual) transfer on the IO0 and IO1 signals, or they may be done in 4 bit groups per (quad) transfer on the IO0-IO3 signals. Within the dual or quad groups the least significant bit is on IO0. More significant bits are placed in significance order on each higher numbered IO signal. Single bits or parallel bit groups are transferred in most to least significant bit order.
- Some instructions send an instruction modifier called mode bits, following the address, to indicate that the next command will be of the same type with an implied, rather than an explicit, instruction. The next command thus does not provide an instruction byte, only a new address and mode bits. This reduces the time needed to send each command when the same command type is repeated in a sequence of commands. The mode bit transfers occur on SCK rising edge.
- The address or mode bits may be followed by write data to be stored in the memory device or by a read latency period before read data is returned to the host.
- Write data bit transfers occur on SCK rising edge.
- SCK continues to toggle during any read access latency period. The latency may be zero to several SCK cycles (also referred to as dummy cycles). At the end of the read latency cycles, the first read data bits are driven from the outputs on SCK falling edge at the end of the last read latency cycle. The first read data bits are considered transferred to the host on the following SCK rising edge. Each following transfer occurs on the next SCK rising edge.
- If the command returns read data to the host, the device continues sending data transfers until the host takes the CS# signal HIGH. The CS# signal can be driven HIGH after any transfer in the read data sequence. This will terminate the command.

- At the end of a command that does not return data, the host drives the CS# input HIGH. The CS# signal must go HIGH after the eighth bit, of a standalone instruction or, of the last write data byte that is transferred. That is, the CS# signal must be driven HIGH when the number of clock cycles after CS# signal was driven LOW is an exact multiple of eight cycles. If the CS# signal does not go HIGH exactly at the eight SCK cycle boundary of the instruction or write data, the command is rejected and not executed.
- All instruction, address, and mode bits are shifted into the device with the Most Significant bits (MSb) first. The data bits are shifted in and out of the device MSb first. All data is transferred in byte units with the lowest address byte sent first. Following bytes of data are sent in lowest to highest byte address order i.e. the byte address increments.
- All attempts to read the flash memory array during a program, erase, or a write cycle (embedded operations) are ignored. The embedded operation will continue to execute without any affect. A very limited set of commands are accepted during an embedded operation. These are discussed in the individual command descriptions.
- Depending on the command, the time for execution varies. A command to read status information from an executing command is available to determine when the command completes execution and whether the command was successful.

4.2.1 Command sequence examples

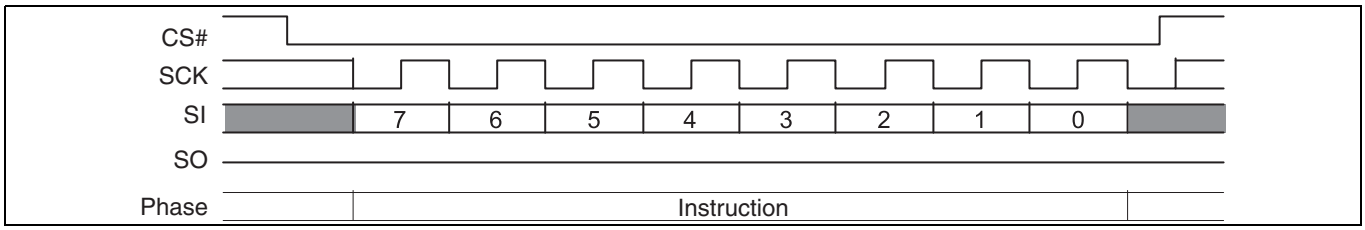


Figure 6 Standalone Instruction command

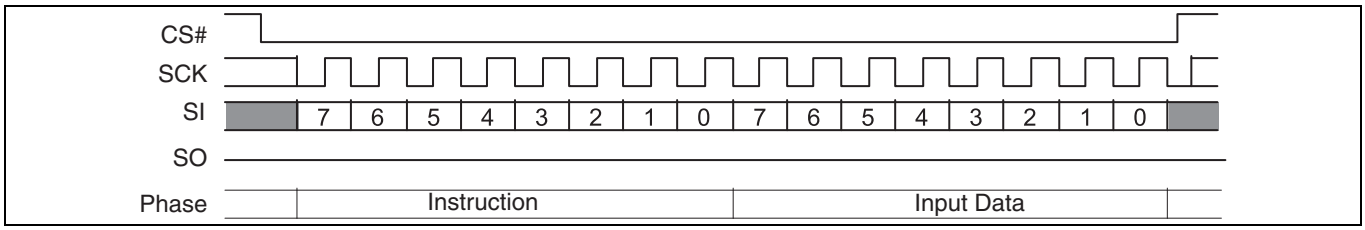


Figure 7 Single Bit Wide Input command

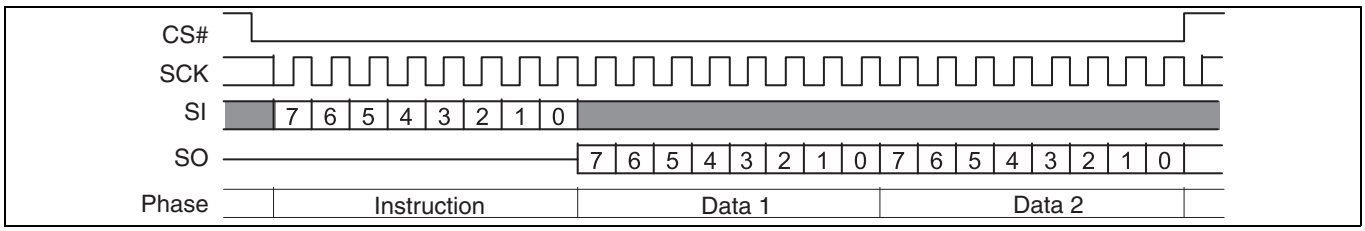


Figure 8 Single Bit Wide Output command

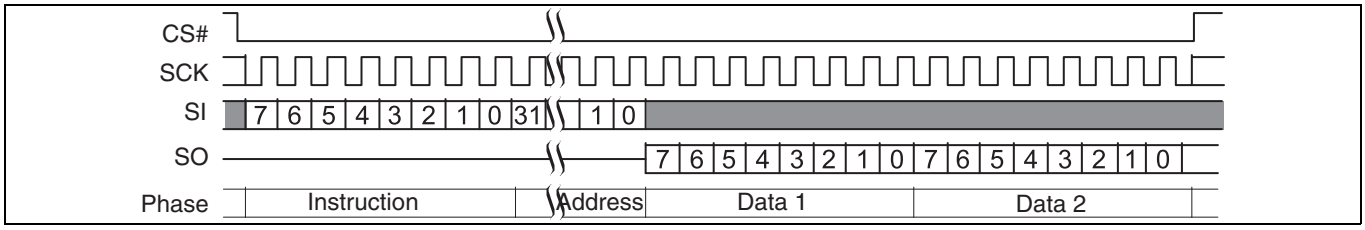


Figure 9 Single Bit Wide I/O command without latency

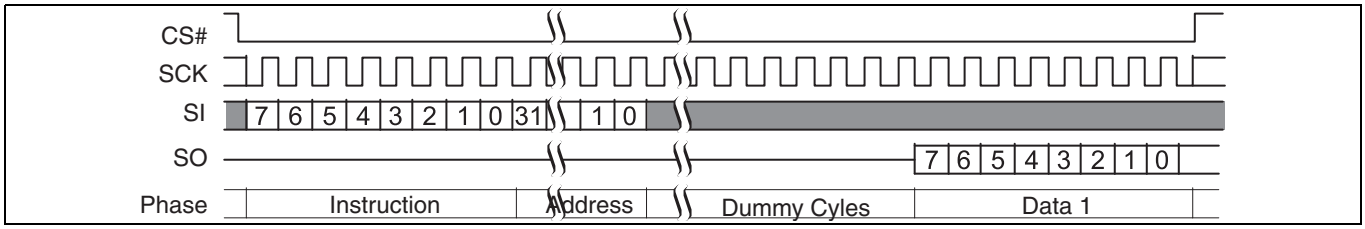


Figure 10 Single Bit Wide I/O command with latency

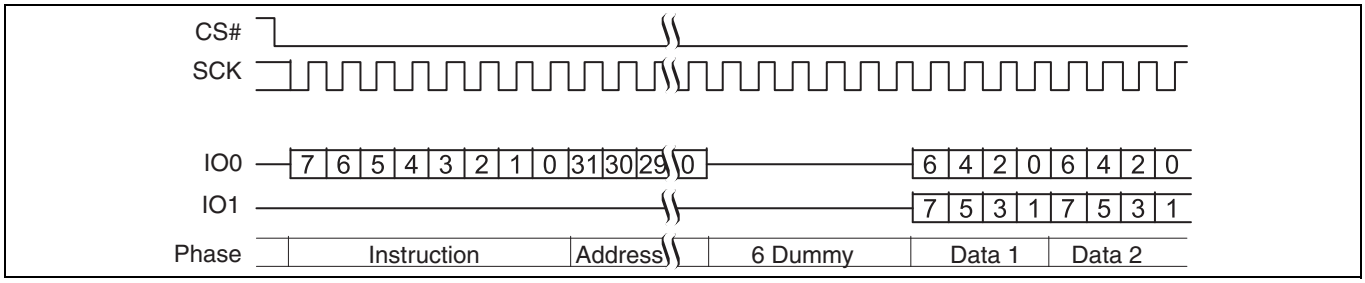


Figure 11 Dual Output command

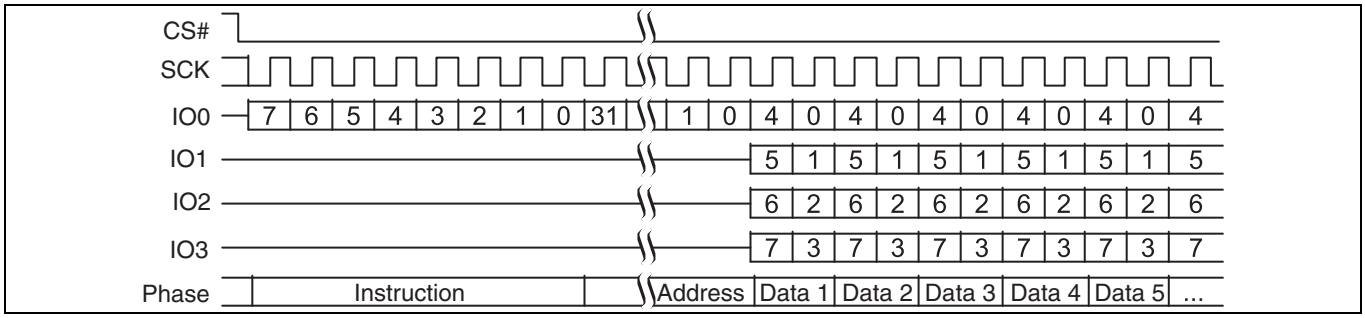


Figure 12 Quad Output command without latency

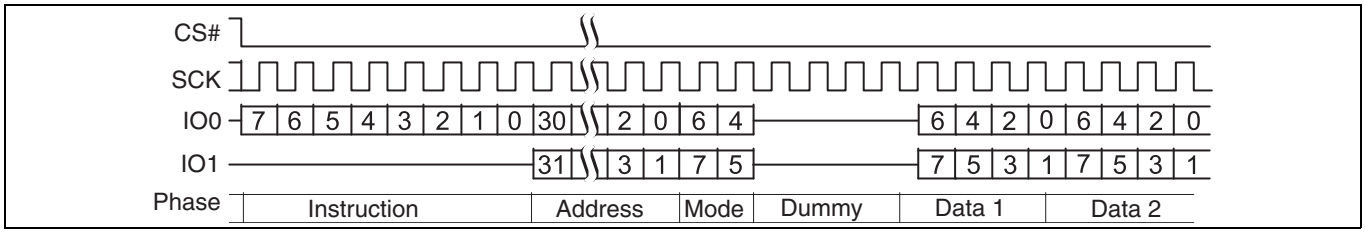


Figure 13 Dual I/O command

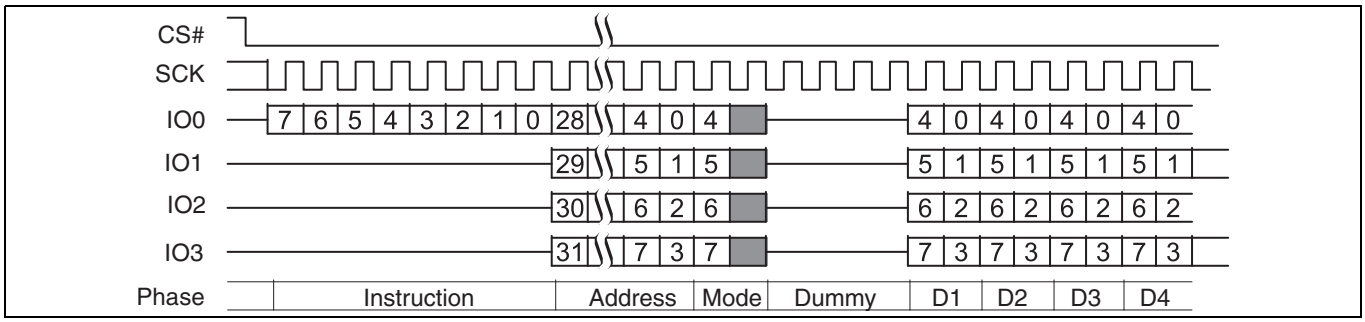


Figure 14 Quad I/O command

Additional sequence diagrams, specific to each command, are provided in **"Commands"** on page 76.

4.3 Interface states

This section describes the input and output signal levels as related to the SPI interface behavior.

Table 3 Interface states summary with separate reset

Interface state	V_{CC}	RESET#	SCK	CS#	HOLD# / IO3	WP# / IO2	SO / IO1	SI / IO0
Power-Off	<V_{CC} (low)	X	X	X	X	X	Z	X
Low Power Hardware Data Protection	<V_{CC} (cut-off)	X	X	X	X	X	Z	X
Power-On (Cold) Reset	≥V_{CC} (min)	X	X	HH	X	X	Z	X
Hardware (Warm) Reset	≥V_{CC} (min)	HL	X	X	X	X	Z	X
Interface Standby	≥V_{CC} (min)	HH	X	HH	X	X	Z	X
Instruction Cycle	≥V_{CC} (min)	HH	HT	HL	HH	HV	Z	HV
Hold Cycle	≥V_{CC} (min)	HH	HV or HT	HL	HL	X	X	X
Single Input Cycle Host to Memory Transfer	≥V_{CC} (min)	HH	HT	HL	HH	X	Z	HV
Single Latency (Dummy) Cycle	≥V_{CC} (min)	HH	HT	HL	HH	X	Z	X
Single Output Cycle Memory to Host Transfer	≥V_{CC} (min)	HH	HT	HL	HH	X	MV	X
Dual Input Cycle Host to Memory Transfer	≥V_{CC} (min)	HH	HT	HL	HH	X	HV	HV
Dual Latency (Dummy) Cycle	≥V_{CC} (min)	HH	HT	HL	HH	X	X	X
Dual Output Cycle Memory to Host Transfer	≥V_{CC} (min)	HH	HT	HL	HH	X	MV	MV
QPP Address Input Cycle Host to Memory Transfer	≥V_{CC} (min)	HH	HT	HL	X	X	X	HV
Quad Input Cycle Host to Memory Transfer	≥V_{CC} (min)	HH	HT	HL	HV	HV	HV	HV
Quad Latency (Dummy) Cycle	≥V_{CC} (min)	HH	HT	HL	X	X	X	X
Quad Output Cycle Memory to Host Transfer	≥V_{CC} (min)	HH	HT	HL	MV	MV	MV	MV

Legend

Z = No driver - floating signal
HL = Host driving V_{IL}
HH = Host driving V_{IH}
HV = Either HL or HH
X = HL or HH or Z
HT = Toggling between HL and HH
ML = Memory driving V_{IL}
MH = Memory driving V_{IH}
MV = Either ML or MH

Table 4 Interface states summary with IO3 / RESET# enabled

Interface state	V_{CC}	SCK	CS#	HOLD# / IO3	WP# / IO2	SO / IO1	SI / IO0
Power-Off	<V_{CC} (low)	X	X	X	X	Z	X
Low Power Hardware Data Protection	<V_{CC} (cut-off)	X	X	X	X	Z	X
Power-On (Cold) Reset	≥V_{CC} (min)	X	HH	X	X	Z	X
Hardware (Warm) Reset — Non-Quad Mode	≥V_{CC} (min)	X	X	HL	X	Z	X
Hardware (Warm) Reset — Quad Mode	≥V_{CC} (min)	X	HH	HL	X	Z	X
Interface Standby	≥V_{CC} (min)	X	HH	X	X	Z	X
Instruction Cycle (Legacy SPI)	≥V_{CC} (min)	HT	HL	HH	HV	Z	HV
Single Input Cycle Host to Memory Transfer	≥V_{CC} (min)	HT	HL	HH	X	Z	HV
Single Latency (Dummy) Cycle	≥V_{CC} (min)	HT	HL	HH	X	Z	X
Single Output Cycle Memory to Host Transfer	≥V_{CC} (min)	HT	HL	HH	X	MV	X
Dual Input Cycle Host to Memory Transfer	≥V_{CC} (min)	HT	HL	HH	X	HV	HV
Dual Latency (Dummy) Cycle	≥V_{CC} (min)	HT	HL	HH	X	X	X
Dual Output Cycle Memory to Host Transfer	≥V_{CC} (min)	HT	HL	HH	X	MV	MV
QPP Address Input Cycle Host to Memory Transfer	≥V_{CC} (min)	HT	HL	X	X	X	HV
Quad Input Cycle Host to Memory Transfer	≥V_{CC} (min)	HT	HL	HV	HV	HV	HV
Quad Latency (Dummy) Cycle	≥V_{CC} (min)	HT	HL	X	X	X	X
Quad Output Cycle Memory to Host Transfer	≥V_{CC} (min)	HT	HL	MV	MV	MV	MV

Legend

Z = No driver - floating signal
HL = Host driving V_{IL}
HH = Host driving V_{IH}
HV = Either HL or HH
X = HL or HH or Z
HT = Toggling between HL and HH
ML = Memory driving V_{IL}
MH = Memory driving V_{IH}
MV = Either ML or MH

Table 5 Interface states summary with HOLD# / IO3 enabled

Interface State	V_{DD}	SCK	CS#	HOLD# / IO3	WP# / IO2	SO / IO1	SI / IO0
Power-Off	$<V_{CC}$ (low)	X	X	X	X	Z	X
Low Power Hardware Data Protection	$<V_{CC}$ (cut-off)	X	X	X	X	Z	X
Power-On (Cold) Reset	$\geq V_{CC}$ (min)	X	HH	X	X	Z	X
Interface Standby	$\geq V_{CC}$ (min)	X	HH	X	X	Z	X
Instruction Cycle (Legacy SPI)	$\geq V_{CC}$ (min)	HT	HL	HH	HV	Z	HV
Hold Cycle	$\geq V_{CC}$ (min)	HV or HT	HL	HL	X	X	X
Single Input Cycle Host to Memory Transfer	$\geq V_{CC}$ (min)	HT	HL	HH	X	Z	HV
Single Latency (Dummy) Cycle	$\geq V_{CC}$ (min)	HT	HL	HH	X	Z	X
Single Output Cycle Memory to Host Transfer	$\geq V_{CC}$ (min)	HT	HL	HH	X	MV	X
Dual Input Cycle Host to Memory Transfer	$\geq V_{CC}$ (min)	HT	HL	HH	X	HV	HV
Dual Latency (Dummy) Cycle	$\geq V_{CC}$ (min)	HT	HL	HH	X	X	X
Dual Output Cycle Memory to Host Transfer	$\geq V_{CC}$ (min)	HT	HL	HH	X	MV	MV
QPP Address Input Cycle Host to Memory Transfer	$\geq V_{CC}$ (min)	HT	HL	X	X	X	HV
Quad Input Cycle Host to Memory Transfer	$\geq V_{CC}$ (min)	HT	HL	HV	HV	HV	HV
Quad Latency (Dummy) Cycle	$\geq V_{CC}$ (min)	HT	HL	X	X	X	X
Quad Output Cycle Memory to Host Transfer	$\geq V_{CC}$ (min)	HT	HL	MV	MV	MV	MV

Legend

Z = No driver - floating signal
HL = Host driving V_{IL}
HH = Host driving V_{IH}
HV = Either HL or HH
X = HL or HH or Z
HT = Toggling between HL and HH
ML = Memory driving V_{IL}
MH = Memory driving V_{IH}
MV = Either ML or MH

4.3.1 Power-off

When the core supply voltage is at or below the V_{CC} (low) voltage, the device is considered to be powered off. The device does not react to external signals, and is prevented from performing any program or erase operation.

4.3.2 Low power hardware data protection

When V_{CC} is less than V_{CC} (cut-off), the memory device will ignore commands to ensure that program and erase operations can not start when the core supply voltage is out of the operating range.

4.3.3 Power-on (cold) reset

When the core voltage supply remains at or below the V_{CC} (low) voltage for $\geq t_{PD}$ time, then rises to $\geq V_{CC\,(Minimum)}$ the device will begin its power-on reset (POR) process. POR continues until the end of t_{PU}. During t_{PU}, the device does not react to external input signals nor drive any outputs. Following the end of t_{PU} the device transitions to the Interface Standby state and can accept commands. For additional information on POR, see **"Power-on (cold) reset"** on page 35.

4.3.4 Hardware (Warm) Reset

Some of the device package options provide a RESET# input. When RESET# is driven low for t_{RP} time the device starts the hardware reset process. The process continues for t_{RPH} time. Following the end of both t_{RPH} and the reset hold time following the rise of RESET# (t_{RH}) the device transitions to the Interface Standby state and can accept commands. For additional information on hardware reset, see **"Separate RESET# input initiated hardware (warm) reset"** on page 36.

A configuration option is provided to allow IO3 to be used as a hardware reset input when the device is not in Quad mode or when it is in Quad mode and CS# is HIGH. When IO3 / RESET# is driven LOW, for t_{RP} time the device starts the hardware reset process. The process continues for t_{RPH} time. Following the end of both t_{RPH} and the reset hold time following the rise of RESET# (t_{RH}), the device transitions to the Interface Standby state and can accept commands. For additional information on hardware reset, see **"Reset"** on page 35.

4.3.5 Interface standby

When CS# is HIGH, the SPI interface is in Standby state. Inputs other than RESET# are ignored. The interface waits for the beginning of a new command. The next interface state is Instruction Cycle when CS# goes LOW to begin a new command.

While in Interface Standby state, the memory device draws standby current (I_{SB}) if no embedded algorithm is in progress. If an embedded algorithm is in progress, the related current is drawn until the end of the algorithm when the entire device returns to standby current draw.

4.3.6 Instruction cycle

When the host drives the MSb of an instruction and CS# goes LOW, on the next rising edge of SCK the device captures the MSb of the instruction that begins the new command. On each following rising edge of SCK, the device captures the next lower significance bit of the 8-bit instruction. The host keeps RESET# HIGH, CS# LOW, HOLD# HIGH, and drives Write Protect (WP#) signal as needed for the instruction. However, WP# is only relevant during instruction cycles of a WRR command and is otherwise ignored.

Each instruction selects the address space that is operated on and the transfer format used during the remainder of the command. The transfer format may be Single, Dual output, Quad output, Dual I/O, or Quad I/O. The expected next interface state depends on the instruction received.

Some commands are standalone, needing no address or data transfer to or from the memory. The host returns CS# HIGH after the rising edge of SCK for the eighth bit of the instruction in such commands. The next interface state in this case is Interface Standby.

4.3.7 Hold (HOLD# / IO3 selected by SR2[5])

When Quad mode is not enabled (CR[1] = 0), the HOLD# / IO3 signal is used as the HOLD# input. The host keeps RESET# HIGH, HOLD# LOW, SCK may be at a valid level or continue toggling, and CS# is LOW. When HOLD# is LOW a command is paused, as though SCK were held LOW. SI / IO0 and SO / IO1 ignore the input level when acting as inputs and are high impedance when acting as outputs during Hold state. Whether these signals are input or output depends on the command and the point in the command sequence when HOLD# is asserted LOW.

When HOLD# returns HIGH, the next state is the same state the interface was in just before HOLD# was asserted LOW.

When Quad mode is enabled, the HOLD# / IO3 signal is used as IO3.

4.3.8 Single input cycle - Host to Memory transfer

Several commands transfer information after the instruction on the single serial input (SI) signal from host to the memory device. The Dual Output, and Quad Output commands send address to the memory using only SI but return read data using the I/O signals. The host keeps RESET# HIGH, CS# LOW, HOLD# HIGH, and drives SI as needed for the command. The memory does not drive the Serial Output (SO) signal.

The expected next interface state depends on the instruction. Some instructions continue sending address or data to the memory using additional single input cycles. Others may transition to Single Latency, or directly to Single, Dual, or Quad Output.

4.3.9 Single latency (dummy) cycle

Read commands may have zero to several latency cycles during which read data is read from the main flash memory array before transfer to the host. The number of latency cycles are determined by the latency code in the Configuration Register (CR[7:6]). During the latency cycles, the host keeps RESET# HIGH, CS# LOW, and HOLD# HIGH. The Write Protect (WP#) signal is ignored. The host may drive the SI signal during these cycles or the host may leave SI floating. The memory does not use any data driven on SI / I/O0 or other I/O signals during the latency cycles. In Dual or Quad Read commands, the host must stop driving the I/O signals on the falling edge at the end of the last latency cycle. It is recommended that the host stop driving I/O signals during latency cycles so that there is sufficient time for the host drivers to turn off before the memory begins to drive at the end of the latency cycles. This prevents driver conflict between host and memory when the signal direction changes. The memory does not drive the Serial Output (SO) or I/O signals during the latency cycles.

The next interface state depends on the command structure i.e. the number of latency cycles, and whether the read is single, dual, or quad width.

4.3.10 Single output cycle - Memory to Host transfer

Several commands transfer information back to the host on the single Serial Output (SO) signal. The host keeps RESET# HIGH, CS# LOW, and HOLD# HIGH. The Write Protect (WP#) signal is ignored. The memory ignores the Serial Input (SI) signal. The memory drives SO with data.

The next interface state continues to be Single Output Cycle until the host returns CS# to HIGH ending the command.

4.3.11 Dual input cycle - Host to Memory transfer

The Read Dual I/O command transfers two address or mode bits to the memory in each cycle. The host keeps RESET# HIGH, CS# LOW, HOLD# HIGH. The Write Protect (WP#) signal is ignored. The host drives address on SI / IO0 and SO / IO1.

The next interface state following the delivery of address and mode bits is a Dual Latency Cycle if there are latency cycles needed or Dual Output Cycle if no latency is required.

4.3.12 Dual latency (dummy) cycle

Read commands may have zero to several latency cycles during which read data is read from the main flash memory array before transfer to the host. The number of latency cycles are determined by the latency code in the Configuration Register (CR[7:6]). During the latency cycles, the host keeps RESET# HIGH, CS# LOW, and HOLD# HIGH. The Write Protect (WP#) signal is ignored. The host may drive the SI / IO0 and SO / IO1 signals during these cycles or the host may leave SI / IO0 and SO / IO1 floating. The memory does not use any data driven on SI / IO0 and SO / IO1 during the latency cycles. The host must stop driving SI / IO0 and SO / IO1 on the falling edge at the end of the last latency cycle. It is recommended that the host stop driving them during all latency cycles so that there is sufficient time for the host drivers to turn off before the memory begins to drive at the end of the latency cycles. This prevents driver conflict between host and memory when the signal direction changes. The memory does not drive the SI / IO0 and SO / IO1 signals during the latency cycles.

The next interface state following the last latency cycle is a Dual Output Cycle.

4.3.13 Dual output cycle - Memory to Host transfer

The Read Dual Output and Read Dual I/O return data to the host two bits in each cycle. The host keeps RESET# HIGH, CS# LOW, and HOLD# HIGH. The Write Protect (WP#) signal is ignored. The memory drives data on the SI / IO0 and SO / IO1 signals during the dual output cycles.

The next interface state continues to be Dual Output Cycle until the host returns CS# to HIGH ending the command.

4.3.14 QPP or QOR address input cycle

The Quad Page Program and Quad Output Read commands send address to the memory only on IO0. The other IO signals are ignored because the device must be in Quad mode for these commands thus the Hold and Write Protect features are not active. The host keeps RESET# HIGH, CS# LOW, and drives IO0.

For QPP the next interface state following the delivery of address is the quad input cycle.

For QOR the next interface state following address is a quad latency cycle if there are latency cycles needed or quad output cycle if no latency is required.

4.3.15 Quad Input Cycle - Host to Memory Transfer

The Quad I/O Read command transfers four address or mode bits to the memory in each cycle. The Quad Page Program command transfers four data bits to the memory in each cycle. The host keeps RESET# high, CS# low, and drives the IO signals.

For Quad I/O Read, the next interface state following the delivery of address and mode bits is a quad latency cycle if there are latency cycles needed or quad output cycle if no latency is required. For Quad Page Program, the host returns CS# HIGH following the delivery of data to be programmed and the interface returns to Standby state.

4.3.16 Quad latency (dummy) cycle

Read commands may have zero to several latency cycles during which read data is read from the main flash memory array before transfer to the host. The number of latency cycles are determined by the Latency Code in the Configuration Register (CR[7:6]). During the latency cycles, the host keeps RESET# HIGH, CS# LOW. The host may drive the IO signals during these cycles or the host may leave the IO floating. The memory does not use any data driven on IO during the latency cycles. The host must stop driving the IO signals on the falling edge at the end of the last latency cycle. It is recommended that the host stop driving them during all latency cycles so that there is sufficient time for the host drivers to turn off before the memory begins to drive at the end of the latency cycles. This prevents driver conflict between host and memory when the signal direction changes. The memory does not drive the IO signals during the latency cycles.

The next interface state following the last latency cycle is a Quad Output Cycle.

4.3.17 Quad output cycle - Memory to Host transfer

The Quad Output Read and Quad I/O Read return data to the host four bits in each cycle. The host keeps RESET# HIGH, and CS# LOW. The memory drives data on IO0-IO3 signals during the Quad output cycles.

The next interface state continues to be Quad Output Cycle until the host returns CS# to HIGH ending the command.

4.4 Configuration register effects on the interface

The Configuration Register Bits 7 and 6 (CR1[7:6]) select the latency code for all read commands. The latency code selects the number of mode bit and latency cycles for each type of instruction.

The Configuration Register Bit 1 (CR1[1]) selects whether Quad mode is enabled to ignore HOLD# and WP# and allow Quad Page Program, Quad Output Read, and Quad I/O Read commands.

4.5 Data protection

Some basic protection against unintended changes to stored data are provided and controlled purely by the hardware design. These are described below in the **Data protection on page 69**.

4.5.1 Power-up

When the core supply voltage is at or below the V_{CC} (low) voltage, the device is considered to be powered off. The device does not react to external signals, and is prevented from performing any program or erase operation. Program and erase operations continue to be prevented during the power-on reset because no command is accepted until the exit from POR to the Interface Standby state.

4.5.2 Low power

When V_{CC} is less than V_{CC} (cut-off), the memory device will ignore commands to ensure that program and erase operations can not start when the core supply voltage is out of the operating range.

4.5.3 Clock pulse count

The device verifies that all program, erase, and Write Registers (WRR) commands consist of a clock pulse count that is a multiple of eight before executing them. A command not having a multiple of 8 clock pulse count is ignored and no error status is set for the command.

5 Electrical specifications

5.1 Absolute maximum ratings

Table 6 Absolute maximum ratings

Parameter	Value
Storage temperature plastic packages	–65°C to +150°C
Ambient temperature with power applied	–65°C to +125°C
V_{CC}	–0.5 V to +4.0 V
Input voltage with respect to Ground (V_{SS})[6]	–0.5 V to + (V_{CC} + 0.5 V)
Output short circuit current[7]	100 mA

Notes
6. See **"Input signal overshoot"** on page 29 for allowed maximums during signal transition.
7. No more than one output may be shorted to ground at a time. Duration of the short circuit should not be greater than one second.
8. Stresses above those listed in this table may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational sections of this datasheet is not implied. Exposure of the device to absolute maximum rating conditions for extended periods may affect device reliability.

5.2 Thermal resistance

Table 7 Thermal resistance

Parameter	Description	Test conditions	SOC008	SO3016	WND008	FAB024	FAC024	Unit
Theta JA	Thermal resistance (Junction to ambient)	Test conditions follow standard test methods and procedures for measuring thermal impedance in accordance with EIA/JESD51. with Still Air (0 m/s).	63	40	31	39	39	°C/W
Theta JB	Thermal resistance (Junction to board)		36.6	20.6	8.4	21.9	21.9	°C/W
Theta JC	Thermal resistance (Junction to case)		29.4	12	20.8	14	14	°C/W

5.3 Operating ranges

Operating ranges define those limits between which the functionality of the device is guaranteed.

5.3.1 Temperature ranges

Table 8 Temperature ranges

Parameter	Symbol	Device	Spec		Unit
			Min	Max	
Ambient temperature	T_A	Industrial (I)	–40	+85	°C
		Industrial Plus (V)	–40	+105	
		Automotive, AEC-Q100 grade 3 (A)	–40	+85	
		Automotive, AEC-Q100 grade 2 (B)	–40	+105	

Industrial Plus operating and performance parameters will be determined by device characterization and may vary from standard industrial temperature range devices as currently shown in this specification.

5.3.2 Power supply voltage

V_{CC}: 2.7 V to 3.6 V

5.3.3 Input signal overshoot

During DC conditions, input or I/O signals should remain equal to or between V_{SS} and V_{CC}. During voltage transitions, inputs or I/Os may overshoot V_{SS} to –2.0 V or overshoot to V_{CC} + 2.0 V, for periods up to 20 ns.

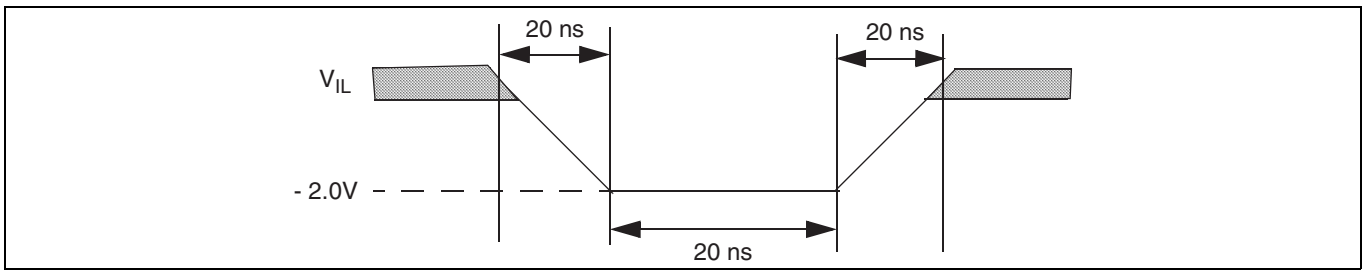


Figure 15 Maximum negative overshoot waveform

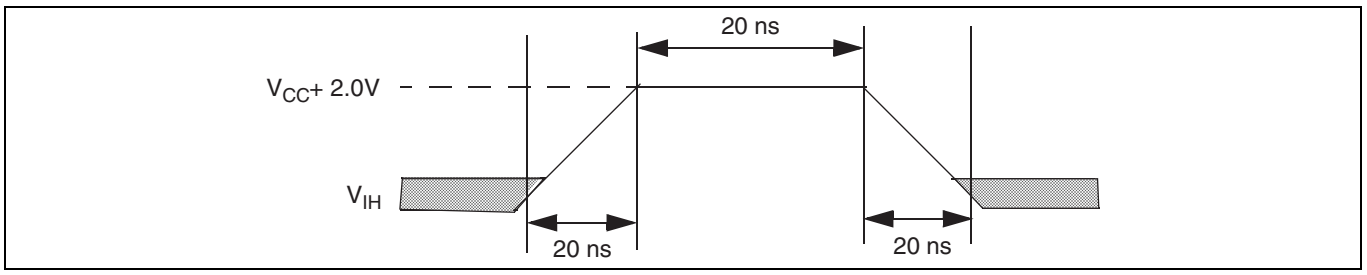


Figure 16 Maximum positive overshoot waveform

5.4 Power-up and power-down

The device must not be selected at power-up or power-down (that is, CS# must follow the voltage applied on V_{CC}) until V_{CC} reaches the correct value as follows:

- V_{CC} (min) at power-up, and then for a further delay of t_{PU}
- V_{SS} at power-down

A simple pull-up resistor (generally of the order of 100 kΩ) on Chip Select (CS#) can usually be used to insure safe and proper power-up and power-down.

The device ignores all instructions until a time delay of t_{PU} has elapsed after the moment that V_{CC} rises above the minimum V_{CC} threshold (see **Figure 17**). However, correct operation of the device is not guaranteed if V_{CC} returns below V_{CC} (min) during t_{PU}. No command should be sent to the device until the end of t_{PU}.

The device draws I_{POR} during t_{PU}. After power-up (t_{PU}), the device is in Standby mode, draws CMOS standby current (I_{SB}), and the WEL bit is reset.

During power-down or voltage drops below V_{CC} (cut-off), the voltage must drop below V_{CC} (low) for a period of t_{PD} for the part to initialize correctly on power-up (see **Figure 18**). If during a voltage drop the V_{CC} stays above V_{CC} (cut-off) the part will stay initialized and will work correctly when V_{CC} is again above V_{CC} (min). In the event power-on reset did not complete correctly after power up, the assertion of the RESET# signal or receiving a software reset command (RESET) will restart the POR process.

Normal precautions must be taken for supply rail decoupling to stabilize the V_{CC} supply at the device. Each device in a system should have the V_{CC} rail decoupled by a suitable capacitor close to the package supply connection (this capacitor is generally of the order of 0.1 µF).

Table 9 Power-up/power-down voltage and timing

Symbol	Parameter	Min	Max	Unit
V_{CC} (min)	V_{CC} (minimum operation voltage)	2.7	–	V
V_{CC} (cut-off)	V_{CC} (cut 0ff where re-initialization is needed)	2.4	–	V
V_{CC} (low)	V_{CC} (low voltage for initialization to occur)	1.0	–	V
t_{PU}	V_{CC} (min) to Read operation	–	300	µs
t_{PD}	V_{CC} (low) time	1.0	–	µs

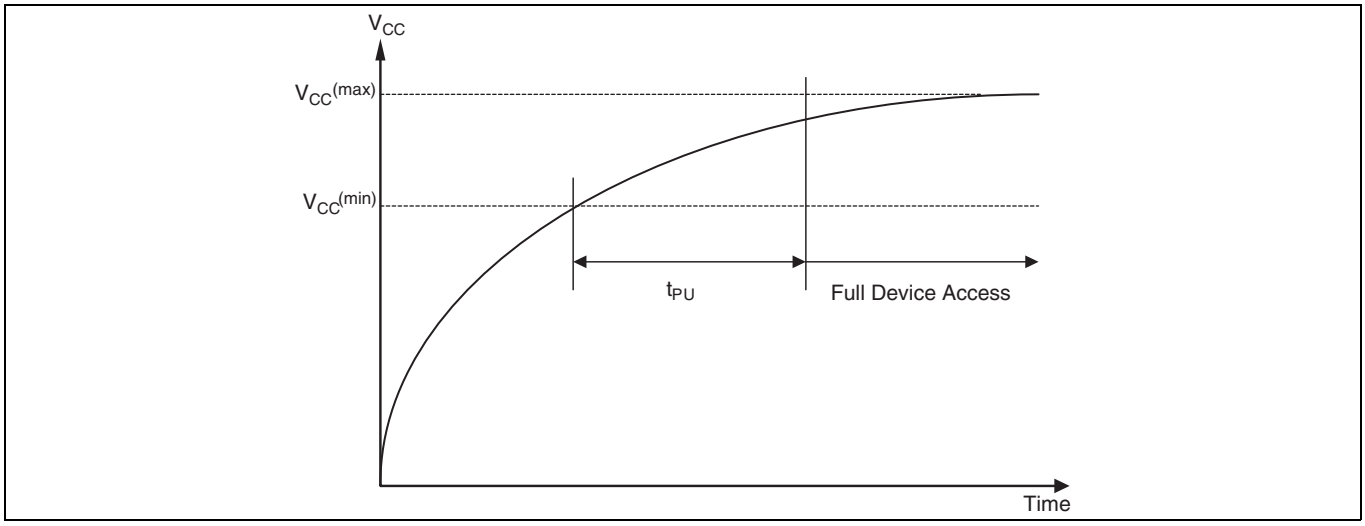


Figure 17 Power-up

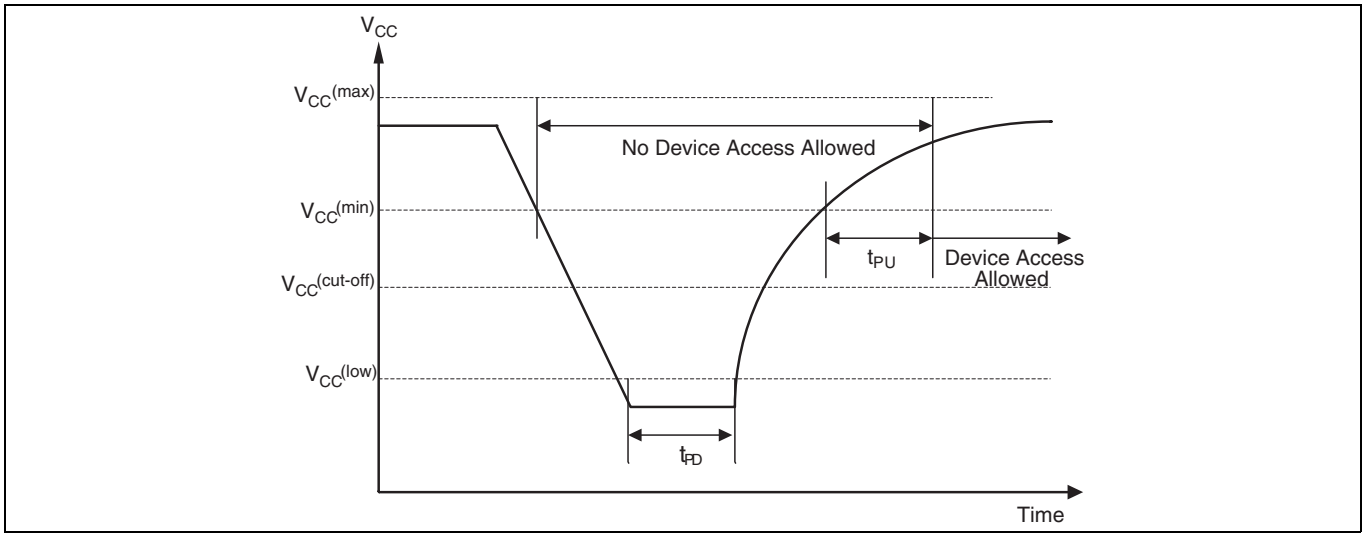


Figure 18 Power-down and voltage drop

5.5 DC characteristics

Applicable within operating ranges.

Table 10 DC characteristics

Symbol	Parameter	Test conditions	Min	Typ[9]	Max	Unit
V_{IL}	Input low voltage	–	–0.5	–	0.2 × V_{CC}	V
V_{IH}	Input high voltage	–	0.7 × V_{CC}	–	V_{CC} + 0.4	V
V_{OL}	Output low voltage	I_{OL} = 1.6 mA, V_{CC} = V_{CC} min	–	–	0.15 x V_{CC}	V
V_{OH}	Output high voltage	I_{OH} = –0.1 mA	0.85 x V_{CC}	–	–	V
I_{LI} (Industrial)	Input leakage current	V_{CC} = V_{CC} Max, V_{IN} = 0 to V_{IL} Max or V_{IH}, CS# = V_{IH}	–	–	± 2	µA
I_{LO} (Industrial)	Output leakage current	V_{CC} = V_{CC} Max, V_{IN} = V_{IH} or V_{IL}	–	–	± 2	µA
I_{LI} (Industrial Plus)	Input leakage current	V_{CC} = V_{CC} Max, V_{IN}= 0 to V_{IL} Max or V_{IH}, CS# = V_{IH}	–	–	± 4	µA
I_{LO} (Industrial Plus)	Output leakage current	V_{CC} = V_{CC} Max, V_{IN} = V_{IH} or V_{IL}	–	–	± 4	µA
I_{CC1}	Active power supply current (READ)	Serial @50 MHz Serial @108 MHz Quad @108 MHz Outputs unconnected during read data return[10]	–	–	16 24 47	mA
I_{CC2}	Active power supply current (Page Program)	CS# = V_{CC}	–	–	50	mA

Notes
9. Typical values are at T_{AI} = 25°C and V_{CC} = 3 V.
10. Output switching current is not included.

Table 10 DC characteristics (Continued)

Symbol	Parameter	Test conditions	Min	Typ[9]	Max	Unit
I_{CC3}	Active power supply current (WRR)	CS# = V_{CC}	–	–	50	mA
I_{CC4}	Active power supply current (SE)	CS# = V_{CC}	–	–	50	mA
I_{CC5}	Active power supply current (BE)	CS# = V_{CC}	–	–	50	mA
I_{SB} (–40°C to 85°C)	Standby current	RESET#, CS# = V_{CC}; SI, SCK = V_{CC} or V_{SS}	–	70	100	µA
I_{SB} (–40°C to 105°C)	Standby current	RESET#, CS# = V_{CC}; SI, SCK = V_{CC} or V_{SS}	–	70	300	µA
I_{POR}	Power on reset current	RESET#, CS# = V_{CC}; SI, SCK = V_{CC} or V_{SS}	–	–	63	mA

Notes
9. Typical values are at T_{AI} = 25°C and V_{CC} = 3 V.
10. Output switching current is not included.

5.5.1 Active Power and Standby Power modes

The device is enabled and in the Active Power mode when Chip Select (CS#) is LOW. When CS# is HIGH, the device is disabled, but may still be in an Active Power mode until all program, erase, and write operations have completed. The device then goes into the Standby Power mode, and power consumption drops to I_{SB}.

6 Timing specifications

6.1 Key to switching waveforms

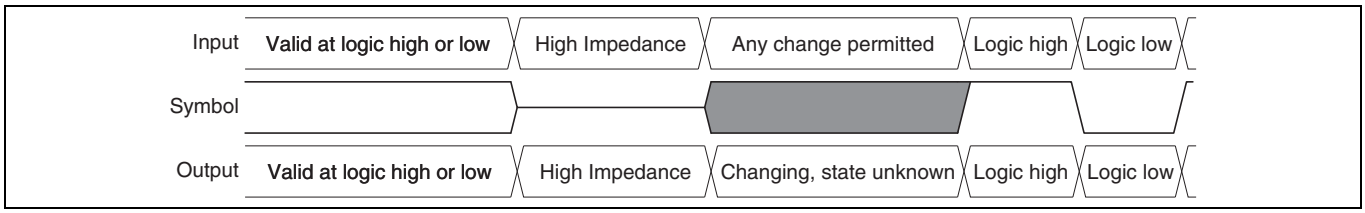


Figure 19 Waveform element meanings

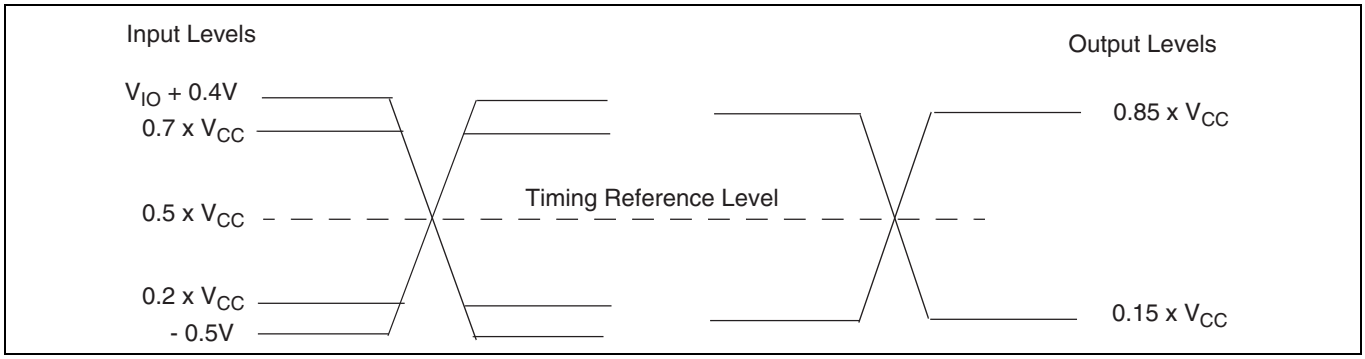


Figure 20 Input, output, and timing reference levels

6.2 AC test conditions

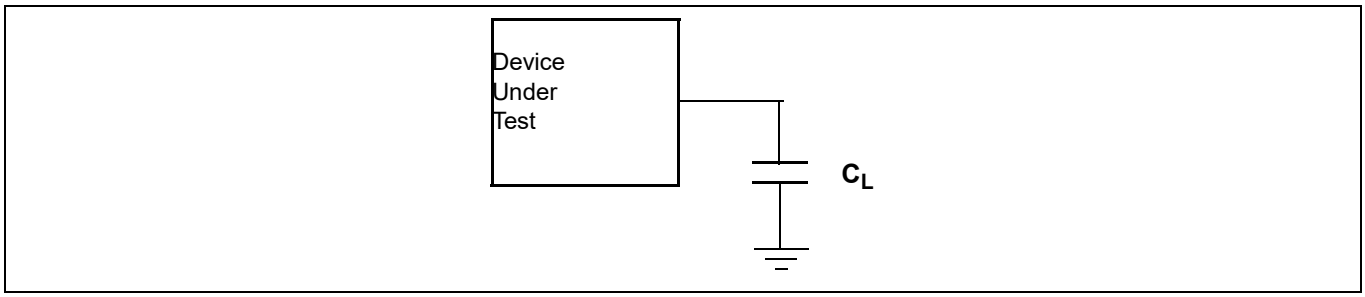


Figure 21 Test setup

Table 11 AC measurement conditions

Symbol	Parameter	Min	Max	Unit
C_L	Load capacitance	30		pF
	Input rise and fall times	–	2.4	ns
	Input pulse voltage	$0.2 \times V_{CC}$ to $0.8 \times V_{CC}$		V
	Input timing ref voltage	$0.5 \times V_{CC}$		V
	Output timing ref voltage	$0.5 \times V_{CC}$		V

6.2.1 Capacitance characteristics

Table 12 Capacitance

Symbol	Parameter	Test conditions	Min	Max	Unit
C_{IN}	Input capacitance (applies to SCK, CS#, RESET#)	1 MHz	–	8	pF
C_{OUT}	Output capacitance (applies to All I/O)	1 MHz	–	8	pF

Notes
11. Output High-Z is defined as the point where data is no longer driven.
12. Input slew rate: 1.5 V/ns.
13. AC characteristics tables assume clock and data signals have the same slew rate (slope).
14. Parameter values are not 100% tested. For more information on capacitance, please consult the IBIS models.

6.3 Reset

6.3.1 Power-on (cold) reset

The device executes a POR process until a time delay of t_{PU} has elapsed after the moment that V_{CC} rises above the minimum V_{CC} threshold. See **Figure 17**, **Table 9**, and **Figure 22**. The device must not be selected (CS# to go HIGH with V_{CC}) during power-up (t_{PU}), i.e. no commands may be sent to the device until the end of t_{PU}.

The IO3 / RESET# signal functions as the RESET# input when CS# is HIGH for more than t_{RP} time or when Quad Mode is not enabled CR1V[1] = 0.

RESET# is ignored during POR. If RESET# is LOW during POR and remains LOW through and beyond the end of t_{PU}, CS# must remain HIGH until t_{RH} after RESET# returns HIGH. RESET# must return HIGH for greater than t_{RS} before returning LOW to initiate a hardware reset.

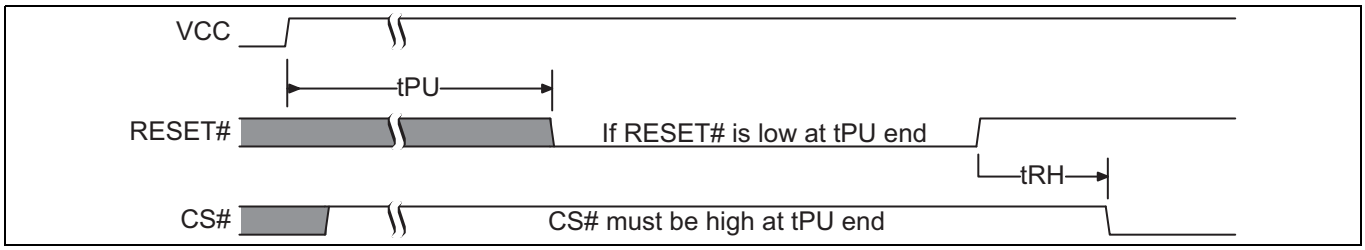


Figure 22 Reset LOW at the end of POR

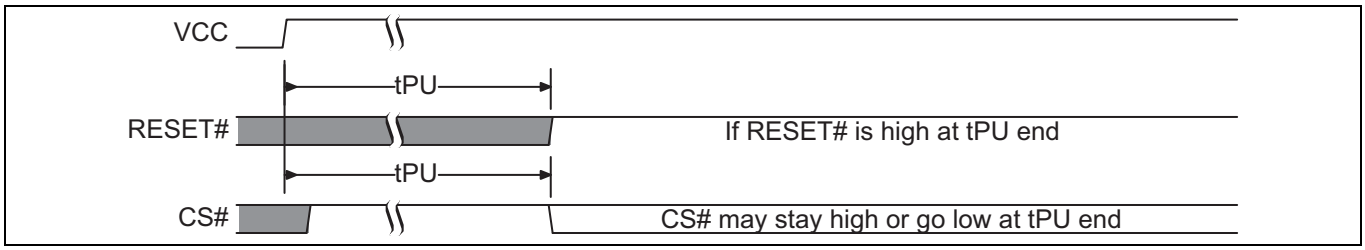


Figure 23 Reset HIGH at the end of POR

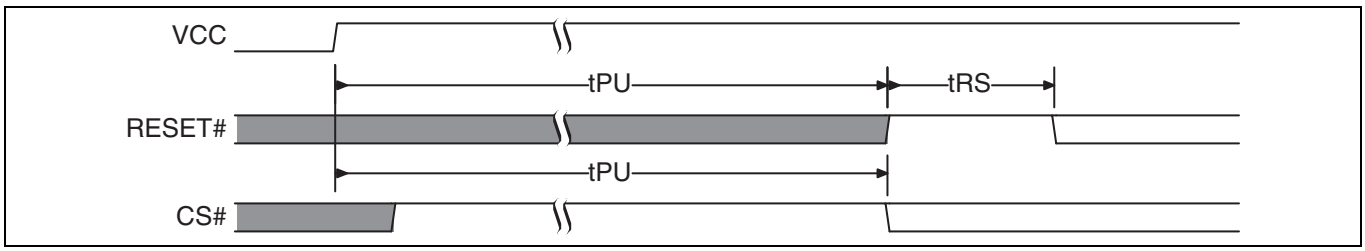


Figure 24 POR followed by hardware reset

6.3.2 Separate RESET# input initiated hardware (warm) reset

When the RESET# input transitions from V_{IH} to V_{IL} for > t_{RP}, the device will reset register states in the same manner as POR but, does not go through the full reset process that is performed during POR. The hardware reset process requires a period of t_{RPH} to complete. If the POR process did not complete correctly for any reason during power-up (t_{PU}), RESET# going LOW will initiate the full POR process instead of the hardware reset process and will require t_{PU} to complete the POR process.

A separate RESET# input is available only in the SOIC16 and BGA package options. The RESET# input has an internal pull-up to V_{CC} and should be left unconnected if not used. The RESET command is independent of the state of RESET#. If RESET# is HIGH or unconnected, and the RESET instruction is issued, the device will perform software reset.

The RESET# input provides a hardware method of resetting the flash memory device to Standby state.

- RESET# must be HIGH for t_{RS} following t_{PU} or t_{RPH}, before going LOW again to initiate a hardware reset.
- When RESET# is driven LOW for at least a minimum period of time (t_{RP}), the device terminates any operation in progress, makes all outputs high impedance, and ignores all read/write commands for the duration of t_{RPH}. The device resets the interface to standby state.
- If CS# is LOW at the time RESET# is asserted, CS# must return HIGH during t_{RPH} before it can be asserted LOW again after t_{RH}.

Table 13 Hardware reset parameters

Parameter	Description	Limit	Time	Unit
t_{RS}	Reset setup - prior reset end and RESET# HIGH before RESET# LOW	Min	50	ns
t_{RPH}	Reset pulse hold - RESET# LOW to CS# LOW	Min	35	µs
t_{RP}	RESET# pulse width	Min	200	ns
t_{RP}	RESET# pulse width (only when AutoBoot enabled)	Max	5	µs
t_{RH}	Reset hold - RESET# HIGH before CS# LOW	Min	50	ns

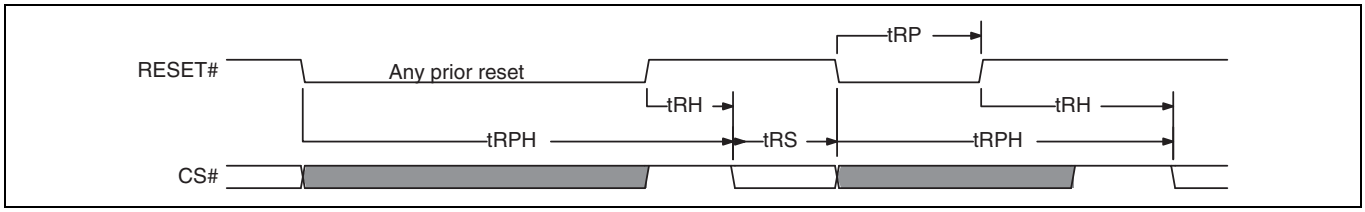


Figure 25 Separate RESET# input initiated hardware reset

Notes

15. RESET# LOW is ignored during power-up (t_{PU}). If Reset# is asserted during the end of t_{PU}, the device will remain in the Reset state and t_{RH} will determine when CS# may go LOW.
16. Sum of t_{RP} and t_{RH} must be equal to or greater than t_{RPH}.

6.3.3 IO3 / RESET# input initiated hardware (warm) reset

The IO3 / RESET# signal functions as a RESET# input when enabled by SR2[5] = 1 and CS# is HIGH for more than t_{CS} time or when Quad mode is not enabled (CR1V[1] = 0). The IO3 RESET# input provides a hardware method of resetting the flash memory device to standby state. The IO3 / RESET# input has an internal pull-up to V_{CC} and may be left unconnected if Quad mode is not used.

When the IO3 / RESET# feature and Quad mode are both enabled, IO3 / RESET# is ignored for t_{CS} following CS# going HIGH, to avoid an unintended Reset operation. This allows some time for the memory or host system to actively drive IO3 / RESET# to a valid level following the end of a transfer. Following the end of a Quad I/O read the memory will actively drive IO3 HIGH before disabling the output during t_{DIS}. Following a transfer in which IO3 was used to transfer data to the memory, e.g. the QPP command, the host system is responsible for driving IO3 HIGH before disabling the host IO3 output. The integrated pull-up on IO3 will then hold IO3 until the host system actively drives IO3 / RESET# to initiate a reset. If CS# is driven LOW to start a new command, IO3 / RESET# is used as IO3.

When the device is not in quad mode or when CS# is HIGH, and the IO3 / RESET# transitions from V_{IH} to V_{IL} for > t_{RP}, the device terminates any operation in progress, makes all outputs high impedance, ignores all read/write commands and resets the interface to standby state. The hardware reset process requires a period of t_{RPH} to complete. During t_{RPH}, the device will reset register states in the same manner as power-on reset but, does not go through the full reset process that is performed during POR. If the POR process did not complete correctly for any reason during power-up (t_{PU}), RESET# going LOW for t_{RP} will initiate the full POR process instead of the hardware reset process and will require t_{PU} to complete the POR process. IO3 / RESET# must be HIGH for t_{RS} following t_{PU} or t_{RPH}, before going LOW again to initiate a hardware reset.

If Quad mode is not enabled, and if CS# is LOW at the time IO3 / RESET# is asserted LOW, CS# must return HIGH during t_{RPH} before it can be asserted LOW again after t_{RH}.

The RESET command is independent of the state of RESET#. If IO3 / RESET# is HIGH or unconnected, and the RESET instruction is issued, the device will perform software reset.

Table 14 Hardware reset parameters

Parameter	Description	Limit	Time	Unit
t_{RS}	Reset setup - prior reset end and RESET# HIGH before RESET# LOW	Min	50	ns
t_{RPH}	Reset Pulse Hold - RESET# LOW to CS# LOW	Min	35	µs
t_{RP}	RESET# Pulse Width	Min	200	ns
t_{RP}	RESET# Pulse Width (only when AutoBoot enabled)	Max	5	µs
t_{RH}	Reset Hold - RESET# HIGH before CS# LOW	Min	50	ns

Notes
17. IO3 / RESET# LOW is ignored during power-up (t_{PU}). If Reset# is asserted during the end of t_{PU}, the device will remain in the Reset state and t_{RH} will determine when CS# may go LOW.
18. If Quad mode is enabled, IO3 / RESET# LOW is ignored during t_{CS}.
19. Sum of t_{RP} and t_{RH} must be equal to or greater than t_{RPH}.

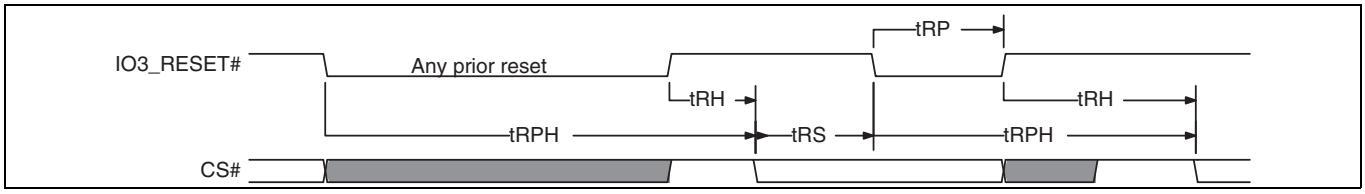


Figure 26 Hardware reset when quad mode is not enabled and IO3 / Reset# is enabled

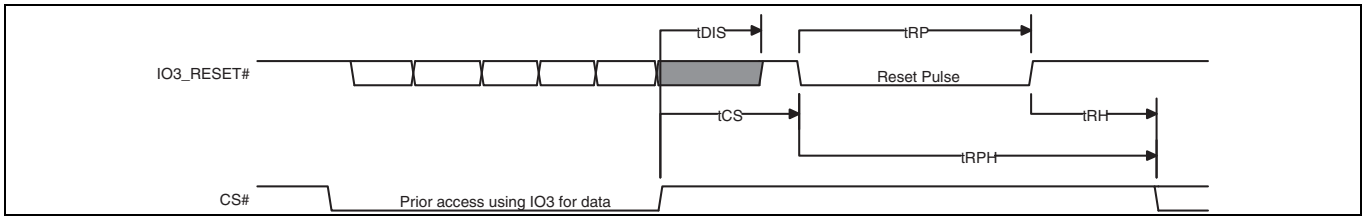


Figure 27 Hardware reset when quad mode and IO3 / Reset# are enabled

6.4 AC characteristics

Table 15 AC characteristics

Symbol	Parameter	Min	Typ	Max	Unit
$F_{SCK, R}$	SCK clock frequency for READ and 4READ instructions	DC	–	50	MHz
$F_{SCK, C}$	SCK clock frequency for single commands as shown in **Table 40**[23]	DC	–	108	MHz
$F_{SCK, C}$	SCK clock frequency for the following Dual and Quad commands: DOR, 4DOR, QOR, 4QOR, DIOR, 4DIOR, QIOR, 4QIOR	DC	–	108	MHz
$F_{SCK, QPP}$	SCK clock frequency for the QPP, 4QPP commands	DC	–	80	MHz
P_{SCK}	SCK clock period	1/ FSCK	–	∞	
t_{WH}, t_{CH}	Clock high time[24]	50% PSCK – 5%	–	50% PSCK + 5%	ns
t_{WL}, t_{CL}	Clock low time[24]	50% PSCK – 5%	–	50% PSCK + 5%	ns
t_{CRT}, t_{CLCH}	Clock rise time (slew rate)	0.1	–	–	V/ns
t_{CFT}, t_{CHCL}	Clock fall time (slew rate)	0.1	–	–	V/ns
t_{CS}	CS# high time (read instructions) CS# high time (read instructions when Reset feature and Quad mode are both enabled) CS# high time (program/erase instructions)	10 20[26] 50	–	–	ns
t_{CSS}	CS# active setup time (relative to SCK)	3	–	–	ns
t_{CSH}	CS# active hold time (relative to SCK)	3	–	–	ns
t_{SU}	Data in setup time	1.5	–	–	ns
t_{HD}	Data in hold time	2	–	–	ns
t_V	Clock low to output valid	1	–	8.0 [21] 7.65[22] 6.5[23]	ns
t_{HO}	Output hold time	2	–		ns
t_{DIS}	Output disable time[25]	–	–	8	ns
	Output disable time (when Reset feature and Quad mode are both enabled)	–	–	20[26]	ns
t_{WPS}	WP# setup time	20[20]	–	–	ns
t_{WPH}	WP# hold time	100[20]	–	–	ns
t_{HLCH}	HOLD# active setup time (relative to SCK)	3	–	–	ns
t_{CHHH}	HOLD# active hold time (relative to SCK)	3	–	–	ns
t_{HHCH}	HOLD# non active setup time (relative to SCK)	3	–	–	ns

Notes
20. Only applicable as a constraint for WRR instruction when SRWD is set to a 1.
21. Full V_{CC} range (2.7 V–3.6 V) and CL = 30 pF.
22. Regulated V_{CC} range (3.0 V–3.6 V) and CL = 30 pF.
23. Regulated V_{CC} range (3.0 V–3.6 V) and CL = 15 pF.
24. ±10% duty cycle is supported for frequencies ≤ 50 MHz.
25. Output High-Z is defined as the point where data is no longer driven.
26. t_{CS} and t_{DIS} require additional time when the Reset feature and Quad mode are enabled (CR2V[5] = 1 and CR1V[1] = 1).

Table 15 AC characteristics (Continued)

Symbol	Parameter	Min	Typ	Max	Unit
t_{CHHL}	HOLD# non active hold time (relative to SCK)	3	–	–	ns
t_{HZ}	HOLD# enable to output invalid	–	–	8	ns
t_{LZ}	HOLD# enable to output valid	–	–	8	ns

Notes
20. Only applicable as a constraint for WRR instruction when SRWD is set to a 1.
21. Full V_{CC} range (2.7 V–3.6 V) and CL = 30 pF.
22. Regulated V_{CC} range (3.0 V–3.6 V) and CL = 30 pF.
23. Regulated V_{CC} range (3.0 V–3.6 V) and CL = 15 pF.
24. ±10% duty cycle is supported for frequencies ≤ 50 MHz.
25. Output High-Z is defined as the point where data is no longer driven.
26. t_{CS} and t_{DIS} require additional time when the Reset feature and Quad mode are enabled (CR2V[5] = 1 and CR1V[1] = 1).

6.4.1 Clock timing

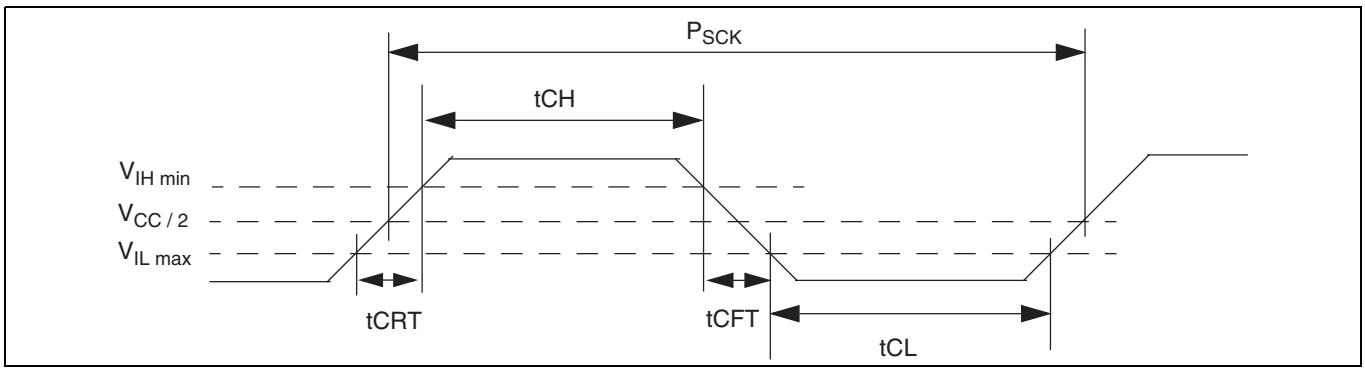


Figure 28 Clock timing

6.4.2 Input / output timing

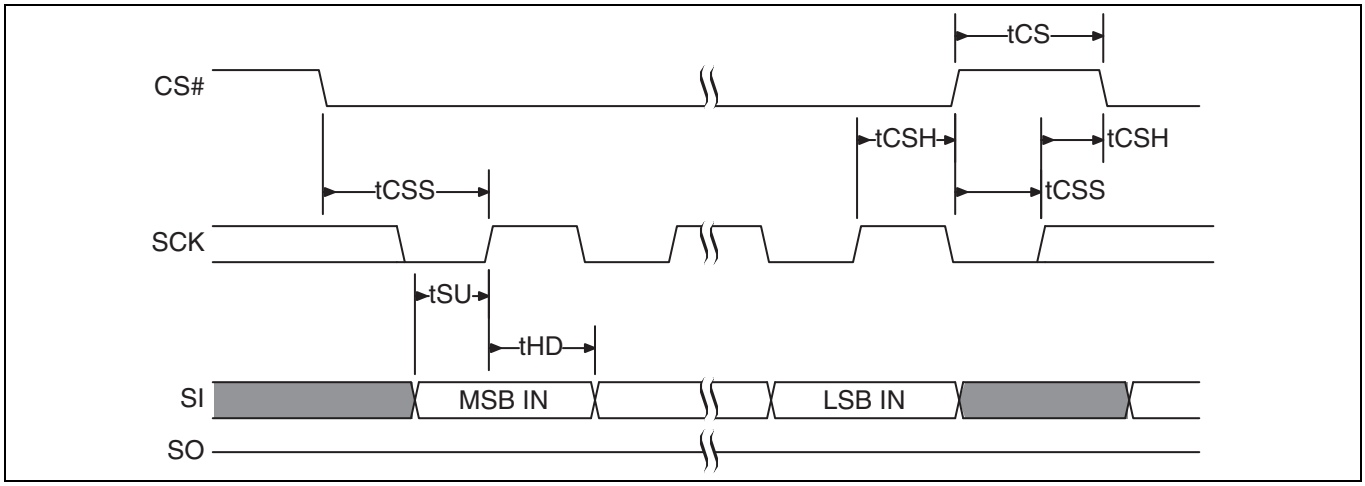


Figure 29 SPI single bit input timing

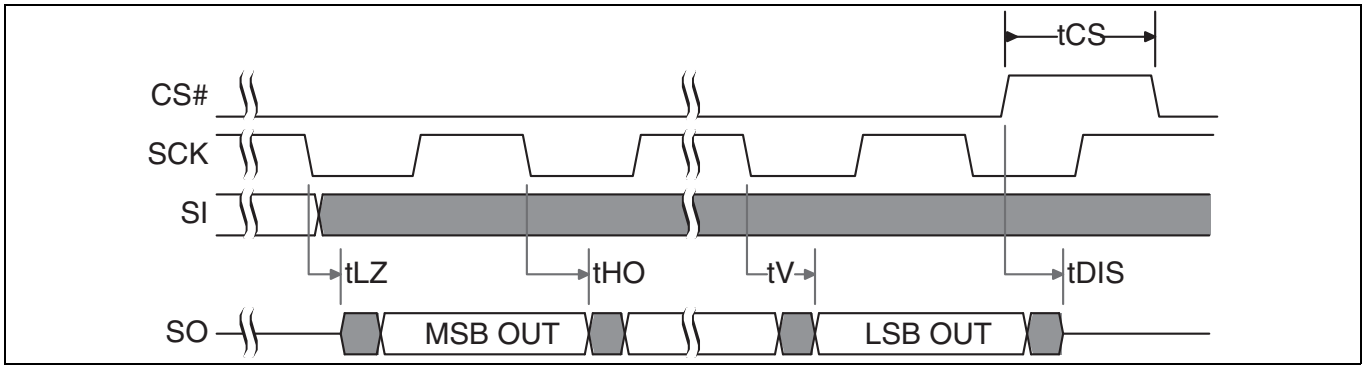


Figure 30 SPI single bit output timing

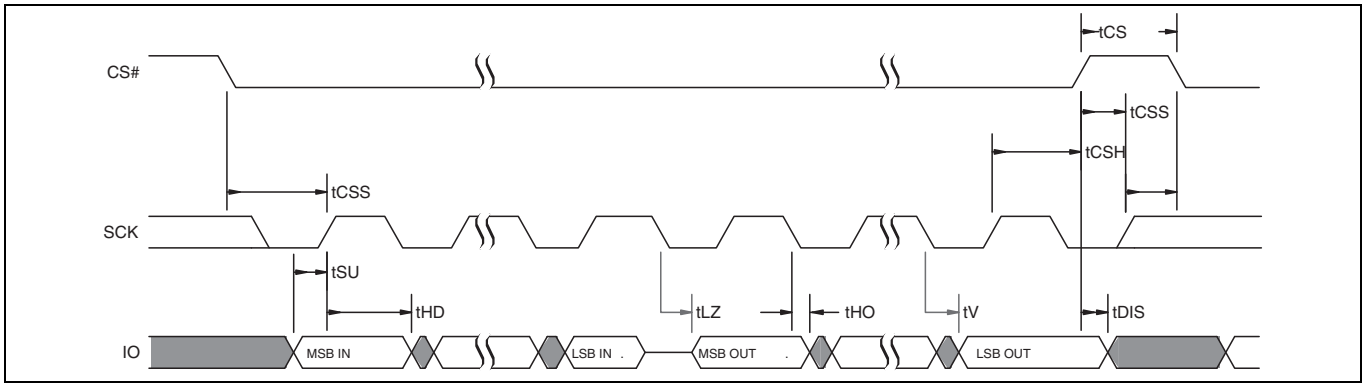


Figure 31 SPI MIO timing

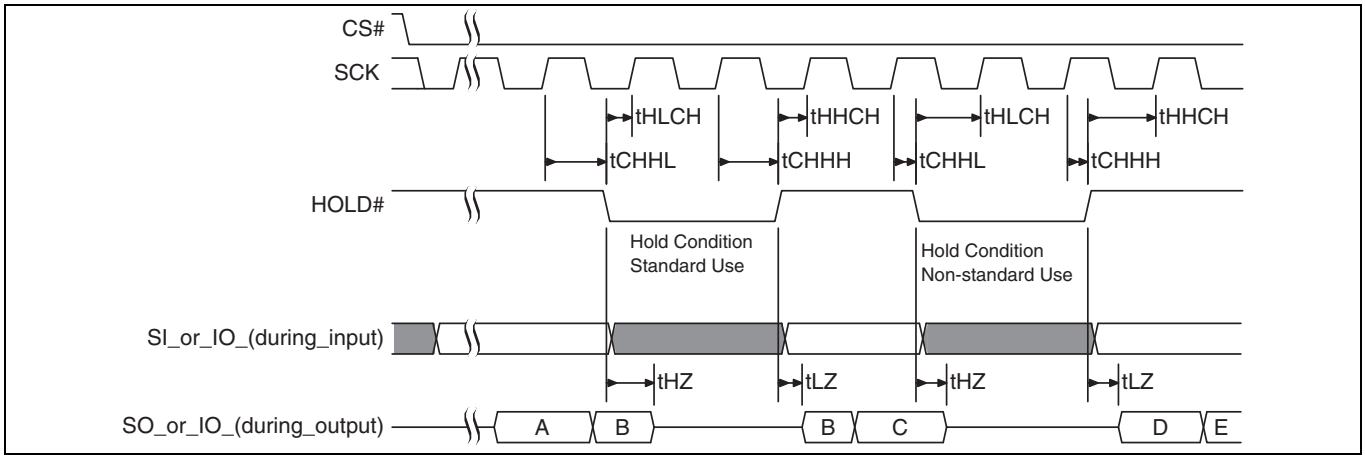


Figure 32 Hold timing

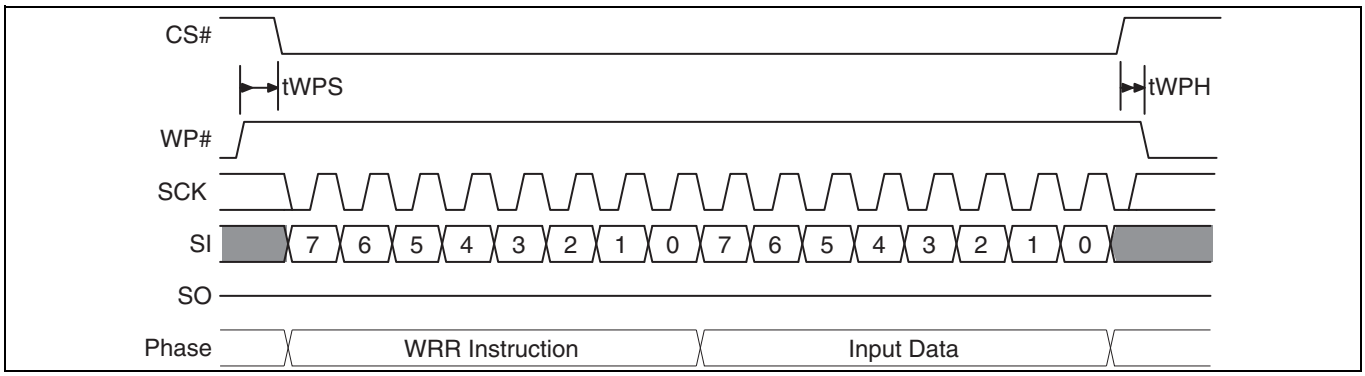


Figure 33 WP# input timing

7 Physical interface

Table 16 Model specific connections

Signal name	Description
RESET# / RFU	RESET# or RFU - Some device models bond this connector to the device RESET# signal, other models bond the RESET# signal to Vcc within the package leaving this package connector unconnected.

7.1 SOIC 8-lead package

7.1.1 SOIC-8 connection diagram

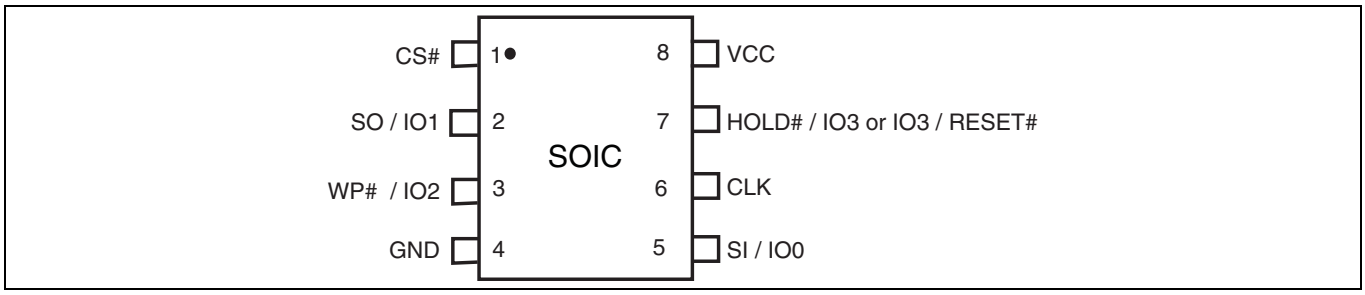
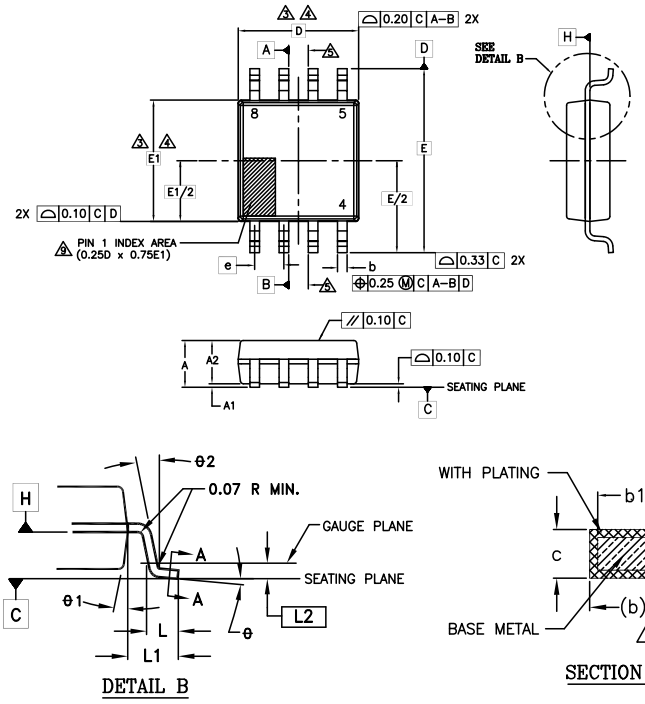


Figure 34 8-pin plastic small outline package (SO)[28]

Notes
27. Refer to **Table 2** for signal descriptions.
28. Lead 7 HOLD# / IO3 or IO3 / RESET# function depends on the selected configuration, If the IO3 / RESET# function is used, the host system should actively or passively pull-up the IO3 / RESET# connection when Quad mode is not enabled, or when CS# is HIGH and a Reset operation is not intended.

7.1.2 SOIC 8 physical diagram



SYMBOL	DIMENSIONS		
	MIN.	NOM.	MAX.
A	1.75	-	2.16
A1	0.05	-	0.25
A2	1.70	-	1.90
b	0.36	-	0.48
b1	0.33	-	0.46
c	0.19	-	0.24
c1	0.15	-	0.20
D	5.28 BSC		
E	8.00 BSC		
E1	5.28 BSC		
e	1.27 BSC		
L	0.51	-	0.76
L1	1.36 REF		
L2	0.25 BSC		
N	8		
θ	0°	-	8°
θ 1	5°	-	15°
θ 2	0-8° REF		

NOTES:

1. ALL DIMENSIONS ARE IN MILLIMETERS.
2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M - 1994.
3. DIMENSION D DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.15 mm PER END. DIMENSION E1 DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 mm PER SIDE. D AND E1 DIMENSIONS ARE DETERMINED AT DATUM H.
4. THE PACKAGE TOP MAY BE SMALLER THAN THE PACKAGE BOTTOM. DIMENSIONS D AND E1 ARE DETERMINED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY EXCLUSIVE OF MOLD FLASH, TIE BAR BURRS, GATE BURRS AND INTERLEAD FLASH, BUT INCLUSIVE OF ANY MISMATCH BETWEEN THE TOP AND BOTTOM OF THE PLASTIC BODY.
5. DATUMS A AND B TO BE DETERMINED AT DATUM H.
6. "N" IS THE MAXIMUM NUMBER OF TERMINAL POSITIONS FOR THE SPECIFIED PACKAGE LENGTH.
7. THE DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN 0.10 TO 0.25 mm FROM THE LEAD TIP.
8. DIMENSION "b" DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.10 mm TOTAL IN EXCESS OF THE "b" DIMENSION AT MAXIMUM MATERIAL CONDITION. THE DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OF THE LEAD FOOT.
9. THIS CHAMFER FEATURE IS OPTIONAL. IF IT IS NOT PRESENT, THEN A PIN 1 IDENTIFIER MUST BE LOCATED WITHIN THE INDEX AREA INDICATED.
10. LEAD COPLANARITY SHALL BE WITHIN 0.10 mm AS MEASURED FROM THE SEATING PLANE.

002-15548 **

Figure 35 8-lead SOIC (5.28 × 5.28 × 2.16 mm) package outline, 002-15548

7.2 SOIC 16-lead package

7.2.1 SOIC 16 connection diagram

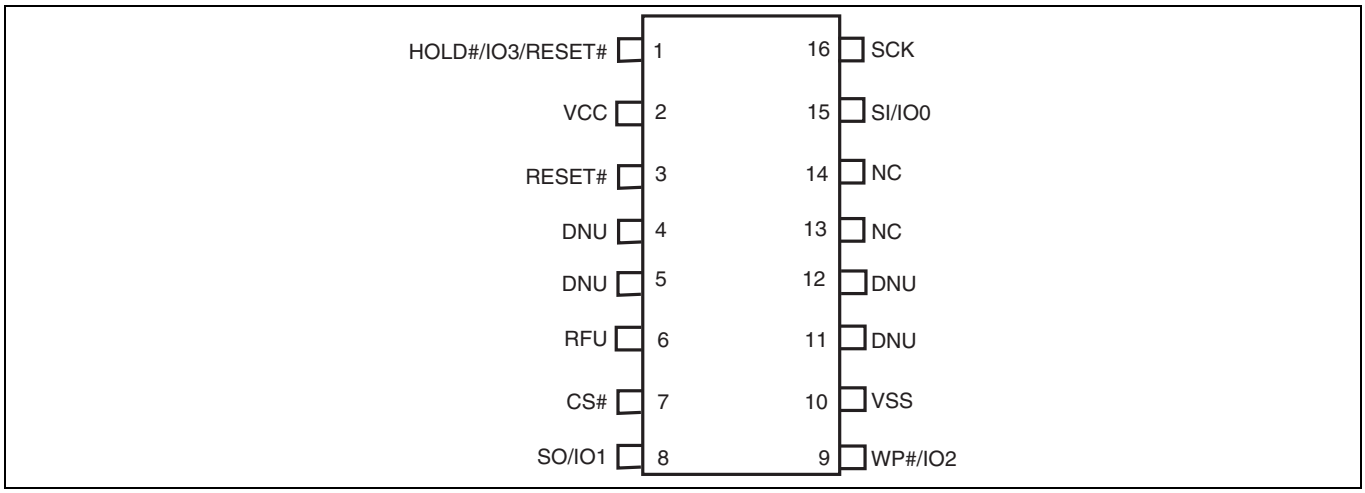
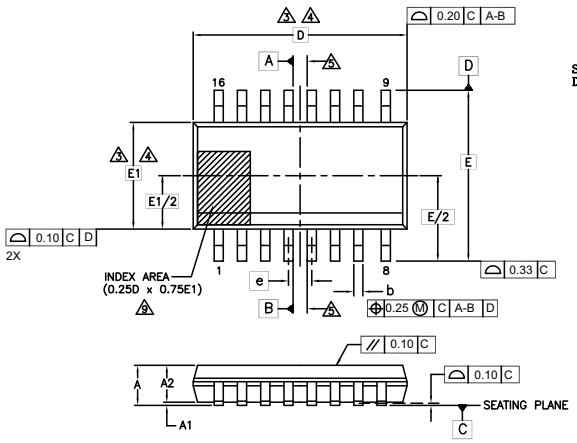
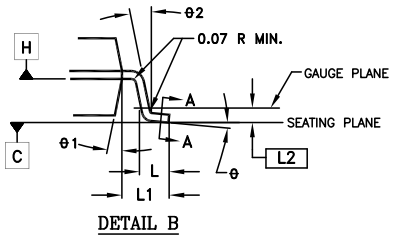
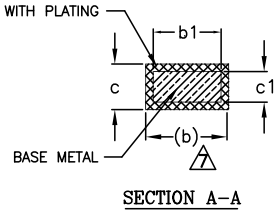


Figure 36 16-lead SOIC package, top view

7.2.2 SOIC 16 physical diagram







SYMBOL	DIMENSIONS		
	MIN.	NOM.	MAX.
A	2.35	-	2.65
A1	0.10	-	0.30
A2	2.05	-	2.55
b	0.31	-	0.51
b1	0.27	-	0.48
c	0.20	-	0.33
c1	0.20	-	0.30
D	10.30 BSC		
E	10.30 BSC		
E1	7.50 BSC		
e	1.27 BSC		
L	0.40	-	1.27
L1	1.40 REF		
L2	0.25 BSC		
N	16		
h	0.25	-	0.75
θ	0°	-	8°
θ1	5°	-	15°
θ2	0°	-	-

NOTES:

1. ALL DIMENSIONS ARE IN MILLIMETERS.
2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M - 1994.
3. DIMENSION D DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.15 mm PER END. DIMENSION E1 DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 mm PER SIDE. D AND E1 DIMENSIONS ARE DETERMINED AT DATUM H.
4. THE PACKAGE TOP MAY BE SMALLER THAN THE PACKAGE BOTTOM. DIMENSIONS D AND E1 ARE DETERMINED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY EXCLUSIVE OF MOLD FLASH, TIE BAR BURRS, GATE BURRS AND INTERLEAD FLASH, BUT INCLUSIVE OF ANY MISMATCH BETWEEN THE TOP AND BOTTOM OF THE PLASTIC BODY.
5. DATUMS A AND B TO BE DETERMINED AT DATUM H.
6. "N" IS THE MAXIMUM NUMBER OF TERMINAL POSITIONS FOR THE SPECIFIED PACKAGE LENGTH.
7. THE DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN 0.10 TO 0.25 mm FROM THE LEAD TIP.
8. DIMENSION "b" DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.10 mm TOTAL IN EXCESS OF THE "b" DIMENSION AT MAXIMUM MATERIAL CONDITION. THE DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OF THE LEAD FOOT.
9. THIS CHAMFER FEATURE IS OPTIONAL. IF IT IS NOT PRESENT, THEN A PIN 1 IDENTIFIER MUST BE LOCATED WITHIN THE INDEX AREA INDICATED.
10. LEAD COPLANARITY SHALL BE WITHIN 0.10 mm AS MEASURED FROM THE SEATING PLANE.

002-15547 *A

Figure 37 16-lead SOIC (10.30 × 7.50 × 2.65 mm) package outline, 002-15547

7.3 WSON 6 x 5 package

7.3.1 WSON 6 x 5 mm connection diagram

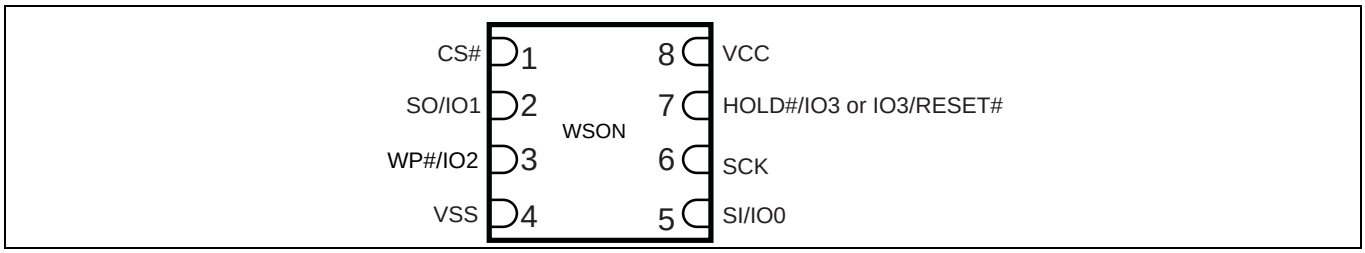
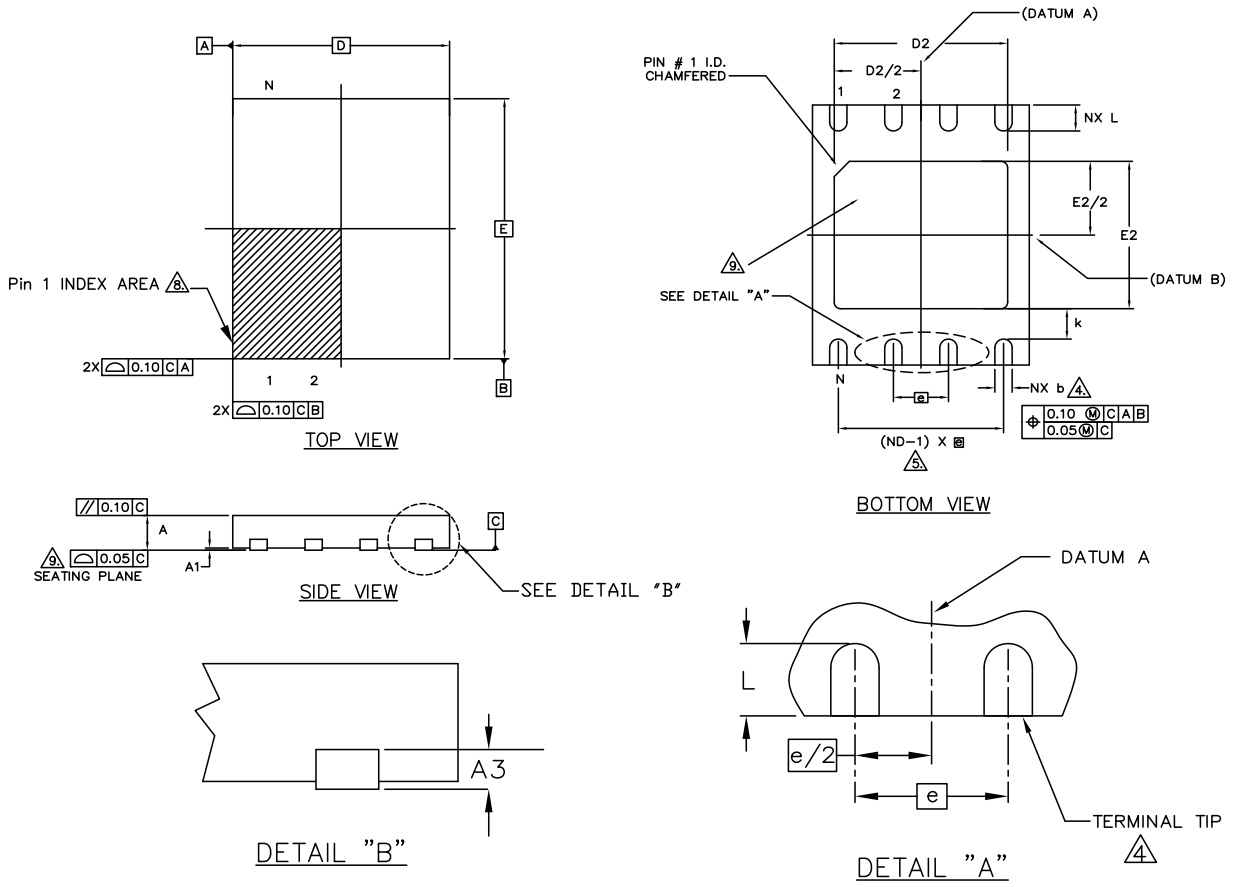


Figure 38 8-Contact WSON 6 x 5 mm, top view[29, 30]

Notes

29. Lead 7 HOLD# / IO3 or IO3 / RESET# function depends on the selected configuration, If the IO3 / RESET# function is used, the host system should actively or passively pull-up the IO3 / RESET# connection when Quad mode is not enabled, or when CS# is HIGH and a Reset operation is not intended.
30. There is an exposed central pad on the underside of the WSON package. This pad should not be connected to any voltage or signal line on the PCB. Connecting the central pad to GND (V_{SS}) is possible, provided PCB routing ensures 0 mV difference between voltage at the WSON GND (V_{SS}) lead and the central exposed pad.

7.3.2 WSON physical diagram



SYMBOL	DIMENSIONS		
	MIN.	NOM.	MAX.
e		1.27 BSC.	
N		8	
ND		4	
L	0.55	0.60	0.65
b	0.35	0.40	0.45
D2	3.90	4.00	4.10
E2	3.30	3.40	3.50
D		5.00 BSC	
E		6.00 BSC	
A	0.70	0.75	0.80
A1	0.00	0.02	0.05
A3		0.20 REF	
K		0.20 MIN.	

NOTES:

1. DIMENSIONING AND TOLERANCING CONFORMS TO ASME Y14.5M-1994.
2. ALL DIMENSIONS ARE IN MILLIMETERS.
3. N IS THE TOTAL NUMBER OF TERMINALS.
4. DIMENSION "b" APPLIES TO METALLIZED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30mm FROM TERMINAL TIP. IF THE TERMINAL HAS THE OPTIONAL RADIUS ON THE OTHER END OF THE TERMINAL, THE DIMENSION "b" SHOULD NOT BE MEASURED IN THAT RADIUS AREA.
5. ND REFERS TO THE NUMBER OF TERMINALS ON D SIDE.
6. MAX. PACKAGE WARPAGE IS 0.05mm.
7. MAXIMUM ALLOWABLE BURR IS 0.076mm IN ALL DIRECTIONS.
8. PIN #1 ID ON TOP WILL BE LOCATED WITHIN THE INDICATED ZONE.
9. BILATERAL COPLANARITY ZONE APPLIES TO THE EXPOSED HEAT SINK SLUG AS WELL AS THE TERMINALS.
10. A MAXIMUM 0.15mm PULL BACK (L1) MAY BE PRESENT.

002-18755 **

Figure 39 8-lead DFN (5.0 × 6.0 × 0.8 mm) package outline, 002-18755

7.4 FAB024 24-ball BGA package

7.4.1 Connection diagram

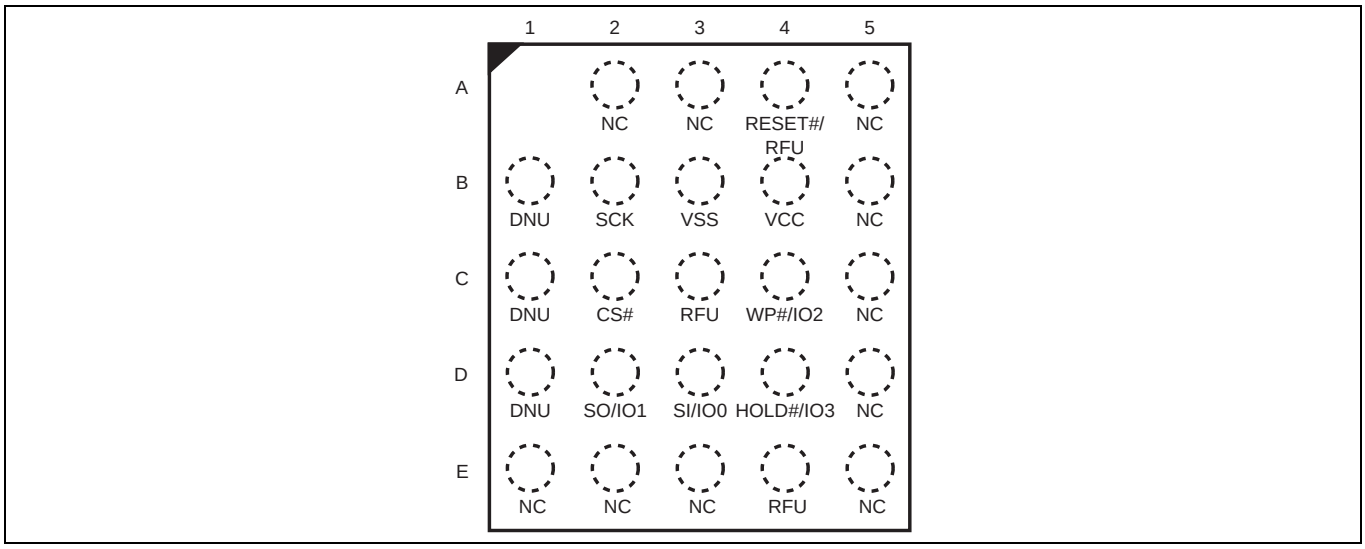
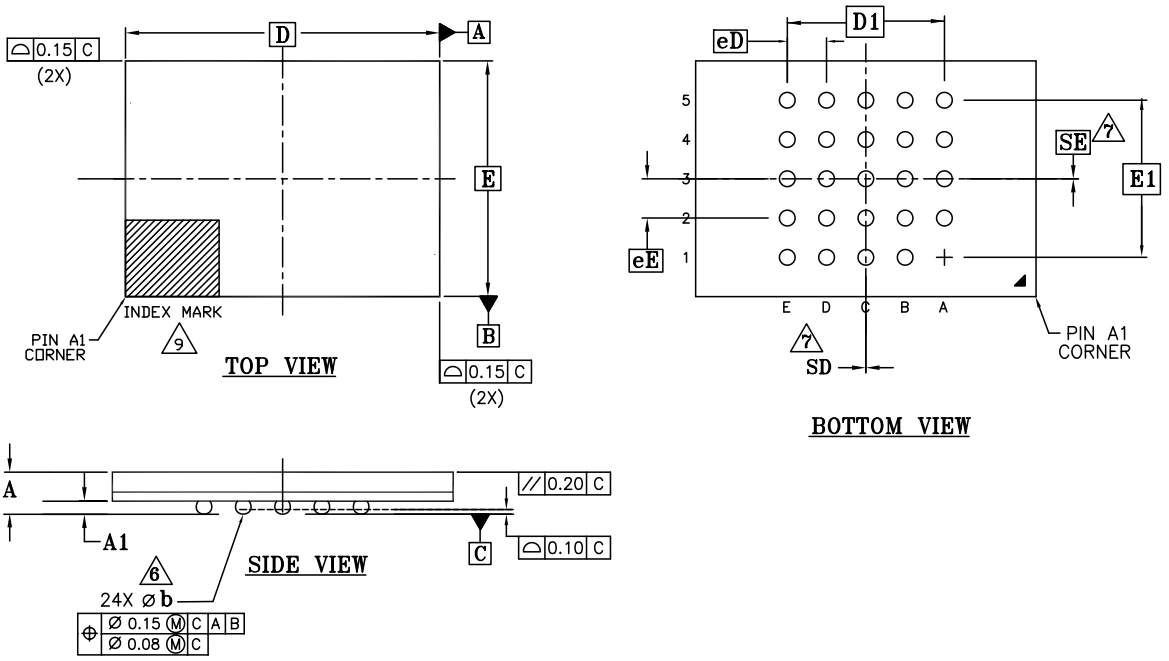


Figure 40 24-ball BGA, 5 x 5 ball footprint (FAB024), top view[31]

Note
31. Signal connections are in the same relative positions as FAC024 BGA, allowing a single PCB footprint to use either package.

7.4.2 Physical diagram



SYMBOL	DIMENSIONS		
	MIN.	NOM.	MAX.
A	-	-	1.20
A1	0.20	-	-
D	8.00 BSC		
E	6.00 BSC		
D1	4.00 BSC		
E1	4.00 BSC		
MD	5		
ME	5		
N	24		
⌀ b	0.35	0.40	0.45
eE	1.00 BSC		
eD	1.00 BSC		
SD	0.00 BSC		
SE	0.00 BSC		

NOTES:

1. DIMENSIONING AND TOLERANCING METHODS PER ASME Y14.5M-1994.
2. ALL DIMENSIONS ARE IN MILLIMETERS.
3. BALL POSITION DESIGNATION PER JEP95, SECTION 3, SPP-020.
4. e REPRESENTS THE SOLDER BALL GRID PITCH.
5. SYMBOL "MD" IS THE BALL MATRIX SIZE IN THE "D" DIRECTION.
   SYMBOL "ME" IS THE BALL MATRIX SIZE IN THE "E" DIRECTION.
   N IS THE NUMBER OF POPULATED SOLDER BALL POSITIONS FOR MATRIX SIZE MD X ME.
6. DIMENSION "b" IS MEASURED AT THE MAXIMUM BALL DIAMETER IN A PLANE PARALLEL TO DATUM C.
7. "SD" AND "SE" ARE MEASURED WITH RESPECT TO DATUMS A AND B AND DEFINE THE POSITION OF THE CENTER SOLDER BALL IN THE OUTER ROW.
   WHEN THERE IS AN ODD NUMBER OF SOLDER BALLS IN THE OUTER ROW, "SD" OR "SE" = 0.
   WHEN THERE IS AN EVEN NUMBER OF SOLDER BALLS IN THE OUTER ROW, "SD" = eD/2 AND "SE" = eE/2.
8. "+" INDICATES THE THEORETICAL CENTER OF DEPOPULATED BALLS.
9. A1 CORNER TO BE IDENTIFIED BY CHAMFER, LASER OR INK MARK, METALLIZED MARK INDENTATION OR OTHER MEANS.

002-15534 **

Figure 41 24-ball FBGA (8.0 × 6.0 × 1.2 mm) package outline, 002-15534

7.5 FAC024 24-ball BGA package

7.5.1 Connection diagram

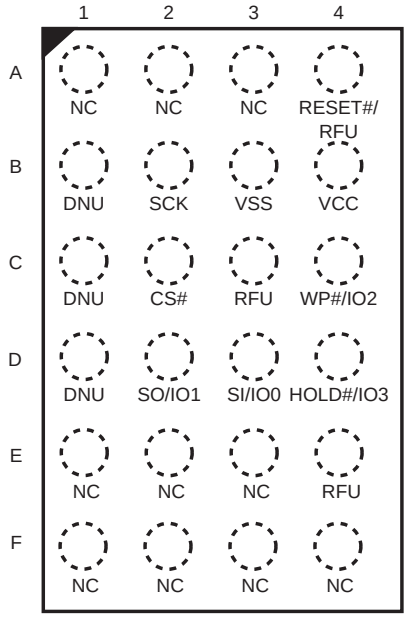
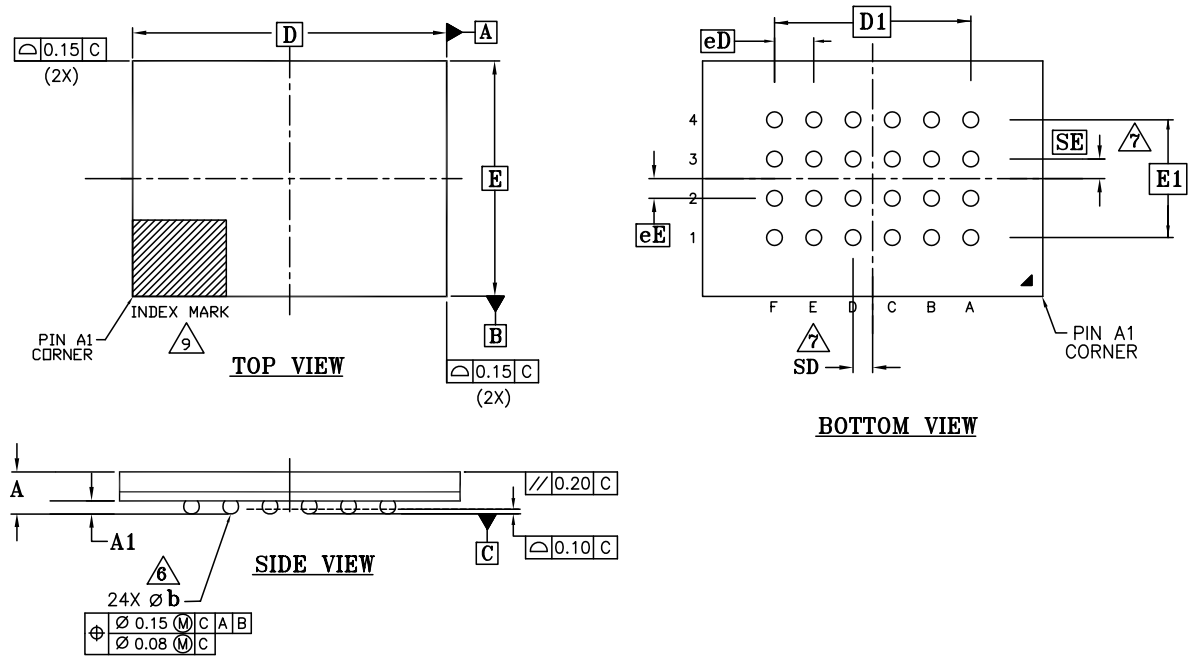


Figure 42 24-ball BGA, 4 x 6 ball footprint (FAC024), top view[31]

Note
32. Signal connections are in the same relative positions as FAC024 BGA, allowing a single PCB footprint to use either package.

7.5.2 Physical diagram



SYMBOL	DIMENSIONS		
	MIN.	NOM.	MAX.
A	-	-	1.20
A1	0.25	-	-
D	8.00 BSC		
E	6.00 BSC		
D1	5.00 BSC		
E1	3.00 BSC		
MD	6		
ME	4		
N	24		
⌀ b	0.35	0.40	0.45
eE	1.00 BSC		
eD	1.00 BSC		
SD	0.50 BSC		
SE	0.50 BSC		

NOTES:

1. DIMENSIONING AND TOLERANCING METHODS PER ASME Y14.5M-1994.
2. ALL DIMENSIONS ARE IN MILLIMETERS.
3. BALL POSITION DESIGNATION PER JEP95, SECTION 3, SPP-020.
4. [e] REPRESENTS THE SOLDER BALL GRID PITCH.
5. SYMBOL "MD" IS THE BALL MATRIX SIZE IN THE "D" DIRECTION.
   SYMBOL "ME" IS THE BALL MATRIX SIZE IN THE "E" DIRECTION.
   N IS THE NUMBER OF POPULATED SOLDER BALL POSITIONS FOR MATRIX SIZE MD X ME.

△6 DIMENSION "b" IS MEASURED AT THE MAXIMUM BALL DIAMETER IN A PLANE PARALLEL TO DATUM C.

△7 "SD" AND "SE" ARE MEASURED WITH RESPECT TO DATUMS A AND B AND DEFINE THE POSITION OF THE CENTER SOLDER BALL IN THE OUTER ROW.
WHEN THERE IS AN ODD NUMBER OF SOLDER BALLS IN THE OUTER ROW, "SD" OR "SE" = 0.
WHEN THERE IS AN EVEN NUMBER OF SOLDER BALLS IN THE OUTER ROW, "SD" = eD/2 AND "SE" = eE/2.

8. "+" INDICATES THE THEORETICAL CENTER OF DEPOPULATED BALLS.

△9 A1 CORNER TO BE IDENTIFIED BY CHAMFER, LASER OR INK MARK, METALLIZED MARK INDENTATION OR OTHER MEANS.

002-15535 **

Figure 43 24-ball FBGA (8.0 × 6.0 × 1.2 mm) package outline, 002-15535

7.5.3 Special handling instructions for FBGA packages

Flash memory devices in BGA packages may be damaged if exposed to ultrasonic cleaning methods. The package and/or data integrity may be compromised if the package body is exposed to temperatures above 150°C for prolonged periods of time.

8 Address space maps

8.1 Overview

8.1.1 Extended address

The FL-S family of devices supports 32-bit addresses to enable higher density devices than allowed by previous generation (legacy) SPI devices that supported only 24-bit addresses. A 24-bit byte resolution address can access only 16 MB (128 Mb) of maximum density. A 32-bit byte resolution address allows direct addressing of up to a 4 Gbytes (32 Gbits) of address space.

Legacy commands continue to support 24-bit addresses for backward software compatibility. Extended 32-bit addresses are enabled in three ways:

- Bank Address register — a software (command) loadable internal register that supplies the high order bits of address when legacy 24-bit addresses are in use.
- Extended Address mode — a bank address register bit that changes all legacy commands to expect 32 bits of address supplied from the host system.
- New commands — that perform both legacy and new functions, which expect 32-bit address.

The default condition at power-up or reset, is the Bank address register loaded with zeros and the extended address mode set for 24-bit addresses. This enables legacy software compatible access to the first 128 Mb of a device.

The S25FL127S, 128 Mb density member of the FL-S Family, supports the extended address features in the same way but in essence ignores bits 31 to 24 of any address because the main flash array only needs 24 bits of address. This enables simple migration from the 128-Mb density to higher density devices without changing the address handling aspects of software.

8.1.2 Multiple address spaces

Many commands operate on the main flash memory array. Some commands operate on address spaces separate from the main flash array. Each separate address space uses the full 32-bit address but may only define a small portion of the available address space.

8.2 Flash memory array

The main flash array is divided into erase units called sectors. The sectors are organized either as a hybrid combination of 4-KB and 64-KB sectors, or as uniform 256-KB sectors. The sector organization depends on the D8h_O control bit configuration in the Status Register 2 (SR2[7]).

Table 17 S25FL127S sector and memory address map, bottom 4-KB sectors

Sector size (KB)	Sector count	Sector range	Address range (byte address)	Notes
4	16	SA00	00000000h–00000FFFh	Sector Starting Address
		:	:	—
		SA15	0000F000h–0000FFFFh	
64	255	SA16	00010000h–0001FFFFh	
		:	:	
		SA270	00FF0000h–00FFFFFFh	Sector Ending Address

Table 18 S25FL127S sector and memory address map, top 4-KB sectors

Sector size (KB)	Sector count	Sector range	Address range (byte address)	Notes
64	255	SA00	0000000h–000FFFFh	Sector Starting Address
		:	:	—
		SA255	00FE0000h–00FEFFFFh	
4	16	SA256	00FF0000h–00FF0FFFh	
		:	:	
		SA270	00FFF000h–00FFFFFFh	Sector Ending Address

Table 19 S25FL127S sector and memory address map, uniform 256-KB sectors

Sector size (KB)	Sector count	Sector range	Address range (byte address)	Notes
256	64	SA00	0000000h–003FFFFh	Sector Starting Address
		:	:	—
		SA63	0FC0000h–0FFFFFFh	Sector Ending Address

Note These are condensed tables that use a couple of sectors as references. There are address ranges that are not explicitly listed. All 4-KB sectors have the pattern XXXX000h–XXXXFFFh. All 64-KB sectors have the pattern XXX0000h–XXXFFFFh. All 256-KB sectors have the pattern XX00000h–XX3FFFFh, XX40000h–XX7FFFFh, XX80000h–XXCFFFFh, or XXD0000h–XXFFFFFh.

8.3 ID-CFI address space

The RDID command (9Fh) reads information from a separate flash memory address space for device identification (ID) and Common Flash Interface (CFI) information. See **"Device ID and Common Flash Interface (ID-CFI) address map"** on page 137 for the tables defining the contents of the ID-CFI address space. The ID-CFI address space is programmed by Infineon and read-only for the host system.

8.4 JEDEC JESD216B serial flash discoverable parameters (SFDP) space

The RSFDP command (5Ah) reads information from a separate Flash memory address space for device identification, feature, and configuration information, in accord with the JEDEC JESD216B standard for serial flash discoverable parameters. The ID-CFI address space is incorporated as one of the SFDP parameters. See **"Serial flash discoverable parameters (SFDP) address map"** on page 133 for the tables defining the contents of the SFDP address space. The SFDP address space is programmed by Infineon and read-only for the host system.

8.5 OTP address space

Each FL-S family memory device has a 1024-byte one time program (OTP) address space that is separate from the main flash array. The OTP area is divided into 32, individually lockable, 32-byte aligned and length regions.

In the 32-byte region starting at address 0:

- The 16 lowest address bytes are programmed by Infineon with a 128-bit random number. Only Infineon is able to program these bytes.
- The next 4 higher address bytes (OTP Lock Bytes) are used to provide one bit per OTP region to permanently protect each region from programming. The bytes are erased when shipped from Infineon. After an OTP region is programmed, it can be locked to prevent further programming, by programming the related protection bit in the OTP Lock Bytes.
- The next higher 12 bytes of the lowest address region are Reserved for Future Use (RFU). The bits in these RFU bytes may be programmed by the host system but it must be understood that a future device may use those bits for protection of a larger OTP space. The bytes are erased when shipped from Cypress.

The remaining regions are erased when shipped from Cypress, and are available for programming of additional permanent data.

Refer to **Figure 44** for a pictorial representation of the OTP memory space.

The OTP memory space is intended for increased system security. OTP values, such as the random number programmed by Cypress, can be used to "mate" a flash component with the system CPU/ASIC to prevent device substitution.

The Configuration Register FREEZE (CR1[0]) bit protects the entire OTP memory space from programming when set to 1. This allows trusted boot code to control programming of OTP regions then set the FREEZE bit to prevent further OTP memory space programming during the remainder of normal power-on system operation.

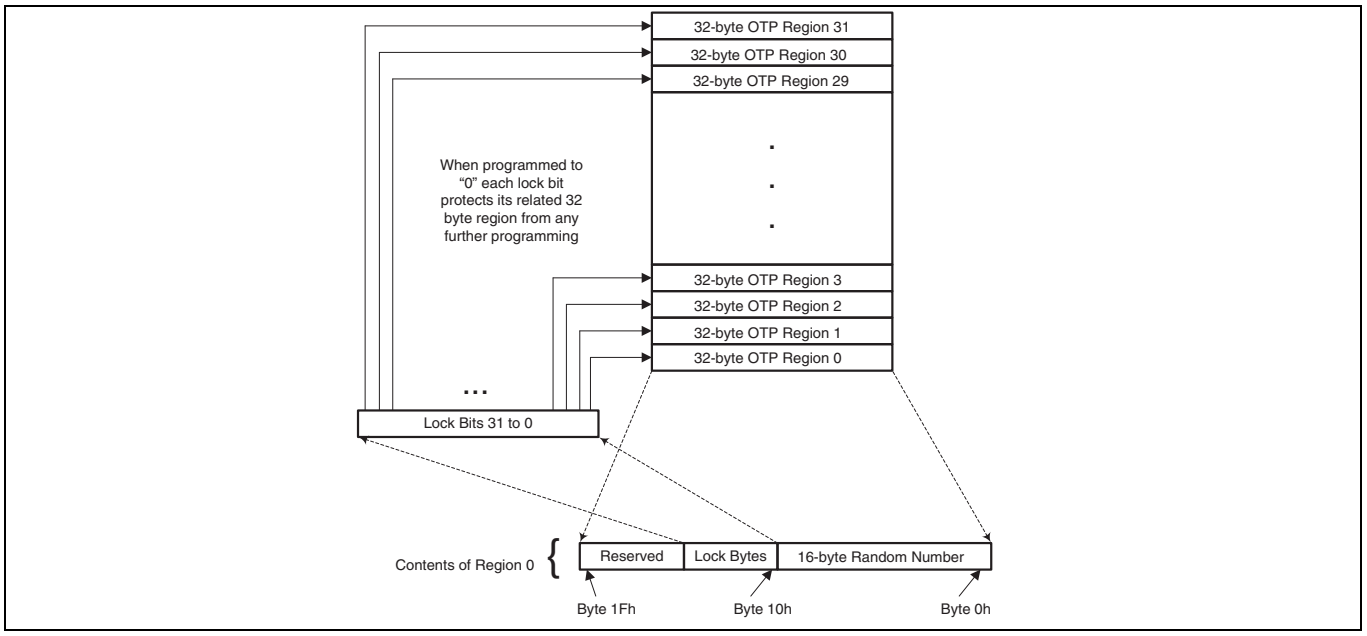


Figure 44 OTP address space

Table 20 OTP address map

Region	Byte address range (Hex)	Contents	Initial delivery state (Hex)
Region 0	000	Least Significant Byte of Infineon programmed random number	Cypress Programmed Random Number
	...	...	
	00F	Most Significant Byte of Infineon programmed random number	
	010 to 013	Region Locking Bits Byte 10 [bit 0] locks region 0 from programming when = 0 ... Byte 13 [bit 7] locks region 31 from programming when = 0	All bytes = FF
	014 to 01F	Reserved for Future Use (RFU)	All bytes = FF
Region 1	020 to 03F	Available for user programming	All bytes = FF
Region 2	040 to 05F	Available for user programming	All bytes = FF
...	...	Available for user programming	All bytes = FF
Region 31	3E0 to 3FF	Available for user programming	All bytes = FF

8.6 Registers

Registers are small groups of memory cells used to configure how the S25FL-S memory device operates or to report the status of device operations. The registers are accessed by specific commands. The commands (and hexadecimal instruction codes) used for each register are noted in each register description. The individual register bits may be volatile, nonvolatile, or one time programmable (OTP). The type for each bit is noted in each register description. The default state shown for each bit refers to the state after power-on reset, hardware reset, or software reset if the bit is volatile. If the bit is nonvolatile or OTP, the default state is the value of the bit when the device is shipped from Cypress. Nonvolatile bits have the same cycling (erase and program) endurance as the main flash array.

Table 21 Register descriptions

Register	Abbreviation	Type	Bit location
Status Register 1	SR1[7:0]	Volatile	7:0
Configuration Register 1	CR1[7:0]	Volatile	7:0
Status Register 2	SR2[7:0]	RFU	7:0
AutoBoot Register	ABRD[31:0]	Nonvolatile	31:0
Bank Address Register	BRAC[7:0]	Volatile	7:0
ECC Status Register	ECCSR[7:0]	Volatile	7:0
ASP Register	ASPR[15:1]	OTP	15:1
ASP Register	ASPR[0]	RFU	0
Password Register	PASS[63:0]	Nonvolatile OTP	63:0
PPB Lock Register	PPBL[7:1]	Volatile	7:1
PPB Lock Register	PPBL[0]	Volatile Read Only	0
PPB Access Register	PPBAR[7:0]	Nonvolatile	7:0
DYB Access Register	DYBAR[7:0]	Volatile	7:0
SPI DDR Data Learning Registers	NVDLR[7:0]	Nonvolatile	7:0
SPI DDR Data Learning Registers	VDLR[7:0]	Volatile	7:0

8.6.1 Status Register 1 (SR1)

Related Commands: Read Status Register (RDSR1 05h), Write Registers (WRR 01h), Write Enable (WREN 06h), Write Disable (WRDI 04h), Clear Status Register (CLSR 30h).

Table 22 Status Register 1 (SR1)

Bits	Field Name	Function	Type	Default State	Description
7	SRWD	Status Register Write Disable	Nonvolatile	0	1 = Locks state of SRWD, BP, and Configuration Register bits when WP# is LOW by ignoring WRR command 0 = No protection, even when WP# is LOW
6	P_ERR	Programming Error Occurred	Volatile, Read only	0	1 = Error occurred 0 = No Error
5	E_ERR	Erase Error Occurred	Volatile, Read only	0	1 = Error occurred 0 = No Error
4	BP2	Block Protection	Volatile if CR1[3] = 1, Nonvolatile if CR1[3] = 0	1 if CR1[3] = 1, 0 when shipped from Cypress	Protects selected range of sectors (Block) from Program or Erase.
3	BP1				
2	BP0				
1	WEL	Write Enable Latch	Volatile	0	1 = Device accepts Write Registers (WRR), Program or Erase commands 0 = Device ignores Write Registers (WRR), Program or Erase commands This bit is not affected by WRR, only WREN and WRDI commands affect this bit.
0	WIP	Write in Progress	Volatile, Read only	0	1 = Device Busy, a Write Registers (WRR), program, erase or other operation is in progress 0 = Ready Device is in Standby mode and can accept commands

The Status Register contains both status and control bits:

Status Register Write Disable (SRWD) SR1[7]: Places the device in the Hardware Protected mode when this bit is set to '1' and the WP# input is driven LOW. In this mode, the Write Registers (WRR) command is no longer accepted for execution, effectively locking the state of the SRWD bit, BP bits, and Configuration Register bits by making the Status Register and Configuration Register read-only. If WP# is HIGH, the SRWD bit and BP bits may be changed by the WRR command. If SRWD is '0', WP# has no effect and the SRWD bit and BP bits may be changed by the WRR command. The SRWD bit has the same nonvolatile endurance as the main flash array.

Program Error (P_ERR) SR1[6]: The Program Error Bit is used as a program operation success or failure indication. When the Program Error bit is set to '1', it indicates that there was an error in the last program operation. This bit will also be set when the user attempts to program within a protected main memory sector or locked OTP region. When the Program Error bit is set to '1', this bit can be reset to 0 with the Clear Status Register (CLSR) command. This is a read-only bit and is not affected by the WRR command.

Erase Error (E_ERR) SR1[5]: The Erase Error Bit is used as an Erase operation success or failure indication. When the Erase Error bit is set to ‘1’, it indicates that there was an error in the last erase operation. This bit will also be set when the user attempts to erase an individual protected main memory sector. The Bulk Erase command will not set E_ERR if a protected sector is found during the command execution. When the Erase Error bit is set to ‘1’, this bit can be reset to 0 with the Clear Status Register (CLSR) command. This is a read-only bit and is not affected by the WRR command.

Block Protection (BP2, BP1, BP0) SR1[4:2]: These bits define the main flash array area to be software-protected against program and erase commands. The BP bits are either volatile or nonvolatile, depending on the state of the BP nonvolatile bit (BPNV) in the configuration register. When one or more of the BP bits is set to ‘1’, the relevant memory area is protected against program and erase. The Bulk Erase (BE) command can be executed only when the BP bits are cleared to 0’s. See **“Block protection”** on page 70 for a description of how the BP bit values select the memory array area protected. The BP bits have the same nonvolatile endurance as the main flash array.

Write Enable Latch (WEL) SR1[1]: The WEL bit must be set to ‘1’ to enable program, write, or erase operations as a means to provide protection against inadvertent changes to memory or register values. The Write Enable (WREN) command execution sets the Write Enable Latch to ‘1’ to allow any program, erase, or write commands to execute afterwards. The Write Disable (WRDI) command can be used to set the Write Enable Latch to ‘0’ to prevent all program, erase, and write commands from execution. The WEL bit is cleared to ‘0’ at the end of any successful program, write, or erase operation. Following a failed operation the WEL bit may remain set and should be cleared with a WRDI command following a CLSR command. After a power down/power up sequence, hardware reset, or software reset, the Write Enable Latch is set to ‘0’. The WRR command does not affect this bit.

Write In Progress (WIP) SR1[0]: Indicates whether the device is performing a program, write, erase operation, or any other operation, during which a new operation command will be ignored. When the bit is set to ‘1’, the device is busy performing an operation. While WIP is ‘1’, only Read Status (RDSR1 or RDSR2), Erase Suspend (ERSP), Program Suspend (PGSP), Clear Status Register (CLSR), and Software Reset (RESET) commands may be accepted. ERSP and PGSP will only be accepted if memory array erase or program operations are in progress. The status register E_ERR and P_ERR bits are updated while WIP = 1. When P_ERR or E_ERR bits are set to one, the WIP bit will remain set to1 indicating the device remains busy and unable to receive new operation commands. A Clear Status Register (CLSR) command must be received to return the device to standby mode. When the WIP bit is cleared to ‘0’, no operation is in progress. This is a read-only bit.

8.6.2 Configuration Register 1 (CR1)

Related Commands: Read Configuration Register (RDCR 35h), Write Registers (WRR 01h). The Configuration Register bits can be changed using the WRR command with sixteen input cycles.

The configuration register controls certain interface and data protection functions.

Table 23 Configuration Register (CR1)

Bits	Field Name	Function	Type	Default state	Description
7	LC1	Latency Code	Nonvolatile	0	Selects number of initial read latency cycles See **Table 24**
6	LC0			0	
5	TBPROT	Configures Start of Block Protection	OTP	0	1 = BP starts at bottom (Low address) 0 = BP starts at top (High address)
4	DNU	DNU	OTP	0	Do Not Use
3	BPNV	Configures BP2-0 in Status Register	OTP	0	1 = Volatile 0 = Nonvolatile
2	TBPARM	Configures Parameter Sectors location	OTP	0	1 = 4-KB physical sectors at top, (high address) 0 = 4-KB physical sectors at bottom (Low address) RFU in uniform sector devices
1	QUAD	Puts the device into Quad I/O operation	Nonvolatile	0	1 = Quad 0 = Dual or Serial
0	FREEZE	Lock current state of BP2-0 bits in Status Register, TBPROT and TBPARM in Configuration Register, and OTP regions	Volatile	0	1 = Block Protection and OTP locked 0 = Block Protection and OTP un-locked

Latency Code (LC) CR1[7:6]: The Latency Code selects the number of mode and dummy cycles between the end of address and the start of read data output for all read commands.

Some read commands send mode bits following the address to indicate that the next command will be of the same type with an implied, rather than an explicit, instruction. The next command thus does not provide an instruction byte, only a new address and mode bits. This reduces the time needed to send each command when the same command type is repeated in a sequence of commands.

Dummy cycles provide additional latency that is needed to complete the initial read access of the flash array before data can be returned to the host system. Some read commands require additional latency cycles as the SCK frequency is increased.

The following latency code tables provide different latency settings that are configured by Cypress.

Where mode or latency (dummy) cycles are shown in the tables as a dash, that read command is not supported at the frequency shown. Read is supported only up to 50 MHz but the same latency value is assigned in each latency code and the command may be used when the device is operated at ≤ 50 MHz with any latency code setting. Similarly, only the Fast Read command is supported up to 108 MHz but the same 10b latency code is used for Fast Read up to 108 MHz and for the other dual and quad read commands up to 108 MHz. It is not necessary to change the latency code from a higher to a lower frequency when operating at lower frequencies where a particular command is supported. The latency code values for a higher frequency can be used for accesses at lower frequencies.

Table 24 Latency codes

Freq. (MHz)	LC	Read (03h, 13h)		Fast Read (0Bh, 0Ch)		Read Dual Out (3Bh, 3Ch)		Read Quad Out (6Bh, 6Ch)		Dual I/O Read (BBh, BCh)		Quad I/O Read (EBh, ECh)	
		Mode	Dummy	Mode	Dummy	Mode	Dummy	Mode	Dummy	Mode	Dummy	Mode	Dummy
≤ 50	11	0	0	0	0	0	0	0	0	4	0	2	1
≤ 80	00	–	–	0	8	0	8	0	8	4	4	2	4
≤ 90	01	–	–	0	8	0	8	0	8	4	1	2	4
≤104	10	–	–	0	8	0	8	0	8	4	2	2	5
≤ 108	10	–	–	0	8	–	–	–	–	–	–	–	–

Top or Bottom Protection (TBPROT) CR1[5]: This bit defines the operation of the Block Protection bits BP2, BP1, and BP0 in the Status Register. As described in the status register section, the BP2–0 bits allow the user to optionally protect a portion of the array, ranging from 1/64, 1/4, 1/2, etc., up to the entire array. When TBPROT is set to '0', the Block Protection is defined to start from the top (maximum address) of the array. When TBPROT is set to '1', the Block Protection is defined to start from the bottom (zero address) of the array. The TBPROT bit is OTP and set to '0' when shipped from Cypress. If TBPROT is programmed to '1', an attempt to change it back to 0 will fail and set the Program Error bit (P_ERR in SR1[6]).

The desired state of TBPROT must be selected during the initial configuration of the device during system manufacture; before the first program or erase operation on the main flash array. TBPROT must not be programmed after programming or erasing is done in the main flash array.

CR1[4]: Do Not Use

Block Protection Nonvolatile (BPNV) CR1[3]: The BPNV bit defines whether or not the BP2–0 bits in the Status Register are volatile or nonvolatile. The BPNV bit is OTP and cleared to '0' with the BP bits cleared to 000 when shipped from Cypress. When BPNV is set to a 0 the BP2–0 bits in the Status Register are nonvolatile. The time required to write the BP bits when they are nonvolatile is t_W. When BPNV is set to '1', the BP2–0 bits in the Status Register are volatile and will be reset to binary 111 after POR, hardware reset, or command reset. This allows the BP bits to be written an unlimited number of times because they are volatile and the time to write the volatile BP bits is the much faster t_{CS} volatile register write time. If BPNV is programmed to '1', an attempt to change it back to 0 will fail and set the Program Error bit (P_ERR in SR1[6]).

TBPARM CR1[2]: TBPARM defines the logical location of the parameter block. The parameter block consists of sixteen 4-KB small sectors, which replace one 64-KB sector. When TBPARM is set to '1', the parameter block is in the top of the memory array address space. When TBPARM is set to a 0 the parameter block is at the Bottom of the array. TBPARM is OTP and set to a 0 when it ships from Cypress. If TBPARM is programmed to '1', an attempt to change it back to '0' will fail and set the Program Error bit (P_ERR in SR1[6]).

The desired state of TBPARM must be selected during the initial configuration of the device during system manufacture; before the first program or erase operation on the main flash array. TBPARM must not be programmed after programming or erasing is done in the main flash array.

TBPROT can be set or cleared independent of the TBPARM bit. Therefore, the user can elect to store parameter information from the bottom of the array and protect boot code starting at the top of the array, and vice versa. Or the user can select to store and protect the parameter information starting from the top or bottom together.

When the memory array is logically configured as uniform 256-KB sectors, the TBPARM bit is Reserved for Future Use (RFU) and has no effect because all sectors are uniform size.

Quad Data Width (QUAD) CR1[1]: When set to '1', this bit switches the data width of the device to 4-bit Quad mode. That is, WP# becomes IO2 and HOLD# becomes IO3. The WP# and HOLD# inputs are not monitored for their normal functions and are internally set to high (inactive). The commands for Serial, Dual Output, and Dual I/O Read still function normally but, there is no need to drive WP# and Hold# inputs for those commands when switching between commands using different data path widths. The QUAD bit must be set to '1' when using Read Quad Out, Quad I/O Read, and Quad Page Program commands. The QUAD bit is nonvolatile.

Freeze Protection (FREEZE) CR1[0]: The Freeze Bit, when set to '1', locks the current state of the BP2–0 bits in Status Register, the TBPROT and TBPARM bits in the Configuration Register, and the OTP address space. This prevents writing, programming, or erasing these areas. As long as the FREEZE bit remains cleared to logic 0 the other bits of the Configuration Register, including FREEZE, are writable, and the OTP address space is programmable. Once the FREEZE bit has been written to a logic 1 it can only be cleared to a logic 0 by a power-off to power-on cycle or a hardware reset. Software reset will not affect the state of the FREEZE bit. The FREEZE bit is volatile and the default state of FREEZE after power-on is 0. The FREEZE bit can be set in parallel with updating other values in CR1 by a single WRR command.

8.6.3 Status Register 2 (SR2)

Related Commands: Read Status Register 2 (RDSR2 07h), Write Registers (WRR 01h). The Status Register 2 OTP bits can be changed using the WRR command with 24 input cycles.

Table 25 Status Register 2 (SR2)

Bits	Field name	Function	Type	Default state	Description
7	D8h_O	Block Erase Size	OTP	0	1 = 256 KB Erase (Uniform sectors). 0 = 64 KB Erase (Hybrid 4-KB / 64-KB sectors).
6	02h_O	Page Buffer Wrap	OTP	0	1 = Wrap at 512B 0 = Wrap at 256B.
5	IO3R_O	IO3 Reset	OTP	0	1 = IO3 alternate function is RESET#. 0 = IO3 alternate function is HOLD#.
4	RFU	Reserved		0	Reserved for Future Use.
3	RFU	Reserved		0	Reserved for Future Use.
2	RFU	Reserved		0	Reserved for Future Use.
1	ES	Erase Suspend	Volatile, Read only	0	1 = In Erase Suspend mode. 0 = Not in Erase Suspend mode.
0	PS	Program Suspend	Volatile, Read only	0	1 = In Program Suspend mode. 0 = Not in Program Suspend mode.

D8h SR2[7]: This bit controls the area erased by the D8h instruction. The D8h instruction can be used to erase 64-KB or 256-KB size and aligned blocks. The option to erase 256-KB blocks in the lower density family members allows for consistent software behavior across all densities that can ease migration between different densities. When the default 64-KB erase option is in use the flash memory array has a hybrid of sixteen 4-KB sectors at the top or bottom of the array with all other sectors being 64 KB. Individual 4-KB sectors are erased by the 20h instruction. A 64-KB block of 4-KB sectors or an individual 64-KB sector can be erased by the D8h instruction. When the 256-KB option is in use, the flash memory array is treated as uniform 256-KB blocks that are individually erased by the D8h instruction.

The desired state of this bit (D8h_O) must be selected during the initial configuration of the device during system manufacture - before the first program or erase operation on the main flash array is performed. D8h_O must not be programmed after programming or erasing is done in the main flash array.

02h SR2[6]: This bit controls the page programming buffer address wrap point. Legacy SPI devices generally have used a 256-byte page programming buffer and defined that if data is loaded into the buffer beyond the 255-byte location, the address at which additional bytes are loaded would be wrapped to address 0 of the buffer. The FL-S Family provides a 512-byte page programming buffer that can increase programming performance. For legacy software compatibility, this configuration bit provides the option to continue the wrapping behavior at the 256-byte boundary or to enable full use of the available 512-byte buffer by not wrapping the load address at the 256-byte boundary.

IO3 Reset Nonvolatile SR2[5]: This bit controls the POR, hardware reset, or software reset state of the IO3 signal behavior. Most legacy SPI devices do not have a hardware reset input signal due to the limited signal count and connections available in traditional SPI device packages. The S25FL127S device provides the option to use the IO3 signal as a hardware reset input when the IO3 signal is not in use for transferring information between the host system and the memory. This OTP IO3 Reset configuration bit enables the device to start immediately (boot) with IO3 enabled for alternate use as a RESET# signal. When left in the default state, the IO3 signal has an alternate use as HOLD#.

Erase Suspend (ES) SR2[1]: The Erase Suspend bit is used to determine when the device is in Erase Suspend mode. This is a status bit that cannot be written. When Erase Suspend bit is set to '1', the device is in erase suspend mode. When Erase Suspend bit is cleared to 0, the device is not in erase suspend mode. Refer to **"Erase Suspend and Resume commands (ERSP 75h or ERRS 7Ah)"** on page 116 for details about the Erase Suspend/Resume commands.

Program Suspend (PS) SR2[0]: The Program Suspend bit is used to determine when the device is in Program Suspend mode. This is a status bit that cannot be written. When Program Suspend bit is set to '1', the device is in program suspend mode. When the Program Suspend bit is cleared to 0, the device is not in program suspend mode. Refer to **"Program Suspend (PGSP 85h) and Resume (PGRS 8Ah)"** on page 112 for details.

8.6.4 AutoBoot Register

Related Commands: AutoBoot Read (ABRD 14h) and AutoBoot Write (ABWR 15h).

The AutoBoot Register provides a means to automatically read boot code as part of the power on reset, hardware reset, or software reset process.

Table 26 AutoBoot Register

Bits	Field name	Function	Type	Default state	Description
31 to 9	ABSA	AutoBoot Start Address	Nonvolatile	000000h	512-byte boundary address for the start of boot code access
8 to 1	ABSD	AutoBoot Start Delay	Nonvolatile	00h	Number of initial delay cycles between CS# going LOW and the first bit of boot code being transferred
0	ABE	AutoBoot Enable	Nonvolatile	0	1 = AutoBoot is enabled 0 = AutoBoot is not enabled

8.6.5 Bank Address Register

Related Commands: Bank Register Access (BRAC B9h), Write Register (WRR 01h), Bank Register Read (BRRD 16h) and Bank Register Write (BRWR 17h).

The Bank Address register supplies additional high order bits of the main flash array byte boundary address for legacy commands that supply only the low order 24 bits of address. The Bank Address is used as the high bits of address (above A23) for all 3-byte address commands when EXTADD = 0. The Bank Address is not used when EXTADD = 1 and traditional 3-byte address commands are instead required to provide all four bytes of address.

Table 27 Bank Address Register (BAR)

Bits	Field name	Function	Type	Default state	Description
7	EXTADD	Extended Address Enable	Volatile	0b	1 = 4 byte (32 bits) addressing required from command. 0 = 3 byte (24 bits) addressing from command + Bank Address.
6 to 2	RFU	Reserved	Volatile	00000b	Reserved for Future Use.
1	BA25	Bank Address	Volatile	0	RFU.
0	BA24	Bank Address	Volatile	0	RFU.

Extended Address (EXTADD) BAR[7]: EXTADD controls the address field size for legacy SPI commands. By default (power up reset, hardware reset, and software reset), it is cleared to 0 for 3 bytes (24 bits) of address. When set to 1, the legacy commands will require 4 bytes (32 bits) for the address field. This is a volatile bit.

8.6.6 ECC Status Register (ECCSR)

Related Commands: ECC Read (ECCRD 18h). ECCSR does not have user programmable nonvolatile bits. All defined bits are volatile read only status. The default state of these bits are set by hardware. See **"Automatic ECC"** on page 108.

The status of ECC in each ECC unit is provided by the 8-bit ECC Status Register (ECCSR). The ECC Register Read command is written followed by an ECC unit address. The contents of the status register then indicates, for the selected ECC unit, whether there is an error in the ECC unit eight bit error correction code, the ECC unit of 16 Bytes of data, or that ECC is disabled for that ECC unit.

Table 28 ECC Status Register (ECCSR)

Bits	Field name	Function	Type	Default state	Description
7 to 3	RFU	Reserved		0	Reserved for Future Use
2	EECC	Error in ECC	Volatile, Read only	0	1 = Single Bit Error found in the ECC unit eight bit error correction code 0 = No error.
1	EECCD	Error in ECC unit data	Volatile, Read only	0	1 = Single Bit Error corrected in ECC unit data. 0 = No error.
0	ECCDI	ECC Disabled	Volatile, Read only	0	1 = ECC is disabled in the selected ECC unit. 0 = ECC is enabled in the selected ECC unit.

ECCSR[2] = 1 indicates an error was corrected in the ECC. ECCSR[1] = 1 indicates an error was corrected in the ECC unit data. ECCSR[0] = 1 indicates the ECC is disabled. The default state of "0" for all these bits indicates no failures and ECC is enabled.

ECCSR[7:3] are reserved. These have undefined high or low values that can change from one ECC status read to another. These bits should be treated as "don't care" and ignored by any software reading status.

8.6.7 ASP Register (ASPR)

Related Commands: ASP Read (ASPRD 2Bh) and ASP Program (ASPP 2Fh).

The ASP register is a 16-bit OTP memory location used to permanently configure the behavior of Advanced Sector Protection (ASP) features.

Table 29 ASP Register (ASPR)

Bits	Field Name	Function	Type	Default State	Description
15 to 9	RFU	Reserved	OTP	1	Reserved for Future Use.
8	RFU	Reserved	OTP	Note [33]	Reserved for Future Use.
7	RFU	Reserved	OTP	Note [33]	Reserved for Future Use.
6	RFU	Reserved	OTP	1	Reserved for Future Use.
5	RFU	Reserved	OTP	Note [33]	Reserved for Future Use.
4	RFU	Reserved	OTP	Note [33]	Reserved for Future Use.
3	RFU	Reserved	OTP	Note [33]	Reserved for Future Use.
2	PWDMLB	Password Protection Mode Lock Bit	OTP	1	0 = Password Protection Mode permanently enabled. 1 = Password Protection Mode not permanently enabled.
1	PSTMLB	Persistent Protection Mode Lock Bit	OTP	1	0 = Persistent Protection Mode permanently enabled. 1 = Persistent Protection Mode not permanently enabled.
0	RFU	Reserved	OTP	Note [33]	Reserved for Future Use.

Note
33.Default value depends on ordering part number, see **"Initial delivery state"** on page 167.

Reserved for Future Use (RFU) ASPR[15:3, 0].

Password Protection Mode Lock Bit (PWDMLB) ASPR[2]: When programmed to 0, the Password Protection Mode is permanently selected.

Persistent Protection Mode Lock Bit (PSTMLB) ASPR[1]: When programmed to 0, the Persistent Protection Mode is permanently selected. PWDMLB and PSTMLB are mutually exclusive, only one may be programmed to 0.

When the ASP protection mode is selected by programming either ASPR[2] or ASPR[1], certain OTP configuration bits are locked and permanently protected from further programming. The bits protected are:

- SR2[7:5]
- ASPR
- PASS

The OTP configuration must be selected before selecting the ASP protection mode.

Attempting to program the listed OTP configuration bits when ASPR[2:1] is not = 11b will result in a programming error with P_ERR (SR1[6]) set to 1.

The ASP protection mode should be selected during system configuration to ensure that a malicious program does not select an undesired protection mode at a later time. By locking all the protection configuration via the ASP mode selection, later alteration of the protection methods by malicious programs is prevented.

8.6.8 Password Register (PASS)

Related Commands: Password Read (PASSRD E7h) and Password Program (PASSP E8h).

Table 30 Password Register (PASS)

Bits	Field Name	Function	Type	Default State	Description
63 to 0	PWD	Hidden Password	OTP	FFFFFFFF–FFFFFFFFh	Nonvolatile OTP storage of 64-bit password. The password is no longer readable after the password protection mode is selected by programming ASP register bit 2 to 0.

8.6.9 PPB Lock Register (PPBL)

Related Commands: PPB Lock Read (PLBRD A7h, PLBWR A6h).

Table 31 PPB Lock Register (PPBL)

Bits	Field Name	Function	Type	Default State	Description
7 to 1	RFU	Reserved	Volatile	00h	Reserved for Future Use
0	PPBLOCK	Protect PPB Array	Volatile	Persistent Protection Mode = 1 Password Protection Mode = 0	0 = PPB array protected until next power cycle or hardware reset 1 = PPB array may be programmed or erased.

8.6.10 PPB Access Register (PPBAR)

Related Commands: PPB Read (PPBRD E2h), PPB Program (PPBP E3), PPB Erase (PPBE E4).

Table 32 PPB Access Register (PPBAR)

Bits	Field Name	Function	Type	Default State	Description
7 to 0	PPB	Read or Program per sector PPB	Nonvolatile	FFh	00h = PPB for the sector addressed by the PPBRD or PPBP command is programmed to ‘0’, protecting that sector from program or erase operations. FFh = PPB for the sector addressed by the PPBRD or PPBP command is erased to ‘1’, not protecting that sector from program or erase operations.

8.6.11 DYB Access Register (DYBAR)

Related Commands: DYB Read (DYBRD E0h) and DYB Program (DYBWR E1h).

Table 33 DYB Access Register (DYBAR)

Bits	Field Name	Function	Type	Default State	Description
7 to 0	DYB	Read or Write per sector DYB	Volatile	FFh	00h = DYB for the sector addressed by the DYBRD or DYBP command is cleared to ‘0’, protecting that sector from program or erase operations. FFh = DYB for the sector addressed by the DYBRD or DYBP command is set to ‘1’, not protecting that sector from program or erase operations.

9 Data protection

9.1 Secure silicon region (OTP)

The device has a 1024-byte one time program (OTP) address space that is separate from the main flash array. The OTP area is divided into 32, individually lockable, 32-byte aligned and length regions.

The OTP memory space is intended for increased system security. OTP values can “mate” a flash component with the system CPU/ASIC to prevent device substitution. See **“OTP address space”** on page 55, **“One Time Program Array commands”** on page 119, and **“OTP Read (OTPR 4Bh)”** on page 119.

9.1.1 Reading OTP memory space

The OTP Read command uses the same protocol as Fast Read. OTP Read operations outside the valid 1-KB OTP address range will yield indeterminate data.

9.1.2 Programming OTP memory space

The protocol of the OTP programming command is the same as Page Program. The OTP Program command can be issued multiple times to any given OTP address, but this address space can never be erased.

Automatic ECC is programmed on the first programming operation to each 16-byte region. Programming within a 16-byte region more than once disables the ECC. It is recommended to program each 16-byte portion of each 32-byte region once so that ECC remains enabled to provide the best data integrity.

The valid address range for OTP Program is depicted in **Figure 44**. OTP Program operations outside the valid OTP address range will be ignored and the WEL in SR1 will remain high (set to ‘1’). OTP Program operations while FREEZE = 1 will fail with P_ERR in SR1 set to 1.

9.1.3 Infineon programmed random number

Infineon standard practice is to program the low order 16 bytes of the OTP memory space (locations 0x0 to 0xF) with a 128-bit random number using the Linear Congruential Random Number method. The seed value for the algorithm is a random number concatenated with the day and time of tester insertion.

9.1.4 Lock bytes

The LSb of each Lock byte protects the lowest address region related to the byte, the MSb protects the highest address region related to the byte. The next higher address byte similarly protects the next higher 8 regions. The LSb bit of the lowest address Lock Byte protects the higher address 16 bytes of the lowest address region. In other words, the LSb of location 0x10 protects all the Lock Bytes and RFU bytes in the lowest address region from further programming. See **“OTP address space”** on page 55.

9.2 Write Enable command

The Write Enable (WREN) command must be written prior to any command that modifies nonvolatile data. The WREN command sets the Write Enable Latch (WEL) bit. The WEL bit is cleared to ‘0’ (disables writes) during power-up, hardware reset, or after the device completes the following commands:

- Reset
- Page Program (PP)
- Sector Erase (SE)
- Bulk Erase (BE)
- Write Disable (WRDI)
- Write Registers (WRR)
- Quad-input Page Programming (QPP)
- OTP Byte Programming (OTPP)

9.3 Block protection

The Block Protect bits (Status Register bits BP2, BP1, BP0) in combination with the Configuration Register TBPROT bit can be used to protect an address range of the main flash array from program and erase operations. The size of the range is determined by the value of the BP bits and the upper or lower starting point of the range is selected by the TBPROT bit of the Configuration Register.

Table 34 Upper array start of protection (TBPROT = 0)

Status register content			Protected fraction of memory array	Protected memory (KB)
BP2	BP1	BP0		FL127S 128 Mb
0	0	0	None	0
0	0	1	Upper 64th	256
0	1	0	Upper 32nd	512
0	1	1	Upper 16th	1024
1	0	0	Upper 8th	2048
1	0	1	Upper 4th	4096
1	1	0	Upper Half	8192
1	1	1	All Sectors	16384

Table 35 Lower array start of protection (TBPROT = 1)

Status register content			Protected fraction of memory array	Protected memory (KB)
BP2	BP1	BP0		FL127S 128 Mb
0	0	0	None	0
0	0	1	Lower 64th	256
0	1	0	Lower 32nd	512
0	1	1	Lower 16th	1024
1	0	0	Lower 8th	2048
1	0	1	Lower 4th	4096
1	1	0	Lower Half	8192
1	1	1	All Sectors	16384

When Block Protection is enabled (i.e., any BP2–0 are set to 1), advanced sector protection (ASP) can still be used to protect sectors not protected by the Block Protection scheme. In the case that both ASP and block protection are used on the same sector the logical OR of ASP and block protection related to the sector is used. Recommendation: ASP and block protection should not be used concurrently. Use one or the other, but not both.

9.3.1 Freeze bit

Bit 0 of the Configuration Register is the FREEZE bit. The FREEZE bit locks the BP2-0 bits in Status Register 1 and the TBPROT bit in the Configuration Register to their value at the time the FREEZE bit is set to 1. Once the FREEZE bit has been written to a logic 1 it cannot be cleared to a logic 0 until a power-on-reset is executed. As long as the FREEZE bit is cleared to logic 0 the status register BP bits and the TBPROT bit of the Configuration Register are writable. The FREEZE bit also protects the entire OTP memory space from programming when set to 1. Any attempt to change the BP bits with the WRR command while FREEZE = 1 is ignored and no error status is set.

9.3.2 Write Protect signal

The Write Protect (WP#) input in combination with the Status Register Write Disable (SRWD) bit provide hardware input signal controlled protection. When WP# is LOW and SRWD is set to 1 the Status and Configuration register is protected from alteration. This prevents disabling or changing the protection defined by the Block Protect bits. See **"Status Register 1 (SR1)"** on page 58.

9.4 Advanced sector protection

Advanced sector protection (ASP) is the name used for a set of independent hardware and software methods used to disable or enable programming or erase operations, individually, in any or all sectors. An overview of these methods is shown in **Figure 45**.

Block Protection and ASP protection settings for each sector are logically OR'd to define the protection for each sector, i.e. if either mechanism is protecting a sector the sector cannot be programmed or erased. Refer to **"Block protection"** on page 70 for full details of the BP2–0 bits.

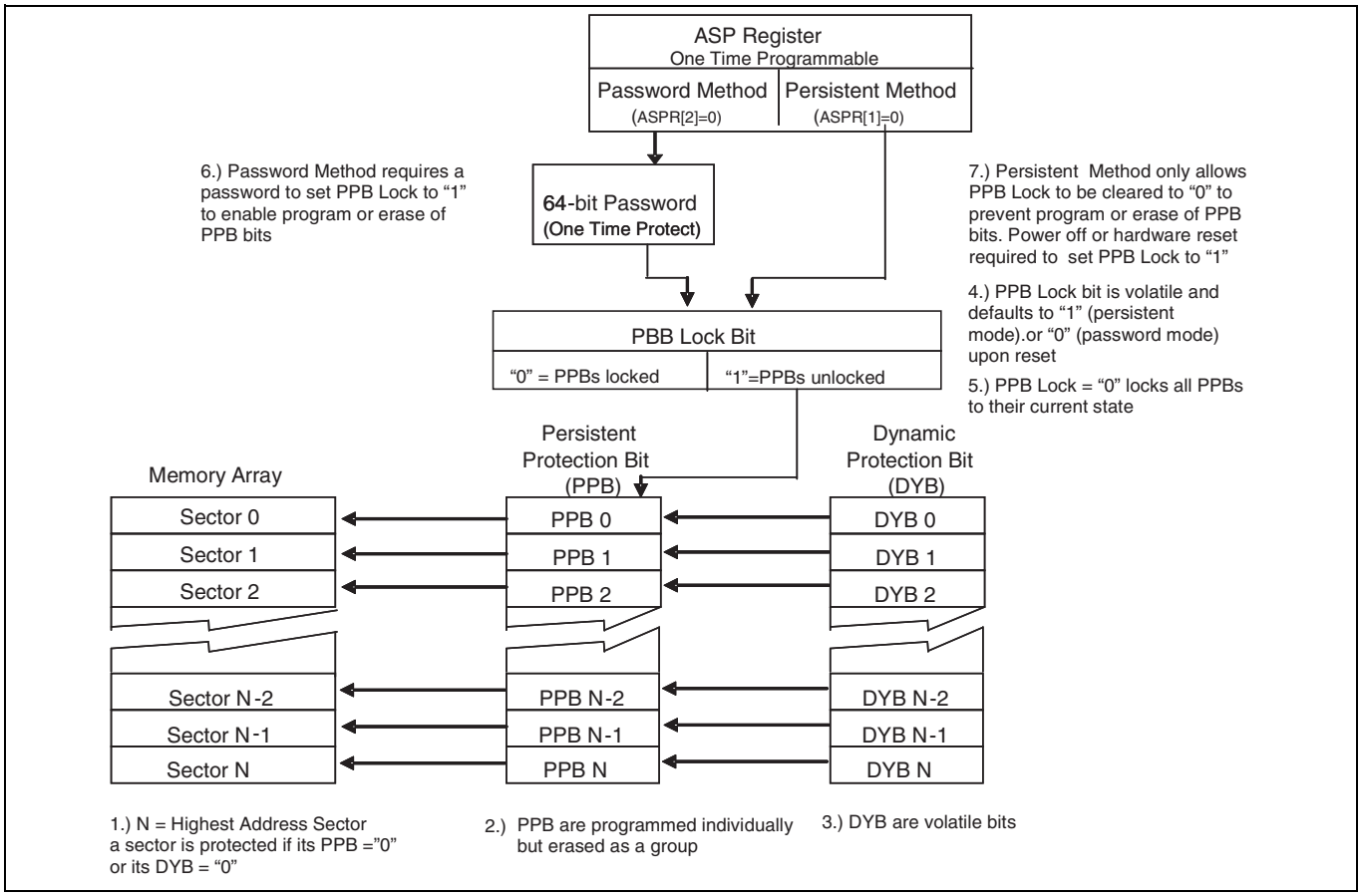


Figure 45 Advanced sector protection overview

Every main flash array sector has a nonvolatile (PPB) and a volatile (DYB) protection bit associated with it. When either bit is 0, the sector is protected from program and erase operations.

The PPB bits are protected from program and erase when the PPB Lock bit is 0. There are two methods for managing the state of the PPB Lock bit, Persistent Protection and Password Protection.

The Persistent Protection method sets the PPB Lock bit to 1 during POR, or Hardware Reset so that the PPB bits are unprotected by a device reset. There is a command to clear the PPB Lock bit to 0 to protect the PPB. There is no command in the Persistent Protection method to set the PPB Lock bit to '1', therefore the PPB Lock bit will remain at '0' until the next power-off or hardware reset. The Persistent Protection method allows boot code the option of changing sector protection by programming or erasing the PPB, then protecting the PPB from further change for the remainder of normal system operation by clearing the PPB Lock bit to '0'. This is sometimes called Boot-code controlled sector protection.

The Password method clears the PPB Lock bit to '0' during POR, or Hardware Reset to protect the PPB. A 64 bit password may be permanently programmed and hidden for the password method. A command can be used to provide a password for comparison with the hidden password. If the password matches, the PPB Lock bit is set to '1' to unprotect the PPB. A command can be used to clear the PPB Lock bit to '0'. This method requires use of a password to control PPB protection.

The selection of the PPB Lock bit management method is made by programming OTP bits in the ASP Register so as to permanently select the method used.

9.4.1 ASP Register

The ASP register is used to permanently configure the behavior of Advanced Sector Protection (ASP) features. See **Table 29**.

As shipped from the factory, all devices default ASP to the Persistent Protection mode, with all sectors unprotected, when power is applied. The device programmer or host system must then choose which sector protection method to use. Programming either of the, one-time programmable, Protection Mode Lock Bits, locks the part permanently in the selected mode:

- ASPR[2:1] = 11 = No ASP mode selected, Persistent Protection Mode is the default.
- ASPR[2:1] = 10 = Persistent Protection Mode permanently selected.
- ASPR[2:1] = 01 = Password Protection Mode permanently selected.
- ASPR[2:1] = 00 = Illegal condition, attempting to program both bits to '0' results in a programming failure.

ASP register programming rules:

- If the password mode is chosen, the password must be programmed prior to setting the Protection Mode Lock Bits.
- Once the Protection Mode is selected, the Protection Mode Lock Bits are permanently protected from programming and no further changes to the ASP register is allowed.

The programming time of the ASP Register is the same as the typical page programming time. The system can determine the status of the ASP register programming operation by reading the WIP bit in the Status Register. See **"Status Register 1 (SR1)"** on page 58 for information on WIP.

After selecting a sector protection method, each sector can operate in each of the following states:

- Dynamically Locked — A sector is protected and can be changed by a simple command.
- Persistently Locked — A sector is protected and cannot be changed if its PPB Bit is '0'.
- Unlocked — The sector is unprotected and can be changed by a simple command. The Block Protection bits may be used to lock a sector/sectors.

9.4.2 Persistent protection bits

The persistent protection bits (PPB) are located in a separate nonvolatile flash array. One of the PPB bits is related to each sector. When a PPB is '0', its related sector is protected from program and erase operations. The PPB are programmed individually but must be erased as a group, similar to the way individual words may be programmed in the main array but an entire sector must be erased at the same time. The PPB have the same program and erase endurance as the main flash memory array. Preprogramming and verification prior to erasure are handled by the device.

Programming a PPB bit requires the typical page programming time. Erasing all the PPBs requires typical sector erase time. During PPB bit programming and PPB bit erasing, status is available by reading the Status register. Reading of a PPB bit requires the initial access time of the device.

Notes

- Each PPB is individually programmed to '0' and all are erased to '1' in parallel.
- If the PPB Lock bit is '0', the PPB Program or PPB Erase command does not execute and fails without programming or erasing the PPB.
- The state of the PPB for a given sector can be verified by using the PPB Read command.

9.4.3 Dynamic protection bits

Dynamic protection bits are volatile and unique for each sector and can be individually modified. DYB only control the protection for sectors that have their PPB set to '1'. By issuing the DYB Write command, a DYB is cleared to '0' or set to '1', thus placing each sector in the protected or unprotected state respectively. This feature allows software to easily protect sectors against inadvertent changes, yet does not prevent the easy removal of protection when changes are needed. The DYBs can be set or cleared as often as needed as they are volatile bits.

9.4.4 PPB Lock Bit (PPBL[0])

The PPB Lock Bit is a volatile bit for protecting all PPB bits. When cleared to '0', it locks all PPBs and when set to '1', it allows the PPBs to be changed.

The PLBWR command is used to clear the PPB Lock bit to '0'. The PPB Lock Bit must be cleared to '0' only after all the PPBs are configured to the desired settings.

In Persistent Protection mode, the PPB Lock is set to '1' during POR or a hardware reset. When cleared to '0', no software command sequence can set the PPB Lock bit to '1', only another hardware reset or power-up can set the PPB Lock bit.

In the Password Protection mode, the PPB Lock bit is cleared to '0' during POR or a hardware reset. The PPB Lock bit can only be set to '1' by the Password Unlock command.

9.4.5 Sector protection states summary

Each sector can be in one of the following protection states:

- Unlocked — The sector is unprotected and protection can be changed by a simple command. The protection state defaults to unprotected after a power cycle, software reset, or hardware reset. The Block Protection bits may be used to protect a sector/sectors.
- Dynamically Locked — A sector is protected and protection can be changed by a simple command. The protection state is not saved across a power cycle or reset.
- Persistently Locked — A sector is protected and protection can only be changed if the PPB Lock Bit is set to 1. The protection state is nonvolatile and saved across a power cycle or reset. Changing the protection state requires programming and or erase of the PPB bits.

Table 36 Sector protection states

Protection bit values			Sector state
PPB lock	PPB	DYB	
1	1	1	Unprotected – PPB and DYB are changeable
1	1	0	Protected – PPB and DYB are changeable
1	0	1	Protected – PPB and DYB are changeable
1	0	0	Protected – PPB and DYB are changeable
0	1	1	Unprotected – PPB not changeable, DYB is changeable
0	1	0	Protected – PPB not changeable, DYB is changeable
0	0	1	Protected – PPB not changeable, DYB is changeable
0	0	0	Protected – PPB not changeable, DYB is changeable

9.4.6 Persistent Protection mode

The Persistent Protection method sets the PPB Lock bit to 1 during POR or Hardware Reset so that the PPB bits are unprotected. Software reset does not affect the PPB Lock bit. The PLBWR command can clear the PPB Lock bit to 0 to protect the PPB. There is no command to set the PPB Lock bit therefore the PPB Lock bit will remain at 0 until the next power-off or hardware reset.

9.4.7 Password Protection mode

Password Protection mode allows an even higher level of security than the Persistent Sector Protection Mode, by requiring a 64-bit password for unlocking the PPB Lock bit. In addition to this password requirement, after power up and hardware reset, the PPB Lock bit is cleared to 0 to ensure protection at power-up. Successful execution of the Password Unlock command by entering the entire password sets the PPB Lock bit to 1, allowing for sector PPB modifications.

Password protection notes:

- Once the Password is programmed and verified, the Password Mode (ASPR[2] = 0) must be set in order to prevent reading the password.
- The Password Program Command is only capable of programming “0”s. Programming a 1 after a cell is programmed as a 0 results in the cell left as a 0 with no programming error set.
- The password is all 1’s when shipped from Cypress. It is located in its own memory space and is accessible through the use of the Password Program and Password Read commands.
- All 64-bit password combinations are valid as a password.
- The Password mode, once programmed, prevents reading the 64-bit password and further password programming. All further program and read commands to the password region are disabled and these commands are ignored. There is no means to verify what the password is after the Password Mode Lock Bit is selected. Password verification is only allowed before selecting the Password Protection mode.
- The Protection mode Lock Bits are not erasable.
- The exact password must be entered in order for the unlocking function to occur. If the password unlock command provided password does not match the hidden internal password, the unlock operation fails in the same manner as a programming operation on a protected sector. The P_ERR bit is set to one, the WIP Bit remains set, and the PPB Lock bit remains cleared to ‘0’.
- The Password Unlock command cannot be accepted any faster than once every 100 µs ± 20 µs. This makes it take an unreasonably long time (58 million years) for a hacker to run through all the 64-bit combinations in an attempt to correctly match a password. The Read Status Register 1 command may be used to read the WIP bit to determine when the device has completed the password unlock command or is ready to accept a new command. When a valid password is provided the password unlock command does not insert the 100 µs delay before returning the WIP bit to 0.
- If the password is lost after selecting the Password Mode, there is no way to set the PPB Lock bit.
- ECC status may only be read from sectors that are readable. In read protection mode the addresses are forced to the boot sector address. ECC status is shown in that sector while read protection mode is active.

10 Commands

All communication between the host system and S25FL127S memory devices is in the form of units called commands.

All commands begin with an instruction that selects the type of information transfer or device operation to be performed. Commands may also have an address, instruction modifier, latency period, data transfer to the memory, or data transfer from the memory. All instruction, address, and data information is transferred serially between the host system and memory device.

All instructions are transferred from host to memory as a single bit serial sequence on the SI signal.

Single bit wide commands may provide an address or data sent only on the SI signal. Data may be sent back to the host serially on SO signal.

Dual or Quad Output commands provide an address sent to the memory only on the SI signal. Data will be returned to the host as a sequence of bit pairs on IO0 and IO1 or four bit (nibble) groups on IO0, IO1, IO2, and IO3.

Dual or Quad Input/Output (I/O) commands provide an address sent from the host as bit pairs on IO0 and IO1 or, four bit (nibble) groups on IO0, IO1, IO2, and IO3. Data is returned to the host similarly as bit pairs on IO0 and IO1 or, four bit (nibble) groups on IO0, IO1, IO2, and IO3.

Commands are structured as follows:

- Each command begins with an eight bit (byte) instruction.
- The instruction may be standalone or may be followed by address bits to select a location within one of several address spaces in the device. The address may be either a 24-bit or 32-bit address.
- The Serial Peripheral Interface with Multiple IO provides the option for each transfer of address and data information to be done one, two, or four bits in parallel. This enables a trade off between the number of signal connections (IO bus width) and the speed of information transfer. If the host system can support a two or four bit wide IO bus the memory performance can be increased by using the instructions that provide parallel two bit (dual) or parallel four bit (quad) transfers.
- The width of all transfers following the instruction are determined by the instruction sent.
- All single bits or parallel bit groups are transferred in most to least significant bit order.
- Some instructions send instruction modifier (mode) bits following the address to indicate that the next command will be of the same type with an implied, rather than an explicit, instruction. The next command thus does not provide an instruction byte, only a new address and mode bits. This reduces the time needed to send each command when the same command type is repeated in a sequence of commands.
- The address or mode bits may be followed by write data to be stored in the memory device or by a read latency period before read data is returned to the host.
- Read latency may be zero to several SCK cycles (also referred to as dummy cycles).
- All instruction, address, mode, and data information is transferred in byte granularity. Addresses are shifted into the device with the most significant byte first. All data is transferred with the lowest address byte sent first. Following bytes of data are sent in lowest to highest byte address order i.e. the byte address increments.
- All attempts to read the flash memory array during a program, erase, or a write cycle (embedded operations) are ignored. The embedded operation will continue to execute without any affect. A very limited set of commands are accepted during an embedded operation. These are discussed in the individual command descriptions. While a program, erase, or write operation is in progress, it is recommended to check that the Write-In Progress (WIP) bit is 0 before issuing most commands to the device, to ensure the new command can be accepted.
- Depending on the command, the time for execution varies. A command to read status information from an executing command is available to determine when the command completes execution and whether the command was successful.

- Although host software in some cases is used to directly control the SPI interface signals, the hardware interfaces of the host system and the memory device generally handle the details of signal relationships and timing. For this reason, signal relationships and timing are not covered in detail within this software interface focused section of the document. Instead, the focus is on the logical sequence of bits transferred in each command rather than the signal timing and relationships. Following are some general signal relationship descriptions to keep in mind. For additional information on the bit level format and signal timing relationships of commands, see **"Command protocol"** on page 17.
  - The host always controls the Chip Select (CS#), Serial Clock (SCK), and Serial Input (SI) - SI for single bit wide transfers. The memory drives Serial Output (SO) for single bit read transfers. The host and memory alternately drive the IO0-IO3 signals during Dual and Quad transfers.
  - All commands begin with the host selecting the memory by driving CS# LOW before the first rising edge of SCK. CS# is kept LOW throughout a command and when CS# is returned high the command ends. Generally, CS# remains LOW for eight bit transfer multiples to transfer byte granularity information. Some commands will not be accepted if CS# is returned high not at an 8 bit boundary.

10.1 Command set summary

10.1.1 Extended addressing

To accommodate addressing above 128 Mb, there are three options:

1. New instructions are provided with 4-byte address, used to access up to 32 Gb of memory.

Table 37 Instructions and corresponding details

Instruction name	Description	Code (Hex)
4FAST_READ	Read Fast (4-byte Address)	0C
4READ	Read (4-byte Address)	13
4DOR	Read Dual Out (4-byte Address)	3C
4QOR	Read Quad Out (4-byte Address)	6C
4DIOR	Dual I/O Read (4-byte Address)	BC
4QIOR	Quad I/O Read (4-byte Address)	EC
4PP	Page Program (4-byte Address)	12
4QPP	Quad Page Program (4-byte Address)	34
4P4E	Parameter 4-KB Erase (4-byte Address)	21
4SE	Erase 64/256 KB (4-byte Address)	DC

2. For backward compatibility to the 3-byte address instructions, the standard instructions can be used in conjunction with the EXTADD Bit in the Bank Address Register (BAR[7]). By default BAR[7] is cleared to 0 (following power up and hardware reset), to enable 3-byte (24-bit) addressing. When set to 1, the legacy commands are changed to require 4 bytes (32 bits) for the address field. The following instructions can be used in conjunction with EXTADD bit to switch from 3 bytes to 4 bytes of address field.

Table 38 Instructions and corresponding details

Instruction name	Description	Code (Hex)
READ	Read (3-byte Address)	03
FAST_READ	Read Fast (3-byte Address)	0B
DOR	Read Dual Out (3-byte Address)	3B
QOR	Read Quad Out (3-byte Address)	6B
DIOR	Dual I/O Read (3-byte Address)	BB
QIOR	Quad I/O Read (3-byte Address)	EB
PP	Page Program (3-byte Address)	02
QPP	Quad Page Program (3-byte Address)	32
P4E	Parameter 4-KB Erase (3-byte Address)	20
SE	Erase 64 / 256 KB (3-byte Address)	D8

3. For backward compatibility to the 3-byte addressing, the standard instructions can be used in conjunction with the Bank Address Register:
   a. The Bank Address Register is used to switch between 128-Mb (16-MB) banks of memory, The standard 3-byte address selects an address within the bank selected by the Bank Address Register.
      i. The host system writes the Bank Address Register to access beyond the first 128 Mb of memory.
      ii. This applies to read, erase, and program commands.
   b. The Bank Register provides the high order (4th) byte of address, which is used to address the available memory at addresses greater than 16 MB.
   c. Bank Register bits are volatile.
      i. On power up, the default is Bank0 (the lowest address 16 MB).
   d. For Read, the device will continuously transfer out data until the end of the array.
      i. There is no bank to bank delay.
      ii. The Bank Address Register is not updated.
      iii. The Bank Address Register value is used only for the initial address of an access.

Table 39 Bank address map

Bank address register bits		Bank	Memory array address range (Hex)	
Bit 1	Bit 0			
0	0	0	00000000	00FFFFFF

10.1.2 Command summary sorted by function

Table 40 S25FL127S command set (sorted by function)

Function	Command name	Command description	Instruction value (Hex)	Maximum frequency (MHz)
Read Device Identification	READ_ID (REMS)	Read Electronic Manufacturer Signature	90	108
	RDID	Read ID (JEDEC Manufacturer ID and JEDEC CFI)	9F	108
	RSFDP	Read JEDEC Serial Flash Discoverable Parameters	5A	108
	RES	Read Electronic Signature	AB	50
Register Access	RDSR1	Read Status Register 1	05	108
	RDSR2	Read Status Register 2	07	108
	RDCR	Read Configuration Register 1	35	108
	WRR	Write Register (Status-1, Configuration-1)	01	108
	WRDI	Write Disable	04	108
	WREN	Write Enable	06	108
	CLSR	Clear Status Register 1 - Erase/Prog. Fail Reset	30	108
	ECCRD	ECC Read (4-byte address)	18	108
	ABRD	AutoBoot Register Read	14	108 (QUAD=0) 108 (QUAD=1)
	ABWR	AutoBoot Register Write	15	108
	BRRD	Bank Register Read	16	108
	BRWR	Bank Register Write	17	108
	BRAC	Bank Register Access (Legacy Command formerly used for Deep Power Down)	B9	108
	DLPRD	Data Learning Pattern Read	41	108
	PNVDLR	Program NV Data Learning Register	43	108
	WVDLR	Write Volatile Data Learning Register	4A	108

Table 40 S25FL127S command set (sorted by function) (Continued)

Function	Command name	Command description	Instruction value (Hex)	Maximum frequency (MHz)
Read Flash Array	READ	Read (3- or 4-byte address)	03	50
	4READ	Read (4-byte address)	13	50
	FAST_READ	Fast Read (3- or 4-byte address)	0B	108
	4FAST_READ	Fast Read (4-byte address)	0C	108
	DOR	Read Dual Out (3- or 4-byte address)	3B	108
	4DOR	Read Dual Out (4-byte address)	3C	108
	QOR	Read Quad Out (3- or 4-byte address)	6B	108
	4QOR	Read Quad Out (4-byte address)	6C	108
	DIOR	Dual I/O Read (3- or 4-byte address)	BB	108
	4DIOR	Dual I/O Read (4-byte address)	BC	108
	QIOR	Quad I/O Read (3- or 4-byte address)	EB	108
	4QIOR	Quad I/O Read (4-byte address)	EC	108
Program Flash Array	PP	Page Program (3- or 4-byte address)	02	108
	4PP	Page Program (4-byte address)	12	108
	QPP	Quad Page Program (3- or 4-byte address)	32	80
	QPP	Quad Page Program - Alternate instruction (3- or 4-byte address)	38	80
	4QPP	Quad Page Program (4-byte address)	34	80
	PGSP	Program Suspend	85	108
	PGRS	Program Resume	8A	108
Erase Flash Array	P4E	Parameter 4-KB, sector Erase (3- or 4-byte address)	20	108
	4P4E	Parameter 4-KB, sector Erase (4-byte address)	21	108
	BE	Bulk Erase	60	108
	BE	Bulk Erase (alternate command)	C7	108
	SE	Erase 64 KB or 256 KB (3- or 4-byte address)	D8	108
	4SE	Erase 64 KB or 256 KB (4-byte address)	DC	108
	ERSP	Erase Suspend	75	108
	ERRS	Erase Resume	7A	108
One Time Program Array	OTPP	OTP Program	42	108
	OTPR	OTP Read	4B	108

Table 40 S25FL127S command set (sorted by function) (Continued)

Function	Command name	Command description	Instruction value (Hex)	Maximum frequency (MHz)
Advanced Sector Protection	DYBRD	DYB Read	E0	108
	DYBWR	DYB Write	E1	108
	PPBRD	PPB Read	E2	108
	PPBP	PPB Program	E3	108
	PPBE	PPB Erase	E4	108
	ASPRD	ASP Read	2B	108
	ASPP	ASP Program	2F	108
	PLBRD	PPB Lock Bit Read	A7	108
	PLBWR	PPB Lock Bit Write	A6	108
	PASSRD	Password Read	E7	108
	PASSP	Password Program	E8	108
	PASSU	Password Unlock	E9	108
Reset	RESET	Software Reset	F0	108
	MBR	Mode Bit Reset	FF	108

10.1.3 Read Device identification

There are multiple commands to read information about the device manufacturer, device type, and device features. SPI memories from different vendors have used different commands and formats for reading information about the memories. The FL-S Family supports the three most common device information commands.

10.1.4 Register read or write

There are multiple registers for reporting embedded operation status or controlling device configuration options. There are commands for reading or writing these registers. Registers contain both volatile and nonvolatile bits. Nonvolatile bits in registers are automatically erased and programmed as a single (write) operation.

10.1.4.1 Monitoring operation status

The host system can determine when a write, program, erase, suspend or other embedded operation is complete by monitoring the Write in Progress (WIP) bit in the Status Register. The Read from Status Register 1 command provides the state of the WIP bit. The program error (P_ERR) and erase error (E_ERR) bits in the status register indicate whether the most recent program or erase command has not completed successfully. When P_ERR or E_ERR bits are set to one, the WIP bit will remain set to 1 indicating the device remains busy and unable to receive most new operation commands. Only status read (RDSR1 05h), status clear (CLSR 30h), write disable (WRDI 04h), and software reset (RESET 0Fh) are valid commands when P_ERR or E_ERR is set to 1. A Clear Status Register (CLSR) followed by a Write Disable (WRDI) command must be sent to return the device to standby state. CLSR clears the WIP, P_ERR, and E_ERR bits. WRDI clears the WEL bit. Alternatively, hardware reset, or software reset (RESET) may be used to return the device to standby state.

10.1.4.2 Configuration

There are commands to read, write, and protect registers that control interface path width, interface timing, interface address length, and some aspects of data protection.

10.1.5 Read flash array

Data may be read from the memory starting at any byte boundary. Data bytes are sequentially read from incrementally higher byte addresses until the host ends the data transfer by driving CS# input HIGH. If the byte address reaches the maximum address of the memory array, the read will continue at address 0 of the array.

There are several different read commands to specify different access latency and data path widths.

- The Read command provides a single address bit per SCK rising edge on the SI signal with read data returning a single bit per SCK falling edge on the SO signal. This command has zero latency between the address and the returning data but is limited to a maximum SCK rate of 50 MHz.
- Other read commands have a latency period between the address and returning data but can operate at higher SCK frequencies. The latency depends on the configuration register latency code.
- The Fast Read command provides a single address bit per SCK rising edge on the SI signal with read data returning a single bit per SCK falling edge on the SO signal and may operate up to 108 MHz.
- Dual or Quad Output read commands provide address a single bit per SCK rising edge on the SI / IO0 signal with read data returning two bits, or four bits of data per SCK falling edge on the IO0–IO3 signals.
- Dual or Quad I/O Read commands provide address two bits or four bits per SCK rising edge with read data returning two bits, or four bits of data per SCK falling edge on the IO0–IO3 signals.

10.1.6 Program flash array

Programming data requires two commands: Write Enable (WREN), and Page Program (PP or QPP). The Page Program command accepts from 1 byte up to 256 or 512 consecutive bytes of data (page) to be programmed in one operation. Programming means that bits can either be left at 1, or programmed from 1 to 0. Changing bits from 0 to 1 requires an erase operation.

10.1.7 Erase flash array

The Sector Erase (SE) and Bulk Erase (BE) commands set all the bits in a sector or the entire memory array to 1. A bit needs to be first erased to 1 before programming can change it to a 0. While bits can be individually programmed from a 1 to 0, erasing bits from 0 to 1 must be done on a sector-wide (SE) or array-wide (BE) level. The Write Enable (WREN) command must precede an erase command.

10.1.8 OTP, block protection, and advanced sector protection

There are commands to read and program a separate OTP array for permanent data such as a serial number. There are commands to control a contiguous group (block) of flash memory array sectors that are protected from program and erase operations. There are commands to control which individual flash memory array sectors are protected from program and erase operations.

10.1.9 Reset

There is a command to reset to the default conditions present after power on to the device. There is a command to reset (exit from) the Enhanced Performance Read modes.

10.1.10 Reserved

Some instructions are reserved for future use. In this generation of the FL-S family, some of these command instructions may be unused and not affect device operation, some may have undefined results.

Some commands are reserved to ensure that a legacy or alternate source device command is allowed without affect. This allows legacy software to issue some commands that are not relevant for the current generation FL-S Family with the assurance these commands do not cause some unexpected action.

Some commands are reserved for use in special versions of the FL-S not addressed by this document or for a future generation. This allows new host memory controller designs to plan the flexibility to issue these command instructions. The command format is defined if known at the time this document revision is published.

10.2 Identification commands

10.2.1 Read Identification - REMS (Read_ID or REMS 90h)

The READ_ID command identifies the Device Manufacturer ID and the Device ID. The command is also referred to as Read Electronic Manufacturer and device Signature (REMS). READ-ID (REMS) is only supported for backward compatibility and should not be used for new software designs. New software designs should instead make use of the RDID command.

The command is initiated by shifting on SI the instruction code “90h” followed by a 24-bit address of 00000h. Following this, the Manufacturer ID and the Device ID are shifted out on SO starting at the falling edge of SCK after address. The Manufacturer ID and the Device ID are always shifted out with the MSb first. If the 24-bit address is set to 000001h, then the Device ID is read out first followed by the Manufacturer ID. The Manufacturer ID and Device ID output data toggles between address 000000H and 000001H until terminated by a LOW to HIGH transition on CS# input. The maximum clock frequency for the READ_ID command is 108 MHz.

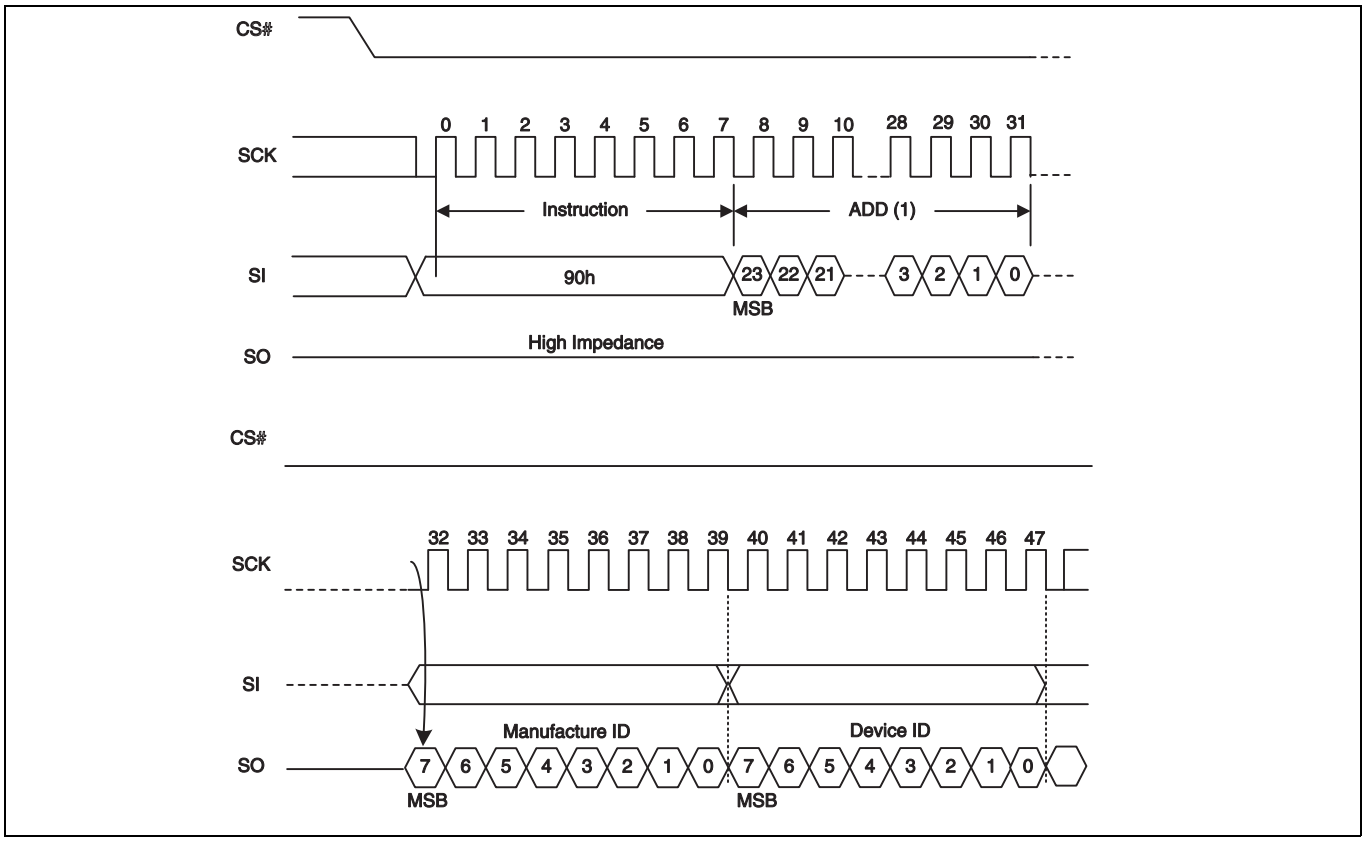


Figure 46 READ_ID command sequence

Table 41 Read_ID values

Device	Manufacturer ID (Hex)	Device ID (Hex)
S25FL127S	01	17

10.2.2 Read Identification (RDID 9Fh)

The Read Identification (RDID) command provides read access to manufacturer identification, device identification, and Common Flash Interface (CFI) information. The manufacturer identification is assigned by JEDEC. The CFI structure is defined by JEDEC standard. The device identification and CFI values are assigned by Cypress.

The JEDEC Common Flash Interface (CFI) specification defines a device information structure, which allows a vendor-specified software flash management program (driver) to be used for entire families of flash devices. Software support can then be device-independent, JEDEC manufacturer ID independent, forward and backward-compatible for the specified flash device families. System vendors can standardize their flash drivers for long-term software compatibility by using the CFI values to configure a family driver from the CFI information of the device in use.

Any RDID command issued while a program, erase, or write cycle is in progress is ignored and has no effect on execution of the program, erase, or write cycle that is in progress.

The RDID instruction is shifted on SI. After the last bit of the RDID instruction is shifted into the device, a byte of manufacturer identification, two bytes of device identification, extended device identification, and CFI information will be shifted sequentially out on SO. As a whole this information is referred to as ID-CFI. See **"ID-CFI address space"** on page 54 for the detail description of the ID-CFI contents.

Continued shifting of output beyond the end of the defined ID-CFI address space will provide undefined data. The RDID command sequence is terminated by driving CS# to the logic high state anytime during data output.

The maximum clock frequency for the RDID command is 108 MHz.

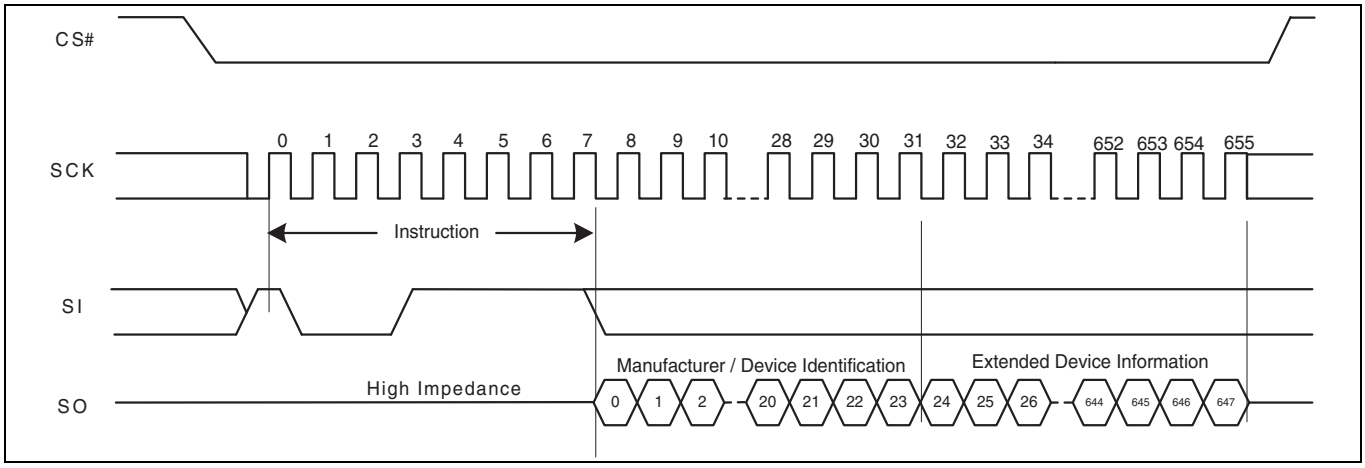


Figure 47 Read Identification (RDID) command sequence

10.2.3 Read Electronic Signature (RES) (ABh)

The RES command is used to read a single byte Electronic Signature from SO. RES is only supported for backward compatibility and should not be used for new software designs. New software designs should instead make use of the RDID command.

The RES instruction is shifted in followed by three dummy bytes onto SI. After the last bit of the three dummy bytes are shifted into the device, a byte of Electronic Signature will be shifted out of SO. Each bit is shifted out by the falling edge of SCK. The maximum clock frequency for the RES command is 50 MHz.

The Electronic Signature can be read repeatedly by applying multiples of eight clock cycles.

The RES command sequence is terminated by driving CS# to the logic high state anytime during data output.

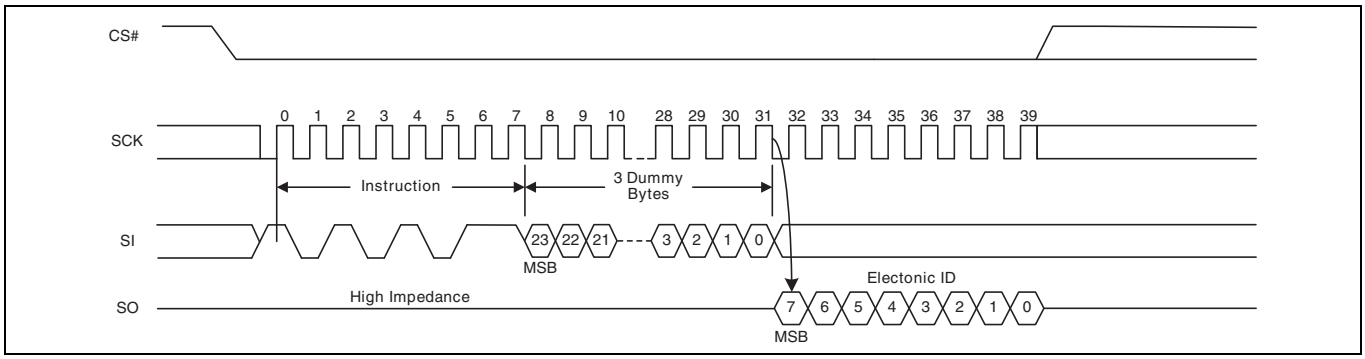


Figure 48 Read Electronic Signature (RES) command sequence

Table 42 RES values

Device	Device ID (Hex)
S25FL127S	17

10.2.4 Read Serial Flash Discoverable Parameters (RSFDP 5Ah)

The command is initiated by shifting on SI the instruction code “5Ah”, followed by a 24-bit address of 000000h, followed by eight dummy cycles. The SFDP bytes are then shifted out on SO starting at the falling edge of SCK after the eight dummy cycles. The SFDP bytes are always shifted out with the MSb first. If the 24-bit address is set to any other value, the selected location in the SFDP space is the starting point of the data read. This enables random access to any parameter in the SFDP space. The maximum clock frequency for the RSFDP command is 108 MHz.

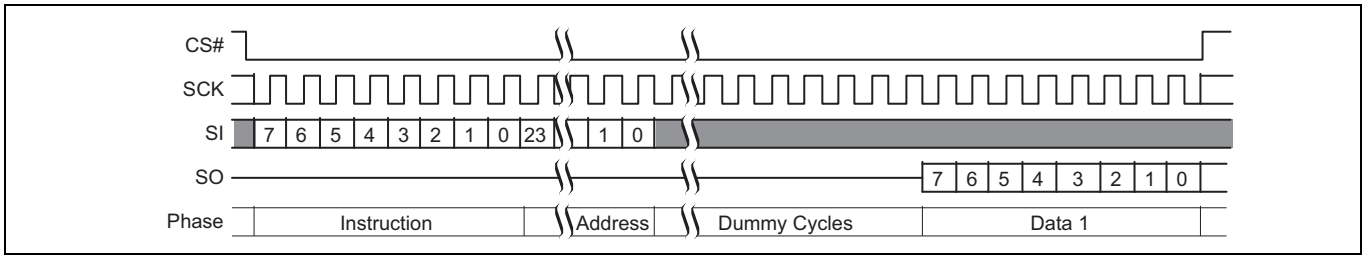


Figure 49 RSFDP command sequence

10.3 Register Access commands

10.3.1 Read Status Register 1 (RDSR1 05h)

The Read Status Register 1 (RDSR1) command allows the Status Register 1 contents to be read from SO. The Status Register 1 contents may be read at any time, even while a program, erase, or write operation is in progress. It is possible to read the Status Register 1 continuously by providing multiples of eight clock cycles. The status is updated for each eight cycle read. The maximum clock frequency for the RDSR1 (05h) command is 108 MHz.

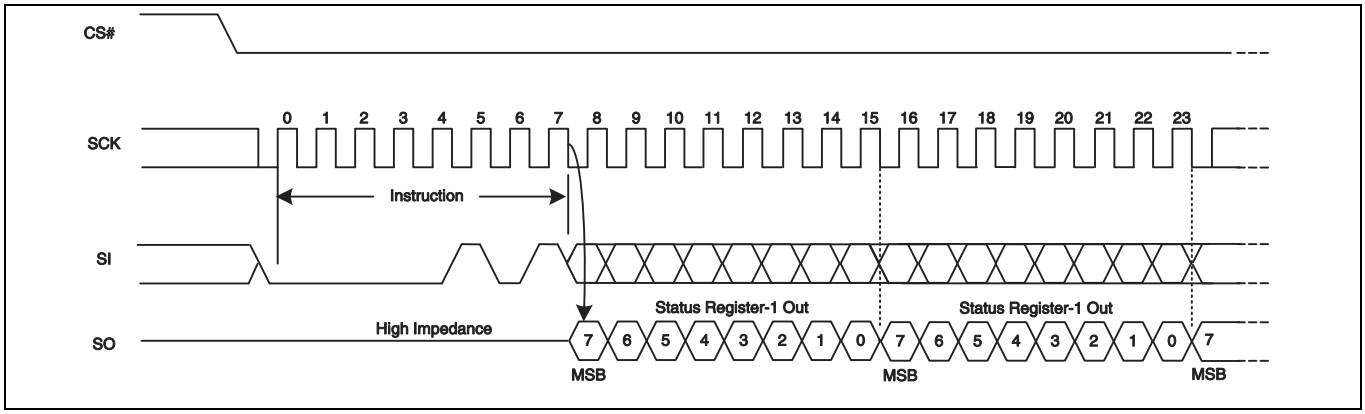


Figure 50 Read Status Register 1 (RDSR1) command sequence

10.3.2 Read Status Register 2 (RDSR2 07h)

The Read Status Register (RDSR2) command allows the Status Register 2 contents to be read from SO. The Status Register 2 contents may be read at any time, even while a program, erase, or write operation is in progress. It is possible to read the Status Register 2 continuously by providing multiples of eight clock cycles. The status is updated for each eight cycle read. The maximum clock frequency for the RDSR2 command is 108 MHz.

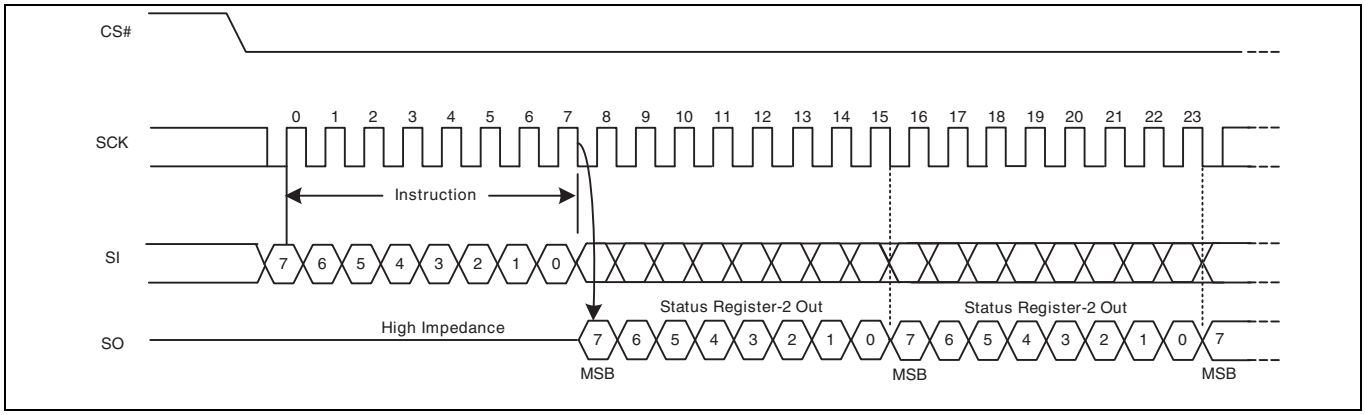


Figure 51 Read Status Register 2 (RDSR2) command

10.3.3 Read Configuration Register (RDCR 35h)

The Read Configuration Register (RDCR) command allows the Configuration Register contents to be read from SO. It is possible to read the Configuration Register continuously by providing multiples of eight clock cycles. The Configuration Register contents may be read at any time, even while a program, erase, or write operation is in progress.

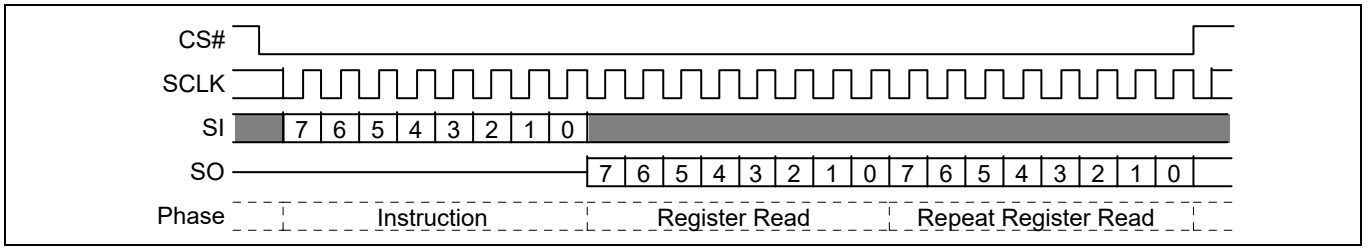


Figure 52 Read Configuration Register (RDCR) command sequence

10.3.4 Bank Register Read (BRRD 16h)

The Read the Bank Register (BRRD) command allows the Bank address Register contents to be read from SO. The instruction is first shifted in from SI. Then the 8-bit Bank Register is shifted out on SO. It is possible to read the Bank Register continuously by providing multiples of eight clock cycles. The maximum operating clock frequency for the BRRD command is 108 MHz.

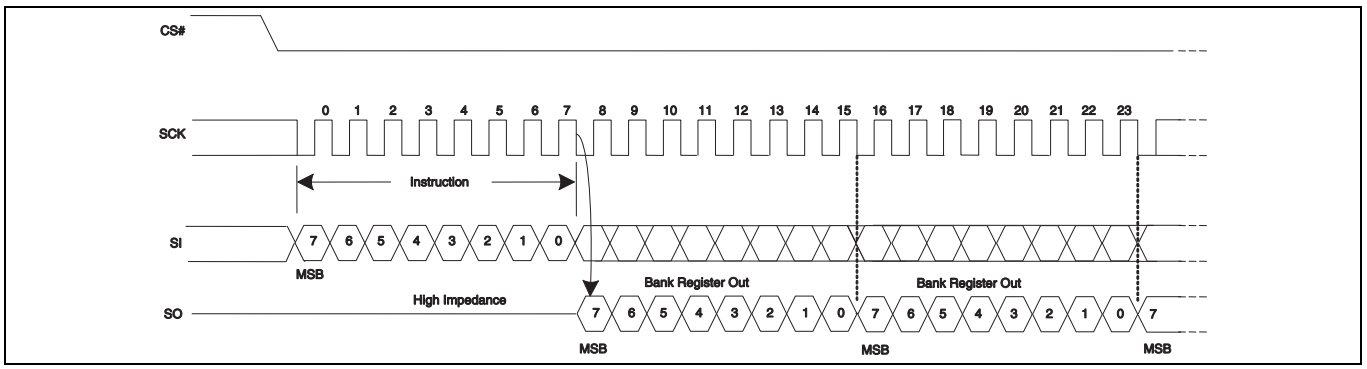


Figure 53 Read Bank Register (BRRD) command

10.3.5 Bank Register Write (BRWR 17h)

The Bank Register Write (BRWR) command is used to write address bits above A23, into the Bank Address Register (BAR). The command is also used to write the Extended address control bit (EXTADD) that is also in BAR[7]. BAR provides the high order addresses needed by devices having more than 128 Mb (16 MB), when using 3-byte address commands without extended addressing enabled (BAR[7] EXTADD = 0). Because this command is part of the addressing method and is not changing data in the flash memory, this command does not require the WREN command to precede it.

The BRWR instruction is entered, followed by the data byte on SI. The Bank Register is one data byte in length.

The BRWR command has no effect on the P_ERR, E_ERR or WIP bits of the Status and Configuration Registers. Any bank address bit reserved for the future should always be written as a 0.

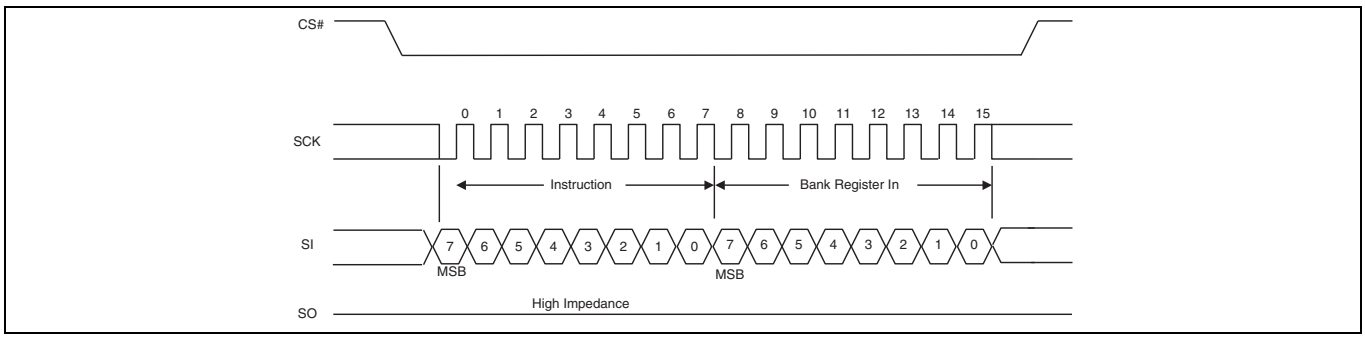


Figure 54 Bank Register Write (BRWR) command

10.3.6 Bank Register Access (BRAC B9h)

The Bank Register Read and Write commands provide full access to the Bank Address Register (BAR) but they are both commands that are not present in legacy SPI memory devices. Host system SPI memory controller interfaces may not be able to easily support such new commands. The Bank Register Access (BRAC) command uses the same command code and format as the Deep Power Down (DPD) command that is available in legacy SPI memories. The FL-S family does not support a DPD feature but assigns this legacy command code to the BRAC command to enable write access to the Bank Address Register for legacy systems that are able to send the legacy DPD (B9h) command.

When the BRAC command is sent, the FL-S family device will then interpret an immediately following Write Register (WRR) command as a write to the lower address bits of the BAR. A WREN command is not used between the BRAC and WRR commands. Only the lower two bits of the first data byte following the WRR command code are used to load BAR[1:0]. The upper bits of that byte and the content of the optional WRR command second data byte are ignored. Following the WRR command the access to BAR is closed and the device interface returns to the standby state. The combined BRAC followed by WRR command sequence has no affect on the value of the ExtAdd bit (BAR[7]).

Commands other than WRR may immediately follow BRAC and execute normally. However, any command other than WRR, or any other sequence in which CS# goes LOW and returns HIGH, following a BRAC command, will close the access to BAR and return to the normal interpretation of a WRR command as a write to Status Register 1 and the Configuration Register.

The BRAC + WRR sequence is allowed only when the device is in standby, program suspend, or erase suspend states. This command sequence is illegal when the device is performing an embedded algorithm or when the program (P_ERR) or erase (E_ERR) status bits are set to ‘1’.

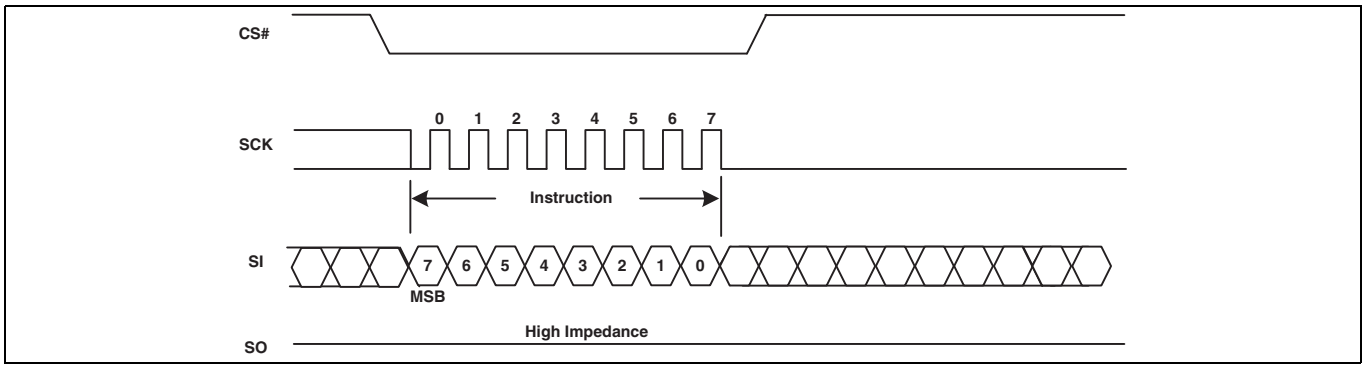


Figure 55 BRAC (B9h) command sequence

10.3.7 Write Registers (WRR 01h)

The Write Registers (WRR) command allows new values to be written to Status Register 1, Configuration Register, and Status Register 2. Before the Write Registers (WRR) command can be accepted by the device, a Write Enable (WREN) command must be received. After the Write Enable (WREN) command has been decoded successfully, the device will set the Write Enable Latch (WEL) in the Status Register to enable any write operations.

The Write Registers (WRR) command is entered by shifting the instruction and the data bytes on SI.

The Write Registers (WRR) command will set the P_ERR or E_ERR bits if there is a failure in the WRR operation. Any Status or Configuration Register bit that is:

- reserved for the future, must be written as a 0
- read only, is not affected by the value written to that bit
- OTP, may be written to '1' but, if the value is already '1', it cannot be written to '0', it will remain '1'.

CS# must be driven to the logic high state after the eighth, sixteenth, or twenty-fourth bit of data has been latched. If not, the Write Registers (WRR) command is not executed. If CS# is driven high after the eighth cycle then only the Status Register 1 is written; after the sixteenth cycle both the Status and Configuration Registers are written; after the twenty fourth cycle the Status Register 1, Configuration Register, and Status Register 2 are written. When the configuration register QUAD bit CR[1] is '1', only the WRR command formats with 16 or 24 data bits may be used.

As soon as CS# is driven to the logic high state, the self-timed Write Registers (WRR) operation is initiated. While the Write Registers (WRR) operation is in progress, the Status Register may still be read to check the value of the Write-In Progress (WIP) bit. The Write-In Progress (WIP) bit is '1' during the self-timed Write Registers (WRR) operation, and is '0' when it is completed. When only changing the value of volatile bits, the operation is completed in t_{CS} time (the WIP bit will be '0' before a status read can be completed). When changing nonvolatile bits, the WRR operation is completed in t_W time. When the Write Registers (WRR) operation is completed, the Write Enable Latch (WEL) is set to '0'. The maximum clock frequency for the WRR command is 108 MHz.

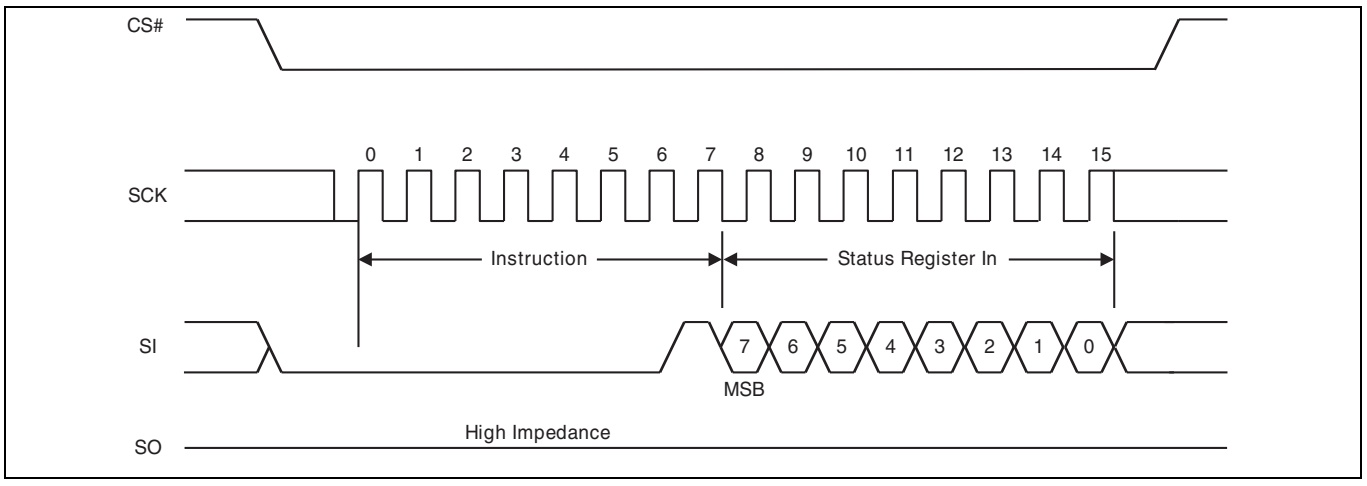


Figure 56 Write Registers (WRR) command sequence – 8 data bits

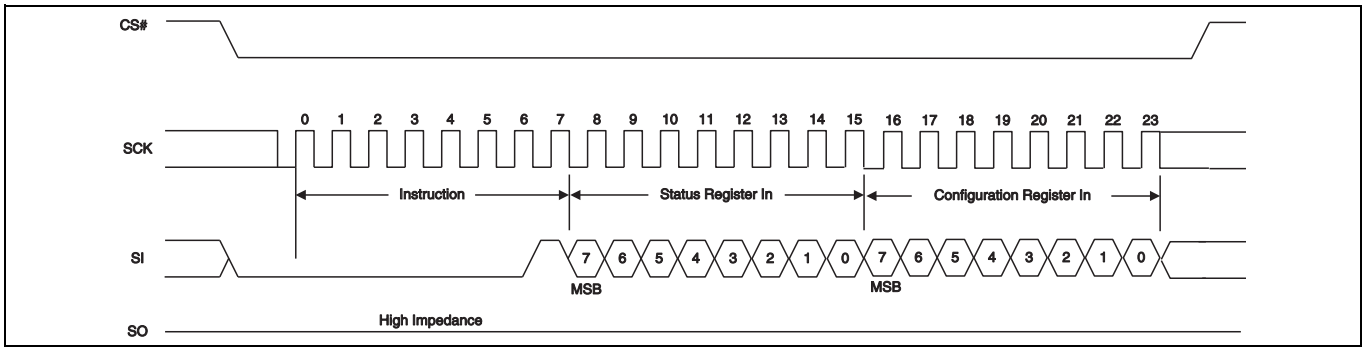


Figure 57 Write Registers (WRR) command sequence – 16 data bits

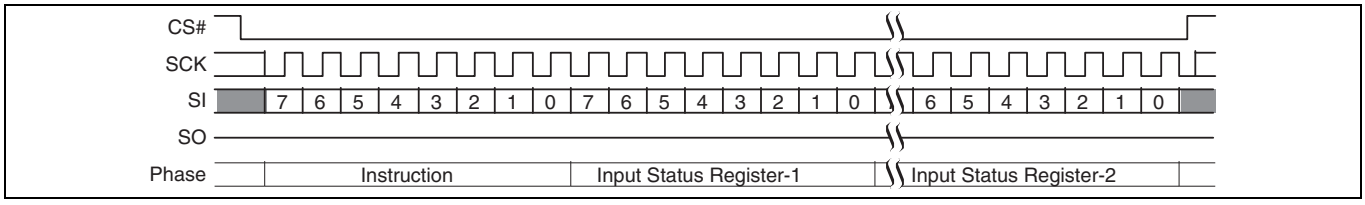


Figure 58 Write Registers (WRR 01h) command sequence – 24 data bits

The Write Registers (WRR) command allows the user to change the values of the Block Protect (BP2, BP1, and BP0) bits to define the size of the area that is to be treated as read-only. The Write Registers (WRR) command also allows the user to set the Status Register Write Disable (SRWD) bit to '1' or '0'. The Status Register Write Disable (SRWD) bit and Write Protect (WP#) signal allow the BP bits to be hardware protected.

When the Status Register Write Disable (SRWD) bit of the Status Register is '0' (its initial delivery state), it is possible to write to the Status Register provided that the Write Enable Latch (WEL) bit has previously been set by a Write Enable (WREN) command, regardless of the whether Write Protect (WP#) signal is driven to the logic HIGH or logic LOW state.

When the Status Register Write Disable (SRWD) bit of the Status Register is set to '1', two cases need to be considered, depending on the state of Write Protect (WP#):

- If Write Protect (WP#) signal is driven to the logic high state, it is possible to write to the Status and Configuration Registers provided that the Write Enable Latch (WEL) bit has previously been set to '1' by initiating a Write Enable (WREN) command.
- If Write Protect (WP#) signal is driven to the logic LOW state, it is not possible to write to the Status and Configuration Registers even if the Write Enable Latch (WEL) bit has previously been set to '1' by a Write Enable (WREN) command. Attempts to write to the Status and Configuration Registers are rejected, and are not accepted for execution. As a consequence, all the data bytes in the memory area that are protected by the Block Protect (BP2, BP1, BP0) bits of the Status Register, are also hardware protected by WP#.

The WP# hardware protection can be provided:

- by setting the Status Register Write Disable (SRWD) bit after driving Write Protect (WP#) signal to the logic LOW state;
- or by driving Write Protect (WP#) signal to the logic LOW state after setting the Status Register Write Disable (SRWD) bit to '1'.

The only way to release the hardware protection is to pull the Write Protect (WP#) signal to the logic high state. If WP# is permanently tied high, hardware protection of the BP bits can never be activated.

Table 43 Block Protection modes

WP#	SRWD bit	Mode	Write protection of registers	Memory content	
				Protected area	Unprotected area
1	1	Software Protected	Status and Configuration Registers are Writable (if WREN command has set the WEL bit). The values in the SRWD, BP2, BP1, and BP0 bits and those in the Configuration Register and Status Register 2 can be changed.	Protected against Page Program, Quad Input Program, Sector Erase, and Bulk Erase	Ready to accept Page Program, Quad Input Program and Sector Erase commands
1	0				
0	0				
0	1	Hardware Protected	Status and Configuration Registers are Hardware Write Protected. The values in the SRWD, BP2, BP1, and BP0 bits and those in the Configuration Register and Status Register 2 cannot be changed.	Protected against Page Program, Sector Erase, and Bulk Erase	Ready to accept Page Program or Erase commands

Notes
34. The Status Register originally shows 00h when the device is first shipped from Cypress to the customer.
35. Hardware protection is disabled when Quad Mode is enabled (QUAD bit = 1 in Configuration Register). WP# becomes IO2; therefore, it cannot be utilized.

The WRR command has an alternate function of loading the Bank Address Register if the command immediately follows a BRAC command. See **"Bank Register Access (BRAC B9h)"** on page 90.

10.3.8 Write Enable (WREN 06h)

The Write Enable (WREN) command sets the Write Enable Latch (WEL) bit of the Status Register 1 (SR1[1]) to a 1. The Write Enable Latch (WEL) bit must be set to a 1 by issuing the Write Enable (WREN) command to enable write, program and erase commands.

CS# must be driven into the logic high state after the eighth bit of the instruction byte has been latched in on SI. Without CS# being driven to the logic high state after the eighth bit of the instruction byte has been latched in on SI, the write enable operation will not be executed.

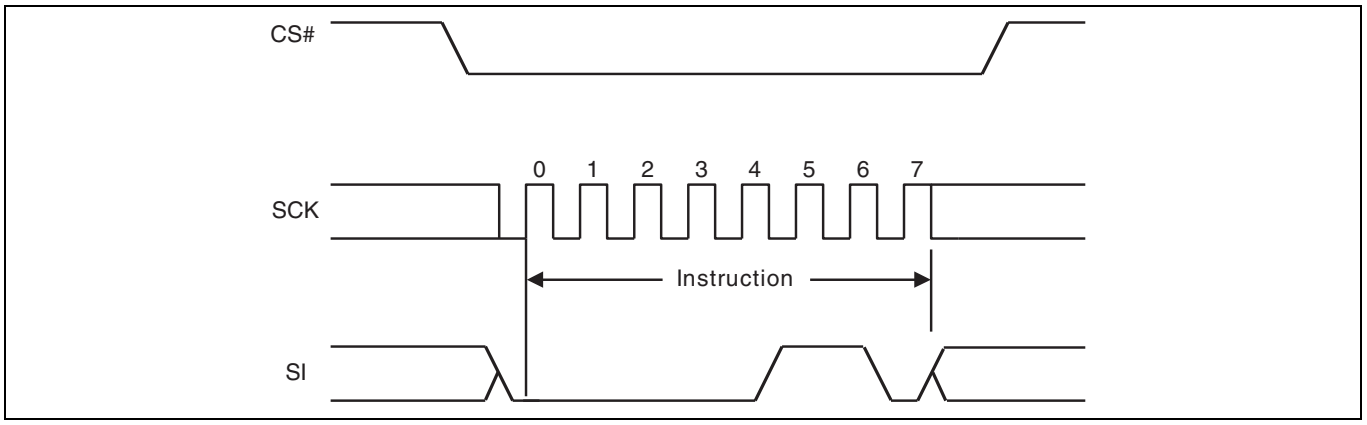


Figure 59 Write Enable (WREN) command sequence

10.3.9 Write Disable (WRDI 04h)

The Write Disable (WRDI) command sets the Write Enable Latch (WEL) bit of the Status Register 1 (SR1[1]) to a 0.

The Write Enable Latch (WEL) bit may be set to a 0 by issuing the Write Disable (WRDI) command to disable Page Program (PP), Sector Erase (SE), Bulk Erase (BE), Write Registers (WRR), OTP Program (OTPP), and other commands, that require WEL be set to 1 for execution. The WRDI command can be used by the user to protect memory areas against inadvertent writes that can possibly corrupt the contents of the memory. The WRDI command is ignored during an embedded operation while WIP bit = 1.

CS# must be driven into the logic high state after the eighth bit of the instruction byte has been latched in on SI. Without CS# being driven to the logic high state after the eighth bit of the instruction byte has been latched in on SI, the write disable operation will not be executed.

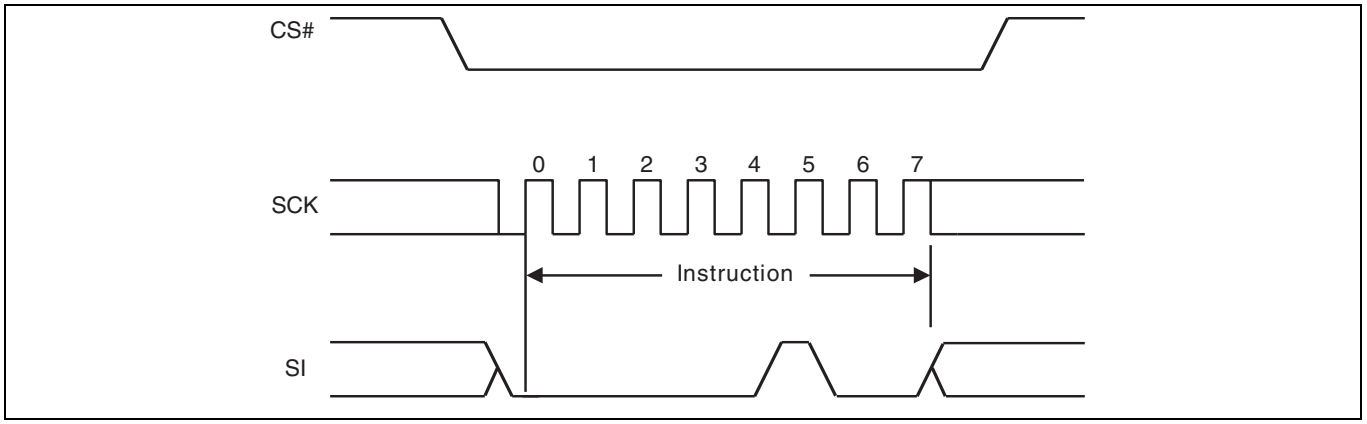


Figure 60 Write Disable (WRDI) command sequence

10.3.10 Clear Status Register (CLSR 30h)

The Clear Status Register command resets bit SR1[5] (Erase Fail Flag) and bit SR1[6] (Program Fail Flag). It is not necessary to set the WEL bit before the Clear SR command is executed. The Clear SR command will be accepted even when the device remains busy with WIP set to 1, as the device does remain busy when either error bit is set. The WEL bit will be unchanged after this command is executed.

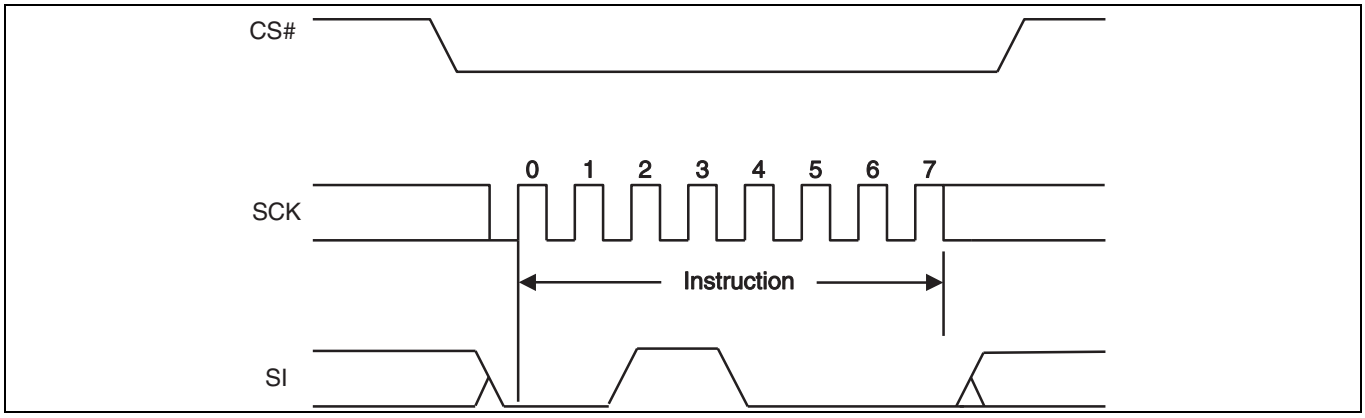


Figure 61 Clear Status Register (CLSR) command sequence

10.3.11 ECC Status Register Read (ECCRD 18h)

To read the ECC Status Register, the command is followed by the ECC unit (32 bit) address, the four least significant bits (LSb) of address must be set to zero. This is followed by eight dummy cycles. Then the 8-bit contents of the ECC Register, for the ECC unit selected, are shifted out on SO 16 times, once for each byte in the ECC Unit. If CS# remains LOW the next ECC unit status is sent through SO 16 times, once for each byte in the ECC Unit, this continues until CS# goes HIGH. The maximum operating clock frequency for the ECC READ command is 133 MHz. See **“Automatic ECC”** on page 108 for details on ECC unit.

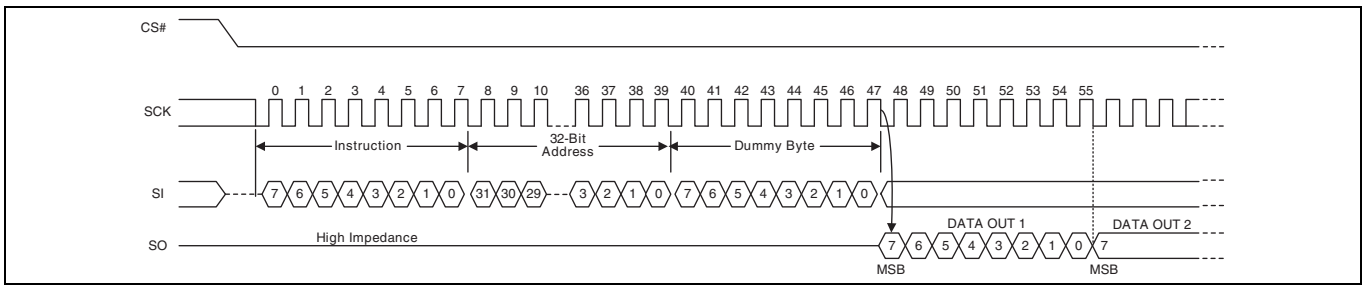


Figure 62 ECC Status Register Read command sequence

10.3.12 AutoBoot

SPI devices normally require 32 or more cycles of command and address shifting to initiate a read command. And, in order to read boot code from an SPI device, the host memory controller or processor must supply the read command from a hardwired state machine or from some host processor internal ROM code.

Parallel NOR devices need only an initial address, supplied in parallel in a single cycle, and initial access time to start reading boot code.

The AutoBoot feature allows the host memory controller to take boot code from an FL-S Family device immediately after the end of reset, without having to send a read command. This saves 32 or more cycles and simplifies the logic needed to initiate the reading of boot code.

- As part of the power up reset, hardware reset, or command reset process the AutoBoot feature automatically starts a read access from a pre-specified address. At the time the reset process is completed, the device is ready to deliver code from the starting address. The host memory controller only needs to drive CS# signal from HIGH to LOW and begin toggling the SCK signal. The FL-S Family device will delay code output for a pre-specified number of clock cycles before code streams out.
  - The Auto Boot Start Delay (ABSD) field of the AutoBoot register specifies the initial delay if any is needed by the host.
  - The host cannot send commands during this time.
  - If ABSD = 0, the maximum SCK frequency is 50 MHz.
  - If ABSD > 0, the maximum SCK frequency is 108 MHz if the QUAD bit CR1[1] is 0 or 108 MHz if the QUAD bit is set to 1.
- The starting address of the boot code is selected by the value programmed into the AutoBoot Start Address (ABSA) field of the AutoBoot Register which specifies a 512-byte boundary aligned location; the default address is 00000000h.
  - Data will continuously shift out until CS# returns HIGH.
- At any point after the first data byte is transferred, when CS# returns HIGH, the SPI device will reset to standard SPI mode; able to accept normal command operations.
  - A minimum of 1 byte must be transferred.
  - AutoBoot mode will not initiate again until another power cycle or a reset occurs.
- An AutoBoot Enable bit (ABE) is set to enable the AutoBoot feature.

The AutoBoot register bits are nonvolatile and provide:

- The starting address (512-byte boundary), set by the AutoBoot Start Address (ABSA). The size of the ABSA field is 23 bits for devices up to 32-Gbit.
- The number of initial delay cycles, set by the AutoBoot Start Delay (ABSD) 8-bit count value.
- The AutoBoot Enable.

If the configuration register QUAD bit CR1[1] is set to 1, the boot code will be provided 4 bits per cycle in the same manner as a Read Quad Out command. If the QUAD bit is 0 the code is delivered serially in the same manner as a Read command.

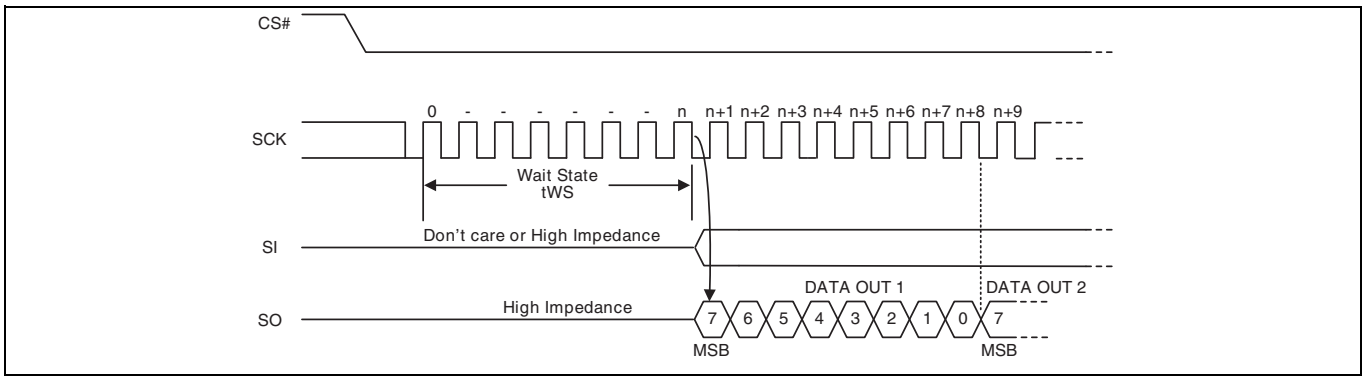


Figure 63 AutoBoot Sequence (CR1[1] = 0)

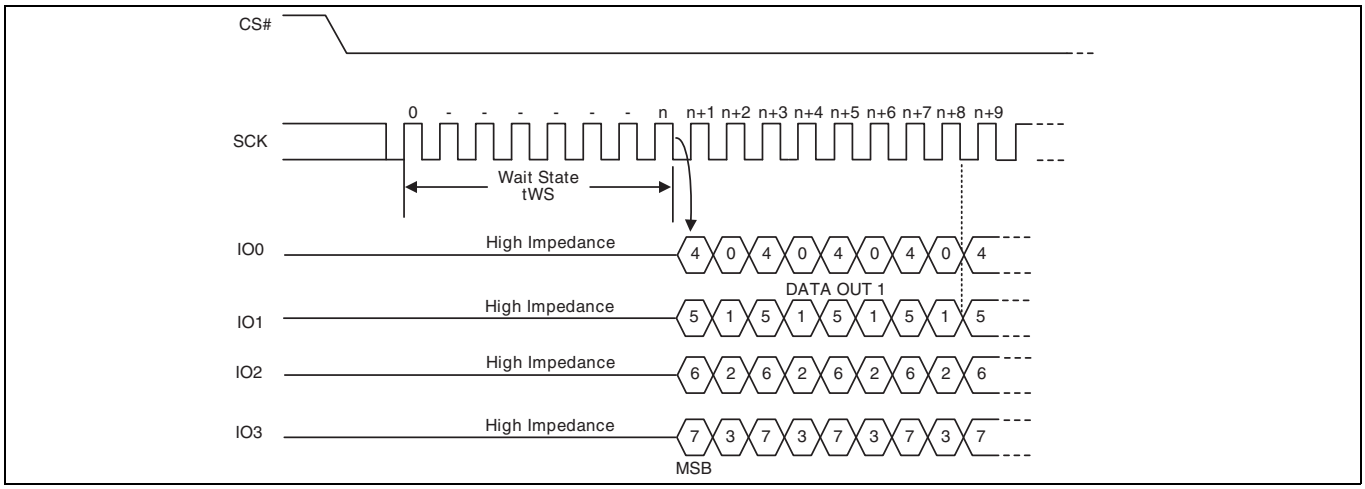


Figure 64 AutoBoot Sequence (CR1[1] = 1)

10.3.13 AutoBoot Register Read (ABRD 14h)

The AutoBoot Register Read command is shifted into SI. Then the 32-bit AutoBoot Register is shifted out on SO, least significant byte first, most significant bit of each byte first. It is possible to read the AutoBoot Register continuously by providing multiples of 32 clock cycles. If the QUAD bit CR1[1] is cleared to 0, the maximum operating clock frequency for ABRD command is 108 MHz. If the QUAD bit CR1[1] is set to 1, the maximum operating clock frequency for ABRD command is 108 MHz.

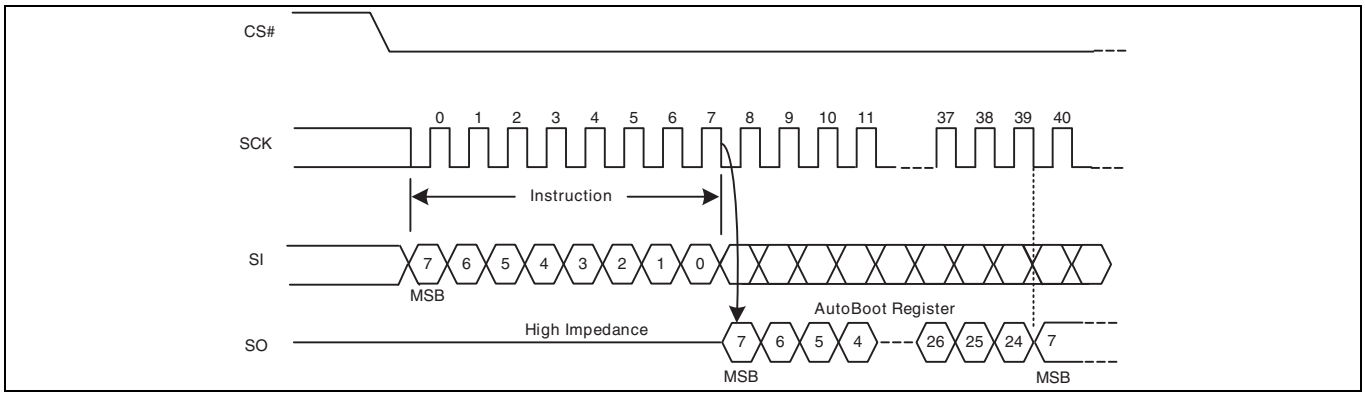


Figure 65 AutoBoot Register Read (ABRD) command

10.3.14 AutoBoot Register Write (ABWR 15h)

Before the ABWR command can be accepted, a Write Enable (WREN) command must be issued and decoded by the device, which sets the Write Enable Latch (WEL) in the Status Register to enable any write operations.

The ABWR command is entered by shifting the instruction and the data bytes on SI, least significant byte first, most significant bit of each byte first. The ABWR data is 32 bits in length.

The ABWR command has status reported in Status Register 1 as both an erase and a programming operation. An E_ERR or a P_ERR may be set depending on whether the erase or programming phase of updating the register fails.

CS# must be driven to the logic high state after the 32nd bit of data has been latched. If not, the ABWR command is not executed. As soon as CS# is driven to the logic high state, the self-timed ABWR operation is initiated. While the ABWR operation is in progress, Status Register 1 may be read to check the value of the Write-In Progress (WIP) bit. The Write-In Progress (WIP) bit is a 1 during the self-timed ABWR operation, and is a 0 when it is completed. When the ABWR cycle is completed, the Write Enable Latch (WEL) is set to a 0. The maximum clock frequency for the ABWR command is 108 MHz.

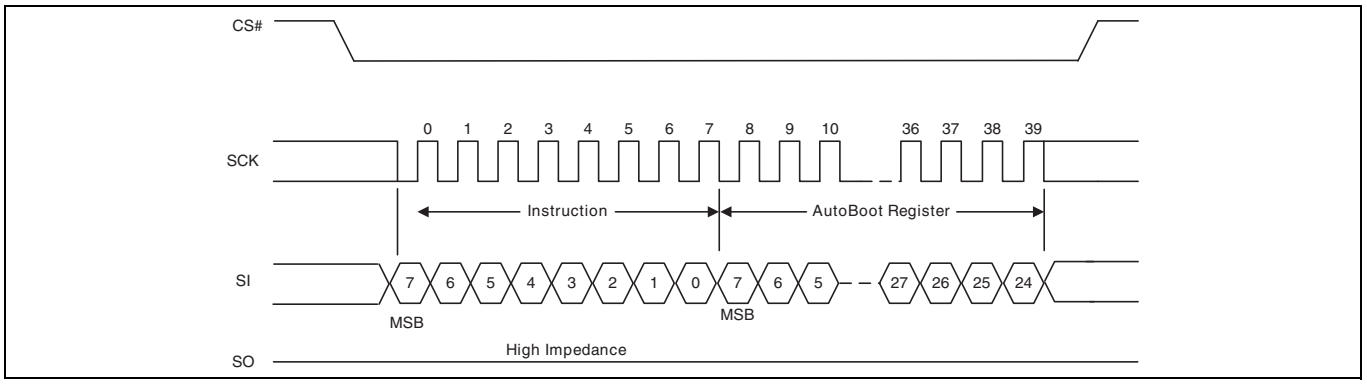


Figure 66 AutoBoot Register Write (ABWR) command

10.4 Read memory array commands

Read commands for the main flash array provide many options for prior generation SPI compatibility or enhanced performance SPI:

- Some commands transfer address one bit per rising edge of SCK and return data 1, 2, or 4 bits of data per rising edge of SCK. These are called Read or Fast Read for 1 bit data; Dual Output Read for 2 bit data, and Quad Output for 4 bit data.
- Some commands transfer both address and data 2 or 4 bits per rising edge of SCK. These are called Dual I/O for 2 bit and Quad I/O for 4 bit.

All of these commands begin with an instruction code that is transferred one bit per SCK rising edge. The instruction is followed by either a 3- or 4-byte address. Commands transferring address or data 2 or 4 bits per clock edge are called Multiple I/O (MIO) commands. For FL-S Family devices at 256 Mb or higher density, the traditional SPI 3-byte addresses are unable to directly address all locations in the memory array. These device have a bank address register that is used with 3-byte address commands to supply the high order address bits beyond the address from the host system. The default bank address is 0. Commands are provided to load and read the bank address register. These devices may also be configured to take a 4-byte address from the host system with the traditional 3-byte address commands. The 4-byte address mode for traditional commands is activated by setting the External Address (EXTADD) bit in the bank address register to 1. In the FL127S, higher order address bits above A23 in the 4-byte address commands, commands using Extended Address mode, and the Bank Address Register are not relevant and are ignored because the flash array is only 128 Mb in size.

The Quad I/O commands provide a performance improvement option controlled by mode bits that are sent following the address bits. The mode bits indicate whether the command following the end of the current read will be another read of the same type, without an instruction at the beginning of the read. These mode bits give the option to eliminate the instruction cycles when doing a series of Quad I/O read accesses.

Some commands require delay cycles following the address or mode bits to allow time to access the memory array. The delay cycles are traditionally called dummy cycles. The dummy cycles are ignored by the memory thus any data provided by the host during these cycles is “don’t care” and the host may also leave the SI signal at high impedance during the dummy cycles. When MIO commands are used the host must stop driving the IO signals (outputs are high impedance) before the end of last dummy cycle. The number of dummy cycles varies with the SCK frequency or performance option selected via the Configuration Register 1 (CR1) Latency Code (LC). Dummy cycles are measured from SCK falling edge to next SCK falling edge. SPI outputs are traditionally driven to a new value on the falling edge of each SCK. Zero dummy cycles means the returning data is driven by the memory on the same falling edge of SCK that the host stops driving address or mode bits.

Each read command ends when CS# is returned HIGH at any point during data return. CS# must not be returned HIGH during the mode or dummy cycles before data returns as this may cause mode bits to be captured incorrectly; making it indeterminate as to whether the device remains in enhanced high performance read mode.

10.4.1 Read (Read 03h or 4READ 13h)

The instruction

- 03h (ExtAdd=0) is followed by a 3-byte address (A23–A0) or
- 03h (ExtAdd=1) is followed by a 4-byte address (A31–A0) or
- 13h is followed by a 4-byte address (A31–A0)

Then the memory contents, at the address given, are shifted out on SO. The maximum operating clock frequency for the READ command is 50 MHz.

The address can start at any byte location of the memory array. The address is automatically incremented to the next higher address in sequential order after each byte of data is shifted out. The entire memory can therefore be read out with one single read instruction and address 000000h provided. When the highest address is reached, the address counter will wrap around and roll back to 000000h, allowing the read sequence to be continued indefinitely.

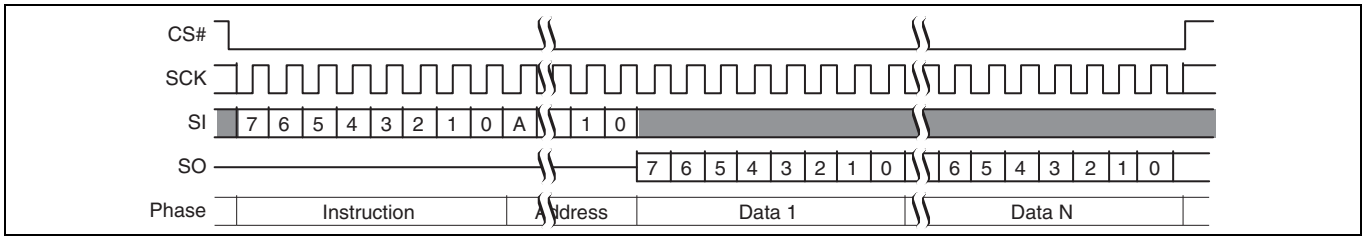


Figure 67 Read command sequence (READ 03h or 13h)[36]

Note
36.A = MSb of address = 23 for ExtAdd = 0, or 31 for ExtAdd = 1 or command 13h.

10.4.2 Fast Read (FAST_READ 0Bh or 4FAST_READ 0Ch)

The instruction

- 0Bh (ExtAdd = 0) is followed by a 3-byte address (A23–A0) or
- 0Bh (ExtAdd = 1) is followed by a 4-byte address (A31–A0) or
- 0Ch is followed by a 4-byte address (A31–A0)

The address is followed by zero or eight dummy cycles depending on the latency code set in the Configuration Register. The dummy cycles allow the device internal circuits additional time for accessing the initial address location. During the dummy cycles the data value on SO is “don’t care” and may be high impedance. Then the memory contents, at the address given, are shifted out on SO.

The maximum operating clock frequency for FAST READ command is 108 MHz.

The address can start at any byte location of the memory array. The address is automatically incremented to the next higher address in sequential order after each byte of data is shifted out. The entire memory can therefore be read out with one single read instruction and address 000000h provided. When the highest address is reached, the address counter will wrap around and roll back to 000000h, allowing the read sequence to be continued indefinitely.

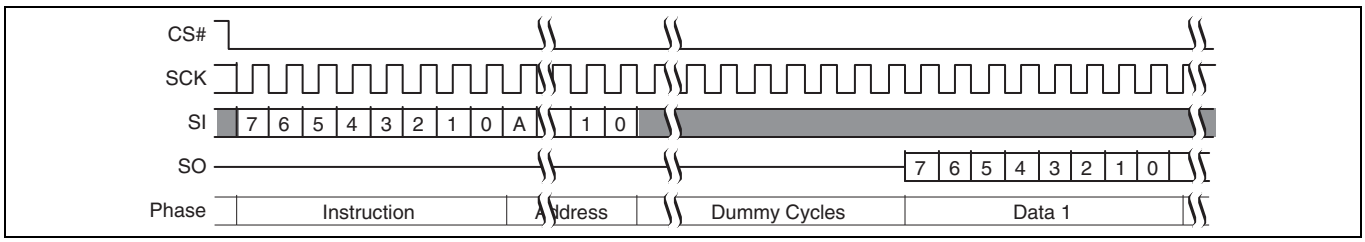


Figure 68 Fast Read (FAST_READ 0Bh or 0Ch) command sequence with read latency

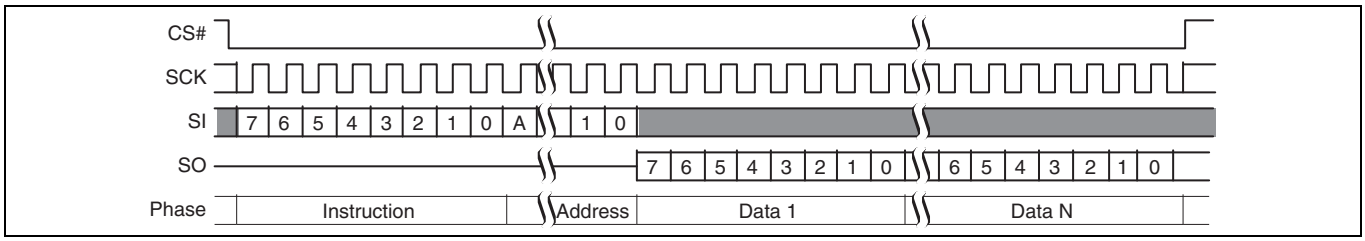


Figure 69 Fast Read Command (FAST_READ 0Bh or 0Ch) sequence without read latency

10.4.3 Dual Output Read (DOR 3Bh or 4DOR 3Ch)

The instruction

- 3Bh (ExtAdd = 0) is followed by a 3-byte address (A23–A0) or
- 3Bh (ExtAdd = 1) is followed by a 4-byte address (A31–A0) or
- 3Ch is followed by a 4-byte address (A31–A0)

Then the memory contents, at the address given, is shifted out two bits at a time through IO0 (SI) and IO1 (SO). Two bits are shifted out at the SCK frequency by the falling edge of the SCK signal.

The maximum operating clock frequency for the Dual Output Read command is 108 MHz. For Dual Output Read commands, there are zero or eight dummy cycles required after the last address bit is shifted into SI before data begins shifting out of IO0 and IO1. This latency period (i.e., dummy cycles) allows the device's internal circuitry enough time to read from the initial address. During the dummy cycles, the data value on SI is a "don't care" and may be high impedance. The number of dummy cycles is determined by the frequency of SCK (refer to **Table 24**).

The address can start at any byte location of the memory array. The address is automatically incremented to the next higher address in sequential order after each byte of data is shifted out. The entire memory can therefore be read out with one single read instruction and address 000000h provided. When the highest address is reached, the address counter will wrap around and roll back to 000000h, allowing the read sequence to be continued indefinitely.

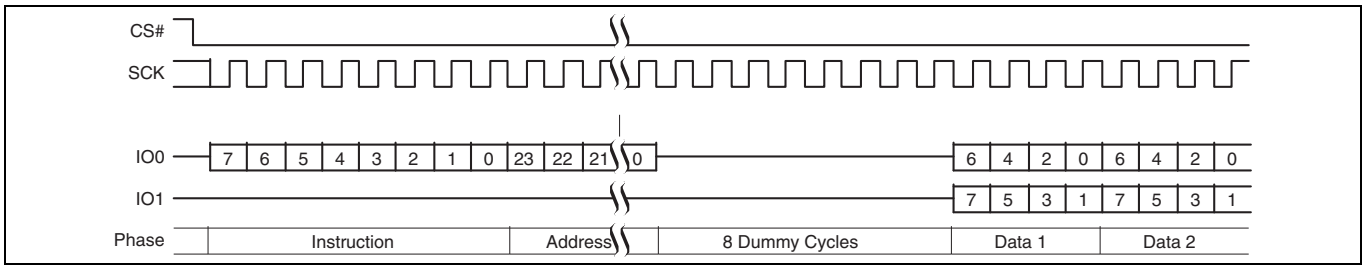


Figure 70 Dual Output Read command sequence (3-byte address, 3Bh [ExtAdd = 0], LC = 10b)

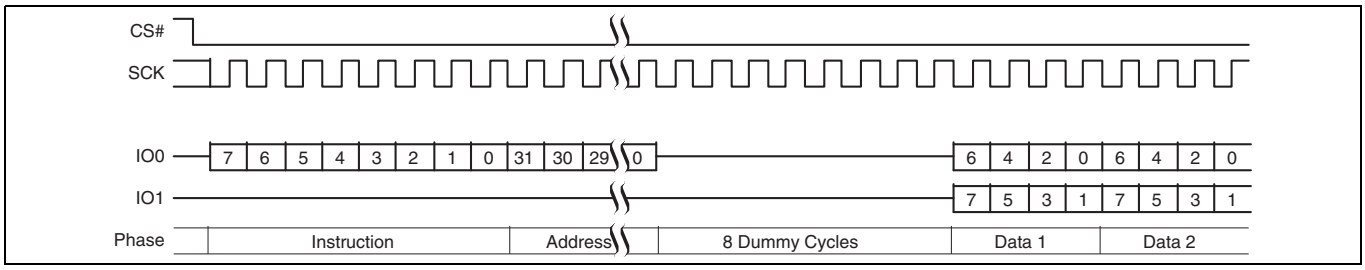


Figure 71 Dual Output Read command sequence (4-byte address, 3Ch or 3Bh [ExtAdd = 1, LC = 10b])

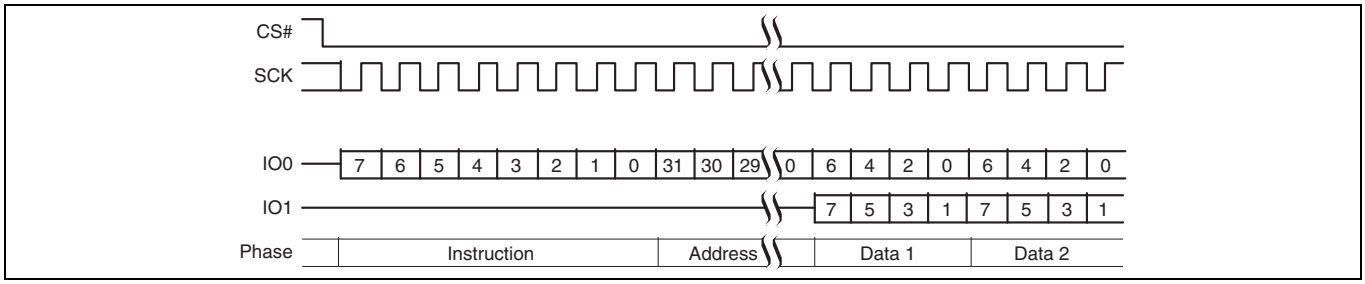


Figure 72 Dual Output Read command sequence (4-byte address, 3Ch or 3Bh [ExtAdd = 1, LC = 11b])

10.4.4 Quad Output Read (QOR 6Bh or 4QOR 6Ch)

The instruction

- 6Bh (ExtAdd = 0) is followed by a 3-byte address (A23–A0) or
- 6Bh (ExtAdd = 1) is followed by a 4-byte address (A31–A0) or
- 6Ch is followed by a 4-byte address (A31–A0)

Then the memory contents, at the address given, is shifted out four bits at a time through IO0–IO3. Each nibble (4 bits) is shifted out at the SCK frequency by the falling edge of the SCK signal.

The maximum operating clock frequency for Quad Output Read command is 108 MHz. For Quad Output Read Mode, there may be dummy cycles required after the last address bit is shifted into SI before data begins shifting out of IO0–IO3. This latency period (i.e., dummy cycles) allows the device's internal circuitry enough time to set up for the initial address. During the dummy cycles, the data value on IO0–IO3 is a "don't care" and may be high impedance. The number of dummy cycles is determined by the frequency of SCK (refer to **Table 24**).

The address can start at any byte location of the memory array. The address is automatically incremented to the next higher address in sequential order after each byte of data is shifted out. The entire memory can therefore be read out with one single read instruction and address 000000h provided. When the highest address is reached, the address counter will wrap around and roll back to 000000h, allowing the read sequence to be continued indefinitely.

The QUAD bit of Configuration Register must be set (CR Bit1 = 1) to enable the Quad mode capability.

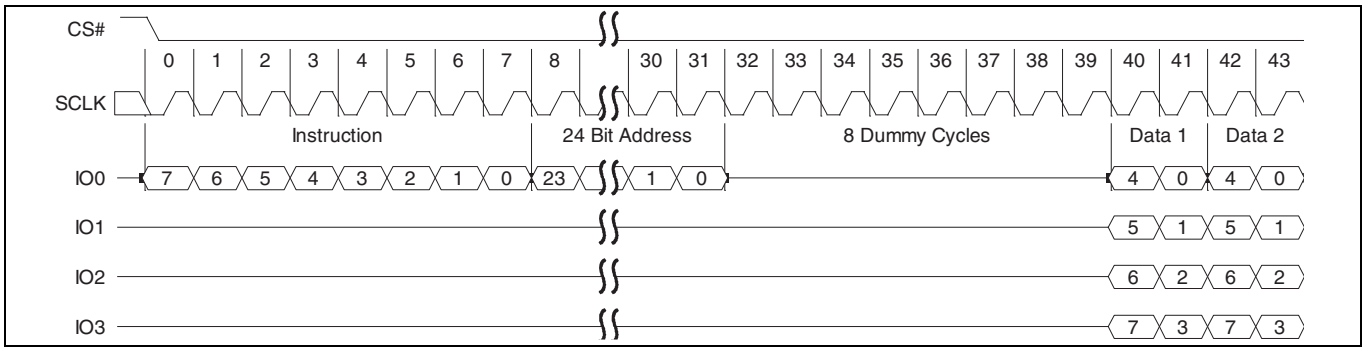


Figure 73 Quad Output Read (QOR 6Bh or 4QOR 6Ch) command sequence with read latency[37, 38]

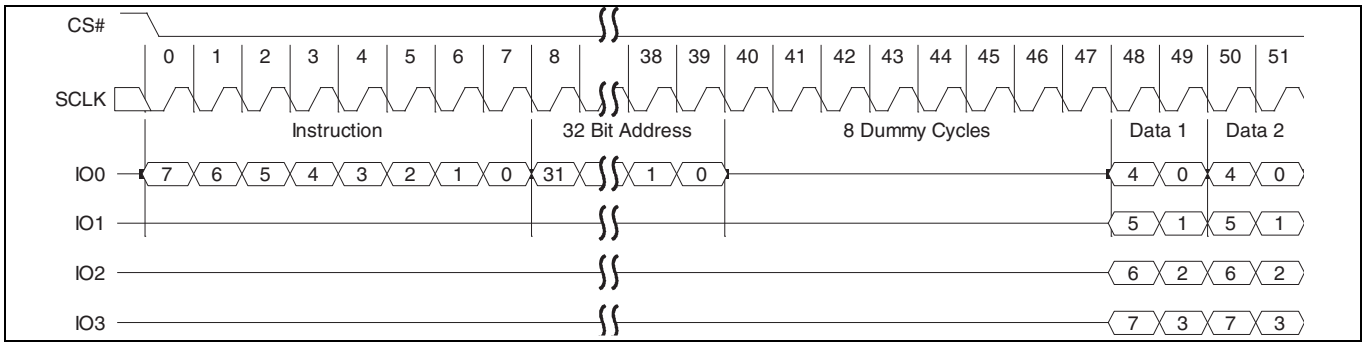


Figure 74 Quad Output Read (QOR 6Bh or 4QOR 6Ch) command sequence without read latency[37, 39]

Notes
37.A = MSb of address = A23 for ExtAdd = 0, or A31 for ExtAdd = 1 or command 6Ch.
38.LC = 01b shown.
39.LC = 11b shown.

10.4.5 Dual I/O Read (DIOR BBh or 4DIOR BCh)

The instruction

- BBh (ExtAdd = 0) is followed by a 3-byte address (A23–A0) or
- BBh (ExtAdd = 1) is followed by a 4-byte address (A31–A0) or
- BCh is followed by a 4-byte address (A31–A0)

The Dual I/O Read commands improve throughput with two I/O signals — IO0 (SI) and IO1 (SO). It is similar to the Dual Output Read command but takes input of the address two bits per SCK rising edge. In some applications, the reduced address input time might allow for code execution in place (XIP) i.e. directly from the memory device.

The maximum operating clock frequency for Dual I/O Read is 108 MHz.

For the Dual I/O Read command, there is a latency required after the last address bits are shifted into SI and SO before data begins shifting out of IO0 and IO1.

This latency period (dummy cycles) allows the device internal circuitry enough time to access data at the initial address. During the dummy cycles, the data value on SI and SO are “don’t care” and may be high impedance. The number of dummy cycles is determined by the frequency of SCK (**Table 24**). The number of dummy cycles is set by the LC bits in the Configuration Register (CR1).

The Latency Code table provides cycles for mode bits so a series of Dual I/O Read commands may eliminate the 8-bit instruction after the first Dual I/O Read command sends a mode bit pattern of Axh that indicates the following command will also be a Dual I/O Read command. The first Dual I/O Read command in a series starts with the 8-bit instruction, followed by address, followed by four cycles of mode bits, followed by a latency period. If the mode bit pattern is Axh the next command is assumed to be an additional Dual I/O Read command that does not provide instruction bits. That command starts with address, followed by mode bits, followed by latency.

The enhanced high performance feature removes the need for the instruction sequence and greatly improves code execution (XIP). The upper nibble (bits 7-4) of the Mode bits control the length of the next Dual I/O Read command through the inclusion or exclusion of the first byte instruction code. The lower nibble (bits 3-0) of the Mode bits are “don’t care” (“x”) and may be high impedance. If the Mode bits equal Axh, then the device remains in Dual I/O enhanced high performance Read Mode and the next address can be entered (after CS# is raised HIGH and then asserted LOW) without the BBh or BCh instruction, as shown in **Figure 77**; thus, eliminating eight cycles for the command sequence. The following sequences will release the device from Dual I/O enhanced high performance Read mode; after which, the device can accept standard SPI commands:

1. During the Dual I/O enhanced high performance Command Sequence, if the Mode bits are any value other than Axh, then the next time CS# is raised high the device will be released from Dual I/O Read enhanced high performance Read mode.
2. During any operation, if CS# toggles HIGH to LOW to HIGH for eight cycles (or less) and data input (IO0 and IO1) are not set for a valid instruction sequence, then the device will be released from Dual I/O enhanced high performance Read mode. Note that the four mode bit cycles are part of the device’s internal circuitry latency time to access the initial address after the last address cycle that is clocked into IO0 (SI) and IO1 (SO).

It is important that the I/O signals be set to high-impedance at or before the falling edge of the first data out clock. At higher clock speeds the time available to turn off the host outputs before the memory device begins to drive (bus turn around) is diminished. It is allowed and may be helpful in preventing I/O signal contention, for the host system to turn off the I/O signal outputs (make them high impedance) during the last two “don’t care” mode cycles or during any dummy cycles.

Following the latency period the memory content, at the address given, is shifted out two bits at a time through IO0 (SI) and IO1 (SO). Two bits are shifted out at the SCK frequency at the falling edge of SCK signal.

The address can start at any byte location of the memory array. The address is automatically incremented to the next higher address in sequential order after each byte of data is shifted out. The entire memory can therefore be read out with one single read instruction and address 000000h provided. When the highest address is reached, the address counter will wrap around and roll back to 000000h, allowing the read sequence to be continued indefinitely.

CS# should not be driven HIGH during mode or dummy bits as this may make the mode bits indeterminate.

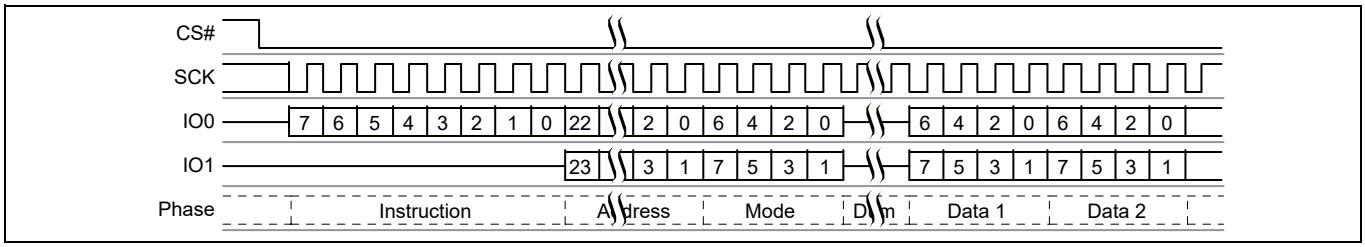


Figure 75 Dual I/O Read command sequence (3-byte address, BBh [ExtAdd = 0])

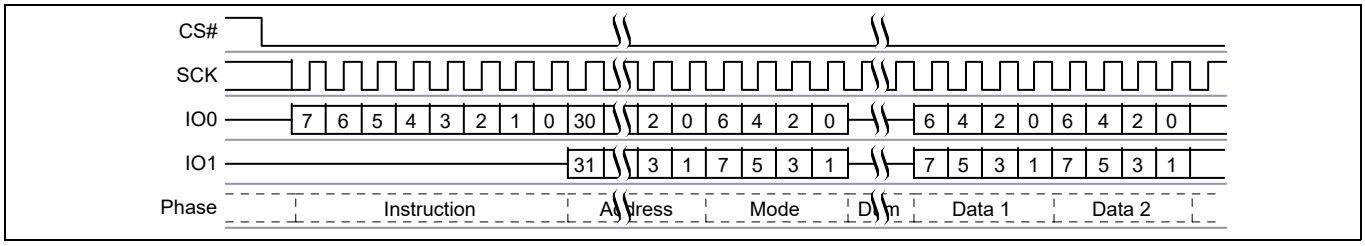


Figure 76 Dual I/O Read command sequence (4-byte address, BCh or BBh [ExtAdd = 1])[40]

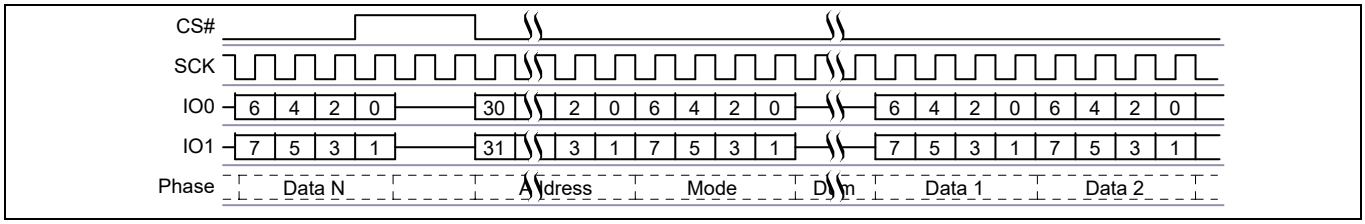


Figure 77 Continuous Dual I/O Read command sequence (4-byte address, BCh or BBh [ExtAdd = 1])[40]

Note

40. Least significant 4 bits of Mode are don't care and it is optional for the host to drive these bits. The host may turn off drive during these cycles to increase bus turn around time between Mode bits from host and returning data from the memory.

10.4.6 Quad I/O Read (QIOR EBh or 4QIOR ECh)

The instruction

- EBh (ExtAdd = 0) is followed by a 3-byte address (A23–A0) or
- EBh (ExtAdd = 1) is followed by a 4-byte address (A31–A0) or
- ECh is followed by a 4-byte address (A31–A0)

The Quad I/O Read command improves throughput with four I/O signals — IO0–IO3. It is similar to the Quad Output Read command but allows input of the address bits four bits per serial SCK clock. In some applications, the reduced instruction overhead might allow for code execution (XIP) directly from FL-S Family devices. The QUAD bit of the Configuration Register must be set (CR Bit1=1) to enable the Quad capability of FL-S Family devices.

The maximum operating clock frequency for Quad I/O Read is 108 MHz.

For the Quad I/O Read command, there is a latency required after the mode bits (described below) before data begins shifting out of IO0–IO3. This latency period (i.e., dummy cycles) allows the device's internal circuitry enough time to access data at the initial address. During latency cycles, the data value on IO0–IO3 are "don't care" and may be high impedance. The number of dummy cycles is determined by the frequency of SCK and the latency code table (refer to **Table 24**). The number of dummy cycles is set by the LC bits in the Configuration Register (CR1). However, both latency code tables use the same latency values for the Quad I/O Read command.

Following the latency period, the memory contents at the address given, is shifted out four bits at a time through IO0–IO3. Each nibble (4 bits) is shifted out at the SCK frequency by the falling edge of the SCK signal.

The address can start at any byte location of the memory array. The address is automatically incremented to the next higher address in sequential order after each byte of data is shifted out. The entire memory can therefore be read out with one single read instruction and address 000000h provided. When the highest address is reached, the address counter will wrap around and roll back to 000000h, allowing the read sequence to be continued indefinitely.

Address jumps can be done without the need for additional Quad I/O Read instructions. This is controlled through the setting of the Mode bits (after the address sequence, as shown in **Figure 78** or **Figure 80**). This added feature removes the need for the instruction sequence and greatly improves code execution (XIP). The upper nibble (bits 7–4) of the Mode bits control the length of the next Quad I/O instruction through the inclusion or exclusion of the first byte instruction code. The lower nibble (bits 3–0) of the Mode bits are "don't care" ("x"). If the Mode bits equal Axh, then the device remains in Quad I/O high performance Read Mode and the next address can be entered (after CS# is raised HIGH and then asserted LOW) without requiring the EBh or ECh instruction, as shown in **Figure 79** or **Figure 81**; thus, eliminating eight cycles for the command sequence. The following sequences will release the device from Quad I/O high performance Read mode; after which, the device can accept standard SPI commands:

1. During the Quad I/O Read Command Sequence, if the Mode bits are any value other than Axh, then the next time CS# is raised HIGH the device will be released from Quad I/O high performance Read mode.
2. During any operation, if CS# toggles HIGH to LOW to HIGH for eight cycles (or less) and data input (IO0–IO3) are not set for a valid instruction sequence, then the device will be released from Quad I/O high performance Read mode.

Note that the two mode bit clock cycles and additional wait states (i.e., dummy cycles) allow the device's internal circuitry latency time to access the initial address after the last address cycle that is clocked into IO0–IO3.

It is important that the IO0–IO3 signals be set to high-impedance at or before the falling edge of the first data out clock. At higher clock speeds the time available to turn off the host outputs before the memory device begins to drive (bus turn around) is diminished. It is allowed and may be helpful in preventing IO0–IO3 signal contention, for the host system to turn off the IO0–IO3 signal outputs (make them high impedance) during the last "don't care" mode cycle or during any dummy cycles.

CS# should not be driven HIGH during mode or dummy bits as this may make the mode bits indeterminate.

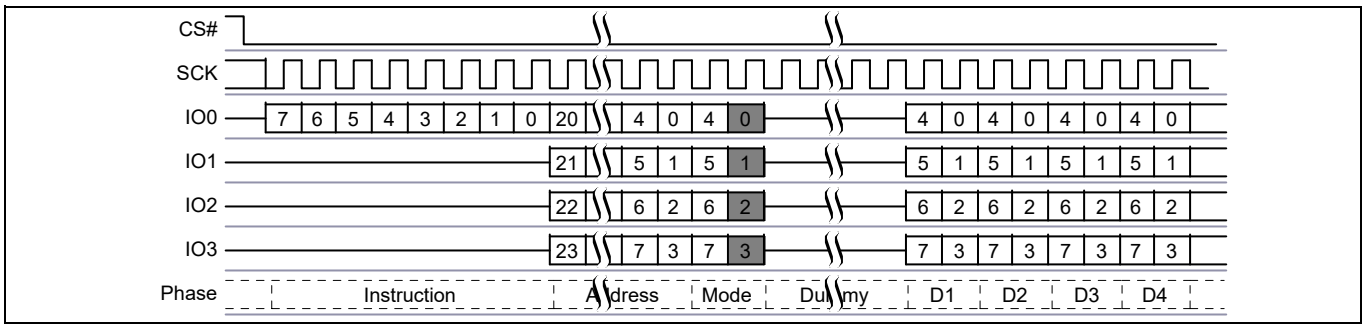


Figure 78 Quad I/O Read command sequence (3-byte address, EBh [ExtAdd = 0])

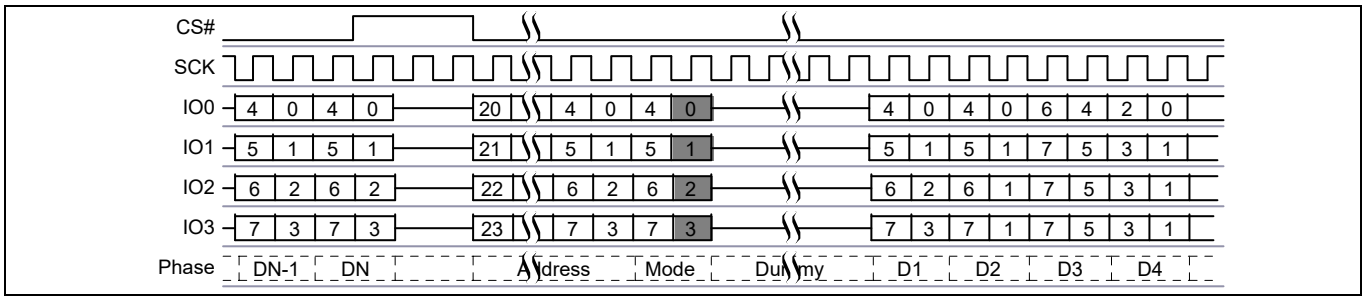


Figure 79 Continuous Quad I/O Read command sequence (3-byte address)

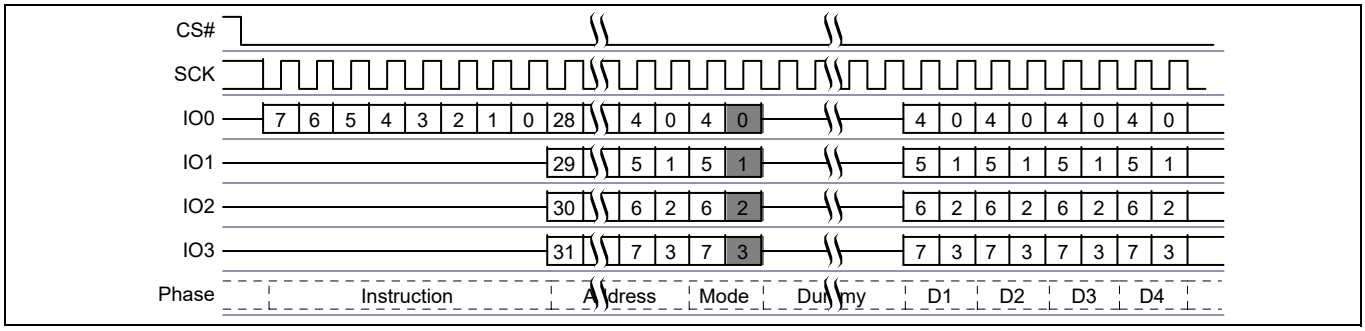


Figure 80 Quad I/O Read command sequence (4-byte address, ECh or EBh [ExtAdd = 1])

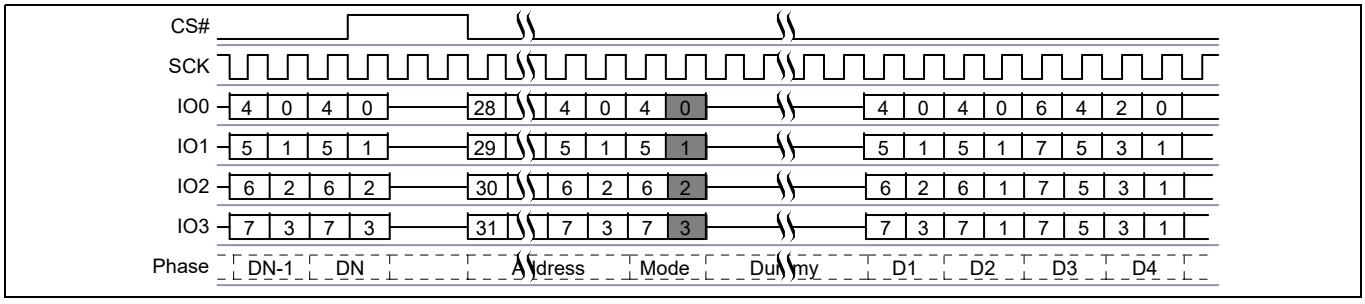


Figure 81 Continuous Quad I/O Read command sequence (4-byte address)

10.5 Program Flash Array commands

10.5.1 Program granularity

10.5.1.1 Automatic ECC

Each 16 byte aligned and 16 byte length Programming Block has an automatic error correction code (ECC) value. The data block plus ECC form an ECC unit. In combination with error detection and correction (EDC) logic the ECC is used to detect and correct any single bit error found during a read access. When data is first programmed within an ECC unit the ECC value is set for the entire ECC unit. If the same ECC unit is programmed more than once the ECC value is changed to disable the Error Detection and Correction (EDC) function. A sector erase is needed to again enable Automatic ECC on that Programming Block. The 16 byte Program Block is the smallest program granularity on which Automatic ECC is enabled.

These are automatic operations transparent to the user. The transparency of the Automatic ECC feature enhances data accuracy for typical programming operations which write data once to each ECC unit but, facilitates software compatibility to previous generations of FL-S family of products by allowing for single byte programming and bit walking in which the same ECC unit is programmed more than once. When an ECC unit has Automatic ECC disabled, EDC is not done on data read from the ECC unit location.

An ECC status register is provided for determining if ECC is enabled on an ECC unit and whether any errors have been detected and corrected in the ECC unit data or the ECC (see **“ECC Status Register (ECCSR)”** on page 65.) The ECC Status Register Read (ECCRD) command is used to read the ECC status on any ECC unit.

EDC is applied to all parts of the Flash address spaces other than registers. An ECC is calculated for each group of bytes protected and the ECC is stored in a hidden area related to the group of bytes. The group of protected bytes and the related ECC are together called an ECC unit.

ECC is calculated for each 16 byte aligned and length ECC unit.

- Single Bit EDC is supported with 8 ECC bits per ECC unit, plus 1 bit for an ECC disable Flag.
- Sector erase resets all ECC bits and ECC disable flags in a sector to the default state (enabled).
- ECC is programmed as part of the standard Program commands operation.
- ECC is disabled automatically if multiple programming operations are done on the same ECC unit.
- Single byte programming or bit walking is allowed but disables ECC on the second program to the same 16-byte ECC unit.
- The ECC disable flag is programmed when ECC is disabled.
- To re-enable ECC for an ECC unit that has been disabled, the Sector that includes the ECC unit must be erased.
- To ensure the best data integrity provided by EDC, each ECC unit should be programmed only once so that ECC is stored for that unit and not disabled.
- The calculation, programming, and disabling of ECC is done automatically as part of a programming operation. The detection and correction, if needed, is done automatically as part of read operations. The host system sees only corrected data from a read operation.
- ECC protects the OTP region - however a second program operation on the same ECC unit will disable ECC permanently on that ECC unit (OTP is one time programmable, hence an erase operation to re-enable the ECC enable/indicator bit is prohibited).

10.5.1.2 Page programming

Page programming is done by loading a Page Buffer with data to be programmed and issuing a programming command to move data from the buffer to the memory array. This sets an upper limit on the amount of data that can be programmed with a single programming command. Page programming allows up to a page size (either 256 or 512 bytes) to be programmed in one operation. The page size is determined by a configuration bit (SR2[6]). The page is aligned on the page size address boundary. It is possible to program from one bit up to a page size in each Page programming operation. It is recommended that a multiple of 16-byte length and aligned Program Blocks be written. For the very best performance, programming should be done in full, aligned, pages of 512 bytes aligned on 512-byte boundaries with each Page being programmed only once.

10.5.1.3 Single byte programming

Single byte programming allows full backward compatibility to the standard SPI page programming (PP) command by allowing a single byte to be programmed anywhere in the memory array. While single byte programming is supported, this will disable Automatic ECC on the 16 byte ECC unit where the byte is located.

10.5.2 Page Program (PP 02h or 4PP 12h)

The Page Program (PP) commands allows bytes to be programmed in the memory (changing bits from 1 to 0). Before the Page Program (PP) commands can be accepted by the device, a Write Enable (WREN) command must be issued and decoded by the device. After the Write Enable (WREN) command has been decoded successfully, the device sets the Write Enable Latch (WEL) in the Status Register to enable any write operations.

The instruction

- 02h (ExtAdd = 0) is followed by a 3-byte address (A23–A0) or
- 02h (ExtAdd = 1) is followed by a 4-byte address (A31–A0) or
- 12h is followed by a 4-byte address (A31–A0)

and at least one data byte on SI. Depending on the device configuration, the page size can either be 256 or 512 bytes. Up to a page can be provided on SI after the 3-byte address with instruction 02h or 4-byte address with instruction 12h has been provided. If the 9 least significant address bits (A8–A0) are not all 0, all transmitted data that goes beyond the end of the current page are programmed from the start address of the same page (from the address whose 9 least significant bits (A8–A0) are all 0) i.e. the address wraps within the page aligned address boundaries. This is a result of only requiring the user to enter one single page address to cover the entire page boundary.

If more than a page of data is sent to the device, the data loading sequence will wrap from the last byte in the page to the zero byte location of the same page and begin overwriting data previously loaded in the page. The last page worth of data (either 256 or 512 bytes) is programmed in the page. This is a result of the device being equipped with a page program buffer that is only page size in length. If less than a page of data is sent to the device, these data bytes will be programmed in sequence, starting at the provided address within the page, without having any affect on the other bytes of the same page.

Using the Page Program (PP) command to load an entire page, within the page boundary, will save overall programming time versus loading less than a page into the program buffer.

The programming process is managed by the flash memory device internal control logic. After a programming command is issued, the programming operation status can be checked using the Read Status Register 1 command. The WIP bit (SR1[0]) will indicate when the programming operation is completed. The P_ERR bit (SR1[6]) will indicate if an error occurs in the programming operation that prevents successful completion of programming. This includes attempted programming of a protected area.

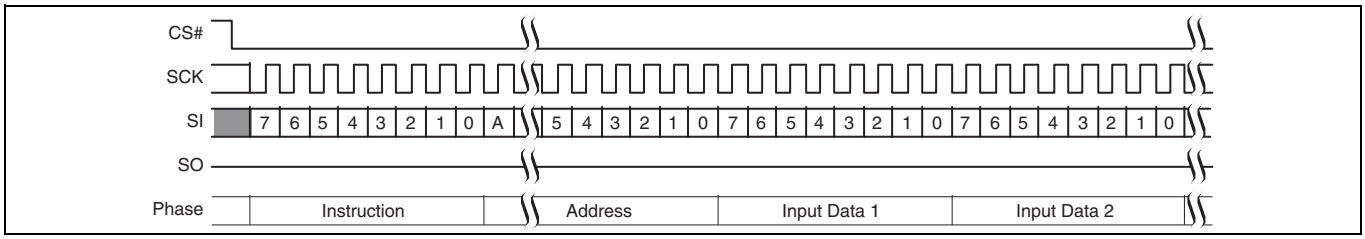


Figure 82 Page Program (PP 02h or 4PP 12h) command sequence[41]

Note
41.A = MSb of address = A23 for PP 02h, or A31 for 4PP 12h.

10.5.3 Quad Page Program (QPP 32h or 38h, or 4QPP 34h)

The Quad-input Page Program (QPP) command allows bytes to be programmed in the memory (changing bits from 1 to 0). The Quad-input Page Program (QPP) command allows up to a page size (either 256 or 512 bytes) of data to be loaded into the Page Buffer using four signals: IO0–IO3. QPP can improve performance for PROM Programmer and applications that have slower clock speeds (< 12 MHz) by loading 4 bits of data per clock cycle. Systems with faster clock speeds do not realize as much benefit for the QPP command since the inherent page program time becomes greater than the time it takes to clock-in the data. The maximum frequency for the QPP command is 80 MHz.

To use Quad Page Program the Quad Enable Bit in the Configuration Register must be set (QUAD = 1). A Write Enable command must be executed before the device will accept the QPP command (Status Register 1, WEL = 1).

The instruction

- 32h (ExtAdd = 0) is followed by a 3-byte address (A23–A0) or
- 32h (ExtAdd = 1) is followed by a 4-byte address (A31–A0) or
- 38h (ExtAdd = 0) is followed by a 3-byte address (A23–A0) or
- 38h (ExtAdd = 1) is followed by a 4-byte address (A31–A0) or
- 34h is followed by a 4-byte address (A31–A0)

and at least one data byte, into the IO signals. Data must be programmed at previously erased (FFh) memory locations.

QPP requires programming to be done one full page at a time. While less than a full page of data may be loaded for programming, the entire page is considered programmed, any locations not filled with data will be left as ones, the same page must not be programmed more than once.

All other functions of QPP are identical to Page Program. The QPP command sequence is shown in the **Figure 83**.

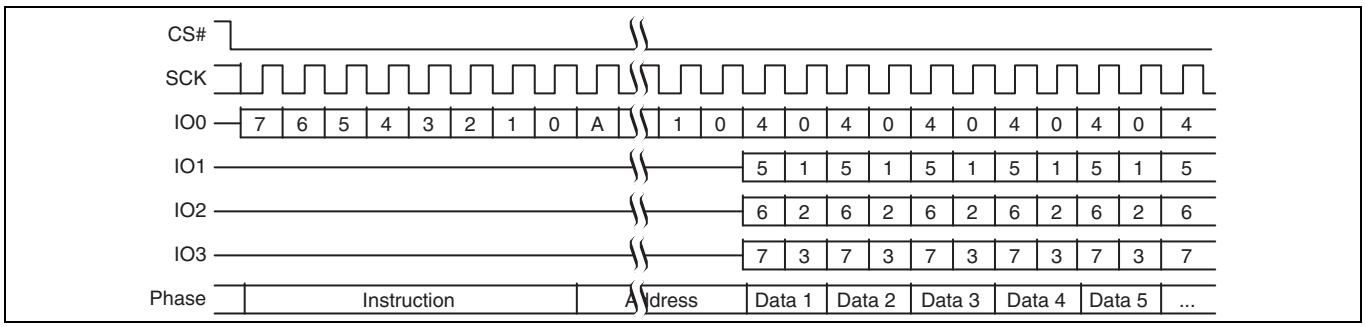


Figure 83 Quad Page Program command sequence

10.5.4 Program Suspend (PGSP 85h) and Resume (PGRS 8Ah)

The Program Suspend command allows the system to interrupt a programming operation and then read from any other non-erase-suspended sector or non-program-suspended-page. Program Suspend is valid only during a programming operation.

Commands allowed after the Program Suspend command is issued:

- Read Status Register 1 (RDSR1 05h)
- Read Status Register 2 (RDSR2 07h)

The Write in Progress (WIP) bit in Status Register 1 (SR1[0]) must be checked to know when the programming operation has stopped. The Program Suspend Status bit in the Status Register 2 (SR2[0]) can be used to determine if a programming operation has been suspended or was completed at the time WIP changes to '0'. The time required for the suspend operation to complete is t_{PSL}, see **Table 46**.

See **Table 44** for the commands allowed while programming is suspend.

The Program Resume command 8Ah must be written to resume the programming operation after a Program Suspend. If the programming operation was completed during the suspend operation, a resume command is not needed and has no effect if issued. Program Resume commands will be ignored unless a Program operation is suspended.

After a Program Resume command is issued, the WIP bit in the Status Register 1 will be set to '1' and the programming operation will resume. Program operations may be interrupted as often as necessary e.g. a program suspend command could immediately follow a program resume command but, in order for a program operation to progress to completion there must be some periods of time between resume and the next suspend command greater than or equal to t_{PRS}. See **Table 46**.

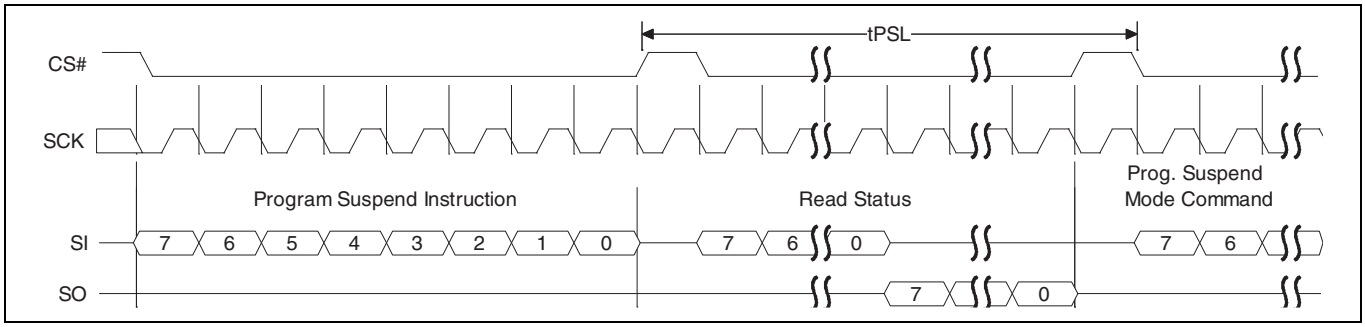


Figure 84 Program Suspend command sequence

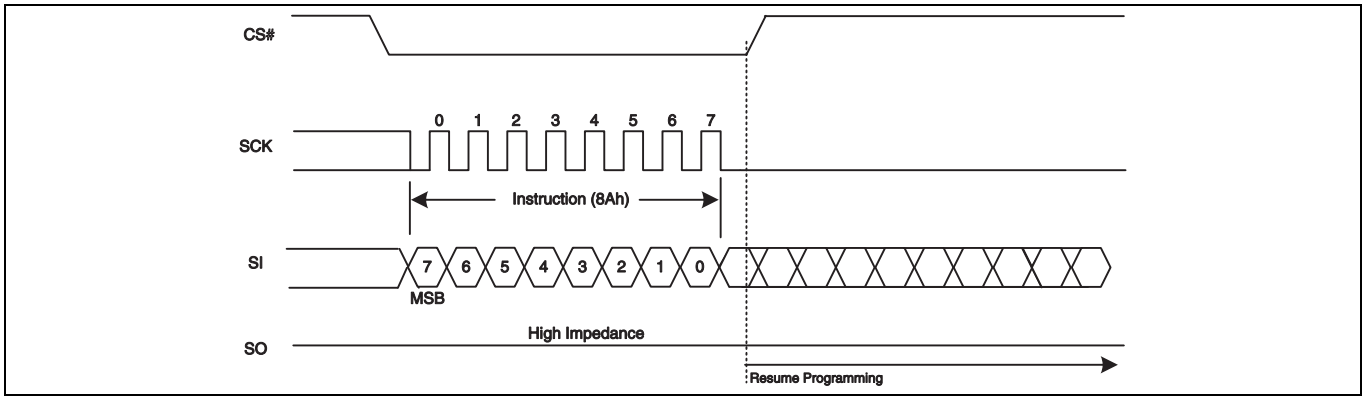


Figure 85 Program Resume command sequence

10.6 Erase Flash Array commands

10.6.1 Parameter 4-KB Sector Erase (P4E 20h or 4P4E 21h)

The P4E command is implemented only in FL127S. The P4E command is ignored when the device is configured with the 256-KB sector option.

The Parameter 4-KB Sector Erase (P4E) command sets all the bits of a 4-KB parameter sector to 1 (all bytes are FFh). Before the P4E command can be accepted by the device, a Write Enable (WREN) command must be issued and decoded by the device, which sets the Write Enable Latch (WEL) in the Status Register to enable any write operations.

The instruction

- 20h [ExtAdd = 0] is followed by a 3-byte address (A23–A0), or
- 20h [ExtAdd = 1] is followed by a 4-byte address (A31–A0), or
- 21h is followed by a 4-byte address (A31–A0)

CS# must be driven into the logic high state after the twenty-fourth or thirty-second bit of the address has been latched in on SI. This will initiate the beginning of internal erase cycle, which involves the pre-programming and erase of the chosen sector of the flash memory array. If CS# is not driven HIGH after the last bit of address, the sector erase operation will not be executed.

As soon as CS# is driven HIGH, the internal erase cycle will be initiated. With the internal erase cycle in progress, the user can read the value of the Write-In Progress (WIP) bit to determine when the operation has been completed. The WIP bit will indicate a 1. when the erase cycle is in progress and a 0 when the erase cycle has been completed.

A P4E command applied to a sector that has been write protected through the Block Protection bits or ASP, will not be executed and will set the E_ERR status. A P4E command applied to a sector that is larger than 4 KB will not be executed and will not set the E_ERR status.

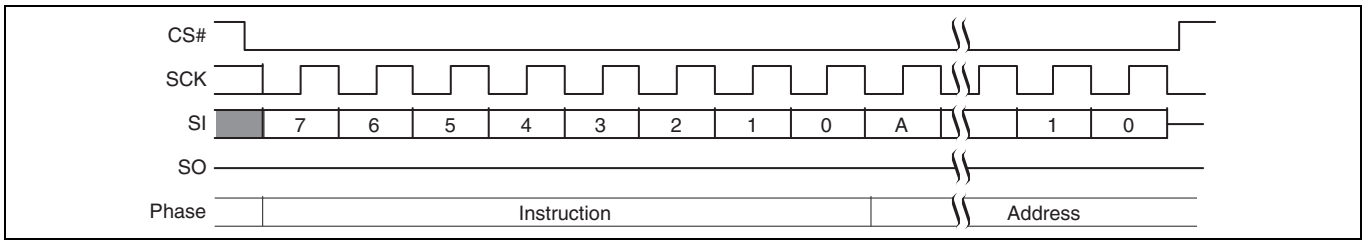


Figure 86 Parameter Sector Erase (P4E 20h or 4P4E 21h) command sequence[42]

Note
42.A = MSb of address = A23 for P4E 20h with ExtAdd = 0, or A31 for P4E 20h with ExtAdd = 1 or 4P4E 21h.

10.6.2 Sector Erase (SE D8h or 4SE DCh)

The Sector Erase (SE) command sets all bits in the addressed sector to 1 (all bytes are FFh). Before the Sector Erase (SE) command can be accepted by the device, a Write Enable (WREN) command must be issued and decoded by the device, which sets the Write Enable Latch (WEL) in the Status Register to enable any write operations.

The instruction

- D8h [ExtAdd = 0] is followed by a 3-byte address (A23–A0), or
- D8h [ExtAdd = 1] is followed by a 4-byte address (A31–A0), or
- DCh is followed by a 4-byte address (A31–A0)

CS# must be driven into the logic HIGH state after the twenty-fourth or thirty-second bit of address has been latched in on SI. This will initiate the erase cycle, which involves the pre-programming and erase of the chosen sector. If CS# is not driven HIGH after the last bit of address, the sector erase operation will not be executed.

As soon as CS# is driven into the logic HIGH state, the internal erase cycle will be initiated. With the internal erase cycle in progress, the user can read the value of the Write-In Progress (WIP) bit to check if the operation has been completed. The WIP bit will indicate a 1 when the erase cycle is in progress and a 0 when the erase cycle has been completed.

A Sector Erase (SE) command applied to a sector that has been Write Protected through the Block Protection bits or ASP, will not be executed and will set the E_ERR status.

A device configuration determines whether the SE command erases 64 KB or 256 KB. The option to use this command to always erase 256 KB provides for software compatibility with higher density and future S25FL family devices.

ASP has a PPB and a DYB protection bit for each sector, including any 4-KB sectors. If a sector erase command is applied to a 64-KB range that includes a protected 4-KB sector, or to a 256-KB range that includes a 64-KB protected address range, the erase will not be executed on the range and will set the E_ERR status.

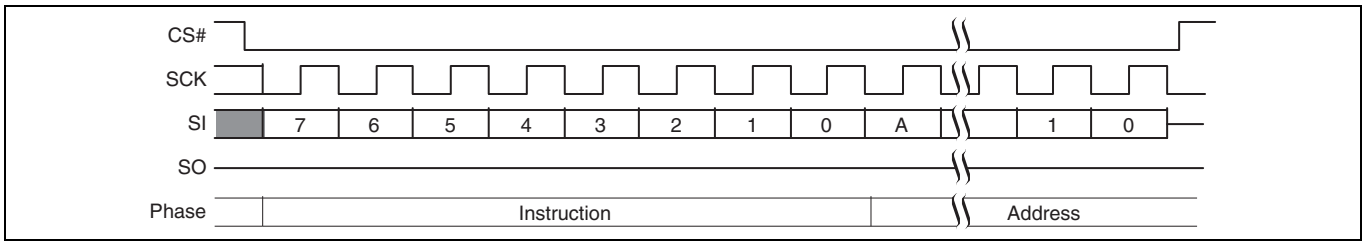


Figure 87 Sector Erase (SE D8h or 4SE DCh) command sequence[43]

Note
43.A = MSb of address = A23 for SE D8h with ExtAdd = 0, or A31 for SE D8h with ExtAdd = 1 or 4P4E DCh.

10.6.3 Bulk Erase (BE 60h or C7h)

The Bulk Erase (BE) command sets all bits to 1 (all bytes are FFh) inside the entire flash memory array. Before the BE command can be accepted by the device, a Write Enable (WREN) command must be issued and decoded by the device, which sets the Write Enable Latch (WEL) in the Status Register to enable any write operations.

CS# must be driven into the logic HIGH state after the eighth bit of the instruction byte has been latched in on SI. This will initiate the erase cycle, which involves the pre-programming and erase of the entire flash memory array. If CS# is not driven HIGH after the last bit of instruction, the BE operation will not be executed.

As soon as CS# is driven into the logic HIGH state, the erase cycle will be initiated. With the erase cycle in progress, the user can read the value of the Write-In Progress (WIP) bit to determine when the operation has been completed. The WIP bit will indicate a 1 when the erase cycle is in progress and a 0 when the erase cycle has been completed.

A BE command can be executed only when the Block Protection (BP2, BP1, BP0) bits are set to 0's. If the BP bits are not 0, the BE command is not executed and E_ERR is not set. The BE command will skip any sectors protected by the DYB or PPB and the E_ERR status will not be set.

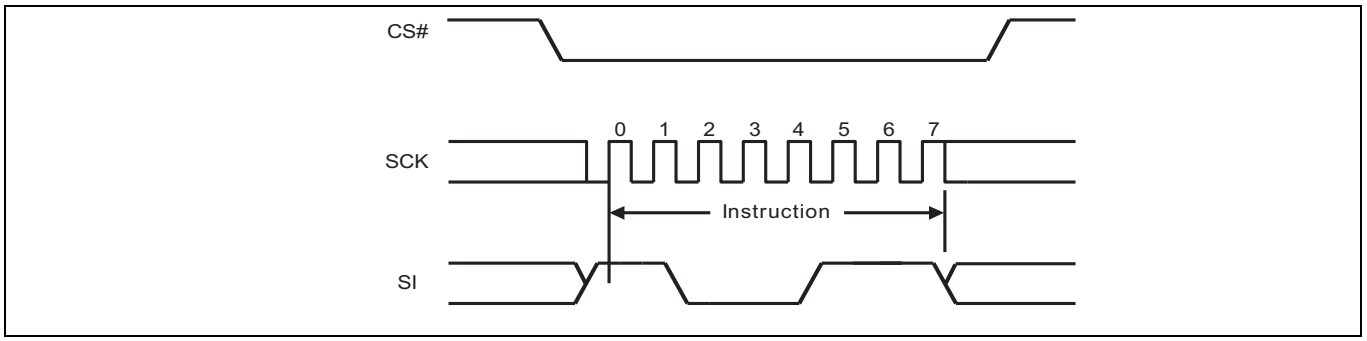


Figure 88 Bulk Erase command sequence

10.6.4 Erase Suspend and Resume commands (ERSP 75h or ERRS 7Ah)

The Erase Suspend command, allows the system to interrupt a sector erase operation and then read from or program data to, any other sector. Erase Suspend is valid only during a sector erase operation. The Erase Suspend command is ignored if written during the Bulk Erase operation.

When the Erase Suspend command is written during the sector erase operation, the device requires a maximum of t_{ESL} (erase suspend latency) to suspend the erase operation and update the status bits. See **Table 47**.

Commands allowed after the Erase Suspend command is issued:

- Read Status Register 1 (RDSR1 05h)
- Read Status Register 2 (RDSR2 07h)

The Write in Progress (WIP) bit in Status Register 1 (SR1[0]) must be checked to know when the erase operation has stopped. The Erase Suspend bit in Status Register 2 (SR2[1]) can be used to determine if an erase operation has been suspended or was completed at the time WIP changes to 0.

If the erase operation was completed during the suspend operation, a resume command is not needed and has no effect if issued. Erase Resume commands will be ignored unless an Erase operation is suspended.

See **Table 44** for the commands allowed while erase is suspend.

After the erase operation has been suspended, the sector enters the erase-suspend mode. The system can read data from or program data to the device. Reading at any address within an erase-suspended sector produces undetermined data.

A WREN command is required before any command that will change nonvolatile data, even during erase suspend.

The WRR and PPB Erase commands are not allowed during Erase Suspend, it is therefore not possible to alter the Block Protection or PPB bits during Erase Suspend. If there are sectors that may need programming during Erase suspend, these sectors should be protected only by DYB bits that can be turned off during Erase Suspend. However, WRR is allowed immediately following the BRAC command; in this special case the WRR is interpreted as a write to the Bank Address Register, not a write to SR1 or CR1.

If a program command is sent for a location within an erase suspended sector the program operation will fail with the P_ERR bit set.

After an erase-suspended program operation is complete, the device returns to the erase-suspend mode. The system can determine the status of the program operation by reading the WIP bit in the Status Register, just as in the standard program operation.

The Erase Resume command 7Ah must be written to resume the erase operation if an Erase is suspended. Erase Resume commands will be ignored unless an Erase is suspended.

After an Erase Resume command is sent, the WIP bit in the status register will be set to a 1 and the erase operation will continue. Further Resume commands are ignored.

Erase operations may be interrupted as often as necessary e.g. an erase suspend command could immediately follow an erase resume command but, in order for an erase operation to progress to completion there must be some periods of time between resume and the next suspend command greater than or equal to t_{ERS}. See **Table 47**.

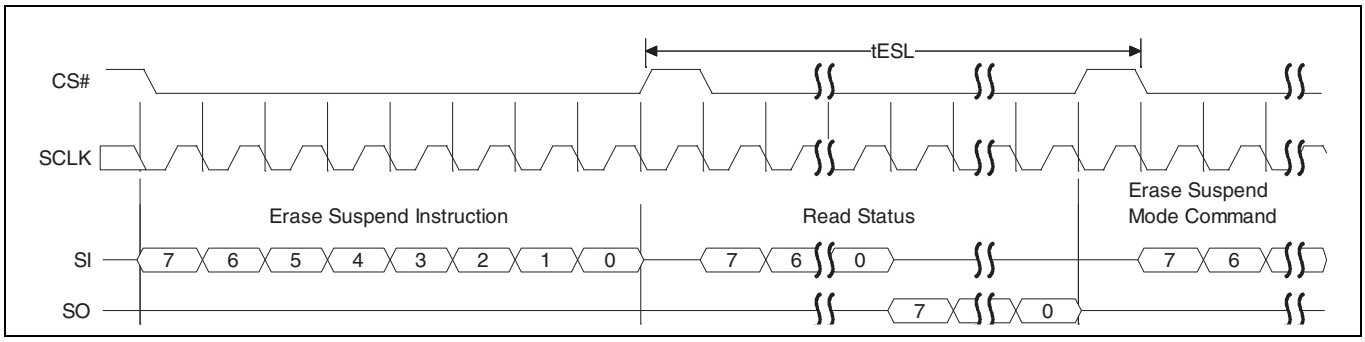


Figure 89 Erase Suspend command sequence

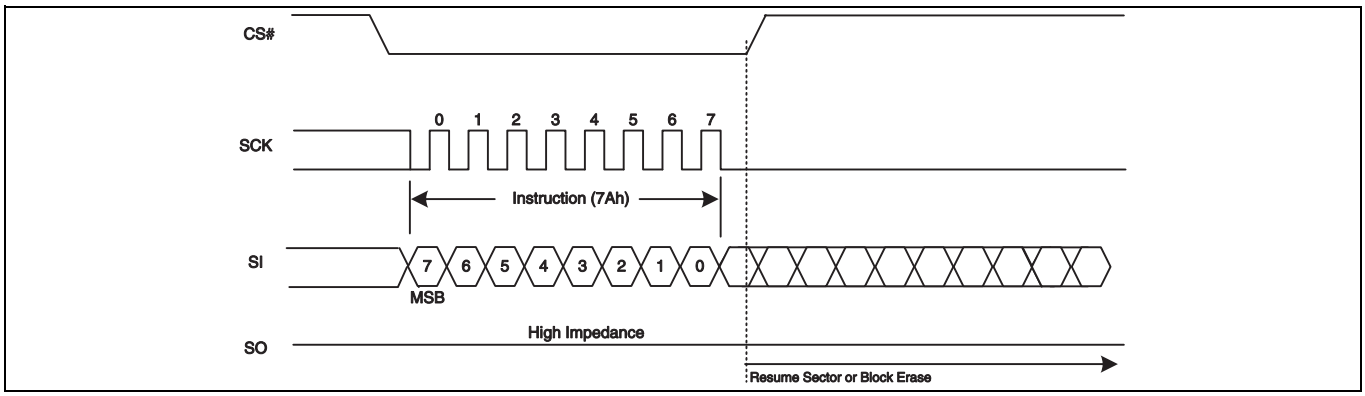


Figure 90 Erase Resume command sequence

Table 44 Commands allowed during program or erase suspend

Instruction name	Instruction code (Hex)	Allowed during erase suspend	Allowed during program suspend	Comment
BRAC	B9	X	X	Bank address register may need to be changed during a suspend to reach a sector for read or program.
BRRD	16	X	X	Bank address register may need to be changed during a suspend to reach a sector for read or program.
BRWR	17	X	X	Bank address register may need to be changed during a suspend to reach a sector for read or program.
CLSR	30	X		Clear status may be used if a program operation fails during erase suspend.
DYBRD	E0	X		It may be necessary to remove and restore dynamic protection during erase suspend to allow programming during erase suspend.
DYBWR	E1	X		It may be necessary to remove and restore dynamic protection during erase suspend to allow programming during erase suspend.
ERRS	7A	X		Required to resume from erase suspend.
FAST_READ	0B	X	X	All array reads allowed in suspend.
4FAST_READ	0C	X	X	All array reads allowed in suspend.
MBR	FF	X	X	May need to reset a read operation during suspend.
PGRS	8A	X	X	Needed to resume a program operation. A program resume may also be used during nested program suspend within an erase suspend.
PGSP	85	X		Program suspend allowed during erase suspend.
PP	02	X		Required for array program during erase suspend.
4PP	12	X		Required for array program during erase suspend.
PPBRD	E2	X		Allowed for checking persistent protection before attempting a program command during erase suspend.
QPP	32, 38	X		Required for array program during erase suspend.
4QPP	34	X		Required for array program during erase suspend.

Table 44 Commands allowed during program or erase suspend (Continued)

Instruction name	Instruction code (Hex)	Allowed during erase suspend	Allowed during program suspend	Comment
4READ	13	X	X	All array reads allowed in suspend.
RDCR	35	X	X	
DIOR	BB	X	X	All array reads allowed in suspend.
4DIOR	BC	X	X	All array reads allowed in suspend.
DOR	3B	X	X	All array reads allowed in suspend.
4DOR	3C	X	X	All array reads allowed in suspend.
QIOR	EB	X	X	All array reads allowed in suspend.
4QIOR	EC	X	X	All array reads allowed in suspend.
QOR	6B	X	X	All array reads allowed in suspend.
4QOR	6C	X	X	All array reads allowed in suspend.
RDSR1	05	X	X	Needed to read WIP to determine end of suspend process.
RDSR2	07	X	X	Needed to read suspend status to determine whether the operation is suspended or complete.
READ	03	X	X	All array reads allowed in suspend.
RESET	F0	X	X	Reset allowed anytime.
WREN	06	X		Required for program command within erase suspend.
WRR	01	X	X	Bank register may need to be changed during a suspend to reach a sector needed for read or program. WRR is allowed when following BRAC.

10.7 One Time Program Array commands

10.7.1 OTP Program (OTPP 42h)

The OTP Program command programs data in the One Time Program region, which is in a different address space from the main array data. The OTP region is 1024 bytes so, the address bits from A23 to A10 must be 0 for this command. Refer to **"OTP address space"** on page 55 for details on the OTP region. The protocol of the OTP Program command is the same as the Page Program command. Before the OTP Program command can be accepted by the device, a Write Enable (WREN) command must be issued and decoded by the device, which sets the Write Enable Latch (WEL) in the Status Register to enable any write operations. The WIP bit in SR1 may be checked to determine when the operation is completed. The P_ERR bit in SR1 may be checked to determine if any error occurred during the operation.

To program the OTP array in bit granularity, the rest of the bits within a data byte can be set to 1.

Each region in the OTP memory space can be programmed one or more times, provided that the region is not locked. Attempting to program 0s in a region that is locked will fail with the P_ERR bit in SR1 set to 1 Programming ones, even in a protected area does not cause an error and does not set P_ERR. Subsequent OTP programming can be performed only on the un-programmed bits (that is, 1 data).

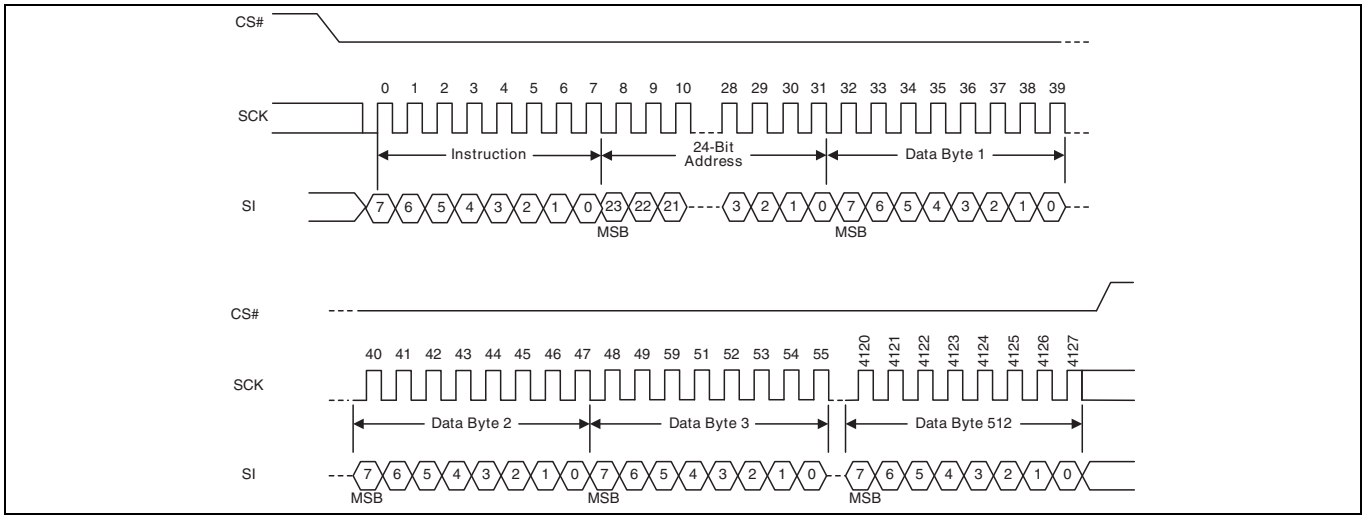


Figure 91 OTP Program command sequence

10.7.2 OTP Read (OTPR 4Bh)

The OTP Read command reads data from the OTP region. The OTP region is 1024 bytes so, the address bits from A23 to A10 must be 0 for this command. Refer to **"OTP address space"** on page 55 for details on the OTP region. The protocol of the OTP Read command is similar to the Fast Read command except that it will not wrap to the starting address after the OTP address is at its maximum; instead, the data beyond the maximum OTP address will be undefined. Also, the OTP Read command is not affected by the latency code. The OTP read command always has one dummy byte of latency as shown below.

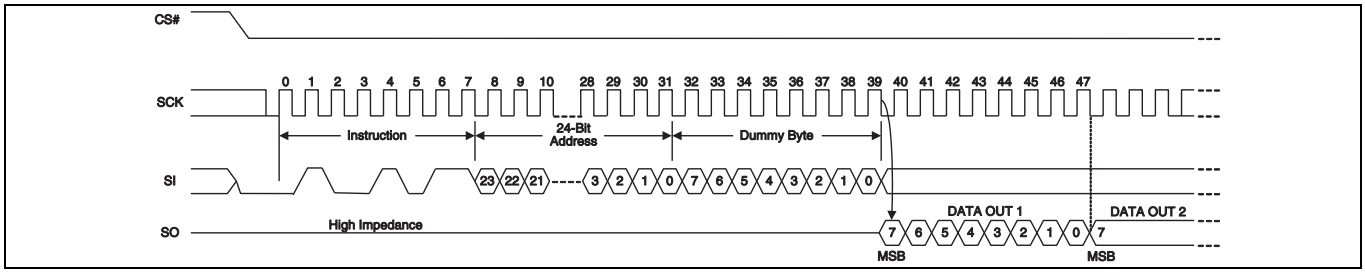


Figure 92 OTP Read command sequence

10.8 Advanced Sector Protection commands

10.8.1 ASP Read (ASPRD 2Bh)

The ASP Read instruction 2Bh is shifted into SI by the rising edge of the SCK signal. Then the 16-bit ASP register contents are shifted out on the serial output SO, least significant byte first. Each bit is shifted out at the SCK frequency by the falling edge of the SCK signal. It is possible to read the ASP register continuously by providing multiples of 16 clock cycles. The maximum operating clock frequency for the ASP Read (ASPRD) command is 108 MHz.

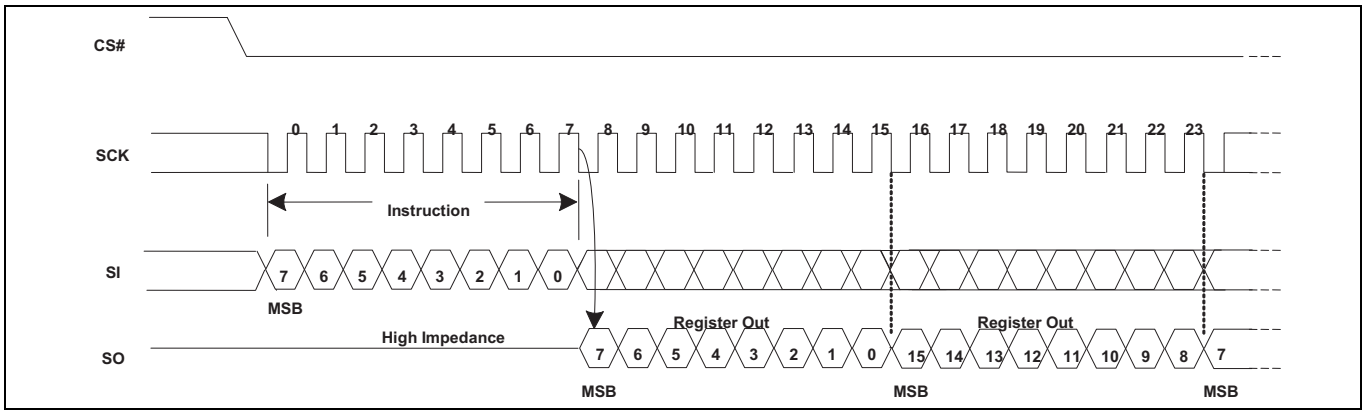


Figure 93 ASPRD command

10.8.2 ASP Program (ASPP 2Fh)

Before the ASP Program (ASPP) command can be accepted by the device, a Write Enable (WREN) command must be issued. After the Write Enable (WREN) command has been decoded, the device will set the Write Enable Latch (WEL) in the Status Register to enable any write operations.

The ASPP command is entered by driving CS# to the logic LOW state, followed by the instruction and two data bytes on SI, least significant byte first. The ASP Register is two data bytes in length.

The ASPP command affects the P_ERR and WIP bits of the Status and Configuration Registers in the same manner as any other programming operation.

CS# input must be driven to the logic HIGH state after the sixteenth bit of data has been latched in. If not, the ASPP command is not executed. As soon as CS# is driven to the logic HIGH state, the self-timed ASPP operation is initiated. While the ASPP operation is in progress, the Status Register may be read to check the value of the Write-In Progress (WIP) bit. The Write-In Progress (WIP) bit is a 1 during the self-timed ASPP operation, and is a 0 when it is completed. When the ASPP operation is completed, the Write Enable Latch (WEL) is set to a 0.

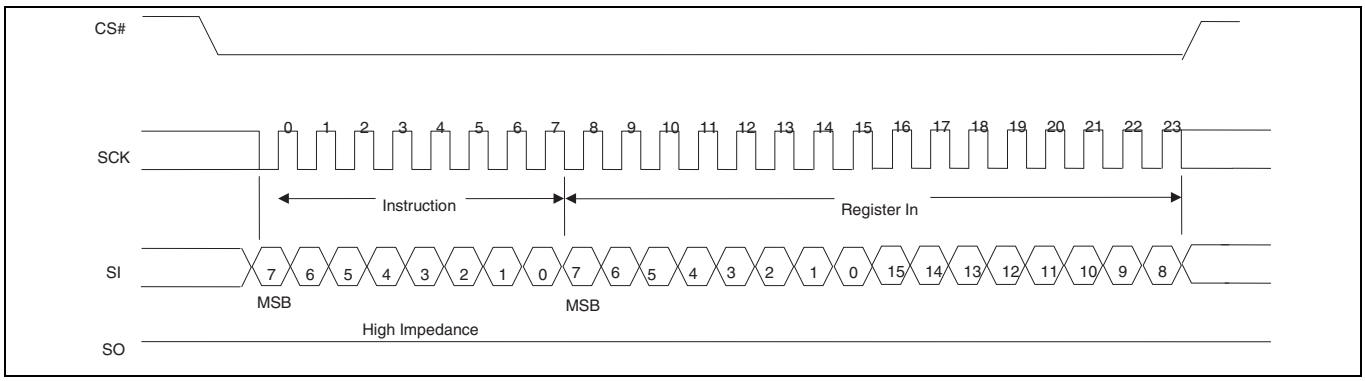


Figure 94 ASPP command

10.8.3 DYB Read (DYBRD E0h)

The instruction E0h is latched into SI by the rising edge of the SCK signal. The instruction is followed by the 32-bit address selecting location zero within the desired sector Note: the high order address bits not used by a particular density device must be 0. Then the 8-bit DYB access register contents are shifted out on the serial output SO. Each bit is shifted out at the SCK frequency by the falling edge of the SCK signal. It is possible to read the same DYB access register continuously by providing multiples of eight clock cycles. The address of the DYB register does not increment so this is not a means to read the entire DYB array. Each location must be read with a separate DYB Read command. The maximum operating clock frequency for READ command is 108 MHz.

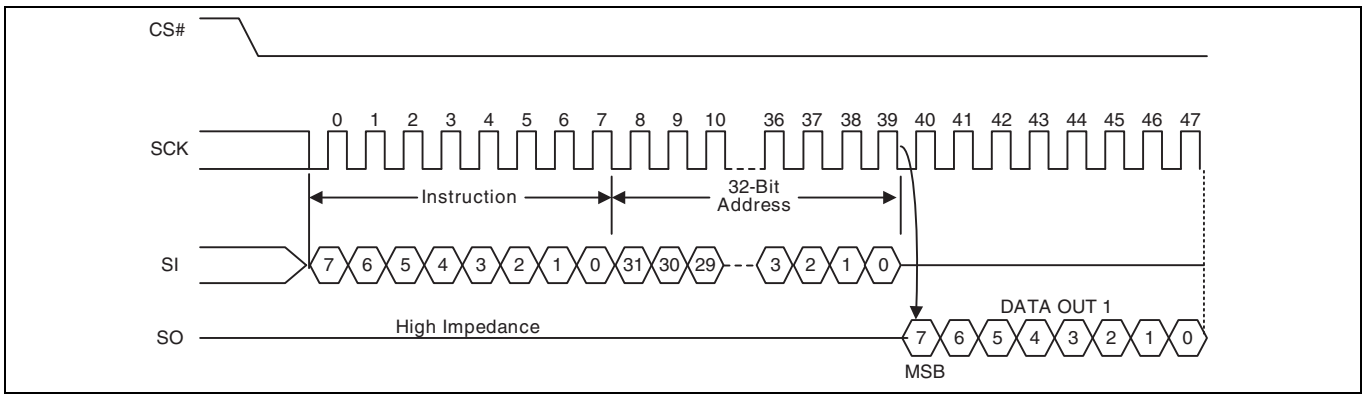


Figure 95 DYBRD command sequence

10.8.4 DYB Write (DYBWR E1h)

Before the DYB Write (DYBWR) command can be accepted by the device, a Write Enable (WREN) command must be issued. After the Write Enable (WREN) command has been decoded, the device will set the Write Enable Latch (WEL) in the Status Register to enable any write operations.

The DYBWR command is entered by driving CS# to the logic LOW state, followed by the instruction, the 32-bit address selecting location zero within the desired sector (note, the high order address bits not used by a particular density device must be 0), then the data byte on SI. The DYB Access Register is one data byte in length.

The DYBWR command affects the P_ERR and WIP bits of the Status and Configuration Registers in the same manner as any other programming operation. CS# must be driven to the logic HIGH state after the eighth bit of data has been latched in. If not, the DYBWR command is not executed. As soon as CS# is driven to the logic HIGH state, the self-timed DYBWR operation is initiated. While the DYBWR operation is in progress, the Status Register may be read to check the value of the Write-In Progress (WIP) bit. The Write-In Progress (WIP) bit is a 1 during the self-timed DYBWR operation, and is a 0 when it is completed. When the DYBWR operation is completed, the Write Enable Latch (WEL) is set to a 0.

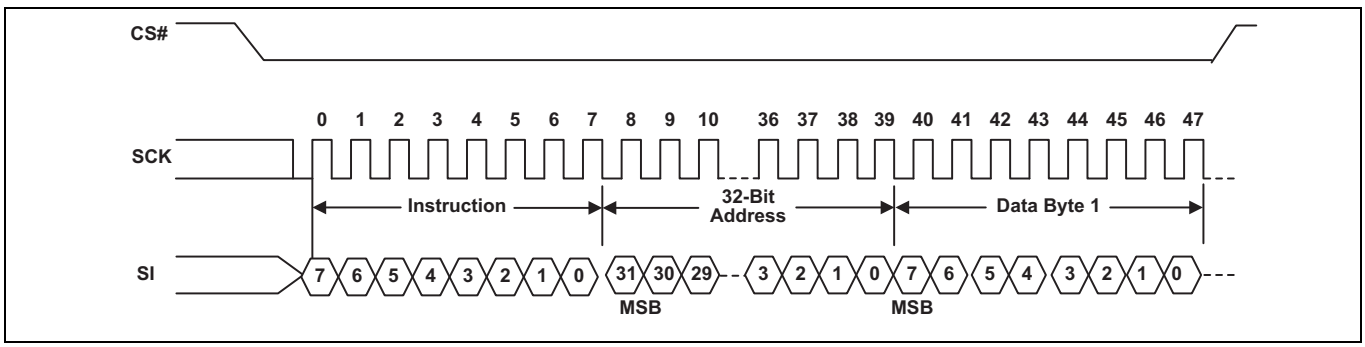


Figure 96 DYBWR command sequence

10.8.5 PPB Read (PPBRD E2h)

The instruction E2h is shifted into SI by the rising edges of the SCK signal, followed by the 32-bit address selecting location zero within the desired sector. Note: the high order address bits not used by a particular density device must be 0. Then the 8-bit PPB access register contents are shifted out on SO.

It is possible to read the same PPB access register continuously by providing multiples of eight clock cycles. The address of the PPB register does not increment so this is not a means to read the entire PPB array. Each location must be read with a separate PPB Read command. The maximum operating clock frequency for the PPB Read command is 108 MHz.

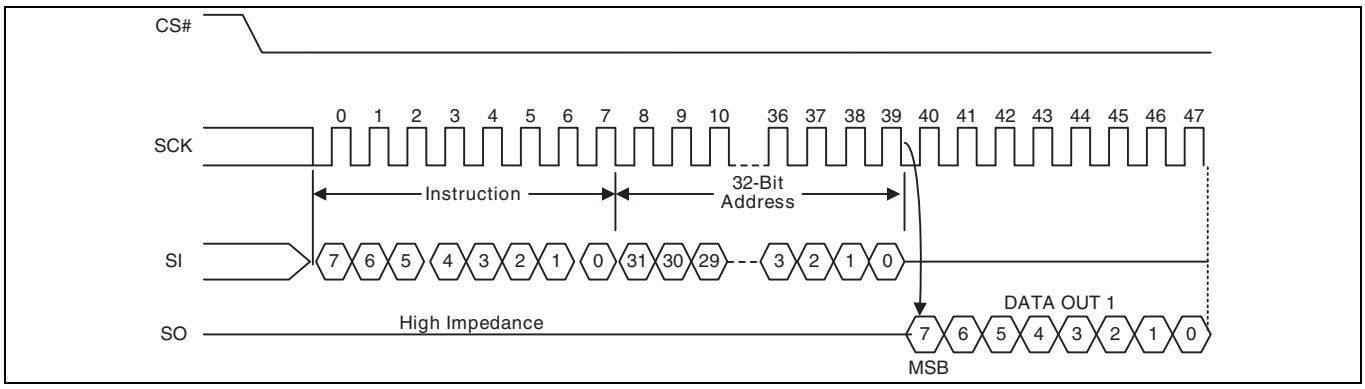


Figure 97 PPBRD command sequence

10.8.6 PPB Program (PPBP E3h)

Before the PPB Program (PPBP) command can be accepted by the device, a Write Enable (WREN) command must be issued. After the Write Enable (WREN) command has been decoded, the device will set the Write Enable Latch (WEL) in the Status Register to enable any write operations.

The PPBP command is entered by driving CS# to the logic LOW state, followed by the instruction, followed by the 32-bit address selecting location zero within the desired sector (note, the high order address bits not used by a particular density device must be 0).

The PPBP command affects the P_ERR and WIP bits of the Status and Configuration Registers in the same manner as any other programming operation.

CS# must be driven to the logic HIGH state after the last bit of address has been latched in. If not, the PPBP command is not executed. As soon as CS# is driven to the logic HIGH state, the self-timed PPBP operation is initiated. While the PPBP operation is in progress, the Status Register may be read to check the value of the Write-In Progress (WIP) bit. The Write-In Progress (WIP) bit is a 1 during the self-timed PPBP operation, and is a 0 when it is completed. When the PPBP operation is completed, the Write Enable Latch (WEL) is set to a 0.

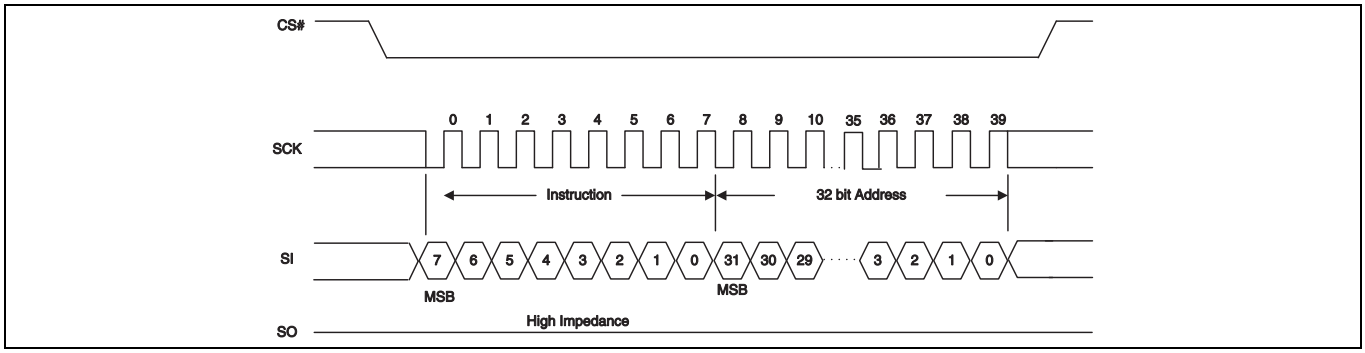


Figure 98 PPBP command sequence

10.8.7 PPB Erase (PPBE E4h)

The PPB Erase (PPBE) command sets all PPB bits to 1. Before the PPB Erase command can be accepted by the device, a Write Enable (WREN) command must be issued and decoded by the device, which sets the Write Enable Latch (WEL) in the Status Register to enable any write operations.

The instruction E4h is shifted into SI by the rising edges of the SCK signal.

CS# must be driven into the logic HIGH state after the eighth bit of the instruction byte has been latched in on SI. This will initiate the beginning of internal erase cycle, which involves the pre-programming and erase of the entire PPB memory array. Without CS# being driven to the logic HIGH state after the eighth bit of the instruction, the PPB erase operation will not be executed.

With the internal erase cycle in progress, the user can read the value of the Write-In Progress (WIP) bit to check if the operation has been completed. The WIP bit will indicate a 1 when the erase cycle is in progress and a 0 when the erase cycle has been completed. Erase suspend is not allowed during PPB Erase.

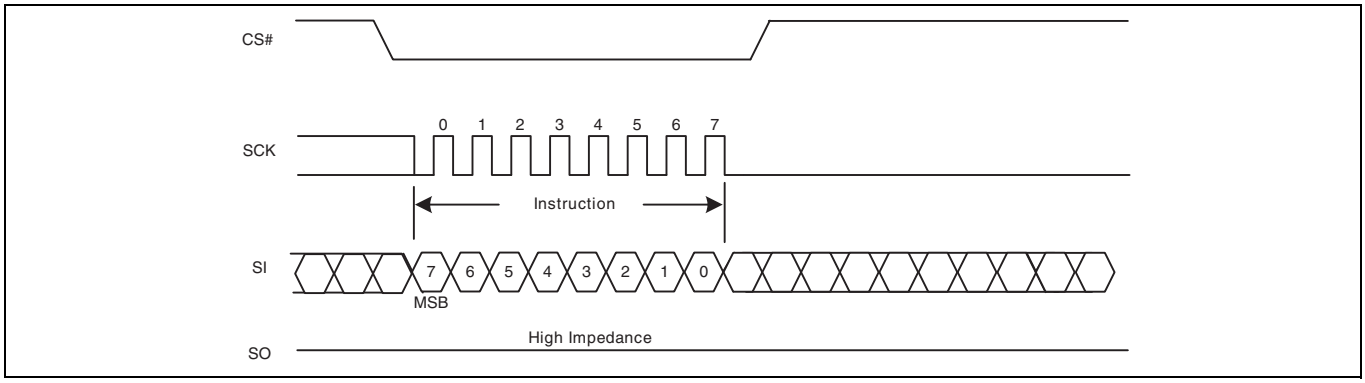


Figure 99 PPB Erase command sequence

10.8.8 PPB Lock Bit Read (PLBRD A7h)

The PPB Lock Bit Read (PLBRD) command allows the PPB Lock Register contents to be read out of SO. It is possible to read the PPB lock register continuously by providing multiples of eight clock cycles. The PPB Lock Register contents may only be read when the device is in standby state with no other operation in progress. It is recommended to check the Write-In Progress (WIP) bit of the Status Register before issuing a new command to the device.

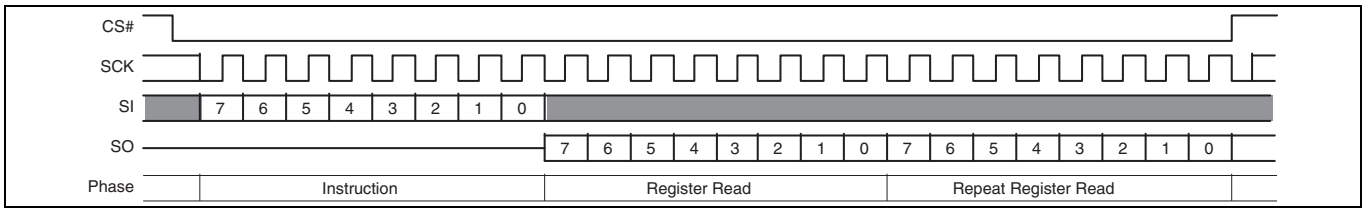


Figure 100 PPB Lock Register Read command sequence

10.8.9 PPB Lock Bit Write (PLBWR A6h)

The PPB Lock Bit Write (PLBWR) command clears the PPB Lock Register to 0. Before the PLBWR command can be accepted by the device, a Write Enable (WREN) command must be issued and decoded by the device, which sets the Write Enable Latch (WEL) in the Status Register to enable any write operations.

The PLBWR command is entered by driving CS# to the logic LOW state, followed by the instruction.

CS# must be driven to the logic HIGH state after the eighth bit of instruction has been latched in. If not, the PLBWR command is not executed. As soon as CS# is driven to the logic HIGH state, the self-timed PLBWR operation is initiated. While the PLBWR operation is in progress, the Status Register may still be read to check the value of the Write-In Progress (WIP) bit. The Write-In Progress (WIP) bit is a 1 during the self-timed PLBWR operation, and is a 0 when it is completed. When the PLBWR operation is completed, the Write Enable Latch (WEL) is set to a 0. The maximum clock frequency for the PLBWR command is 108 MHz.

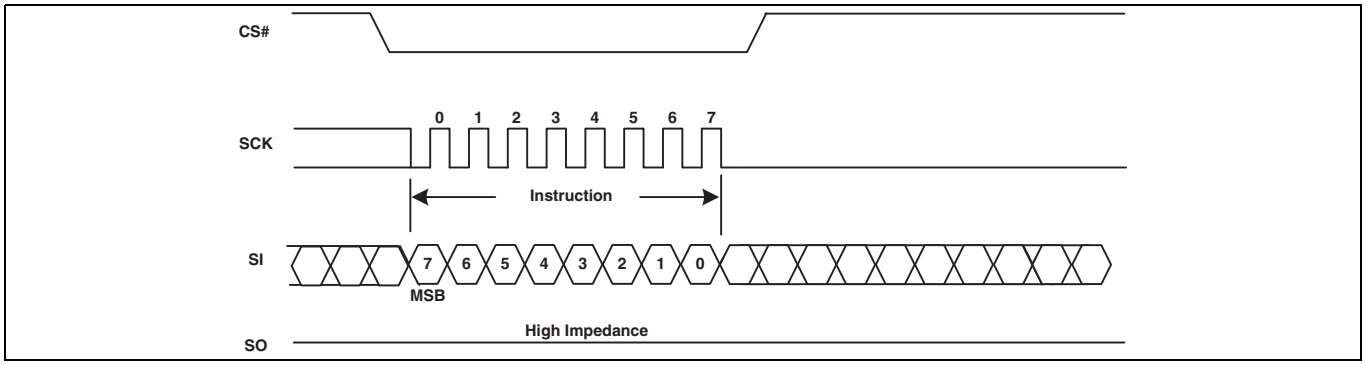


Figure 101 PPB Lock Bit Write command sequence

10.8.10 Password Read (PASSRD E7h)

The correct password value may be read only after it is programmed and before the Password Mode has been selected by programming the Password Protection Mode bit to 0 in the ASP Register (ASP[2]). After the Password Protection Mode is selected the PASSRD command is ignored.

The PASSRD command is shifted into SI. Then the 64-bit Password is shifted out on the serial output SO, least significant byte first, most significant bit of each byte first. Each bit is shifted out at the SCK frequency by the falling edge of the SCK signal. It is possible to read the Password continuously by providing multiples of 64 clock cycles. The maximum operating clock frequency for the PASSRD command is 108 MHz.

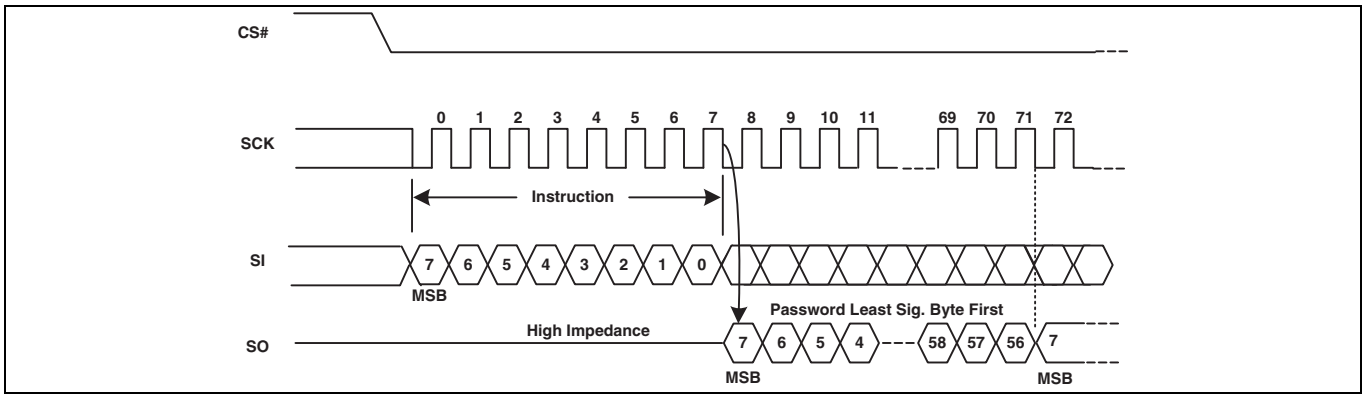


Figure 102 Password Read command sequence

10.8.11 Password Program (PASSP E8h)

Before the Password Program (PASSP) command can be accepted by the device, a Write Enable (WREN) command must be issued and decoded by the device. After the Write Enable (WREN) command has been decoded, the device sets the Write Enable Latch (WEL) to enable the PASSP operation.

The password can only be programmed before the Password Mode is selected by programming the Password Protection Mode bit to 0 in the ASP Register (ASP[2]). After the Password Protection Mode is selected the PASSP command is ignored.

The PASSP command is entered by driving CS# to the logic LOW state, followed by the instruction and the password data bytes on SI, least significant byte first, most significant bit of each byte first. The password is sixty-four (64) bits in length.

CS# must be driven to the logic HIGH state after the sixty-fourth (64^{th}) bit of data has been latched. If not, the PASSP command is not executed. As soon as CS# is driven to the logic HIGH state, the self-timed PASSP operation is initiated. While the PASSP operation is in progress, the Status Register may be read to check the value of the Write-In Progress (WIP) bit. The Write-In Progress (WIP) bit is a 1 during the self-timed PASSP cycle, and is a 0 when it is completed. The PASSP command can report a program error in the P_ERR bit of the status register. When the PASSP operation is completed, the Write Enable Latch (WEL) is set to a 0. The maximum clock frequency for the PASSP command is 108 MHz.

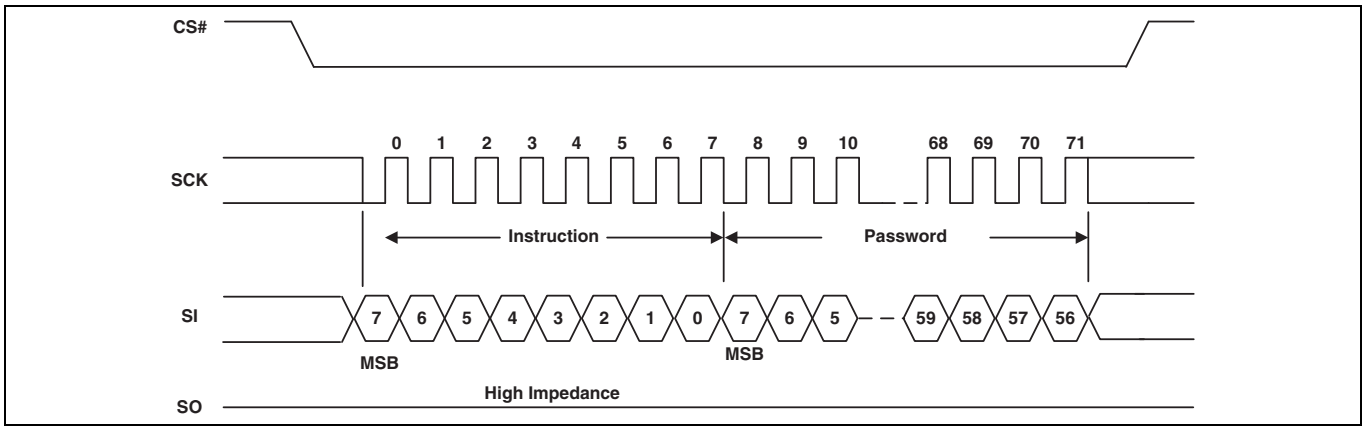


Figure 103 Password Program command sequence

10.8.12 Password Unlock (PASSU E9h)

The PASSU command is entered by driving CS# to the logic LOW state, followed by the instruction and the password data bytes on SI, least significant byte first, most significant bit of each byte first. The password is sixty-four (64) bits in length.

CS# must be driven to the logic HIGH state after the sixty-fourth (64^{th}) bit of data has been latched. If not, the PASSU command is not executed. As soon as CS# is driven to the logic HIGH state, the self-timed PASSU operation is initiated. While the PASSU operation is in progress, the Status Register may be read to check the value of the Write-In Progress (WIP) bit. The Write-In Progress (WIP) bit is a 1 during the self-timed PASSU cycle, and is a 0 when it is completed.

If the PASSU command supplied password does not match the hidden password in the Password Register, an error is reported by setting the P_ERR bit to 1. The WIP bit of the status register also remains set to 1. It is necessary to use the CLSR command to clear the status register, the RESET command to software reset the device, or drive the RESET# input LOW to initiate a hardware reset, in order to return the P_ERR and WIP bits to 0. This returns the device to standby state, ready for new commands such as a retry of the PASSU command.

If the password does match, the PPB Lock bit is set to 1. The maximum clock frequency for the PASSU command is 108 MHz.

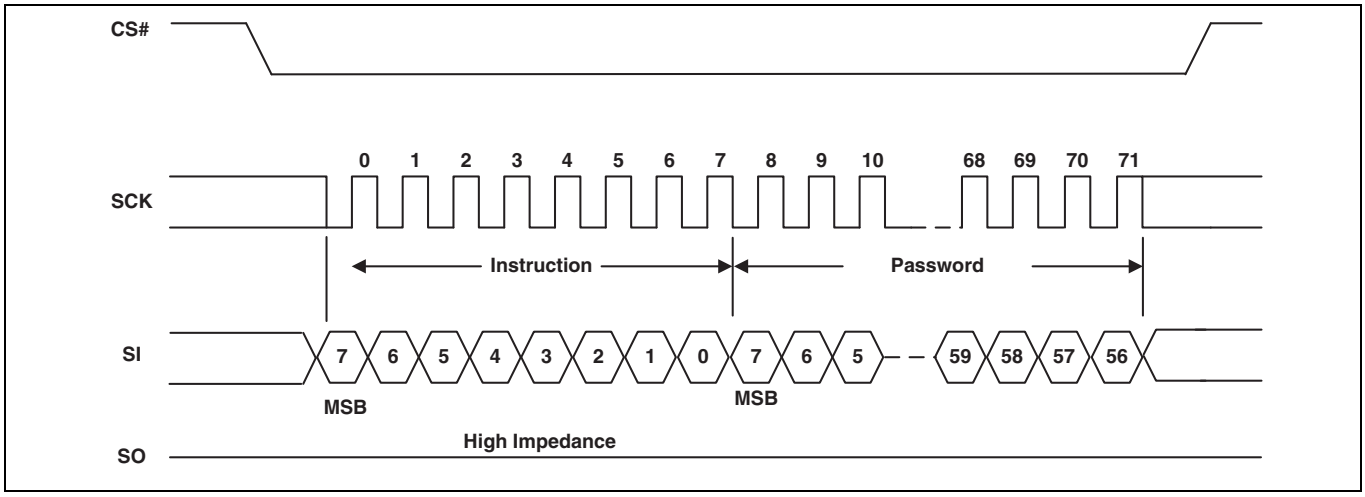


Figure 104 Password Unlock command sequence

10.9 Reset commands

10.9.1 Software Reset Command (RESET F0h)

The Software Reset command (RESET) restores the device to its initial power up state, except for the volatile FREEZE bit in the Configuration register CR1[1] and the volatile PPB Lock bit in the PPB Lock Register. The Freeze bit and the PPB Lock bit will remain set at their last value prior to the software reset. To clear the FREEZE bit and set the PPB Lock bit to its protection mode selected power on state, a full power-on-reset sequence or hardware reset must be done. Note that the nonvolatile bits in the configuration register, TBPROT, TBPARM, and BPNV, retain their previous state after a Software Reset. The Block Protection bits BP2, BP1, and BP0, in the status register will only be reset if they are configured as volatile via the BPNV bit in the Configuration Register (CR1[3]) and FREEZE is cleared to 0. The software reset cannot be used to circumvent the FREEZE or PPB Lock bit protection mechanisms for the other security configuration bits. The reset command is executed when CS# is brought to HIGH state and requires t_{RPH} time to execute.

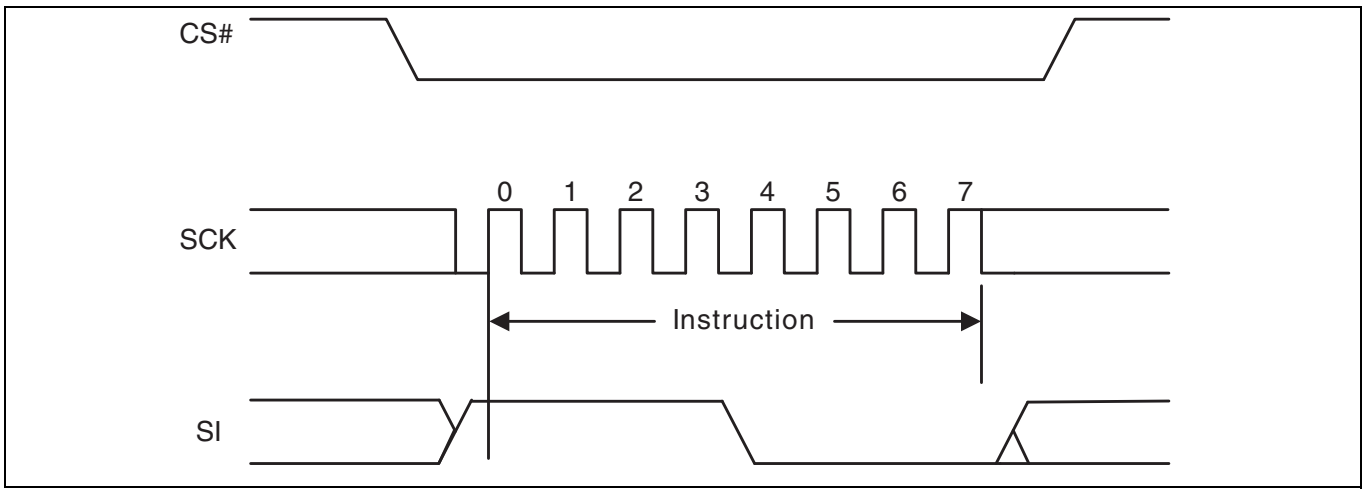


Figure 105 Software Reset command sequence

10.9.2 Mode Bit Reset (MBR FFh)

The Mode Bit Reset (MBR) command can be used to return the device from continuous high performance read mode back to normal standby awaiting any new command. Because some device packages lack a hardware RESET# input and a device that is in a continuous high performance read mode may not recognize any normal SPI command, a system hardware reset or software reset command may not be recognized by the device. It is recommended to use the MBR command after a system reset when the RESET# signal is not available or, before sending a software reset, to ensure the device is released from continuous high performance read mode.

The MBR command sends Ones on SI or IO0 for 8 SCK cycles. IO1 to IO3 are “don’t care” during these cycles.

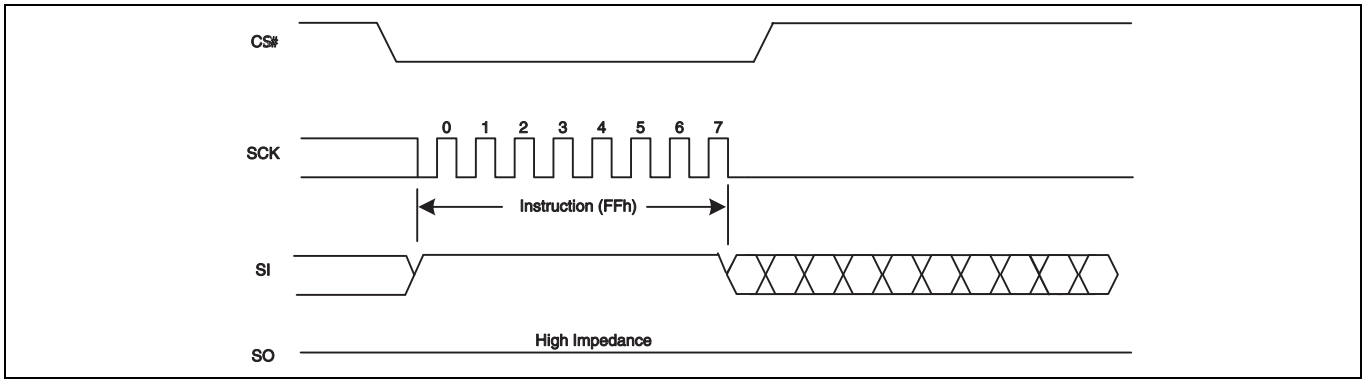


Figure 106 Mode Bit Reset command sequence

10.10 Embedded algorithm performance tables

The Joint Electron Device Engineering Council (JEDEC) standard JESD22-A117 defines the procedural requirements for performing valid endurance and retention tests based on a qualification specification. This methodology is intended to determine the ability of a flash device to sustain repeated data changes without failure (program/erase endurance) and to retain data for the expected life (data retention). Endurance and retention qualification specifications are specified in JESD47 or may be developed using knowledge-based methods as in JESD94.

Table 45 Program and erase performance

Symbol	Parameter	Min	Typ[44]	Max[45]	Unit
t_W	WRR write time		130	780	ms
t_{PP}	Page programming (512 bytes) Page programming (256 bytes)		640 395	1480 1185[46]	µs
t_{SE}	Sector erase time (64-KB / 4-KB physical sectors)		130	780[47]	ms
	Sector erase time (64 KB top/bottom: logical sector = 16 x 4-KB physical sectors)		2,100	12,600	ms
	Sector erase time (256-KB logical sectors = 4 x 64-KB physical sectors)		520	3120	ms
t_{BE}	Bulk erase time (hybrid 4 KB top/bottom with 64-KB uniform)		35	210	sec
	Bulk erase time (256-KB uniform)		33	200	sec
	Erase per sector	100,000			cycles

Notes

44. Typical program and erase times assume the following conditions: 25°C, V_{CC} = 3.0 V; random data pattern.
45. Under worst case conditions of 90 °C; 100,000 cycles max.
46. The programming time for any OTP programming command is the same as t_{PP}. This includes OTPP 42h, PNVDLR 43h, ASPP 2Fh, and PASSP E8h. The programming time for the PPBP E3h command is the same as t_{PP}.
47. The erase time for PPBE E4h command is the same as t_{SE}.
48. Data retention of 20 years is based on 1k erase cycles or less.

Table 46 Program suspend AC parameters

Parameter	Min	Typical	Max	Unit	Comments
Program Suspend Latency (t_{PSL})			45	µs	The time from Program Suspend command until the WIP bit is 0
Program Resume to next Program Suspend (t_{PRS})	0.06	100		µs	Minimum is the time needed to issue the next Program Suspend command but ≥ typical periods are needed for Program to progress to completion

Table 47 Erase suspend AC parameters

Parameter	Min	Typical	Max	Unit	Comments
Erase Suspend Latency (t_{ESL})			45	µs	The time from Erase Suspend command until the WIP bit is 0
Erase Resume to next Erase Suspend (t_{ERS})	0.06	100		µs	Minimum is the time needed to issue the next Erase Suspend command but ≥ typical periods are needed for the Erase to progress to completion

11 Data integrity

11.1 Erase endurance

Table 48 Erase endurance

Parameter	Minimum	Unit
Program/erase cycles per main Flash array sectors	100K	PE cycle
Program/erase cycles per PPB array or nonvolatile register array[49]	100K	PE cycle

Note
49. Each write command to a nonvolatile register causes a PE cycle on the entire nonvolatile register array. OTP bits and registers internally reside in a separate array that is not PE cycled.

11.2 Data retention

Table 49 Data retention

Parameter	Test conditions	Minimum time	Unit
Data Retention Time	10K program/erase cycles	20	Years
	100K program/erase cycles	2	Years

Contact Infineon Sales and FAE for further information on the data integrity. An application note is available at: **www.infineon.com/appnotes**.

12 Software interface reference

12.1 Command summary

Table 50 FL127S command set (sorted by instruction)

Parameter	Minimum	Unit	Parameter
01	WRR	Write Register (Status-1, Configuration-1)	108
02	PP	Page Program (3- or 4-byte address)	108
03	READ	Read (3- or 4-byte address)	50
04	WRDI	Write Disable	108
05	RDSR1	Read Status Register 1	108
06	WREN	Write Enable	108
07	RDSR2	Read Status Register 2	108
0B	FAST_READ	Fast Read (3- or 4-byte address)	108
0C	4FAST_READ	Fast Read (4-byte address)	108
12	4PP	Page Program (4-byte address)	108
13	4READ	Read (4-byte address)	50
14	ABRD	AutoBoot Register Read	108
15	ABWR	AutoBoot Register Write	108
16	BRRD	Bank Register Read	108
17	BRWR	Bank Register Write	108
18	ECCRD	ECC Read	108
20	P4E	Parameter 4 KB-sector Erase (3- or 4-byte address)	108
21	4P4E	Parameter 4 KB-sector Erase (4-byte address)	108
2B	ASPRD	ASP Read	108
2F	ASPP	ASP Program	108
30	CLSR	Clear Status Register - Erase/Program Fail Reset	108
32	QPP	Quad Page Program (3- or 4-byte address)	80
34	4QPP	Quad Page Program (4-byte address)	80
35	RDCR	Read Configuration Register 1	108
38	QPP	Quad Page Program (3- or 4-byte address)	80
3B	DOR	Read Dual Out (3- or 4-byte address)	108
3C	4DOR	Read Dual Out (4-byte address)	108
42	OTPP	OTP Program	108
4B	OTPR	OTP Read	108
5A	RSFDP	Read JEDEC Serial Flash Discoverable Parameters	108
60	BE	Bulk Erase	108
6B	QOR	Read Quad Out (3- or 4-byte address)	108
6C	4QOR	Read Quad Out (4-byte address)	108
75	ERSP	Erase Suspend	108
7A	ERRS	Erase Resume	108
85	PGSP	Program Suspend	108

Table 50 FL127S command set (sorted by instruction) (Continued)

Parameter	Minimum	Unit	Parameter
8A	PGRS	Program Resume	108
90	READ_ID (REMS)	Read Electronic Manufacturer Signature	108
9F	RDID	Read ID (JEDEC Manufacturer ID and JEDEC CFI)	108
A3	Reserved-A3	Reserved	108
A6	PLBWR	PPB Lock Bit Write	108
A7	PLBRD	PPB Lock Bit Read	108
AB	RES	Read Electronic Signature	50
B9	BRAC	Bank Register Access (Legacy Command formerly used for Deep Power Down)	108
BB	DIOR	Dual I/O Read (3- or 4-byte address)	108
BC	4DIOR	Dual I/O Read (4-byte address)	108
C7	BE	Bulk Erase (alternate command)	108
D8	SE	Erase 64 KB or 256 KB (3- or 4-byte address)	108
DC	4SE	Erase 64 KB or 256 KB (4-byte address)	108
E0	DYBRD	DYB Read	108
E1	DYBWR	DYB Write	108
E2	PPBRD	PPB Read	108
E3	PPBP	PPB Program	108
E4	PPBE	PPB Erase	108
E5	Reserved-E5	Reserved	
E6	Reserved-E6	Reserved	
E7	PASSRD	Password Read	108
E8	PASSP	Password Program	108
E9	PASSU	Password Unlock	108
EB	QIOR	Quad I/O Read (3- or 4-byte address)	108
EC	4QIOR	Quad I/O Read (4-byte address)	108
F0	RESET	Software Reset	108
FF	MBR	Mode Bit Reset	108

13 Serial flash discoverable parameters (SFDP) address map

The SFDP address space has a header starting at address 0 that identifies the SFDP data structure and provides a pointer to each parameter. One Basic Flash parameter is mandated by the JEDEC JESD216B standard. Two optional parameter tables for Sector Map and 4-byte Address Instructions follow the Basic Flash table. Cypress provides an additional parameter by pointing to the ID-CFI address space i.e. the IDCFI address space is a sub-set of the SFDP address space. The parameter tables portion of the SFDP data structure are located within the ID-CFI address space and is thus both a CFI parameter and an SFDP parameter. In this way both SFDP and ID-CFI information can be accessed by either the RSFDP or RDID commands.

Table 51 SFDP overview map

Parameter	Minimum
0000h	Location zero within JEDEC JESD216B SFDP space – start of SFDP header
,,,	Remainder of SFDP header followed by undefined space
1000h	Location zero within ID-CFI space – start of ID-CFI parameter tables
...	ID-CFI parameters
1120h	Start of SFDP parameter which is one of the CFI parameter tables
...	Remainder of SFDP parameter tables followed by either more CFI parameters or undefined space

Serial flash discoverable parameters (SFDP)
address map

13.1 SFDP header field definitions

Table 52 SFDP header

Parameter	Minimum	Unit	Parameter
00h	SFDP Header 1st DWORD	53h	This is the entry point for Read SFDP (5Ah) command i.e. location zero within SFDP space ASCII “S”
01h		46h	ASCII “F”
02h		44h	ASCII “D”
03h		50h	ASCII “P”
04h	SFDP Header 2nd DWORD	06h	SFDP Minor Revision (06h = JEDEC JESD216 Revision B) This revision is backward compatible with all prior minor revisions. Minor revisions are changes that define previously reserved fields, add fields to the end, or that clarify definitions of existing fields. Increments of the minor revision value indicate that previously reserved parameter fields may have been assigned a new definition or entire Dwords may have been added to the parameter table. However, the definition of previously existing fields is unchanged and therefore remain backward compatible with earlier SFDP parameter table revisions. Software can safely ignore increments of the minor revision number, as long as only those parameters the software was designed to support are used i.e. previously reserved fields and additional Dwords must be masked or ignored. Do not do a simple compare on the minor revision number, looking only for a match with the revision number that the software is designed to handle. There is no problem with using a higher number minor revision.
05h		01h	SFDP Major Revision. This is the original major revision. This major revision is compatible with all SFDP reading and parsing software.
06h		05h	Number of Parameter Headers (zero based, 05h = 6 parameters)
07h		FFh	Unused
08h	Parameter Header 0 1st DWORD	00h	Parameter ID LSb (00h = JEDEC SFDP Basic SPI Flash Parameter)
09h		00h	Parameter Minor Revision (00h = JESD216) - This older revision parameter header is provided for any legacy SFDP reading and parsing software that requires seeing a minor revision 0 parameter header. SFDP software designed to handle later minor revisions should continue reading parameter headers looking for a higher numbered minor revision that contains additional parameters for that software revision.
0Ah		01h	Parameter Major Revision (01h = The original major revision - all SFDP software is compatible with this major revision.
0Bh		09h	Parameter Table Length (in double words = Dwords = 4 byte units) 09h = 9 Dwords
0Ch	Parameter Header 0 2nd DWORD	20h	Parameter Table Pointer Byte 0 (Dword = 4 byte aligned) JEDEC Basic SPI Flash parameter byte offset = 1120h
0Dh		11h	Parameter Table Pointer Byte 1
0Eh		00h	Parameter Table Pointer Byte 2
0Fh		FFh	Parameter ID MSb (FFh = JEDEC defined legacy Parameter ID)

Serial flash discoverable parameters (SFDP) address map

Table 52 SFDP header (Continued)

Parameter	Minimum	Unit	Parameter
10h	Parameter Header 1 1st DWORD	00h	Parameter ID LSb (00h = JEDEC SFDP Basic SPI Flash Parameter)
11h		05h	Parameter Minor Revision (05h = JESD216 Revision A) - This older revision parameter header is provided for any legacy SFDP reading and parsing software that requires seeing a minor revision 5 parameter header. SFDP software designed to handle later minor revisions should continue reading parameter headers looking for a later minor revision that contains additional parameters.
12h		01h	Parameter Major Revision (01h = The original major revision - all SFDP software is compatible with this major revision.
13h		10h	Parameter Table Length (in double words = Dwords = 4 byte units) 10h = 16 Dwords
14h	Parameter Header 1 2nd DWORD	20h	Parameter Table Pointer Byte 0 (Dword = 4 byte aligned) JEDEC Basic SPI Flash parameter byte offset = 1120h address
15h		11h	Parameter Table Pointer Byte 1
16h		00h	Parameter Table Pointer Byte 2
17h		FFh	Parameter ID MSb (FFh = JEDEC defined Parameter)
18h	Parameter Header 2 1st DWORD	00h	Parameter ID LSb (00h = JEDEC SFDP Basic SPI Flash Parameter)
19h		06h	Parameter Minor Revision (06h = JESD216 Revision B)
1Ah		01h	Parameter Major Revision (01h = The original major revision - all SFDP software is compatible with this major revision.
1Bh		10h	Parameter Table Length (in double words = Dwords = 4 byte units) 10h = 16 Dwords
1Ch	Parameter Header 2 2nd DWORD	20h	Parameter Table Pointer Byte 0 (Dword = 4 byte aligned) JEDEC Basic SPI Flash parameter byte offset = 1120h address
1Dh		11h	Parameter Table Pointer Byte 1
1Eh		00h	Parameter Table Pointer Byte 2
1Fh		FFh	Parameter ID MSb (FFh = JEDEC defined Parameter)
20h	Parameter Header 3 1st DWORD	81h	Parameter ID LSb (81h = SFDP Sector Map Parameter)
21h		00h	Parameter Minor Revision (00h = Initial version as defined in JESD216 Revision B)
22h		01h	Parameter Major Revision (01h = The original major revision - all SFDP software that recognizes this parameter's ID is compatible with this major revision.
23h		0Eh	Parameter Table Length (in double words = Dwords = 4 byte units) 0Eh = 14 Dwords
24h	Parameter Header 3 2nd DWORD	60h	Parameter Table Pointer Byte 0 (Dword = 4 byte aligned) JEDEC parameter byte offset = 1160h
25h		11h	Parameter Table Pointer Byte 1
26h		00h	Parameter Table Pointer Byte 2
27h		FFh	Parameter ID MSb (FFh = JEDEC defined Parameter)

Serial flash discoverable parameters (SFDP) address map

Table 52 SFDP header (Continued)

Parameter	Minimum	Unit	Parameter
28h	Parameter Header 4 1st DWORD	84h	Parameter ID LSb (00h = SFDP 4 Byte Address Instructions Parameter)
29h		00h	Parameter Minor Revision (00h = Initial version as defined in JESD216 Revision B)
2Ah		01h	Parameter Major Revision (01h = The original major revision - all SFDP software that recognizes this parameter's ID is compatible with this major revision.
2Bh		02h	Parameter Table Length (in double words = Dwords = 4 byte units) (2h = 2 Dwords)
2Ch	Parameter Header 4 2nd DWORD	98h	Parameter Table Pointer Byte 0 (Dword = 4 byte aligned) JEDEC parameter byte offset = 1198h
2Dh		11h	Parameter Table Pointer Byte 1
2Eh		00h	Parameter Table Pointer Byte 2
2Fh		FFh	Parameter ID MSb (FFh = JEDEC defined Parameter)
30h	Parameter Header 5 1st DWORD	01h	Parameter ID LSb (Cypress Vendor Specific ID-CFI parameter) Legacy Manufacturer ID 01h = AMD / Cypress
31h		01h	Parameter Minor Revision (01h = ID-CFI updated with SFDP Rev B table)
32h		01h	Parameter Major Revision (01h = The original major revision - all SFDP software that recognizes this parameter's ID is compatible with this major revision.
33h		68h	Parameter Table Length (in double words = Dwords = 4 byte units) CFI starts at 1000h, the final SFDP parameter (CFI ID = A5) starts at 111Eh (SFDP starting point of 1120h -2hB of CFI parameter header), for a length of 11EhB excluding the CFI A5 parameter. The final CFI A5 parameter adds an additional 82hB for a total of 11Eh + 82h = 1A0hB. 1A0hB/4 = 68h Dwords
34h	Parameter Header 5 2nd DWORD	00h	Parameter Table Pointer Byte 0 (Dword = 4 byte aligned) Entry point for ID-CFI parameter is byte offset = 1000h relative to SFDP location zero.
35h		10h	Parameter Table Pointer Byte 1
36h		00h	Parameter Table Pointer Byte 2
37h		01h	Parameter ID MSb (01h = JEDEC JEP106 Bank Number 1)

Serial flash discoverable parameters (SFDP) address map

13.2 Device ID and Common Flash Interface (ID-CFI) address map

13.2.1 Field definitions

Table 53 Manufacturer and Device ID

Byte address	Data	Description
00h	01h	Manufacturer ID for Cypress
01h	20h (128 Mb)	Device ID Most Significant Byte - Memory Interface Type
02h	18h (128 Mb)	Device ID Least Significant Byte - Density
03h	4Dh	ID-CFI Length - number bytes following. Adding this value to the current location of 03h gives the address of the last valid location in the legacy ID-CFI address map. This only includes up to the end of the Primary Vendor Specific table. The Alternate Vendor Specific table contains additional information.
04h	00h (Uniform 256-KB sectors) 01h (4-KB parameter sectors with uniform 64-KB sectors)	Sector Architecture
05h	80h (FL-S Family)	Family ID
06h	xxh	ASCII characters for Model Refer to **"Ordering information"** on page 168 for the model number definitions.
07h	xxh	
08h	xxh	Reserved
09h	xxh	Reserved
0Ah	xxh	Reserved
0Bh	xxh	Reserved
0Ch	xxh	Reserved
0Dh	xxh	Reserved
0Eh	xxh	Reserved
0Fh	xxh	Reserved

Table 54 CFI query identification string

Byte address	Data	Description
10h 11h 12h	51h 52h 59h	Query Unique ASCII string "QRY"
13h 14h	02h 00h	Primary OEM Command Set FL-P backward compatible command set ID
15h 16h	40h 00h	Address for Primary Extended Table
17h 18h	53h 46h	Alternate OEM Command Set ASCII characters "FS" for SPI (F) interface, S Technology
19h 1Ah	51h 00h	Address for Alternate OEM Extended Table

Serial flash discoverable parameters (SFDP) address map

Table 55 CFI system interface string

Byte address	Data	Description
1Bh	27h	V_{CC} Min. (erase/program): 100 millivolts
1Ch	36h	V_{CC} Max. (erase/program): 100 millivolts
1Dh	00h	V_{PP} Min. voltage (00h = no V_{PP} present)
1Eh	00h	V_{PP} Max. voltage (00h = no V_{PP} present)
1Fh	06h	Typical timeout per single byte program 2^N µs
20h	0Ah (256B page) 0Ah (512B page)	Typical timeout for Min. size Page program 2^N µs (00h = not supported)
21h	08h (4 KB or 64 KB) 0Ah (256 KB)	Typical timeout per individual sector erase 2^N ms
22h	0Fh (128 Mb)	Typical timeout for full chip erase 2^N ms (00h = not supported)
23h	02h	Max. timeout for byte program 2^N times typical
24h	02h	Max. timeout for page program 2^N times typical
25h	03h	Max. timeout per individual sector erase 2^N times typical
26h	03h	Max. timeout for full chip erase 2^N times typical (00h = not supported)

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Table 56 Device geometry definition for bottom boot initial delivery state

Byte address	Data	Description
27h	18h (128 Mb)	Device Size = 2^N bytes;
28h	02h	Flash Device Interface Description; 0000h = x8 only 0001h = x16 only 0002h = x8/x16 capable 0003h = x32 only 0004h = Single I/O SPI, 3-byte address 0005h = Multi I/O SPI, 3-byte address 0102h = Multi I/O SPI, 3- or 4-byte address
29h	01h	
2Ah	08h	Max. number of bytes in multi-byte write = 2^N (0000 = not supported 0008h = 256B page 0009h = 512B page)
2Bh	00h	
2Ch	02h	Number of Erase Block Regions within device 1 = Uniform Device, 2 = Boot Device
2Dh	0Fh	Erase Block Region 1 Information (refer to JEDEC JEP137) 16 sectors = 16-1 = 000Fh 4-KB sectors = 256 bytes x 0010h
2Eh	00h	
2Fh	10h	
30h	00h	
31h	FEh	Erase Block Region 2 Information 255 sectors = 255-1 = 00FEh (128 Mb) 64-KB sectors = 0100h x 256 bytes
32h	00h (128 Mb)	
33h	00h	
34h	01h	
35h thru 3Fh	FFh	RFU

Note

50. FL127S 128 Mb devices have either a hybrid sector architecture with sixteen 4 KB sectors and all remaining sectors of 64 KB or with uniform 256 KB sectors. Devices with the hybrid sector architecture are initially shipped from Cypress with the 4 KB sectors located at the bottom of the array address map. However, the device configuration TBPARM bit CR1[2] may be programed to invert the sector map to place the 4 KB sectors at the top of the array address map. The CFI geometry information of the above table is relevant only to the initial delivery state of a hybrid sector device. The Flash device driver software must examine the TBPARM bit to determine if the sector map was inverted at a later time.

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Table 57 Device geometry definition for uniform sector devices

Byte address	Data	Description
27h	18h (128 Mb)	Device Size = 2^N bytes;
28h	02h	Flash Device Interface Description; 0000h = x8 only 0001h = x16 only 0002h = x8/x16 capable 0003h = x32 only 0004h = Single I/O SPI, 3-byte address 0005h = Multi I/O SPI, 3-byte address 0102h = Multi I/O SPI, 3- or 4-byte address
29h	01h	
2Ah	09h	Max. number of bytes in multi-byte write = 2^N (0000 = not supported 0008h = 256B page 0009h = 512B page)
2Bh	00h	
2Ch	01h	Number of Erase Block Regions within device 1 = Uniform Device, 2 = Boot Device
2Dh	3Fh (128 Mb)	Erase Block Region 1 Information (refer to JEDEC JEP137) 64 sectors = 64-1 = 003Fh (128 Mb) 256-KB sectors = 256 bytes x 0400h
2Eh	00h	
2Fh	00h	
30h	04h	
31h thru 3Fh	FFh	RFU

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Table 58 CFI primary vendor-specific extended query

Byte address	Data	Description
40h	50h	Query-unique ASCII string “PRI”
41h	52h	
42h	49h	
43h	31h	Major version number = 1, ASCII
44h	33h	Minor version number = 3, ASCII
45h	21h	Address Sensitive Unlock (Bits 1–0) 00b = Required 01b = Not Required Process Technology (Bits 5-2) 0000b = 0.23 µm Floating Gate 0001b = 0.17 µm Floating Gate 0010b = 0.23 µm MirrorBit 0011b = 0.11 µm Floating Gate 0100b = 0.11 µm MirrorBit 0101b = 0.09 µm MirrorBit 1000b = 0.065 µm MirrorBit
46h	02h	Erase Suspend 0 = Not Supported 1 = Read Only 2 = Read and Program
47h	01h	Sector Protect 00 = Not Supported X = Number of sectors in group
48h	00h	Temporary Sector Unprotect 00 = Not Supported 01 = Supported
49h	08h	Sector Protect/Unprotect Scheme 04 = High Voltage Method 05 = Software Command Locking Method 08 = Advanced Sector Protection Method 09 = Secure
4Ah	00h	Simultaneous Operation 00 = Not Supported X = Number of Sectors
4Bh	01h	Burst Mode (Synchronous sequential read) support 00 = Not Supported 01 = Supported
4Ch	Model Dependent 03h (Models x0) 04h (Models x1)	Page Mode Type, model dependent 00 = Not Supported 01 = 4 Word Read Page 02 = 8 Read Word Page 03 = 256-Byte Program Page 04 = 512-Byte Program Page
4Dh	00h	ACC (Acceleration) Supply Minimum 00 = Not Supported, 100 mV
4Eh	00h	ACC (Acceleration) Supply Maximum 00 = Not Supported, 100 mV

Serial flash discoverable parameters (SFDP)
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Table 58 CFI primary vendor-specific extended query (Continued)

Byte address	Data	Description
4Fh	07h	WP# Protection 01 = Whole Chip 04 = Uniform Device with Bottom WP Protect 05 = Uniform Device with Top WP Protect 07 = Uniform Device with Top or Bottom Write Protect (user select)
50h	01h	Program Suspend 00 = Not Supported 01 = Supported

The alternate vendor-specific extended query provides information related to the expanded command set provided by the FL-S family. The alternate query parameters use a format in which each parameter begins with an identifier byte and a parameter length byte. Driver software can check each parameter ID and can use the length value to skip to the next parameter if the parameter is not needed or not recognized by the software.

Table 59 CFI alternate vendor-specific extended query header

Byte address	Data	Description
51h	41h	Query-unique ASCII string “ALT”
52h	4Ch	
53h	54h	
54h	32h	Major version number = 2, ASCII
55h	30h	Minor version number = 0, ASCII

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Table 60 CFI Alternate Vendor-Specific Extended Query Parameter 0

Parameter relative byte address offset	Data	Description
00h	00h	Parameter ID (ordering part number)
01h	10h	Parameter Length (The number of following bytes in this parameter. Adding this value to the current location value + 1 = the first byte of the next parameter)
02h	53h	ASCII “S” for manufacturer (Infineon)
03h	32h	ASCII “25” for Product Characters (Single Die SPI)
04h	35h	
05h	46h	ASCII “FL” for Interface Characters (SPI 3 Volt)
06h	4Ch	
07h	31h (128 Mb)	ASCII characters for density
08h	32h (128 Mb)	
09h	38h (128 Mb)	
0Ah	53h	ASCII “S” for technology (65-nm MIRRORBIT™)
0Bh	41h	ASCII characters for speed grade Refer to **“Ordering information”** on page 168 for the speed grade definitions.
0Ch	42h	
0Dh	3Fh	ASCII “??” for Package (Generally the package is not specified for an individual memory device because the choice of package is generally made after the device is tested and this parameter is programmed. However, space is provided in this parameter for special cases where devices are tested and programmed for use only in a specific package)
0Eh	3Fh	
0Fh	49h	ASCII character for temperature range
10h	xxh	ASCII characters for Model Refer to **“Ordering information”** on page 168 for the model number definitions.
11h	xxh	

Table 61 CFI Alternate Vendor-Specific Extended Query Parameter 80h Address Options

Parameter relative byte address offset	Data	Description
00h	80h	Parameter ID (address options)
01h	01h	Parameter Length (The number of following bytes in this parameter. Adding this value to the current location value + 1 = the first byte of the next parameter)
02h	F0h	Bits 7:4 - Reserved = 1111b Bit 3 - AutoBoot support - Ye s= 0b, No = 1b Bit 2 - 4-byte address instructions supported - Yes = 0b, No = 1b Bit 1 - Bank address + 3-byte address instructions supported - Yes = 0b, No = 1b Bit 0 - 3-byte address instructions supported - Yes = 0b, No = 1b

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Table 62 CFI Alternate Vendor-Specific Extended Query Parameter 84h Suspend Commands

Parameter relative byte address offset	Data	Description
00h	84h	Parameter ID (Suspend Commands)
01h	08h	Parameter Length (The number of following bytes in this parameter. Adding this value to the current location value + 1 = the first byte of the next parameter)
02h	85h	Program suspend instruction code
03h	2Dh	Program suspend latency maximum (µs)
04h	8Ah	Program resume instruction code
05h	64h	Program resume to next suspend typical (µs)
06h	75h	Erase suspend instruction code
07h	2Dh	Erase suspend latency maximum (µs)
08h	7Ah	Erase resume instruction code
09h	64h	Erase resume to next suspend typical (µs)

Table 63 CFI Alternate Vendor-Specific Extended Query Parameter 88h Data Protection commands

Parameter relative byte address offset	Data	Description
00h	88h	Parameter ID (Data Protection)
01h	04h	Parameter Length (The number of following bytes in this parameter. Adding this value to the current location value + 1 = the first byte of the next parameter)
02h	0Ah	OTP size 2^N bytes, FFh = not supported
03h	01h	OTP address map format, 01h = FL-S format, FFh = not supported
04h	xxh	Block Protect Type, model dependent 00h = FL-P, FL-S, FFh = not supported
05h	xxh	Advanced Sector Protection type, model dependent 01h = FL-S ASP.

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Table 64 CFI Alternate Vendor-Specific Extended Query Parameter 8Ch Reset Timing

Parameter relative byte address offset	Data	Description
00h	8Ch	Parameter ID (Reset Timing)
01h	06h	Parameter Length (The number of following bytes in this parameter. Adding this value to the current location value + 1 = the first byte of the next parameter)
02h	96h	POR maximum value
03h	01h	POR maximum exponent 2^N µs
04h	FFh (without RESET# input) 23h (with RESET# input)	Hardware Reset maximum value
05h	00h	Hardware Reset maximum exponent 2^N µs
06h	23h	Software Reset maximum value, FFh = not supported
07h	00h	Software Reset maximum exponent 2^N µs

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Table 65 CFI Alternate Vendor-Specific Extended Query Parameter 90h – latency code

Parameter relative byte address offset	Data	Description
00h	90h	Parameter ID (Latency Code Table)
01h	56h	Parameter Length (The number of following bytes in this parameter. Adding this value to the current location value + 1 = the first byte of the next parameter)
02h	06h	Number of rows
03h	0Eh	Row length in bytes
04h	46h	Start of header (row 1), ASCII “F” for frequency column header
05h	43h	ASCII “C” for Code column header
06h	03h	Read 3-byte address instruction
07h	13h	Read 4-byte address instruction
08h	0Bh	Read Fast 3-byte address instruction
09h	0Ch	Read Fast 4-byte address instruction
0Ah	3Bh	Read Dual Out 3-byte address instruction
0Bh	3Ch	Read Dual Out 4-byte address instruction
0Ch	6Bh	Read Quad Out 3-byte address instruction
0Dh	6Ch	Read Quad Out 4-byte address instruction
0Eh	BBh	Dual I/O Read 3-byte address instruction
0Fh	BCh	Dual I/O Read 4-byte address instruction
10h	EBh	Quad I/O Read 3-byte address instruction
11h	ECh	Quad I/O Read 4-byte address instruction
12h	32h	Start of row 2, SCK frequency limit for this row (50 MHz)
13h	03h	Latency Code for this row (11b)
14h	00h	Read mode cycles
15h	00h	Read latency cycles
16h	00h	Read Fast mode cycles
17h	00h	Read Fast latency cycles
18h	00h	Read Dual Out mode cycles
19h	00h	Read Dual Out latency cycles
1Ah	00h	Read Quad Out mode cycles
1Bh	00h	Read Quad Out latency cycles
1Ch	04h	Dual I/O Read mode cycles
1Dh	00h	Dual I/O Read latency cycles
1Eh	02h	Quad I/O Read mode cycles
1Fh	01h	Quad I/O Read latency cycles
20h	50h	Start of row 3, SCK frequency limit for this row (80 MHz)
21h	00h	Latency Code for this row (00b)
22h	FFh	Read mode cycles (FFh = command not supported at this frequency)

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Table 65 CFI Alternate Vendor-Specific Extended Query Parameter 90h – latency code (Continued)

Parameter relative byte address offset	Data	Description
23h	FFh	Read latency cycles
24h	00h	Read Fast mode cycles
25h	08h	Read Fast latency cycles
26h	00h	Read Dual Out mode cycles
27h	08h	Read Dual Out latency cycles
28h	00h	Read Quad Out mode cycles
29h	08h	Read Quad Out latency cycles
2Ah	04h	Dual I/O Read mode cycles
2Bh	00h	Dual I/O Read latency cycles
2Ch	02h	Quad I/O Read mode cycles
2Dh	04h	Quad I/O Read latency cycles
2Eh	5Ah	Start of row 4, SCK frequency limit for this row (90 MHz)
2Fh	01h	Latency Code for this row (01b)
30h	FFh	Read mode cycles (FFh = command not supported at this frequency)
31h	FFh	Read latency cycles
32h	00h	Read Fast mode cycles
33h	08h	Read Fast latency cycles
34h	00h	Read Dual Out mode cycles
35h	08h	Read Dual Out latency cycles
36h	00h	Read Quad Out mode cycles
37h	08h	Read Quad Out latency cycles
38h	04h	Dual I/O Read mode cycles
39h	01h	Dual I/O Read latency cycles
3Ah	02h	Quad I/O Read mode cycles
3Bh	04h	Quad I/O Read latency cycles
3Ch	68h	Start of row 5, SCK frequency limit for this row (108 MHz)
3Dh	02h	Latency Code for this row (10b)
3Eh	FFh	Read mode cycles (FFh = command not supported at this frequency)
3Fh	FFh	Read latency cycles
40h	00h	Read Fast mode cycles
41h	08h	Read Fast latency cycles
42h	00h	Read Dual Out mode cycles
43h	08h	Read Dual Out latency cycles
44h	00h	Read Quad Out mode cycles
45h	08h	Read Quad Out latency cycles
46h	04h	Dual I/O Read mode cycles
47h	02h	Dual I/O Read latency cycles
48h	02h	Quad I/O Read mode cycles

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Table 65 CFI Alternate Vendor-Specific Extended Query Parameter 90h – latency code (Continued)

Parameter relative byte address offset	Data	Description
49h	05h	Quad I/O Read latency cycles
4Ah	85h	Start of row 6, SCK frequency limit for this row (133 MHz)
4Bh	02h	Latency Code for this row (10b)
4Ch	FFh	Read mode cycles (FFh = command not supported at this frequency)
4Dh	FFh	Read latency cycles
4Eh	00h	Read Fast mode cycles
4Fh	08h	Read Fast latency cycles
50h	FFh	Read Dual Out mode cycles
51h	FFh	Read Dual Out latency cycles
52h	FFh	Read Quad Out mode cycles
53h	FFh	Read Quad Out latency cycles
54h	FFh	Dual I/O Read mode cycles
55h	FFh	Dual I/O Read latency cycles
56h	FFh	Quad I/O Read mode cycles
57h	FFh	Quad I/O Read latency cycles

Table 66 CFI Alternate Vendor-Specific Extended Query Parameter F0h RFU

Parameter relative byte address offset	Data	Description
00h	F0h	Parameter ID (RFU)
01h	0Fh	Parameter Length (The number of following bytes in this parameter. Adding this value to the current location value + 1 = the first byte of the next parameter)
02h	FFh	RFU
...	FFh	RFU
10h	FFh	RFU

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This parameter type (Parameter ID F0h) may appear multiple times and have a different length each time. The parameter is used to reserve space in the ID-CFI map or to force space (pad) to align a following parameter to a required boundary.

Table 67 CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP Rev B

CFI parameter relative byte address offset	SFDP parameter relative byte address offset	SFDP Dword name	Data	Description
00h	—	N/A	A5h	CFI Parameter ID (A5h = JEDEC SFDP)
01h	—	N/A	80h	CFI Parameter Length (The number of following bytes in this parameter. Adding this value to the current location value + 1 = the first byte of the next parameter)
02h	00h	JEDEC Basic Flash Parameter Dword-1	E7h	Start of SFDP JEDEC parameter, located at 1120h in the overall SFDP address space. Bits 7:5 = unused = 111b Bit 4:3 = 06h is status register write instruction & status register is default nonvolatile= 00b Bit 2 = Program Buffer > 64Bytes = 1 Bits 1:0 = Uniform 4KB erase unavailable = 11b
03h	01h		FFh	Bits 15:8 = Uniform 4KB erase opcode = not supported = FFh
04h	02h		F3h (FLxxxSAG)	Bit 23 = Unused = 1b Bit 22 = Supports Quad Out Read, Yes = 1b Bit 21 = Supports Quad I/O Read, Yes =1b Bit 20 = Supports Dual I/O Read, Yes = 1b Bit19 = Supports DDR, No = 0h Bit 18:17 = Number of Address Bytes, 3 or 4 = 01b Bit 16 = Supports Dual Out Read, Yes = 1b
05h	03h		FFh	Bits 31:24 = Unused = FFh
06h	04h	JEDEC Basic Flash Parameter Dword-2	FFh	Density in bits, zero based, 128Mb = 07FFFFFFh
07h	05h		FFh	
08h	06h		FFh	
09h	07h		07h	
0Ah	08h	JEDEC Basic Flash Parameter Dword-3	44h	Bits 7:5 = number of Quad I/O Mode cycles = 010b Bits 4:0 = number of Quad I/O Dummy cycles = 00100b for default latency code 00b
0Bh	09h		EBh	Quad I/O instruction code
0Ch	0Ah		08h	Bits 23:21 = number of Quad Out Mode cycles = 000b Bits 20:16 = number of Quad Out Dummy cycles = 01000b
0Dh	0Bh		6Bh	Quad Out instruction code

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Table 67 CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP Rev B (Continued)

CFI parameter relative byte address offset	SFDP parameter relative byte address offset	SFDP Dword name	Data	Description
0Eh	0Ch	JEDEC Basic Flash Parameter Dword-4	08h	Bits 7:5 = number of Dual Out Mode cycles = 000b Bits 4:0 = number of Dual Out Dummy cycles = 01000b for default latency code
0Fh	0Dh		3Bh	Dual Out instruction code
10h	0Eh		80h	Bits 23:21 = number of Dual I/O Mode cycles 20:16 = number of Dual I/O Dummy cycles Default Latency code = 00b
11h	0Fh		BBh	Dual I/O instruction code
12h	10h	JEDEC Basic Flash Parameter Dword-5	EEh	Bits 7:5 RFU = 111b Bit 4 = Quad All not supported = 0b Bits 3:1 RFU = 111b Bit 0 = Dual All not supported = 0b
13h	11h		FFh	Bits 15:8 = RFU = FFh
14h	12h		FFh	Bits 23:16 = RFU = FFh
15h	13h		FFh	Bits 31:24 = RFU = FFh
16h	14h	JEDEC Basic Flash Parameter Dword-6	FFh	Bits 7:0 = RFU = FFh
17h	15h		FFh	Bits 15:8 = RFU = FFh
18h	16h		FFh	Bits 23:21 = number of Dual All Mode cycles = 111b Bits 20:16 = number of Dual All Dummy cycles = 11111b
19h	17h		FFh	Dual All instruction code
1Ah	18h	JEDEC Basic Flash Parameter Dword-7	FFh	Bits 7:0 = RFU = FFh
1Bh	19h		FFh	Bits 15:8 = RFU = FFh
1Ch	1Ah		FFh	Bits 23:21 = number of Quad All Mode cycles = 111b Bits 20:16 = number of Quad All Dummy cycles = 11111b
1Dh	1Bh		FFh	Quad All instruction code
1Eh	1Ch	JEDEC Basic Flash Parameter Dword-8	0Ch	Erase type 1 size 2^N Bytes = 4KB = 0Ch (for Hybrid Sector Initial Delivery State)
1Fh	1Dh		20h	Erase type 1 instruction
20h	1Eh		10h	Erase type 2 size 2^N Bytes = 64KB = 10h (for Hybrid Sector Initial Delivery State)
21h	1Fh		D8h	Erase type 2 instruction
22h	20h	JEDEC Basic Flash Parameter Dword-9	12h	Erase type 3 size 2^N Bytes = 256KB = 12h (if Uniform Sectors enabled)
23h	21h		D8h	Erase type 3 instruction
24h	22h		00h	Erase type 4 size 2^N Bytes = not supported = 00h
25h	23h		FFh	Erase type 4 instruction = not supported = FFh

Serial flash discoverable parameters (SFDP) address map

Table 67 CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP Rev B (Continued)

CFI parameter relative byte address offset	SFDP parameter relative byte address offset	SFDP Dword name	Data	Description
26h	24h	JEDEC Basic Flash Parameter Dword-10	82h	Bits 31:30 = Erase type 4 Erase, Typical time units (00b: 1 ms, 01b: 16 ms, 10b: 128 ms, 11b: 1 s) = RFU = 11b Bits 29:25 = Erase type 4 Erase, Typical time count = RFU = 11111b (typ erase time = count + 1 * units = RFU) Bits 24:23 = Erase type 3 Erase, Typical time units (00b: 1 ms, 01b: 16 ms, 10b: 128 ms, 11b: 1 s) = 128mS = 10b Bits 22:18 = Erase type 3 Erase, Typical time count = 00011b (typ erase time = count + 1 * units = 4 * 128 ms = 512 ms) Bits 17:16 = Erase type 2 Erase, Typical time units (00b: 1 ms, 01b: 16 ms, 10b: 128 ms, 11b: 1 s) = 128 ms = 10b Bits 15:11 = Erase type 2 Erase, Typical time count = 00000b (typ erase time = count + 1 * units = 1 * 128 ms = 128 ms) Bits 10:9 = Erase type 1 Erase, Typical time units (00b: 1 ms, 01b: 16 ms, 10b: 128 ms, 11b: 1 s) = 16 ms = 01b Bits 8:4 = Erase type 1 Erase, Typical time count = 01000b (typ erase time = count + 1 * units = 9 * 16 ms = 144 ms) Bits 3:0 = Multiplier from typical erase time to maximum erase time = 2 * (N + 1), N = 2h = 6x multiplier Binary Fields: 11-11111-10-00011-10-00000-01-01000-0010 Nibble Format: 1111_1111_0000_1110_0000_0010_1000_0010 Hex Format: FF_0E_02_82
27h	25h		02h	
28h	26h		0Eh	
29h	27h		FFh	

Serial flash discoverable parameters (SFDP)
address map

Table 67 CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP Rev B (Continued)

CFI parameter relative byte address offset	SFDP parameter relative byte address offset	SFDP Dword name	Data	Description
2Ah	28h	JEDEC Basic Flash Parameter Dword-11	92h	Bit 31 Reserved = 1b Bits 30:29 = Chip Erase, Typical time units (00b: 16 ms, 01b: 256 ms, 10b: 4 s, 11b: 64 s) = 4s = 10b Bits 28:24 = Chip Erase, Typical time count, (count + 1) * units, count = 01000b, (typ Program time = count + 1 * units = 9 * 4 s = 36 s Bits 23 = Byte Program Typical time, additional byte units (0b:1 µs, 1b:8 µs) = 1 µs = 0b Bits 22:19 = Byte Program Typical time, additional byte count, (count + 1) * units, count = 0000b, (typ Program time = count + 1 * units = 1 * 1 µs = 1 µs Bits 18 = Byte Program Typical time, first byte units (0b:1 µs, 1b:8 µs) = 8 µs = 1b Bits 17:14 = Byte Program Typical time, first byte count, (count + 1) * units, count = 1100b, (typ Program time = count + 1 * units = 13 * 8 µs = 104 µs Bits 13 = Page Program Typical time units (0b:8 µs, 1b:64 µs) = 64 µs = 1b Bits 12:8 = Page Program Typical time count, (count + 1)*units, count = 01001b, (typ Program time = count + 1 * units = 10 * 64 µs = 640 µs) Bits 7:4 = Page size 2^N, N = 9h, = 512B page Bits 3:0 = Multiplier from typical time to maximum for Page or Byte program = 2 * (N + 1), N = 2h = 6x multiplier Binary Fields: 1-10-01000-0-0000-1-1100-1-01001-1001-0010 Nibble Format: 1100_1000_0000_0111_0010_1001_1001_0010 Hex Format: C8_07_29_92
2Bh	29h		29h	
2Ch	2Ah		07h	
2Dh	2Bh		C8h	

Serial flash discoverable parameters (SFDP) address map

Table 67 CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP Rev B (Continued)

CFI parameter relative byte address offset	SFDP parameter relative byte address offset	SFDP Dword name	Data	Description
2Eh	2Ch	JEDEC Basic Flash Parameter Dword-12	ECh	Bit 31 = Suspend and Resume supported = 0b Bits 30:29 = Suspend in-progress erase max latency units (00b: 128 ns, 01b: 1 µs, 10b: 8 µs, 11b: 64 µs) = 8 µs= 10b Bits 28:24 = Suspend in-progress erase max latency count = 00101b, max erase suspend latency = count + 1 * units = 6 * 8 µs = 48 µs Bits 23:20 = Erase resume to suspend interval count = 0001b, interval = count + 1 * 64 µs = 2 * 64 µs = 128 µs Bits 19:18 = Suspend in-progress program max latency units (00b: 128 ns, 01b: 1 µs, 10b: 8 µs, 11b: 64 µs) = 8 µs= 10b Bits 17:13 = Suspend in-progress program max latency count = 00101b, max erase suspend latency = count + 1 * units = 6 * 8 µs = 48 µs Bits 12:9 = Program resume to suspend interval count = 0001b, interval = count + 1 * 64 µs = 2 * 64 µs = 128 µs Bit 8 = RFU = 1b Bits 7:4 = Prohibited operations during erase suspend = xxx0b: May not initiate a new erase anywhere (erase nesting not permitted) + xx1xb: May not initiate a page program in the erase suspended sector size + x1xxb: May not initiate a read in the erase suspended sector size + 1xxxb: The erase and program restrictions in bits 5:4 are sufficient = 1110b Bits 3:0 = Prohibited Operations During Program Suspend = xxx0b: May not initiate a new erase anywhere (erase nesting not permitted) + xx0xb: May not initiate a new page program anywhere (program nesting not permitted) + x1xxb: May not initiate a read in the program suspended page size + 1xxxb: The erase and program restrictions in bits 1:0 are sufficient = 1100b Binary Fields: 0-10-00101-0001-10-00101-0001-1-1110-1100 Nibble Format: 0100_0101_0001_1000_1010_0011_1110_1100 Hex Format: 45_18_A3_EC
2Fh	2Dh		A3h	
30h	2Eh		18h	
31h	2Fh		45h	

Serial flash discoverable parameters (SFDP)
address map

Table 67 CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP Rev B (Continued)

CFI parameter relative byte address offset	SFDP parameter relative byte address offset	SFDP Dword name	Data	Description
32h	30h	JEDEC Basic Flash Parameter Dword-13	8Ah	Bits 31:24 = Erase Suspend Instruction = 75h Bits 23:16 = Erase Resume Instruction = 7Ah Bits 15:8 = Program Suspend Instruction = 85h Bits 7:0 = Program Resume Instruction = 8Ah
33h	31h		85h	
34h	32h		7Ah	
35h	33h		75h	
36h	34h	JEDEC Basic Flash Parameter Dword-14	F7h	Bit 31 = Deep Power Down Supported = not supported = 1 Bits 30:23 = Enter Deep Power Down Instruction = not supported = FFh Bits 22:15 = Exit Deep Power Down Instruction = not supported = FFh Bits 14:13 = Exit Deep Power Down to next operation delay units = (00b: 128 ns, 01b: 1 µs, 10b: 8 µs, 11b: 64 µs) = 64 µs = 11b Bits 12:8 = Exit Deep Power Down to next operation delay count = 11111b, Exit Deep Power Down to next operation delay = (count + 1) * units = not supported Bits 7:4 = RFU = Fh Bit 3:2 = Status Register Polling Device Busy = 01b: Legacy status polling supported = Use legacy polling by reading the Status Register with 05h instruction and checking WIP bit[0] (0 = ready; 1 = busy). Bits 1:0 = RFU = 11b Binary Fields: 1-11111111-11111111-11-11111-1111-01-11 Nibble Format: 1111_1111_1111_1111_1111_1111_1111_0111 Hex Format: FF_FF_FF_F7
37h	35h		FFh	
38h	36h		FFh	
39h	37h		FFh	

Serial flash discoverable parameters (SFDP)
address map

Table 67 CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP Rev B (Continued)

CFI parameter relative byte address offset	SFDP parameter relative byte address offset	SFDP Dword name	Data	Description
3Ah	38h	JEDEC Basic Flash Parameter Dword-15	00h	Bits 31:24 = RFU = FFh Bit 23 = Hold and WP Disable = not supported = 0b Bits 22:20 = Quad Enable Requirements = 101b: QE is bit 1 of the status register 2 (SFDP spec calls this Status Register 2, FL127S calls this Configuration Register 1). Status register 1 is read using Read Status instruction 05h. Status register 2 (FL127S Configuration Register 1) is read using instruction 35h. QE is set via Write Status instruction 01h with two data bytes where bit 1 of the second byte is one. It is cleared via Write Status with two data bytes where bit 1 of the second byte is zero. Bits 19:16 0-4-4 Mode Entry Method = xxx1b: Mode Bits[7:0] = A5h Note: QE must be set prior to using this mode + x1xxb: Mode Bits[7:0] = Axh + 1xxxb: RFU = 1101b Bits 15:10 = 0-4-4 Mode Exit Method = xx_xxx1b: Mode Bits[7:0] = 00h will terminate this mode at the end of the current read operation + xx_1xxxb: Input Fh (mode bit reset) on DQ0-DQ3 for 8 clocks. This will terminate the mode prior to the next read operation. + x1_xxxxb: Mode Bit[7:0] != Axh + 1x_x1xx: RFU = 11_1101 Bit 9 = 0-4-4 mode supported = 1 Bits 8:4 = 4-4-4 mode enable sequences = 0_0000b: 4-4-4 not supported = 00000b Bits 3:0 = 4-4-4 mode disable sequences = 0000b: 4-4-4 not supported = 0000b Binary Fields: 11111111-0-101-1101-111101-1-00000-0000 Nibble Format: 1111_1111_0101_1101_1111_0110_0000_0000 Hex Format: FF_5D_F6_00
3Bh	39h		F6h	
3Ch	3Ah		5Dh	
3Dh	3Bh		FFh	

Serial flash discoverable parameters (SFDP) address map

Table 67 CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP Rev B (Continued)

CFI parameter relative byte address offset	SFDP parameter relative byte address offset	SFDP Dword name	Data	Description
3Eh	3Ch	JEDEC Basic Flash Parameter Dword-16	F0h	Bits 31:24 = Enter 4-Byte Addressing = xxxx_1xxxb: 8-bit volatile bank register used to define A[30:A24] bits. MSb (bit[7]) is used to enable/disable 4-byte address mode. When MSb is set to '1', 4-byte address mode is active and A[30:24] bits are don't care. Read with instruction 16h. Write instruction is 17h with 1 byte of data. When MSb is cleared to '0', select the active 128 Mb segment by setting the appropriate A[30:24] bits and use 3-Byte addressing. + xx1x_xxxxb: Supports dedicated 4-Byte address instruction set. Consult vendor data sheet for the instruction set definition or look for 4 Byte Address Parameter Table. + 1xxx_xxxxb: Reserved = 10101000b Bits 23:14 = Exit 4-Byte Addressing = xx_xxxx_1xxxb: 8-bit volatile bank register used to define A[30:A24] bits. MSb (bit[7]) is used to enable/disable 4-byte address mode. When MSb is cleared to '0', 3-byte address mode is active and A30:A24 are used to select the active 128 Mb memory segment. Read with instruction 16h. Write instruction is 17h, data length is 1 byte. + xx_xx1x_xxxxb: Hardware reset + xx_x1xx_xxxxb: Software reset (see bits 13:8 in this DWORD) + xx_1xxx_xxxxb: Power cycle + x1_xxxx_xxxxb: Reserved + 1x_xxxx_xxxxb: Reserved = 1111101000b Bits 13:8 = Soft Reset and Rescue Sequence Support = x0_1xxxb: issue instruction F0h + 1x_xxxxb: exit 0-4-4 mode is required prior to other reset sequences above if the device may be operating in this mode. = 101000b Bit 7 = RFU = 1 Bits 6:0 = Volatile or Nonvolatile Register and Write Enable Instruction for Status Register 1 = xx1_xxxxb: Status Register 1 contains a mix of volatile and nonvolatile bits. The 06h instruction is used to enable writing of the register. + x1x_xxxxb: Reserved + 1xx_xxxxb: Reserved = 1110000b Binary Fields: 10101000-1111101000-101000-1-1110000 Nibble Format: 1010_1000_1111_1010_0010_1000_1111_0000 Hex Format: A8_FA_28_F0
3Fh	3Dh		28h	
40h	3Eh		FAh	
41h	3Fh		A8h	

Serial flash discoverable parameters (SFDP)
address map

Table 67 CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP Rev B (Continued)

CFI parameter relative byte address offset	SFDP parameter relative byte address offset	SFDP Dword name	Data	Description
42h	40h	JEDEC Sector Map Parameter Dword-1 Config. Detect-1	FCh	Bits 31:24 = Read data mask = 10000000b: Select bit 7 of the data byte for D8h_O value Bits 23:22 = Configuration detection command address length = 00b: No address Bits 21:20 = RFU = 11b Bits 19:16 = Configuration detection command latency = 0000b: zero latency Bits 15:8 = Configuration detection instruction = 07h: Read status register 2 Bits 7:2 = RFU = 111111b Bit 1 = Command Descriptor = 0 Bit 0 = not the end descriptor = 0 Binary Fields: 10000000-00-11-0000-00000111-111111-0-0 Nibble Format: 1000_0000_0011_0000_0000_0111_1111_1100 Hex Format: 80_30_07_FC
43h	41h		07h	
44h	42h		30h	
45h	43h		80h	
46h	44h	JEDEC Sector Map Parameter Dword-2 Config. Detect-1	FFh	Bits 31:0 = Sector map configuration detection command address = FFFFh: no address
47h	45h		FFh	
48h	46h		FFh	
49h	47h		FFh	
4Ah	48h	JEDEC Sector Map Parameter Dword-3 Config. Detect-2	FDh	Bits 31:24 = Read data mask = 00000100b: Select bit 2 of the data byte for TBPARM value Bits 23:22 = Configuration detection command address length = 00b: No address Bits 21:20 = RFU = 11b Bits 19:16 = Configuration detection command latency = 0000b: zero latency Bits 15:8 = Configuration detection instruction = 35h: Read configuration register 1 Bits 7:2 = RFU = 111111b Bit 1 = Command Descriptor = 0 Bit 0 = The end descriptor = 1 Binary Fields: 00000100-00-11-0000-00110101-111111-0-1 Nibble Format: 0000_0100_0011_0000_0011_0101_1111_1101 Hex Format: 04_30_35_FD
4Bh	49h		35h	
4Ch	4Ah		30h	
4Dh	4Bh		04h	

Serial flash discoverable parameters (SFDP)
address map

Table 67 CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP Rev B (Continued)

CFI parameter relative byte address offset	SFDP parameter relative byte address offset	SFDP Dword name	Data	Description
4Eh	4Ch	JEDEC Sector Map Parameter Dword-4 Config. Detect-2	FFh	Bits 31:0 = Sector map configuration detection command address = FFFFh: no address
4Fh	4Dh		FFh	
50h	4Eh		FFh	
51h	4Fh		FFh	
52h	50h	JEDEC Sector Map Parameter Dword-5 Config-0 Header	FEh	Bits 31:24 = RFU = FFh Bits 23:16 = Region count (Dwords - 1) = 01h: Two regions Bits 15:8 = Configuration ID = 00h: 4 KB sectors at bottom with remainder 64 KB sectors Bits 7:2 = RFU = 111111b Bit 1 = Map Descriptor = 1 Bit 0 = not the end descriptor = 0
53h	51h		00h	
54h	52h		01h	
55h	53h		FFh	
56h	54h	JEDEC Sector Map Parameter Dword-6 Config-0 Region-0	F3h	Bits 31:8 = Region size = 0000FFh: Region size as count – 1 of 256 Byte units = 16 x 4 KB sectors = 64 KB Count = 64KB/256 = 256, value = count – 1 = 256 – 1 = 255 = FFh Bits 7:4 = RFU = Fh Erase Type not supported = 0/ supported = 1 Bit 3 = Erase Type 4 support = 0b ---Erase Type 4 is not defined Bit 2 = Erase Type 3 support = 0b ---Erase Type 3 is 256 KB erase and is not supported in the 4 KB sector region Bit 1 = Erase Type 2 support = 1b ---Erase Type 2 is 64 KB erase and is supported in the 4 KB sector region Bits 0 = Erase Type 1 support = 1b ---Erase Type 1 is 4 KB erase and is supported in the 4 KB sector region
57h	55h		FFh	
58h	56h		00h	
59h	57h		00h	
5Ah	58h	JEDEC Sector Map Parameter Dword-7 Config-0 Region-1	F2h	Bits 31:8 = Region size = 00FEFFh: Region size as count – 1 of 256 Byte units = 255 x 64 KB sectors = 16320 KB Count = 16320 KB/256 = 65280, value = count – 1 = 65280 – 1 = 65279 = FEFFh Bits 4:7 = RFU = Fh Erase Type not supported = 0 / supported = 1 Bit 3 = Erase Type 4 support = 0b ---Erase Type 4 is not defined Bit 2 = Erase Type 3 support = 0b ---Erase Type 3 is 256 KB erase and is not supported in the 64 KB sector region Bit 1 = Erase Type 2 support = 1b ---Erase Type 2 is 64 KB erase and is supported in the 64 KB sector region Bit 0 = Erase Type 1 support = 0b --- Erase Type 1 is 4 KB erase and is not supported in the 64 KB sector region
5Bh	59h		FFh	
5Ch	5Ah		FEh	
5Dh	5Bh		00h	

Serial flash discoverable parameters (SFDP) address map

Table 67 CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP Rev B (Continued)

CFI parameter relative byte address offset	SFDP parameter relative byte address offset	SFDP Dword name	Data	Description
5Eh	5Ch	JEDEC Sector Map Parameter Dword-8 Config-1 Header	FEh	Bits 31:24 = RFU = FFh Bits 23:16 = Region count (Dwords – 1) = 01h: Two regions Bits 15:8 = Configuration ID = 01h: 4KB sectors at top with remainder 64KB sectors Bits 7:2 = RFU = 111111b Bit 1 = Map Descriptor = 1 Bit 0 = not the end descriptor = 0
5Fh	5Dh		01h	
60h	5Eh		01h	
61h	5Fh		FFh	
62h	60h	JEDEC Sector Map Parameter Dword-9 Config-1 Region-0	F2h	Bits 31:8 = Region size = 00FEFFh: Region size as count – 1 of 256 Byte units = 255 x 64KB sectors = 16320 KB Count = 16320KB/256 = 65280, value = count – 1 = 65280 – 1 = 65279 = FEFFh Bits 4:7 = RFU = Fh Erase Type not supported = 0/ supported = 1 Bit 3 = Erase Type 4 support = 0b ---Erase Type 4 is not defined Bit 2 = Erase Type 3 support = 0b ---Erase Type 3 is 256 KB erase and is not supported in the 64 KB sector region Bit 1 = Erase Type 2 support = 1b ---Erase Type 2 is 64 KB erase and is supported in the 64 KB sector region Bit 0 = Erase Type 1 support = 0b --- Erase Type 1 is 4 KB erase and is not supported in the 64 KB sector region
63h	61h		FFh	
64h	62h		FEh	
65h	63h		00h	
66h	64h	JEDEC Sector Map Parameter Dword-10 Config-1 Region-1	F3h	Bits 31:8 = Region size = 0000FFh: Region size as count – 1 of 256 Byte units = 16 x 4 KB sectors = 64 KB Count = 64 KB/256 = 256, value = count – 1 = 256 – 1 = 255 = FFh Bits 7:4 = RFU = Fh Erase Type not supported = 0/ supported = 1 Bit 3 = Erase Type 4 support = 0b ---Erase Type 4 is not defined Bit 2 = Erase Type 3 support = 0b ---Erase Type 3 is 256 KB erase and is not supported in the 4 KB sector region Bit 1 = Erase Type 2 support = 1b ---Erase Type 2 is 64 KB erase and is supported in the 4 KB sector region Bit 0 = Erase Type 1 support = 1b ---Erase Type 1 is 4 KB erase and is supported in the 4 KB sector region
67h	65h		FFh	
68h	66h		00h	
69h	67h		00h	
6Ah	68h	JEDEC Sector Map Parameter Dword-11 Config-2 Header	FEh	Bits 31:24 = RFU = FFh Bits 23:16 = Region count (Dwords – 1) = 00h: One region Bits 15:8 = Configuration ID = 02h: Uniform 256KB sectors Bits 7:2 = RFU = 111111b Bit 1 = Map Descriptor = 1 Bit 0 = The end descriptor = 0
6Bh	69h		02h	
6Ch	6Ah		00h	
6Dh	6Bh		FFh	

Serial flash discoverable parameters (SFDP) address map

Table 67 CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP Rev B (Continued)

CFI parameter relative byte address offset	SFDP parameter relative byte address offset	SFDP Dword name	Data	Description
6Eh	6Ch	JEDEC Sector Map Parameter Dword-12 Config-2 Region-0	F4h	Bits 31:8 = Region size = 00FFFFh: Region size as count – 1 of 256 Byte units = 16MB/256 = 64K Count = 65536, value = count – 1 = 65536 – 1 = 65535 = FFFFh Bits 4:7 = RFU = Fh Erase Type not supported = 0/ supported = 1 Bit 3 = Erase Type 4 support = 0b ---Erase Type 4 is not defined Bit 2 = Erase Type 3 support = 1b ---Erase Type 3 is 256 KB erase and is supported in the 256 KB sector region Bit 1 = Erase Type 2 support = 0b ---Erase Type 2 is 64 KB erase and is not supported in the 256 KB sector region Bit 0 = Erase Type 1 support = 0b --- Erase Type 1 is 4 KB erase and is not supported in the 256 KB sector region
6Fh	6Dh		FFh	
70h	6Eh		FFh	
71h	6Fh		00h	
72h	70h	JEDEC Sector Map Parameter Dword-13 Config-3 Header	FFh	Bits 31:24 = RFU = FFh Bits 23:16 = Region count (Dwords – 1) = 00h: One region Bits 15:8 = Configuration ID = 03h: Uniform 256 KB sectors Bits 7:2 = RFU = 111111b Bit 1 = Map Descriptor = 1 Bit 0 = The end descriptor = 1
73h	71h		03h	
74h	72h		00h	
75h	73h		FFh	
76h	74h	JEDEC Sector Map Parameter Dword-14 Config-3 Region-0	F4h	Bits 31:8 = Region size = 00FFFFh: Region size as count – 1 of 256 Byte units = 16 MB/256 = 64K Count = 65536, value = count – 1 = 65536 – 1 = 65535 = FFFFh Bits 4:7 = RFU = Fh Erase Type not supported = 0/ supported = 1 Bit 3 = Erase Type 4 support = 0b ---Erase Type 4 is not defined Bit 2 = Erase Type 3 support = 1b ---Erase Type 3 is 256 KB erase and is supported in the 256 KB sector region Bit 1 = Erase Type 2 support = 0b ---Erase Type 2 is 64 KB erase and is not supported in the 256 KB sector region Bit 0 = Erase Type 1 support = 0b --- Erase Type 1 is 4 KB erase and is not supported in the 256 KB sector region
77h	75h		FFh	
78h	76h		FFh	
79h	77h		00h	

Serial flash discoverable parameters (SFDP) address map

Table 67 CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP Rev B (Continued)

CFI parameter relative byte address offset	SFDP parameter relative byte address offset	SFDP Dword name	Data	Description
7Ah	78h	JEDEC 4 Byte Address Instructions Parameter Dword-1	FFh	Supported = 1, Not Supported = 0 Bits 31:20 = RFU = FFFh Bit 19 = Support for nonvolatile individual sector lock write command, Instruction = E3h = 1 Bit 18 = Support for nonvolatile individual sector lock read command, Instruction = E2h = 1 Bit 17 = Support for volatile individual sector lock Write command, Instruction = E1h = 1 Bit 16 = Support for volatile individual sector lock Read command, Instruction = E0h = 1 Bit 15 = Support for (1-4-4) DTR_Read Command, Instruction = EEh = 0 Bit 14 = Support for (1-2-2) DTR_Read Command, Instruction = BEh = 0 Bit 13 = Support for (1-1-1) DTR_Read Command, Instruction = 0Eh = 0 Bit 12 = Support for Erase Command – Type 4 = 0 Bit 11 = Support for Erase Command – Type 3 = 1 Bit 10 = Support for Erase Command – Type 2 = 1 Bit 9 = Support for Erase Command – Type 1 = 1 Bit 8 = Support for (1-4-4) Page Program Command, Instruction = 3Eh =0 Bit 7 = Support for (1-1-4) Page Program Command, Instruction = 34h = 1 Bit 6 = Support for (1-1-1) Page Program Command, Instruction = 12h = 1 Bit 5 = Support for (1-4-4) FAST_READ Command, Instruction = ECh = 1 Bit 4 = Support for (1-1-4) FAST_READ Command, Instruction = 6Ch = 1 Bit 3 = Support for (1-2-2) FAST_READ Command, Instruction = BCh = 1 Bit 2 = Support for (1-1-2) FAST_READ Command, Instruction = 3Ch = 1 Bit 1 = Support for (1-1-1) FAST_READ Command, Instruction = 0Ch = 1 Bit 0 = Support for (1-1-1) READ Command, Instruction = 13h = 1
7Bh	79h		0Eh	
7Ch	7Ah		FFh	
7Dh	7Bh		FFh	
7Eh	7Ch	JEDEC 4 Byte Address Instructions Parameter Dword-2	21h	Bits 31:24 = FFh = Instruction for Erase Type 4: RFU Bits 23:16 = DCh = Instruction for Erase Type 3 Bits 15:8 = DCh = Instruction for Erase Type 2 Bits 7:0 = 21h = Instruction for Erase Type 1
7Fh	7Dh		DCh	
80h	7Eh		DCh	
81h	7Fh		FFh	

Serial flash discoverable parameters (SFDP)
address map

13.3 Device ID and Common Flash Interface (ID-CFI) ASO Map — Automotive Only

The CFI Primary Vendor-Specific Extended Query is extended to include Electronic Marking information for device traceability.

Table 68 Device ID and Common Flash Interface (ID-CFI) map automotive only

Address	Data field	# of bytes	Data Format	Example of actual data	Hex read out of example data
(SA) + 0180h	Size of Electronic Marking	1	Hex	20	14h
(SA) + 0181h	Revision of Electronic Marking	1	Hex	1	01h
(SA) + 0182h	Fab Lot #	8	ASCII	LD87270	4Ch, 44h, 38h, 37h, 32h, 37h, 30h, FFh
(SA) + 018Ah	Wafer #	1	Hex	23	17h
(SA) + 018Bh	Die X Coordinate	1	Hex	10	0Ah
(SA) + 018Ch	Die Y Coordinate	1	Hex	15	0Fh
(SA) + 018Dh	Class Lot #	7	ASCII	BR33150	42h, 52h, 33h, 33h, 31h, 35h, 30h
(SA) + 0194h	Reserved for Future	12	N/A	N/A	FFh, FFh, FFh, FFh, FFh, FFh, FFh, FFh, FFh, FFh, FFh, FFh

Fab Lot # + Wafer # + Die X Coordinate + Die Y Coordinate gives a unique ID for each device.

Serial flash discoverable parameters (SFDP) address map

13.4 Registers

The register maps are copied in this section as a quick reference. See **"Registers"** on page 57 for the full description of the register contents.

Table 69 Status Register 1 (SR1)

Bits	Field name	Function	Type	Default state	Description
7	SRWD	Status Register Write Disable	Nonvolatile	0	1 = Locks state of SRWD, BP, and configuration register bits when WP# is LOW by ignoring WRR command 0 = No protection, even when WP# is LOW
6	P_ERR	Programming Error Occurred	Volatile, Read only	0	1 = Error occurred 0 = No Error
5	E_ERR	Erase Error Occurred	Volatile, Read only	0	1= Error occurred 0 = No Error
4	BP2	Block Protection	Volatile if CR1[3]=1, Nonvolatile if CR1[3] = 0	1 if CR1[3] = 1, 0 when shipped from Cypress	Protects selected range of sectors (Block) from Program or Erase
3	BP1				
2	BP0				
1	WEL	Write Enable Latch	Volatile	0	1 = Device accepts Write Registers (WRR), program or erase commands 0 = Device ignores Write Registers (WRR), program or erase commands This bit is not affected by WRR, only WREN and WRDI commands affect this bit.
0	WIP	Write in Progress	Volatile, Read only	0	1= Device Busy, a Write Registers (WRR), program, erase or other operation is in progress 0 = Ready Device is in standby mode and can accept commands

Serial flash discoverable parameters (SFDP)
address map

Table 70 Configuration Register (CR1)

Bits	Field name	Function	Type	Default state	Description
7	LC1	Latency Code	Nonvolatile	0	Selects number of initial read latency cycles See Latency Code Tables
6	LC0			0	
5	TBPROT	Configures Start of Block Protection	OTP	0	1 = BP starts at bottom (Low address) 0 = BP starts at top (High address)
4	RFU	RFU	OTP	0	Reserved for Future Use
3	BPNV	Configures BP2–0 in Status Register	OTP	0	1 = Volatile 0 = Nonvolatile
2	TBPARM	Configures Parameter Sectors location	OTP	0	1 = 4-KB physical sectors at top, (High address) 0 = 4-KB physical sectors at bottom (Low address) RFU in uniform sector devices.
1	QUAD	Puts the device into Quad I/O operation	Nonvolatile	0	1 = Quad 0 = Dual or Serial
0	FREEZE	Lock current state of BP2-0 bits in Status Register, TBPROT and TBPARM in Configuration Register, and OTP regions	Volatile	0	1 = Block Protection and OTP locked 0 = Block Protection and OTP un-locked

Table 71 Status Register 2 (SR2)

Bits	Field name	Function	Type	Default state	Description
7	D8h_O	Block Erase Size	OTP	0	1 = 256 KB Erase (Uniform sectors). 0 = 64 KB Erase (Hybrid 4 KB / 64 KB sectors).
6	02h_O	Page Buffer Wrap	OTP	0	1 = Wrap at 512B. 0 = Wrap at 256B.
5	IO3R_O	IO3 Reset	OTP	0	1 = IO3 alternate function is RESET#. 0 = IO3 alternate function is HOLD#.
4	RFU	Reserved		0	Reserved for Future Use.
3	RFU	Reserved		0	Reserved for Future Use.
2	RFU	Reserved		0	Reserved for Future Use
1	ES	Erase Suspend	Volatile, Read only	0	1 = In erase suspend mode. 0 = Not in erase suspend mode.
0	PS	Program Suspend	Volatile, Read only	0	1 = In program suspend mode. 0 = Not in program suspend mode.

Serial flash discoverable parameters (SFDP)
address map

Table 72 Bank Address Register (BAR)

Bits	Field name	Function	Type	Default state	Description
7	EXTADD	Extended Address Enable	Volatile	0b	1 = 4-byte (32-bits) addressing required from command. 0 = 3-byte (24-bits) addressing from command + Bank Address
6 to 2	RFU	Reserved	Volatile	00000b	Reserved for Future Use
1	BA25	Bank Address	Volatile	0	RFU for lower density devices
0	BA24	Bank Address	Volatile	0	RFU for lower density device

Table 73 ASP Register (ASPR)

Bits	Field name	Function	Type	Default state	Description
15 to 9	RFU	Reserved	OTP	1	Reserved for Future Use
8	RFU	Reserved	OTP		Reserved for Future Use
7	RFU	Reserved	OTP		Reserved for Future Use
6	RFU	Reserved	OTP	1	Reserved for Future Use
5	RFU	Reserved	OTP		Reserved for Future Use
4	RFU	Reserved	OTP		Reserved for Future Use
3	RFU	Reserved	OTP		Reserved for Future Use
2	PWDMLB	Password Protection Mode Lock Bit	OTP	1	0 = Password Protection Mode permanently enabled 1 = Password Protection Mode not permanently enabled
1	PSTMLB	Persistent Protection Mode Lock Bit	OTP	1	0 = Persistent Protection Mode permanently enabled 1 = Persistent Protection Mode not permanently enabled
0	RFU	Reserved	OTP	1	Reserved for Future Use

Serial flash discoverable parameters (SFDP)
address map

Table 74 Password Register (PASS)

Bits	Field name	Function	Type	Default state	Description
63 to 0	PWD	Hidden Password	OTP	FFFFFFFF–FFFFFFFFh	Nonvolatile OTP storage of 64-bit password. The password is no longer readable after the password protection mode is selected by programming ASP register bit 2 to 0.

Table 75 PPB Lock Register (PPBL)

Bits	Field name	Function	Type	Default state	Description
7 to 1	RFU	Reserved	Volatile	00h	Reserved for Future Use
0	PPBLOCK	Protect PPB Array	Volatile	Persistent Protection Mode = 1 Password Protection Mode = 0	0 = PPB array protected until next power cycle or hardware reset 1 = PPB array may be programmed or erased

Table 76 PPB Access Register (PPBAR)

Bits	Field name	Function	Type	Default state	Description
7 to 0	PPB	Read or Program per sector PPB	Nonvolatile	FFh	00h = PPB for the sector addressed by the PPBRD or PPBP command is programmed to “0”, protecting that sector from program or erase operations. FFh = PPB for the sector addressed by the PPBRD or PPBP command is erased to “1”, not protecting that sector from program or erase operations.

Table 77 DYB Access Register (DYBAR)

Bits	Field name	Function	Type	Default state	Description
7 to 0	DYB	Read or Write per sector DYB	Volatile	FFh	00h = DYB for the sector addressed by the DYBRD or DYBP command is cleared to “0”, protecting that sector from program or erase operations. FFh = DYB for the sector addressed by the DYBRD or DYBP command is set to “1”, not protecting that sector from program or erase operations.

Serial flash discoverable parameters (SFDP)
address map

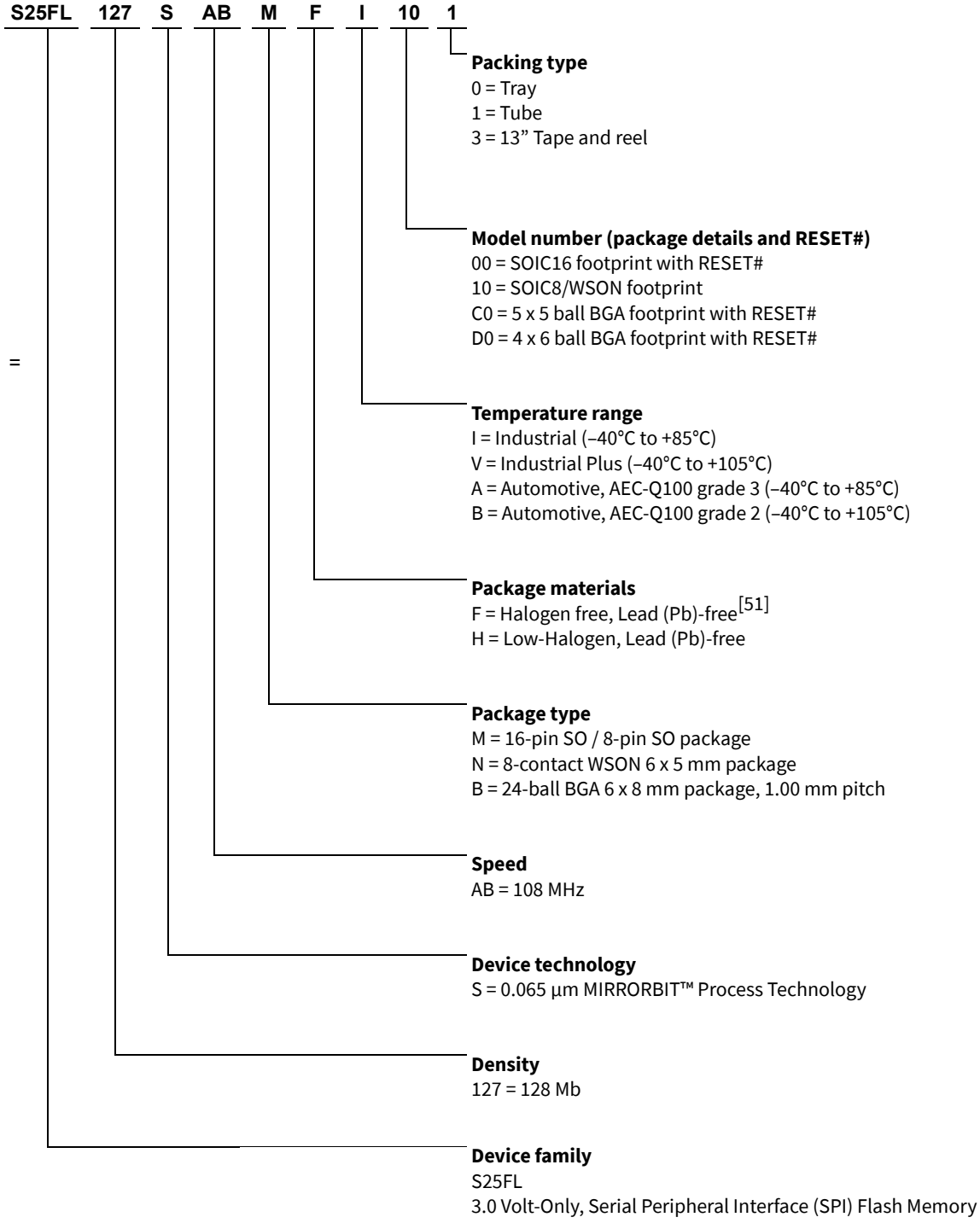
13.5 Initial delivery state

The device is shipped from Infineon with nonvolatile bits set as follows:

- The entire memory array is erased: i.e. all bits are set to 1 (each byte contains FFh).
- The OTP address space has the first 16 bytes programmed to a random number. All other bytes are erased to FFh.
- The SFDP address space contains the values as defined in the description of the SFDP address space.
- The ID-CFI address space contains the values as defined in the description of the ID-CFI address space.
- The Status Register 1 contains 00h (all SR1 bits are cleared to 0's).
- The Configuration Register 1 contains 00h.
- The Autoboot register contains 00h.
- The Password Register contains FFFFFFFF–FFFFFFFFh
- All PPB bits are 1.

14 Ordering information

The ordering part number is formed by a valid combination of the following:



Note
51.Halogen free definition is in accordance with IEC 61249-2-21 specification.

14.1 Valid combinations

Valid combinations list configurations planned to be supported in volume for this device. Contact your local sales office to confirm availability of specific valid combinations and to check on newly released combinations.

Table 78 S25FL127S valid combinations

Valid combinations					
Base ordering part number	**Speed option**	**Package and temperature**	**Model number**	**Packing type**	**Package marking**[52]
S25FL127S	AB	MFI, MFV	00, 10	0, 1, 3	FL127 + S + (Temp) + F + (Model Number)
	AB	NFI, NFV	10		FL127 + S + (Temp) + F + (Model Number)
	AB	BHI, BHV	C0, D0	0, 3	FL127 + S + (Temp) + H + (Model Number)

14.2 Valid combinations — automotive grade / AEC-Q100

Table 79 lists configurations that are automotive grade / AEC-Q100 qualified and are planned to be available in volume. The table will be updated as new combinations are released. Contact your local sales representative to confirm availability of specific combinations and to check on newly released combinations.

Production part approval process (PPAP) support is only provided for AEC-Q100 grade products.

Products to be used in end-use applications that require ISO/TS-16949 compliance must be AEC-Q100 grade products in combination with PPAP. Non–AEC-Q100 grade products are not manufactured or documented in full compliance with ISO/TS-16949 requirements.

AEC-Q100 grade products are also offered without PPAP support for end-use applications that do not require ISO/TS-16949 compliance.

Table 79 S25FL127S valid combinations — automotive grade / AEC-Q100[52]

Valid Combinations					
Base ordering part number	**Speed Option**	**Package and Temperature**	**Model Number**	**Packing Type**	**Package Marking**[52]
S25FL127S	AB	MFA, MFB	00, 10	0, 1, 3	FL127 + S + (Temp) + F + (Model Number)
	AB	NFA, NFB	10		FL127 + S + (Temp) + F + (Model Number)
	AB	BHA, BHB	C0, D0	0, 3	FL127 + S + (Temp) + H + (Model Number)

Note
52.Example, S25FL127SABMFI100 package marking would be FL127SIF10.

Revision history

Document revision	Date	Description of changes
**	2012-12-11	Initial release.
*A	2013-04-25	Global: Data sheet designation updated from Advance Information to Preliminary Performance Summary: Maximum Read Rates table: corrected Dual and Quad Read 'Clock Rate' and 'Mbytes/s' Migration Notes: FL Generations Comparison table: corrected Dual Read Speed and Quad Read Speed for FL127S DC Characteristics: DC Characteristics table: corrected ICC1 Test Conditions for Quad Capacitance Characteristics: Capacitance table: updated note AC Characteristics: AC Characteristics table: corrected Max value for FSCK,C dual and quad command Physical Interface: 8-pin Plastic Small Outline Package (SO) figure: corrected marking 8-Contact USON 6x5 mm, Top View figure: corrected marking 24-Ball BGA, 5 x 5 Ball Footprint (FAB024), Top View figure: removed VIO 24-Ball BGA, 4 x 6 Ball Footprint (FAC024), Top View: removed VIO Command Set Summary: S25FL127S Command Set (sorted by function) table: corrected Maximum Frequency for ABRD, DOR, 4DOR, QOR, 4QOR, DIOR, 4DIOR, QIOR, 4QIOR Embedded Algorithm Performance Tables: Added paragraph Program and Erase Performance table: - added 'Erase per Sector' Parameter - added note Software Interface Reference: FL127S Command Set (sorted by instruction) table: corrected Maximum Frequency for DOR, 4DOR, QOR, 4QOR, DIOR, 4DIOR, QIOR, 4QIOR Serial Flash Discoverable Parameters (SFDP) Address Map: CFI Alternate Vendor-Specific Extended Query Parameter 90h – Latency Code table: corrected Description for 68h Ordering Information: Valid Combinations table: corrected Package Marking and Note
*B	2013-07-26	Features: Added 16-pin SOIC package Glossary: Updated description of Page Signal Descriptions: Changed description of RESET# Hardware Reset (RESET#): Changed RESET# description from "may be left unconnected in the host system if not used" to "should be left unconnected in the host system if not used" Separate RESET# Input Initiated Hardware (Warm) Reset: Changed RESET# description from "may be left unconnected" to "should be left unconnected if not used" SOIC 16-Lead Package: Added section Ordering Information: Added 16-pin SOIC package
*C	2013-09-11	Global: Replaced USON with WSON

Revision history

Document revision	Date	Description of changes
*D	2013-11-15	Global: Data sheet designation updated from Preliminary to Full Production Physical Interface: Updated 8-pin Plastic Small Outline Package (SO) figure Command Set Summary: S25FL127S Command Set (sorted by function) table: added RSFDP command Command Summary: FL127S Command Set (sorted by instruction) table: added RSFDP command
*E	2015-05-28	JEDEC JESD216 Serial Flash Discoverable Parameters (SFDP) Space: Changed JESD216 to JESD216B Serial Flash Discoverable Parameters (SFDP) Address Map: Updated section Updated SFDP Overview Map table SFDP Header Field Definitions: Updated SFDP Header table Updated CFI Alternate Vendor-Specific Extended Query Parameter A5h, JEDEC SFDP table
*F	2015-08-24	Replaced “Automotive Temperature Range” with “Industrial Plus Temperature Range” in all instances across the document. Updated to Cypress template.
*G	2016-07-13	Updated **Serial flash discoverable parameters (SFDP) address map**: Updated **Device ID and Common Flash Interface (ID-CFI) address map**: Updated **Field definitions**: Updated **Table 67** (Updated entire table). Updated to new template.

Document revision	Date	Description of changes
*H	2017-03-24	Updated **Features**: Added ECC information. Added Automotive temperature range support. Updated **Overview**: Updated **Glossary**: Added ECC definition. Updated **Electrical specifications**: Updated **Operating ranges**: Updated **Temperature ranges**: Added Automotive temperature range support. Updated **Address space maps**: Updated **Registers**: Updated **Table 21**: Added ECC Status Register information. Added **ECC Status Register (ECCSR)**. Updated **Data protection**: Updated **Secure silicon region (OTP)**: Updated **Programming OTP memory space**: Added ECC information. Updated **Commands**: Updated **Command set summary**: Updated **Command summary sorted by function**: Updated **Table 40**: Added ECC Read command information. Updated **Register Access commands**: Added **ECC Status Register Read (ECCRD 18h)** Updated **Program Flash Array commands**: Added **Automatic ECC**. Updated **Software interface reference**: Updated **Command summary**: Updated **Table 50**. Updated **Physical interface**: Updated **SOIC 8-lead package**: Updated **SOIC 8 physical diagram**: Updated **Figure 35**. Updated **SOIC 16-lead package**: Updated **SOIC 16 physical diagram**: Updated **Figure 37**. Updated **FAB024 24-ball BGA package**: Updated **Physical diagram**: Updated **Figure 41**. Updated **FAC024 24-ball BGA package**: Updated **Physical diagram**: Updated **Figure 43**. Updated to new template. Completing Sunset Review.
*I	2017-06-08	Updated **Ordering information**: No change in part numbers. Updated **Valid combinations**: Updated **Table 78**: Fixed typo (Replaced “S25FL128S, S25FL256S” with “S25FL127S” in title). Updated **Valid combinations — automotive grade / AEC-Q100**: Updated **Table 79**: Fixed typo (Replaced “S25FL128S, S25FL256S” with “S25FL127S” in title).

Revision history

Document revision	Date	Description of changes
*J	2019-04-30	Updated **Timing specifications**: Added **Thermal resistance**. Updated **Address space maps**: Updated **Registers**: Updated **Configuration Register 1 (CR1)**: Updated **Table 23**. Updated **Ordering information**: Removed Note “Halogen free definition is in accordance with IEC 61249-2-21 specification.” and its reference. Updated to new template. Completing Sunset Review.
*K	2022-07-25	Updated Document Title to read as “S25FL127S, 128 Mb (16 MB) FL-S Flash SPI Multi-I/O, 3.0 V”. Replaced “Cypress” with “Infineon” in required instances across the document. Updated **Overview**: Removed “Glossary”. Removed “Other Resources”. Updated **SPI with multiple input / output (SPI-MIO)**: Replaced “Hardware interface” with “SPI with multiple input / output (SPI-MIO)” in heading. Updated **Signal descriptions**: Updated **Chip Select (CS#)**: Updated description. Updated **Signal protocols**: Updated **Data protection**: Updated description. Updated **Electrical specifications**: Updated **Thermal resistance**: Updated **Table 7**. Updated **DC characteristics**: Updated **Table 10**. Removed “Software interface”. Updated **Address space maps**: Updated **Registers**: Updated **Configuration Register 1 (CR1)**: Updated **Table 23**. Updated **Commands**: Updated **Command set summary**: Updated **Command summary sorted by function**: Updated **Table 40**. Migrated to Infineon template.

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